

**59401A**

# **BUS SYSTEM ANALYZER**

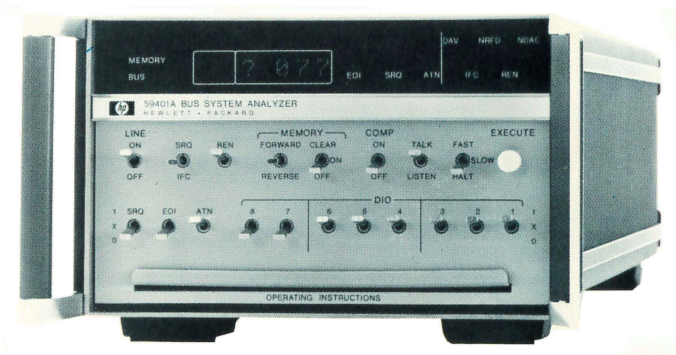
**59401A**



**59401-90002**  
**Printed in U.S.A.**

# OPERATING AND SERVICE MANUAL

## BUS SYSTEM ANALYZER 59401A



 **HEWLETT  
PACKARD**



**MODEL 59401A BUS SYSTEM ANALYZER  
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REPLY REQUESTED?

YES

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LOVELAND, COLORADO 80537  
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HEWLETT  
PACKARD

## OPERATING AND SERVICE MANUAL

MODEL 59401A

### BUS SYSTEM ANALYZER

Applies to Serials Prefixed 1914A

#### IMPORTANT NOTICE

*This manual does not normally require change sheets. All backdating and major change information is integrated into the manual by means of revised pages. However, in cases where only minor changes are required, a change sheet may be supplied. A record of all revisions and changes is located behind the title page. Any changed information is indicated by a vertical bar in the margin and/or a numbered delta ( $\Delta_1$ ). The  $\Delta_1$  refers to a corresponding footnote which explains the change and tells which serial numbers the change applies to.*

#### WARNING

*To help prevent potential fire or shock hazard, do not expose this instrument to rain or moisture.*

Manual Part No. 59401-90002

Microfiche Part No. 59401-90052

Revision B

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P.O. Box 301, Loveland, Colorado 80537 U.S.A.

Printed: February 1979



**HEWLETT  
PACKARD**

### **CERTIFICATION**

*Hewlett-Packard Company certifies that this product met its published specifications at the time of shipment from the factory. Hewlett-Packard further certifies that its calibration measurements are traceable to the United States National Bureau of Standards, to the extent allowed by the Bureau's calibration facility, and to the calibration facilities of other International Standards Organization members.*

### **WARRANTY**

This Hewlett-Packard product is warranted against defects in material and workmanship for a period of one year from date of shipment [except that in the case of certain components listed in Section I of this manual, the warranty shall be for the specified period] . During the warranty period, Hewlett-Packard Company will, at its option, either repair or replace products which prove to be defective.

For warranty service or repair, this product must be returned to a service facility designated by -hp-. Buyer shall prepay shipping charges to -hp- and -hp- shall pay shipping charges to return the product to Buyer. However, Buyer shall pay all shipping charges, duties, and taxes for products returned to -hp- from another country.

Hewlett-Packard warrants that its software and firmware designated by -hp- for use with an instrument will execute its programming instructions when properly installed on that instrument. Hewlett-Packard does not warrant that the operation of the instrument, or software, or firmware will be uninterrupted or error free.

### **LIMITATION OF WARRANTY**

The foregoing warranty shall not apply to defects resulting from improper or inadequate maintenance by Buyer, Buyer-supplied software or interfacing, unauthorized modification or misuse, operation outside of the environmental specifications for the product, or improper site preparation or maintenance.

**NO OTHER WARRANTY IS EXPRESSED OR IMPLIED. HEWLETT-PACKARD SPECIFICALLY DISCLAIMS THE IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A PARTICULAR PURPOSE.**

### **EXCLUSIVE REMEDIES**

**THE REMEDIES PROVIDED HEREIN ARE BUYER'S SOLE AND EXCLUSIVE REMEDIES. HEWLETT-PACKARD SHALL NOT BE LIABLE FOR ANY DIRECT, INDIRECT, SPECIAL, INCIDENTAL, OR CONSEQUENTIAL DAMAGES, WHETHER BASED ON CONTRACT, TORT, OR ANY OTHER LEGAL THEORY.**

### **ASSISTANCE**

*Product maintenance agreements and other customer assistance agreements are available for Hewlett-Packard products.*

*For any assistance, contact your nearest Hewlett-Packard Sales and Service Office. Addresses are provided at the back of this manual.*

# Record of Revisions.

## Model 59401A Bus System Analyzer

### Manual Part Number 59401-90002

Hewlett-Packard Company issues revisions periodically to keep manuals up-to-date. A manual becomes "Revision A" the first time it is reprinted with revised material included. Thus, each revision is associated with a particular date. Each revised page bears the notation "Rev A" at the bottom of the page; It also has a vertical bar in the margin adjacent to the revised information. The second revision of the manual is "Rev. B", and so on.

The Record of Revisions pages provide an index to all of the revised material in the manual. They apply only to manuals with the part number shown at the top of this page. Keep this record with your manual for future reference.

	Pages	Title	Nature of Change
Rev. A 5-13-77	Title Page		Revision Level and Date
	iii	Table of Contents	Page Numbers
	3-1, 4-3	Note	Update Wording (09-14792)
	3-5, 3-8		Correct Errors
	4-1	Table 4-1	Update
	4-2	Table 4-2	Update Test Equipment
	5-1		Correct Wording
	6-12	Parts List MP23	Update Part Number
	7-27		Correct Error
	7-45		Enhance Description
	Appendix A	Introduction	Add
	B1, B2	Appendix B	Add Letter of Appendix
	C1 - C3	Appendix C	Add Letter of Appendix
Rev. B 7-1-78	Title Page		Revision Level and Date
	iii	Record of Revisions	New Format
	iv	Safety Summary	Add
	v, vi	Table of Contents	Added New Page 7-39b
	6-5	Table 6-1	New Part Number for A2J1 (09-15835)
	6-6, 7, 8	Table 6-1	New Part Number for A3U106, Deleted Part Numbers for 13C103, C104, C108, J106, R125-147, U105, U111, U115 - U117 for Units above Serial Number 1714A00490 (09-16291)
	6-10		Correct Part Number for MP1, 2
	7-2, 3, 7, 13, 14, 17, 18	Table 7-1	Changed IC Dictionary for U105, U106, U111, U115 - 177 for Units above Serial Number 1714A00409 (09-16291)
	7-27, 29	Figure 7-2, 3	Change A3 Component Locator to Fit Revision Boards for Units above Serial Number 1714A00490 (09-16280)
	7-37	Figure 7-6a	Change A3 Component Locator and Circuit to Fit Both Rev. A & B Boards (09-16280)
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## **SAFETY SUMMARY**

The following general safety precautions must be observed during all phases of operation, service, and repair of this instrument. Failure to comply with these precautions or with specific warnings elsewhere in this manual violates safety standards of design, manufacture, and intended use of the instrument. Hewlett-Packard Company assumes no liability for the customer's failure to comply with these requirements. This is a Safety Class 1 instrument.

### **GROUND THE INSTRUMENT**

To minimize shock hazard, the instrument chassis and cabinet must be connected to an electrical ground. The instrument is equipped with a three-conductor ac power cable. The power cable must either be plugged into an approved three-contact electrical outlet or used with a three-contact to two-contact adapter with the grounding wire (green) firmly connected to an electrical ground (safety ground) at the power outlet. The power jack and mating plug of the power cable meet International Electrotechnical Commission (IEC) safety standards.

### **DO NOT OPERATE IN AN EXPLOSIVE ATMOSPHERE**

Do not operate the instrument in the presence of flammable gases or fumes. Operation of any electrical instrument in such an environment constitutes a definite safety hazard.

### **KEEP AWAY FROM LIVE CIRCUITS**

Operating personnel must not remove instrument covers. Component replacement and internal adjustments must be made by qualified maintenance personnel. Do not replace components with power cable connected. Under certain conditions, dangerous voltages may exist even with the power cable removed. To avoid injuries, always disconnect power and discharge circuits before touching them.

### **DO NOT SERVICE OR ADJUST ALONE**

Do not attempt internal service or adjustment unless another person, capable of rendering first aid and resuscitation, is present.

### **DO NOT SUBSTITUTE PARTS OR MODIFY INSTRUMENT**

Because of the danger of introducing additional hazards, do not install substitute parts or perform any unauthorized modification to the instrument. Return the instrument to a Hewlett-Packard Sales and Service Office for service and repair to ensure that safety features are maintained.

### **DANGEROUS PROCEDURE WARNINGS**

Warnings, such as the example below, precede potentially dangerous procedures throughout this manual. Instructions contained in the warnings must be followed.

#### **WARNING**

**Dangerous voltages, capable of causing death, are present in this instrument. Use extreme caution when handling, testing, and adjusting.**



## SAFETY SYMBOLS

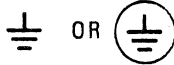
### General Definitions of Safety Symbols Used On Equipment or In Manuals.



Instruction manual symbol: the product will be marked with this symbol when it is necessary for the user to refer to the instruction manual in order to protect against damage to the instrument.



Indicates dangerous voltage (terminals fed from the interior by voltage exceeding 1000 volts must be so marked).



Protective conductor terminal. For protection against electrical shock in case of a fault. Used with field wiring terminals to indicate the terminal which must be connected to ground before operating equipment.



Low-noise or noiseless, clean ground (earth) terminal. Used for a signal common, as well as providing protection against electrical shock in case of a fault. A terminal marked with this symbol must be connected to ground in the manner described in the installation (operating) manual, and before operating the equipment.



Frame or chassis terminal. A connection to the frame (chassis) of the equipment which normally includes all exposed metal structures.



Alternating current (power line).



Direct current (power line).



Alternating or direct current (power line).

**WARNING**

The WARNING sign denotes a hazard. It calls attention to a procedure, practice, condition or the like, which, if not correctly performed or adhered to, could result in injury or death to personnel.



The CAUTION sign denotes a hazard. It calls attention to an operating procedure, practice, condition or the like, which, if not correctly performed or adhered to, could result in damage to or destruction of part or all of the product.

**NOTE :**

The NOTE sign denotes important information. It calls attention to procedure, practice, condition or the like, which is essential to highlight.

## SECTION I

### GENERAL INFORMATION

#### 1-1. INTRODUCTION.

1-2. This manual contains installation and operating instructions, and general performance information for the Model 59401A Bus System Analyzer.

1-3. This section of the manual contains a general description and performance specifications of the Model 59401A. Also included in this section are lists of accessories supplied with the 59401A, other accessories available, and instrument and manual identification information.

#### 1-4. DESCRIPTION.

1-5. The Model 59401A Bus System Analyzer is designed to assist the Hewlett-Packard Interface Bus (HP-IB) user in designing hardware as well as diagnosing software and hardware problems. The 59401A acts as a "listener", "talker", "controller", or "systems controller" for complete testing of HP-IB systems.

#### 1-6. SPECIFICATIONS.

1-7. Table 1-1 is a complete listing of the -hp- Model 59401A critical specifications that are controlled by tolerances. Table 1-2 contains general information that describes the operating characteristics of the Model 59401A.

1-8. Any change in the specifications due to manufacturing, design, or traceability to the U.S. National Bureau of Standards will be listed on the manual change sheet included with this manual. The manual and manual change sheet supersede all previous information concerning specifications of the 59401A.

**Table 1-1. Specifications.**

Listen
Accept Time: < 750 ns
Ready Time: < 750 ns
Talk
1) Data changed > 500 ns before DAV pulled low
2) ATN driven low > 1 $\mu$ s before DAV pulled low
3) DAV driven high < 700 ns after NDAC is false
4) DAV driven low < 700 ns after NRFD is false, if conditions 1 and 2 are met
Power: 100/120/220/240 V + 5%, - 10%, 48 Hz to 66 Hz line operation $\leq$ 42 VA
Operating Temperature: 0° - 50° C
Storage Temperature: - 40° C - + 75° C
Humidity Range: < 95% R.H. 0° C - 40° C

**Table 1-2. General Information.**

External Clock Input: 1 standard power TTL gate input, 10 MHz repetition rate.
Compare Output: 1 standard power TTL gate output (LOW TRUE).
HP-IB: 1 Bus load (capable of driving 14 other bus devices).
Height: 14.55 cm (5.73 inches) including feet
13.28 cm (5.227 inches) without feet
Width: 24.51 cm (9.650 inches) with handles
20.51 cm (8.075 inches) without handles
Depth: 49.53 cm (19.500 inches) overall length
42.60 cm (16.775 inches) for rack mounting purposes
Weight: 5.64 kg (12 lb., 7 oz.)

#### 1-9. ACCESSORIES SUPPLIED.

1-10. The following accessories are supplied with the Model 59401A:

- One six foot bus cable, -hp- Accessory No. 10631B
- One power cable, -hp- Part No. 8120-1538
- One extender board, -hp- Part No. 5061-0734

#### 1-11. ACCESSORIES AVAILABLE.

1-12. The following accessories are available for the Model 59401A:

- Three foot bus cable, -hp- Accessory No. 10631A
- Twelve foot bus cable, -hp- Accessory No. 10631C
- Six foot BNC interconnecting cable, -hp- Accessory No. 10519A
- Rack Mount Frame, -hp- Part No. 5020-8862
- Filler Panel, -hp- Part No. 5061-0006

#### 1-13. Instrument and Manual Identification.

1-14. Instrument identification by serial number is located on the rear panel of the instrument. Hewlett-Packard uses a two section serial number consisting of a four-digit prefix and a five-digit suffix, separated by a letter designating the country in which the instrument was manufactured (A = USA; G = West Germany; J = Japan; U = United Kingdom).

1-15. This manual applies to instruments with the serial numbers shown on the title page. If changes have been made in the instrument since this manual was printed, a "Manual Changes" supplement supplied with the manual will define these changes. Be sure to record these changes in your manual. Backdating information in the back of this manual adapts it to instruments with serial numbers lower than that shown on the title page. Part numbers for the manual and the microfiche copy of the manual are also shown on the title page.



## SECTION II

### INSTALLATION

#### 2-1. INTRODUCTION.

2-2. This section contains information and instructions necessary for installing and interfacing the Model 59401A Bus System Analyzer. Included are initial inspection procedures, power and grounding requirements, environmental information, installation instructions, interface connection procedures, and instructions for repackaging for shipment.

#### 2-3. INITIAL INSPECTION.

2-4. This instrument was carefully inspected both mechanically and electrically before shipment. It should be free of marks or scratches and in perfect electrical order upon receipt. To confirm this, the instrument should be inspected for physical damage incurred in transit. If the instrument has been damaged, file a claim with the carrier as soon as possible. Check for supplied accessories (Paragraph 1-9) and test the electrical performance of the instrument using the performance test procedures outlined in Section IV. If there is damage or deficiency, refer to the warranty in the front of this manual.

#### 2-5. POWER REQUIREMENTS.

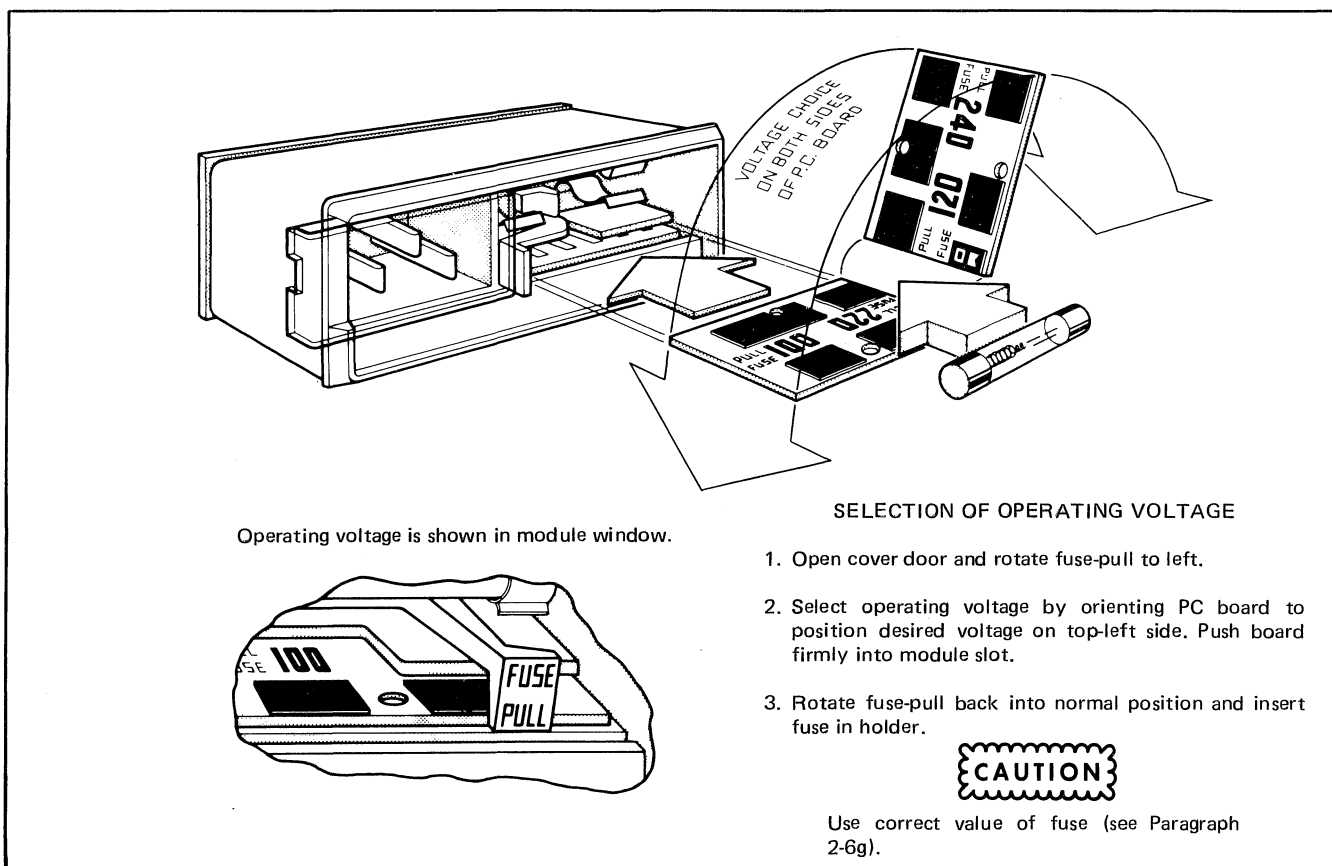
2-6. The Model 59401A can be operated from any power source supplying 100 V, 120 V, 200 V or 240 V (-10%, +5%), 48 Hz to 66 Hz. Power dissipation is 42 VA maximum. A circuit board located beneath the power fuse in the power input module is used to select the appropriate voltage operation. The instrument leaves the manufacturer with this circuit board in the 120 V position. To operate the Model 59401A from another voltage, use the following procedure and Figure 2-1.



*Before switching on this instrument:*

*Make sure the instrument is set to the voltage of the power source.*

*Make sure that only fuses with the required rated current and of the specified type (normal blow, time delay, etc.) are used for replacement. The use of repaired fuses and the short-circuiting of fuse holders must be avoided.*



- a. Remove the power cord from the Model 59401A.
- b. Slide the plastic power module cover to the left to gain access to the fuse compartment.
- c. Remove the line fuse by pulling outward on the fuse puller (see Figure 2-1).
- d. Remove the printed circuit board located beneath the fuse holder.
- e. Position the circuit board such that the desired operating voltage is on the left side of the upper surface.
- f. Replace the circuit board. The selected voltage should be visible after the board is replaced.
- g. Install the appropriate line fuse. (For 110/120 volt operation, use a 1A normal blow fuse, -hp- Part No. 2110-0001; for 220/240 volt operation, use a 500 mA normal blow fuse, -hp- Part No. 2110-0012.)

## 2-7. POWER CORDS.

2-8. Figure 2-2 illustrates the various power cords that are available for the Model 59401A. The part number is shown above each plug drawing. If the appropriate power cord is not included with the instrument, notify the nearest -hp- Sales and Service Office and a replacement power cord will be provided.

## 2-9. GROUNDING REQUIREMENTS.

2-10. To protect operating personnel, the National Electrical Manufacturers Association (NEMA) recommends that the instrument panel and cabinet be grounded. The Model 59401A is equipped with a three-wire power cable which, when plugged into an appropriate receptacle, grounds the instrument. The offset pin on the power cable is the ground connection.

## 2-11. ENVIRONMENTAL REQUIREMENTS.

### 2-12. Cooling.

2-13. The Model 59401A is cooled by convection. The instrument should not be mounted in any manner which can obstruct the flow of air around it.

### 2-14. Operating and Storage Temperature.

2-15. The Model 59401A should not be operated where the ambient temperature range exceeds 0°C (32°F) to 50°C (131°F) or stored where the ambient temperature range exceeds -40°C (-40°F) to 75°C (167°F).

## 2-16. INSTALLATION.

### 2-17. Bench Use.

2-18. The Model 59401A is shipped with plastic feet and tilt stands in place, ready for use as a bench instrument. The front of the instrument may be elevated for convenience of operating and viewing by lowering the tilt stands.

### 2-19. Rack Mounting.

2-20. The Model 59401A may be rack mounted by using an adapter frame, -hp- Part No. 5020-8862. This adapter frame fits all standard 19 inch racks and accepts a combination of submodular units for rack mounting only. If only the 59401A is to be rack mounted, the half modular filler panel, -hp- Part No. 5061-0006, is also required.

## 2-21. INTERFACE CONNECTIONS.

2-22. The Model 59401A is connected to the Hewlett-Packard Interface Bus (HP-IB) with the bus cable provided (-hp- Accessory No. 10631B). This cable is a 24 conductor shielded cable terminated at each end with identical dual blue ribbon connectors. These connectors permit one cable to be plugged into another, eliminating the need for special "Y" or split cables.

2-23. All bus lines may be monitored at test points on the rear panel.

2-24. Two BNC connectors are also provided on the rear panel. The COMPARE OUTPUT, provides a TTL compatible pulse when coincidence occurs between the bus data and the code selected by the front panel DIO switches. The EXT CLOCK input allows the 59401A to be driven at any rate up to maximum HP-IB speed by means of an external signal source.

## 2-25. REPACKAGING FOR SHIPMENT.

2-26. The following paragraphs contain a general guide for repackaging the instrument for shipment. Refer to Paragraph 2-27 if the original container is to be used; 2-28 if it is not. If you have any questions, contact your nearest -hp- Sales and Service Office (see Appendix A for office locations).

### NOTE

*If the instrument is to be shipped to Hewlett-Packard for service or repair, attach a tag to the instrument identifying the owner and indicating the service or repair to be accomplished. Include the model number and full serial number of the instrument. In any correspondence, identify the instrument by model number and full serial number.*

2-27. Place the instrument in the original container with appropriate packing material and seal well with strong tape or metal bands. If the original container is not available, one can be purchased from your nearest -hp- Sales and Service Office.

2-28. If the original container is not to be used, proceed as follows:

a. Wrap the instrument in heavy paper or plastic before placing it in an inner container.

b. Place packing material around all sides of the instrument and protect the panel face with cardboard strips.

c. Place the instrument and inner container in a heavy carton or wooden box and seal with strong tape or metal bands.

d. Mark the shipping container "DELICATE INSTRUMENT", "FRAGILE", etc.

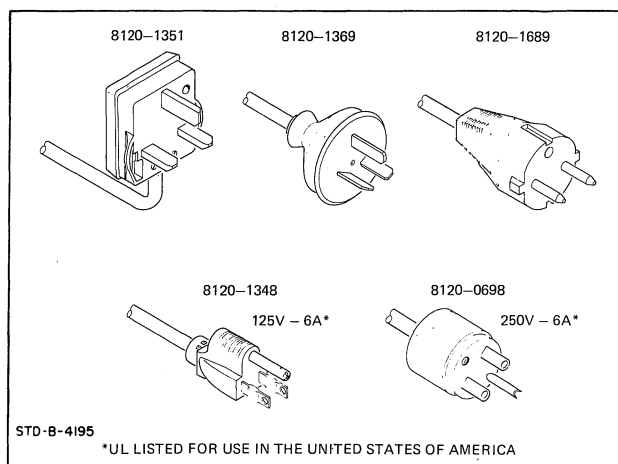


Figure 2-2. Power Cords.



## SECTION III

### OPERATING INSTRUCTIONS

#### 3-1. INTRODUCTION.

3-2. This section contains information and instructions necessary for operation of the -hp- Model 59401A Bus System Analyzer. Included is a functional description of all controls, indicators, and connectors and basic operating procedures and considerations.

#### 3-3. INSTRUMENT CAPABILITIES.

3-4. The Model 59401A is designed to aid HP-IB users in hardware design and in diagnosing hardware and software problems encountered in HP-IB compatible systems. Basically, the 59401A has two modes of operation, as described in the following paragraphs.

#### 3-5. Listen Mode.

3-6. When used as a "listen" device the Model 59401A monitors Bus traffic and can accept and store up to 32 characters from the Bus for later examination, or can be used to compare Bus information to a code selected by the front panel DIO switches. When coincidence occurs between the code selected and the Bus signal, a pulse output is provided at the rear panel COMPARE OUTPUT jack. The 59401A can also be set to stop all Bus traffic when coincidence occurs.

#### 3-7. Talk Mode.

3-8. When used in the "talk" mode the 59401A is used to drive the Bus. The Bus can be driven one character at a time by setting the DIO switches to the appropriate code and outputting this information to the Bus. It is also possible to store a program of up to 32 characters in the 59401A memory and output this information to the Bus at a rate determined by the front panel FAST/SLOW/HALT switch. This switch selects speeds of one character at a time, two characters per second, or full HP-IB system speed.

#### NOTE

*For a description of the Hewlett-Packard Interface Bus, refer to the Hewlett-Packard Interface Bus Abbreviated Description which can be purchased through your local Sales and Service Office under part number 5955-2903. Also available is the pocket-sized HP-IB Quick Reference Card, Part Number 5955-2902.*

#### 3-9. CONTROLS AND INDICATORS.

3-10. Figure 3-1 illustrates groups of controls and indicators. These groups are classified according to function.

Location and a brief description of individual controls are given in Figure 3-2.

#### 3-11. GENERAL OPERATING INSTRUCTIONS.

#### 3-12. Turn On.

#### WARNING

*Before switching on the instrument, the protective earth terminals of the instrument must be connected to the protective conductor of the (mains) power cord. The mains plug shall only be inserted in a socket outlet provided with a protective earth contact. The protective action must not be negated by the use of an extension cord (power cable) without a protective conductor (grounding). Grounding one conductor of a two conductor outlet is not sufficient protection.*

*Ensure that all devices connected to this instrument are connected to the protective (earth) ground.*

3-13. Before connecting ac power to the Model 59401A, make certain the proper operating voltage has been selected to correspond to the voltage of the available power line as outlined in Paragraph 2-6.

#### 3-14. Bus Connection.

3-15. The Model 59401A is connected to the Bus by means of the HP-IB cable provided. Connection can be made at any point on the Bus by plugging this cable into any mating connector on the system cables.

#### 3-16. OPERATING PROCEDURES.

3-17. The following paragraphs describe the basic operating modes of the Model 59401A. These modes are presented in order of operating complexity. To avoid confusion, it is suggested that the operator follow the sequence of operating procedures to familiarize himself with the capabilities of the Model 59401A.

#### NOTE

*For simplicity of explanation, the following operating procedures are written using the Model 59401A to test a system consisting of one or more instruments controlled by an -hp- Model 9820A, 9821A or 9830A Calculator.*

*However, these operating procedures also ap-*



*ply to the testing of individual HP-IB compatible devices and systems controlled by devices other than the calculators mentioned, such as, computers, card readers, or another Model 59401A.*

### 3-18. LISTEN MODES.

3-19. The "listen" modes of the Model 59401A are used to monitor signals on the Bus. The three "listen" modes available are LISTEN/HALT, which monitors Bus signals one byte at a time, LISTEN/SLOW, which monitors the Bus signals at a two bytes per second rate, and LISTEN/FAST, which allows the Bus to be monitored at full system speed.

### 3-20. LISTEN/HALT Mode.

3-21. The LISTEN/HALT mode of the 59401A monitors Bus signals one character at a time. To use this mode, set the front panel switches as follows:

```

LINE .....ON
REN .....OFF
MEMORY, CLEAR/ON/OFF .....OFF
COMP .....OFF
TALK/LISTEN .....LISTEN
FAST/SLOW/HALT .....HALT

```

3-22. Clear the Bus by pressing the calculator STOP key. Start the system program by pressing the calculator RUN PROGRAM or RUN, EXECUTE key(s).

3-23. The first program step should be displayed on the 59401A digital readout (both the ASCII character and the octal equivalent). If not, momentarily press the 59401A EXECUTE button.

3-24. The following 59401A indicator lights should be lit:

BUS	(Indicating the 59401A is monitoring the Bus.)
ATN	(IF the program step is a command, such as a listen or talk address or unaddress code.)
DAV	(Indicates the information on the Bus is valid.)
NRFD	(Indicates the data has been accepted by one or more instruments on the Bus and that they are not ready for further data at this time.)
NDAC	(Indicates that not all units have accepted the data. In this case, the 59401A is usually the last instrument to accept data.)
REN	(Permits instruments on the Bus to go to remote control.)

#### NOTE

*For a description of the Hewlett-Packard Interface Bus, refer to the Hewlett-Packard Interface Bus Abbreviated Description which can be pur-*

*chased through your local Sales and Service Office under part number 5955-2903.*

3-25. The "system" program is stepped by momentarily pressing the 59401A EXECUTE button.

#### NOTE

*Data observed on the 59401A digital readout is valid only when the DAV indicator is lit. It is possible for invalid data to be displayed when the EXECUTE button is held in.*

3-26. The sequence of Bus control (handshake) signals is as follows:

a. The "talker" puts data on the data lines and drives the DAV line low to indicate the data is valid.

b. The fastest "listener" accepts the data and sets NRFD low.

c. All other instruments on the Bus accept the data at their individual rates.

d. The 59401A accepts the data and allows NDAC to go high when the EXECUTE button is pressed.

e. The "talker" senses NDAC high, sets DAV high, and puts new data on the Bus.

f. Instruments on the Bus become "ready for data" (set NDAC low and NRFD high).

g. The 59401A sets its NDAC output low and allows NRFD to go high when the EXECUTE button is released.

h. The "talker" senses NRFD high and sets DAV low, starting the cycle over.

### 3-27. LISTEN/SLOW Mode.

3-28. Operation of the 59401A in the LISTEN/SLOW mode is similar to that of the LISTEN/HALT mode, except data on the Bus is automatically read at a two character per second rate.

3-29. To use the LISTEN/SLOW mode to monitor the Bus, set the front panel switches as follows:

```

LINE .....ON
REN .....OFF
MEMORY, CLEAR/ON/OFF .....OFF
COMP .....OFF
TALK/LISTEN .....LISTEN
FAST/SLOW/HALT .....SLOW

```

3-30. Clear the Bus by pressing the calculator STOP key and start the system program by pressing the calculator RUN PROGRAM or RUN, EXECUTE key(s).

3-31. The Bus data will automatically be displayed on the 59401A digital readout at two characters per second.

### 3-32. LISTEN/FAST Mode.

3-33. The LISTEN/FAST mode allows monitoring of the Bus at full system speed or at any rate up to full system speed by using an external signal to drive the rear panel EXTERNAL CLOCK INPUT. To display the Bus data it is necessary to store the Bus information in the 59401A memory and then recall it one character at a time. The following paragraphs describe use of the memory and compare features of the Model 59401A.

### 3-34. Memory.

3-35. The memory feature of the Model 59401A can be used to store up to 32 bytes of data for later reference or can be used to store a program from the Bus to be later output by the 59401A. The 59401A has a memory capacity of 32 characters (bytes).

3-36. To use the memory feature, first clear the memory by switching the OFF/ON/CLEAR switch to CLEAR and releasing. The memory OFF/ON/CLEAR switch should now be in the ON position. Bus data is now loaded into

memory as the 59401A accepts data. Current data is loaded into memory location 31, the previous contents of location 31 are shifted to location 30, the contents of 30 to 29 and so on, leaving the last program byte stored in location 31. If the program is greater than 32 steps, only the last 32 characters will be stored. All previous data will be lost.

### 3-37. Compare.

3-38. In the LISTEN modes the compare feature (COMP) outputs a pulse at the rear panel COMPARE OUTPUT jack and can be used to halt all Bus traffic when the Bus signal matches the code set on the 59401A lower switch register. A TTL compatible pulse is output in all modes whether the COMP switch is OFF or ON. Bus traffic is halted only when the COMP switch is ON.

3-39. When used with the memory feature, any 32 character segment of a program can be stored by setting the 59401A lower switch register to the code of the last character to be observed and setting the COMP switch to ON. The 59401A will store the program until the program information matches the code selected on the lower switch register and then halt the Bus.

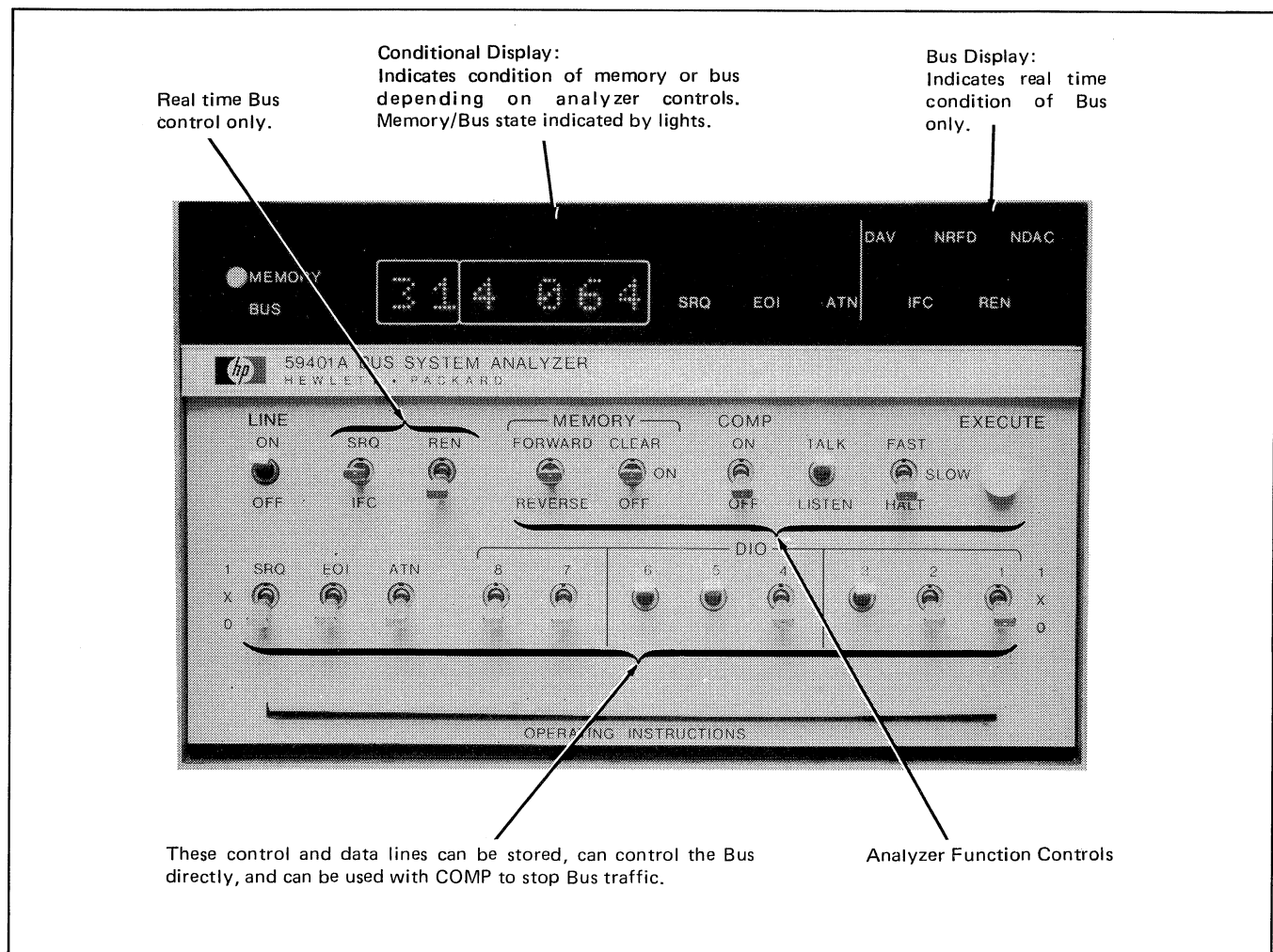


Figure 3-1. Control and Indication Groups.

3-40. When a lower register switch is set to the "X" (don't care) position it automatically matches the corresponding data bit on the Bus.

#### NOTE

*The MEMORY and COMPARE features apply to all "listen" modes but are most commonly used with the LISTEN/FAST mode.*

3-41. To use the LISTEN/FAST mode, set the 59401A front panel switches as follows:

```

LINE .....ON
REN .....OFF
MEMORY, CLEAR/ON/OFF .... CLEAR-ON
COMP .....ON
TALK/LISTEN .....LISTEN
FAST/SLOW/HALT .....FAST

```

Set the lower switch register (SRQ, EOI, ATN, and DIO 1 through 8) to the code of the last character to be observed.

3-42. Clear the Bus by pressing the calculator STOP key and start the system program by pressing the calculator RUN PROGRAM or RUN, EXECUTE key(s).

3-43. The 59401A will automatically halt the Bus when the Bus signal matches the code selected on the lower switch register.

3-44. To display the memory contents, switch the MEMORY FORWARD/REVERSE switch to FORWARD or REVERSE. The first two digits of the display will show the memory location being monitored and the last four digits will show the ASCII character and octal equivalent stored in that location. To step the memory, momentarily switch the FORWARD/REVERSE switch to FORWARD or REVERSE. The 59401A will automatically step the memory at a two character per second rate if this switch is held in FORWARD or REVERSE.

3-45. To monitor another portion of the program, reset the lower switch register to the code of the character desired, momentarily switch the CLEAR/ON/OFF switch to CLEAR and press the EXECUTE button. The 59401A will again store the Bus signals until the code selected matches the Bus data.

#### NOTE

*The MEMORY and COMPARE features do not have to be used in conjunction with one another. The method described in the previous paragraphs is the most common application of these features; however, they may be used separately.*

### 3-46. TALK Modes.

3-47. The Talk modes are used to drive the Bus. The TALK/HALT mode drives the Bus at one character at a time or is used to load program information into the 59401A memory. The TALK/SLOW mode outputs a program stored in memory at a two character per second rate and the TALK/FAST mode outputs the stored program at full system speed.

### 3-48. TALK/HALT Mode (Memory OFF).

3-49. To use the TALK/HALT mode to output data to the Bus, set the front panel switches as follows:

```

LINE .....ON
REN .....ON
MEMORY, CLEAR/ON/OFF .....OFF
COMP .....OFF
TALK/LISTEN .....TALK
FAST/SLOW/HALT .....HALT

```

Insure that the 59401A has control of the Bus by momentarily switching the SRQ/IFC switch to IFC.



*When using the 59401A to test an HP-IB compatible system, it is possible for the 59401A and another instrument on the Bus to be "talking" at the same time. This condition can result in damage to the tri-state output drivers of the 59401A. To insure that no other instrument is talking when the 59401A is to be used to drive the Bus, it is necessary to momentarily switch the SRQ/IFC switch to IFC. When the 59401A is not being used to drive the Bus it should be placed in one of the "listen" modes or in the TALK/HALT/MEMORY ON mode.*

Set the code of the character to be output to the Bus on the lower switch register (SRQ, EOI, ATN, and DIO 1 through 8).

3-50. The 59401A digital readout will display the ASCII character and the octal equivalent corresponding to the position of the DIO switches. The state of the SRQ, EOI, and ATN switches will be shown by the appropriate indicators.

#### NOTE

*If the display information does not agree with the setting of the front panel switches, it is likely that another instrument on the Bus is driving some of the Bus lines. This condition can be overcome by momentarily switching the 59401A SRQ/IFC switch to IFC. (See the CAUTION in Paragraph 3-49.)*

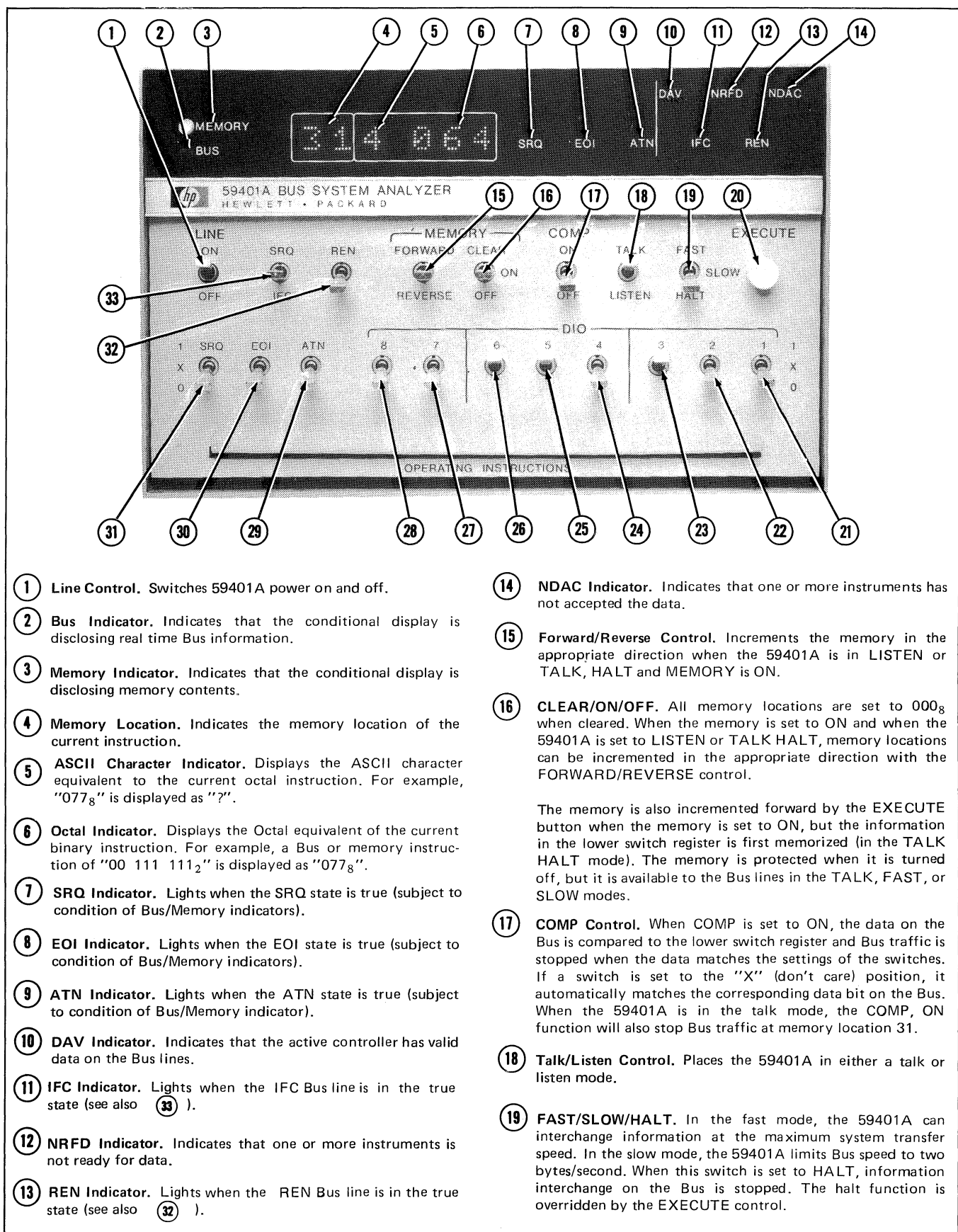


Figure 3-2. Controls and Indicators.

<p><b>20 Execute Control.</b> When EXECUTE is pressed:</p> <p>a. In LISTEN, HALT, the 59401A accepts one character.</p> <p>b. In TALK, HALT, MEMORY OFF, the 59401A sends one character.</p> <p>c. In TALK, HALT, MEMORY ON, the 59401A loads one character into memory.</p> <p>d. In LISTEN, FAST or SLOW, COMP ON, the 59401A permits Bus traffic to continue.</p> <p>e. In TALK, FAST or SLOW the 59401A continues sending data.</p> <p>f. In LISTEN, MEMORY ON (after use of the FORWARD/REVERSE switch has put the 59401A into memory mode), the 59401A leaves the memory mode.</p>	<p><b>26 DIO6 Control*.</b> This switch controls the <math>100000_2</math> (<math>40_8</math>) data line.</p> <p><b>27 DIO7 Control*.</b> This switch controls the <math>1000000_2</math> (<math>100_8</math>) data line.</p> <p><b>28 DIO8 Control*.</b> This switch controls the <math>10000000_2</math> (<math>200_8</math>) data line.</p> <p><b>29 ATN Control*.</b> The 59401A can address an instrument or deliver universal commands when this switch is set to the "1" position.</p> <p><b>30 EOI Control*.</b> EOI true (1) may indicate the end of a data string or, with ATN true, EOI puts the Bus in the parallel polling mode.</p> <p><b>31 SRQ Control*.</b> SRQ calls for the attention of the controller. Typically, this line is used with either the COMP switch or the COMPARE OUTPUT to detect the presence of SRQ in a program.</p>
<p><b>21 DIO1 Control*.</b> This switch controls the <math>1_2</math> (<math>1_8</math>) data line.</p> <p><b>22 DIO2 Control*.</b> This switch controls the <math>10_2</math> (<math>2_8</math>) data line.</p> <p><b>23 DIO3 Control*.</b> This switch controls the <math>100_2</math> (<math>4_8</math>) data line.</p> <p><b>24 DIO4 Control*.</b> This switch controls the <math>1000_2</math> (<math>10_8</math>) data line.</p> <p><b>25 DIO5 Control*.</b> This switch controls the <math>10000_2</math> (<math>20_8</math>) data line.</p>	<p><b>32 REN Control.</b> Instruments that can be set for remote operation are enabled to do so when this switch is set to REN.</p> <p><b>33 SRQ/IFC Control.</b> Setting this switch to IFC stops all communications on the Bus. Setting this switch to SRQ calls for the attention of the controller.</p>

\*The asterisked switches are in the true state when set to the "1" position. These switches are in the false state when set to the "0" position. The "X" (don't care) position is used when comparing the lower switch register to the bus contents. In the "X" position, a comparison is true whether the Bus contains a 1 or a 0. For example, if the DIO switches are set to 00 110 10X<sub>2</sub>, a comparison will be valid for either 00 110 100<sub>2</sub> or 00 110 101.

Figure 3-2. Controls and Indicators (Cont'd).

3-51. The information set on the lower switch register is output to the Bus by momentarily pressing the 59401A EXECUTE button.

3-52. The "handshake" signal sequence for this mode is as follows:

- Initially, DAV and NRFD are high and NDAC is low.
- The 59401A outputs the data set on the lower switch register and sets DAV low when the EXECUTE button is pressed in.
- The first instrument to accept the data sets NRFD low and NDAC high.
- All other instruments accept the data, set NRFD low and NDAC high at their particular rate.
- The last instrument to accept the data sets NDAC high.
- The 59401A senses NRFD low and NDAC high and sets DAV high when the EXECUTE button is released.

g. When DAV goes high, instruments on the bus set NRFD high and NDAC low at their individual rates, turning the Bus to the initial state.

#### NOTE

*For a description of HP-IB signals, refer to the Condensed Description of the Hewlett-Packard Interface Bus which can be purchased through your local Sales and Service Office.*

#### 3-53. TALK/HALT Mode (Memory ON).

3-54. This mode is used to program the 59401A memory. To load information into memory, set the front panel switches as follows:

LINE ..... ON  
 MEMORY, CLEAR/ON/OFF .... CLEAR-ON  
 TALK/LISTEN ..... TALK  
 FAST/SLOW/HALT ..... HALT

Set the memory to location "00" by momentarily switching the FORWARD/REVERSE switch to FORWARD.

3-55. Set the lower switch register to the code of the character to be stored (A list of the available ASCII characters and the octal codes is printed on the front panel "pull out" card.)

3-56. Store the information by pressing the EXECUTE button. When the EXECUTE button is pressed, the digital display shows the memory location and the information being stored in that location. When the EXECUTE button is released the memory is automatically stepped to the next location.

3-57. Repeat the steps in Paragraphs 3-55 and 3-56 until the desired program has been loaded.

3-58. Switch the MEMORY, CLEAR/ON/OFF switch to OFF to protect the memory contents.

### 3-59. TALK/SLOW Mode.

3-60. The TALK/SLOW mode automatically outputs data from the 59401A memory at two bytes per second. To use this mode, load the desired program in the 59401A memory as outlined in Paragraphs 3-53 through 3-58 and set the front panel switches as follows:

```

LINE ..... ON
REN ..... ON
MEMORY, CLEAR/ON/OFF ..... OFF
COMP ..... *
TALK/LISTEN ..... TALK
FAST/SLOW/HALT ..... SLOW

```

\*The COMP switch affects the 59401A operation as follows:

a. COMP OFF. The 59401A will continuously output the data stored in memory.

b. COMP ON (all lower register switches set to "0"). The 59401A will output the program data and halt transmission at memory location 31 if the program contains no information matching the lower switch register (octal code 000).

c. COMP ON (lower switch register set to the code of one of the program characters). The 59401A will output the program data until the program information matches the code set on the lower switch register and then halt transmission.

d. COMP ON (all lower register switches set to the "X" position). The 59401A will halt after outputting each program step. This permits transmitting one character at a time from the memory.

### NOTE

*In all cases the program starts at memory location "00".*

To make the 59401A continue outputting the program after it has halted, momentarily press the EXECUTE button.

3-61. The 59401A digital display will show the memory location and the program information stored in that location as it is output to the Bus.

### NOTE

*If the display indicates the information being output to the Bus disagrees with the information stored in memory, it is possible that another instrument on the Bus is driving some of the Bus lines. This condition can be overcome by momentarily switching the SRQ/IFC switch to IFC. (See the CAUTION in Paragraph 3-49.)*

### 3-62. TALK/FAST Mode.

3-63. Operation of the TALK/FAST mode is the same as the TALK/SLOW mode except the program information is output at full system speed or variable speed if an external source is used to drive the rear panel EXTERNAL CLOCK INPUT. To use this mode follow the procedure outlined in Paragraphs 3-59 through 3-61 with the exception of the FAST/SLOW/HALT switch. This switch should be set to FAST.

### 3-64. OPERATOR'S MAINTENANCE.

#### 3-65. Fuses.

3-66. The 59401A line fuse is located in the power input module on the rear panel. In addition to replacement, it is necessary to change this fuse when the 59401A is set to operate from a different line voltage (see Paragraph 2-5). To change the fuse, use the following procedure and Figure 2-1.

a. Remove the power cord from the Model 59401A.

b. Slide the plastic power module cover to the left to gain access to the fuse compartment.

c. Remove the line fuse by pulling outward and to the left on the fuse puller.

d. Rotate the fuse puller back to its normal position and insert the proper fuse in the holder. (For 110/120 volt operation, use a 1 A normal blow fuse, -hp- Part No. 2110-0001; for 220/240 volt operation, use a 500 mA normal blow fuse, -hp- Part No. 2110-0012.)

e. Slide the plastic cover to the right and replace the power cord.

**3-67. VERIFYING BUS INSTRUMENT INTERFACE FUNCTIONS.**

3-68. The Model 59401A is the ideal instrument for verifying that another bus instrument performs its designed interface functions in accordance with IEEE Standard 488-1975. A detailed procedure for performing the verification is given in Appendix A. Any questions the user may

have regarding these interface functions are answered in the standard.

3-69. Copies of IEEE Standard 488-1975 may be ordered from:

The Institute of Electrical and Electronic Engineers, Inc.  
345 East 47th Street  
New York, NY 10017

## SECTION IV PERFORMANCE TESTS

### 4-1. INTRODUCTION.

4-2. This section contains performance tests to verify that the Model 59401A is operating within its specifications. The 59401A contains no user maintainable assemblies. For service, contact the nearest -hp- Sales and Service Office. See Appendix B for office locations.

### 4-3. RECOMMENDED TEST EQUIPMENT.

4-4. Equipment required for the performance tests is listed in Table 4-1, Recommended Test Equipment. Any equipment that satisfies the critical specifications given in the table may be substituted for the recommended model(s).

**Table 4-1. Recommended Test Equipment.**

Instrument Type	Required Characteristics	Model
Digital Voltmeter	11 volts full scale, $\pm 3\%$ of reading plus 1 digit	-hp- 3476
Function Generator	100 kHz square wave, 0 to + 5 V, complimentary outputs	-hp- 3310A
Oscilloscope	Dual trace, 50 MHz bandwidth	-hp- 180C
DC Power Supply	+ 5 V dc, 1 amp	-hp- 6213A
Test Load	100 ohm load for each "bus" line	See Figure 4-1

### 4-5. PERFORMANCE TEST CARD.

4-6. A Performance Test Card is provided at the end of this section for the purpose of recording the results of the Performance Tests. This form lists all of the Performance Tests and their acceptable limits. The form may be removed from the manual and retained as a permanent record of the incoming inspection or routine maintenance performed on the instrument. The Test Card may be reproduced without written permission from Hewlett-Packard.

### 4-7. PERFORMANCE TESTS.

4-8. The following test verify that your instrument is operating within the specifications outlined in Table 1-1 of this manual. None of these tests require access to the interior of the instrument. If it has been determined, after completing the Performance Tests, that the instrument does not meet one or more of its specifications contact your nearest -hp- Sales and Service Office. See Appendix B for office locations.

#### NOTE

*Do not connect the Model 59401A to the Bus for any of the following Performance Tests.*

### 4-9. Display Indicator Test.

#### DESCRIPTION:

This procedure tests the operation of the Model 59401A front panel display indicators and individual LED's in the numeric display.

#### RECOMMENDED TEST EQUIPMENT:

This test does not require the use of any test equipment.

a. Set the lower row of switches to the "0" position. Set the upper switches as follows:

```

LINE .....ON
SRQ/IFC .....*
REN .....OFF
MEMORY, FORWARD/REVERSE .....*
MEMORY, CLEAR/ON/OFF .....OFF
COMP .....OFF
TALK/LISTEN .....TALK
FAST/SLOW/HALT .....HALT
  
```

\*Does not apply to test

b. Set the DIO switches as indicated in each step of Table 4-2. Observe that all LED's necessary to make up the character or numeral listed in the "Display" column of Table 4-2 light properly.

c. Switch the MEMORY, CLEAR/ON/OFF switch to ON. The BUS indicator should go off and the MEMORY indicator should come on. The numeric display should show memory location "31".

d. Momentarily switch the MEMORY, CLEAR/ON/OFF switch to CLEAR. The numeric display should show an octal code of "000". There should be no ASCII character displayed. All indicators except the MEMORY indicator should be off.

**Table 4-2. Numeric Display Test.**

Step	DIO Switch Settings 87 654 321	Display	
		ASCII Character	Octal Code
1	00 000 000		000
2	10 100 100	\$	244
3	11 110 110		366
4	11 111 111		377
5	01 001 001	I	111
6	01 001 000	H	110
7	00 100 011	#	043



e. Momentarily switch the MEMORY, FORWARD/REVERSE switch to FORWARD. The numeric display should show memory location "00". Momentarily switch the FORWARD/REVERSE switch to REVERSE. The numeric display should again show memory location "31". Hold the switch in the FORWARD position. The memory location numbers should automatically increase from 00 through 31 at a 2 character per second rate. Hold the switch in the REVERSE position. The memory location numbers should automatically decrease at a 2 character per second rate. Switch the CLEAR/ON/OFF switch to OFF.

f. Switch the SRQ, EOI, and ATN switches to the "1" position. The corresponding display indicators should light. Return the SRQ, EOI, and ATN switches to the "0" position.

g. Switch the SRQ/IFC switch to SRQ. The SRQ indicator should light. Switch to IFC and observe that the IFC indicator lights.

h. Switch the REN switch to REN and observe that the REN indicator lights. Return the REN switch to OFF.

i. Press the EXECUTE button and observe that the DAV indicator lights.

j. Switch the TALK/LISTEN switch to LISTEN. The NDAC indicator should light.

k. Use a clip lead to connect the rear panel DAV and NDAC test points. Press and hold the EXECUTE button. Observe that the NRFD indicator lights. Remove the clip lead.

#### 4-10. Switch Register Test.

##### DESCRIPTION:

This procedure tests the operation of the front panel control switches and the corresponding rear panel outputs.

##### RECOMMENDED TEST EQUIPMENT:

Digital Voltmeter, -hp- 3476  
DC Power Supply, -hp- 6213A  
Test Load, See Figure 4-1

a. Set the lower row of switches to the "0" position. Set the upper switches as follows:

LINE .....	ON
SRQ/IFC .....	*
REN .....	OFF
MEMORY, FORWARD/REVERSE .....	*
MEMORY, CLEAR/ON/OFF .....	OFF
COMP .....	OFF
TALK/LISTEN .....	TALK
FAST/SLOW/HALT .....	HALT

\*Does not apply to test

b. Connect the ground lead of the voltmeter to the ground lug on the rear panel of the 59401A. Measure the voltage of each test point on the printed circuit board which extends through the rear panel. These readings must be between + 2.4 and + 5.0 V dc.

c. Set all lower switches to the "X" position and again measure the rear panel test points. The voltage readings should be the same as those measured in Step b.

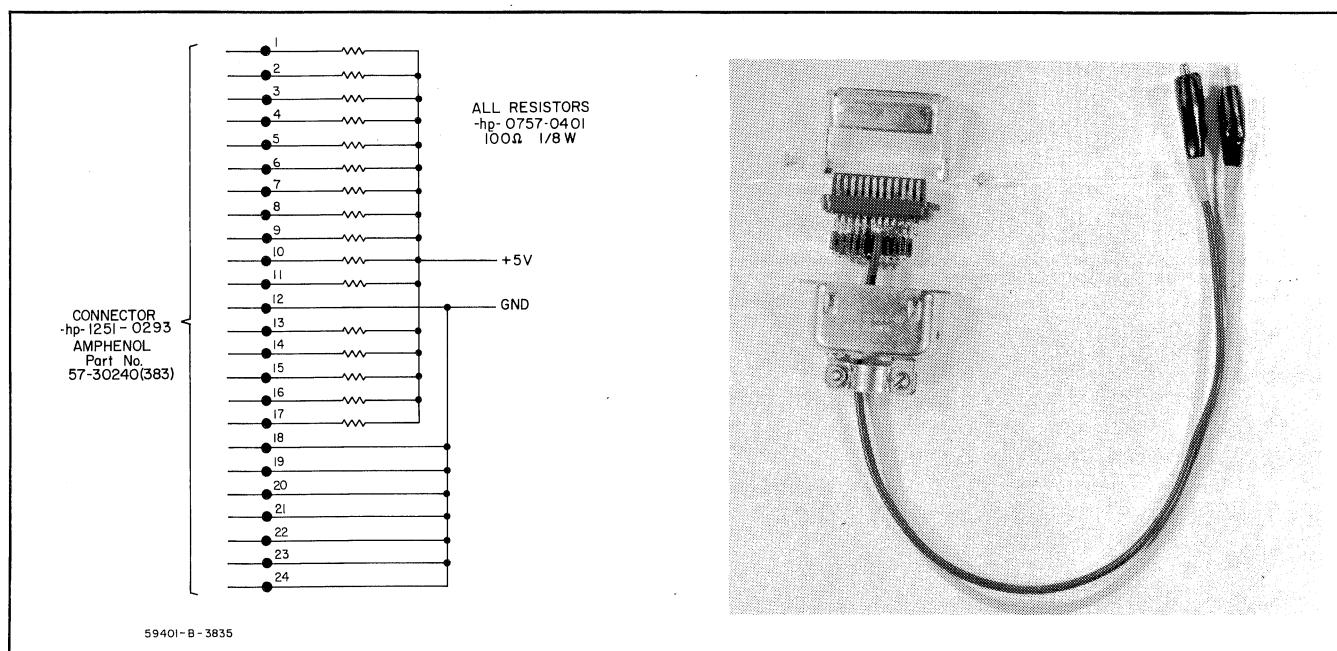


Figure 4-1. Test Load Construction.

- d. Adjust the Power Supply for an output of + 5 V dc.
- e. Connect the Test Load, described in Figure 4-1, to the rear panel "HP-IB" connector. Connect the Test Load ground lead to the negative output of the Power Supply and the + 5 lead to the positive output.
- f. Set all lower switches to the "1" position.
- g. Connect the Voltmeter common lead to the ground lead of the Test Load (negative output of the power supply). Measure the rear panel test points DIO 1 through 8 and SRQ, EOI, and ATN. The voltage readings must be less than +0.4 V dc. Return all lower switches to the "0" position.
- h. Hold the SRQ/IFC switch in the IFC position and measure the IFC test point. The voltage reading must be less than +0.4 V dc.
- i. Switch the REN switch to REN and measure the REN test point. The voltage reading must be less than +0.4 V dc.
- j. Press the EXECUTE button and measure the DAV test point. The voltage reading must be less than +0.4 V dc.
- k. Switch the TALK/LISTEN switch to LISTEN and measure the NDAC test point. The voltage reading should be less than +0.4 V dc.
- l. Use a clip lead to connect the rear panel DAV and NDAC test points. Press and hold the EXECUTE button. Measure the NRFD test point. The voltage reading should be less than +0.4 V dc. Remove the clip lead and Voltmeter test leads.
- m. Switch the TALK/LISTEN switch to TALK, the DIO 1 switch to "1", the COMP switch to ON, and the FAST/SLOW/HALT switch to SLOW. The numeric display should begin at memory location "00", count to memory location "31" and then halt. Press the EXECUTE button. The 59401A should repeat this sequence.
- n. Remove the Test Load from the 59401A.

#### 4-11. Talk Mode Tests.

##### DESCRIPTION:

This procedure tests the response time of the 59401A "Handshake" signals when the 59401A is used in the "talk" mode.

##### NOTE

*For a description of the "HP-IB Handshake" signals, refer to the Hewlett-Packard Interface Bus Abbreviated Description which can be purchased through your local Sales and Service Office under part number 5955-2903.*

#### RECOMMENDED TEST EQUIPMENT:

Function Generator, -hp- Model 3310A  
Oscilloscope, -hp- Model 180C

- a. Set the lower row of switches to the "0" position. Set the upper switches as follows:

LINE .....	ON
SRQ/IFC .....	*
REN .....	OFF
MEMORY, FORWARD/REVERSE .....	*
MEMORY, CLEAR/ON/OFF .....	OFF
COMP .....	OFF
TALK/LISTEN .....	TALK
FAST/SLOW/HALT .....	FAST

\*Does not apply to test

- b. Set the controls of the Function Generator to obtain a 100 kHz square wave. Adjust the OUTPUT LEVEL control for minimum output.
  - c. Set the Oscilloscope controls for a vertical sensitivity of 2 volts per centimeter, a horizontal sweep speed of 100 nanoseconds per centimeter, and a positive going internal trigger from the channel "B" amplifier.
- #### 4-12. Talker Response to NDAC.
- a. Connect the Function Generator SYNC OUTPUT to the 59401A rear panel NDAC test point and the HIGH output to the NRFD test point. Adjust the OUTPUT LEVEL and DC OFFSET controls to obtain an amplitude of 0 to + 5 V at the HIGH OUTPUT connector.
  - b. Connect channel "A" of the Oscilloscope to the 59401A DAV test point, and the channel "B" input to the NDAC test point.
  - c. The Oscilloscope display should be similar to that shown in Figure 4-2. The time between the positive going edge of the NDAC signal and the positive going edge of the DAV signal must be less than 700 nanoseconds.

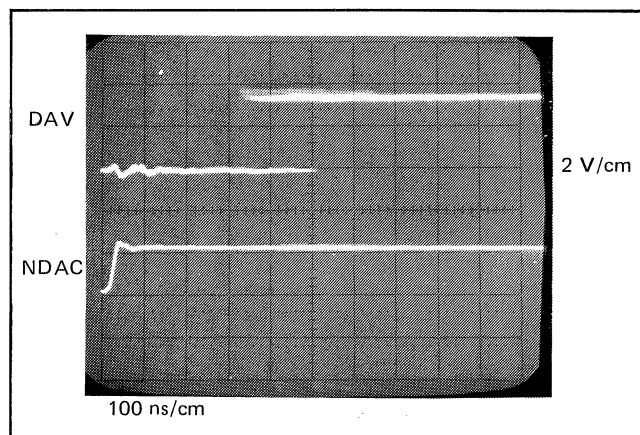


Figure 4-2. Talker Response to NDAC.

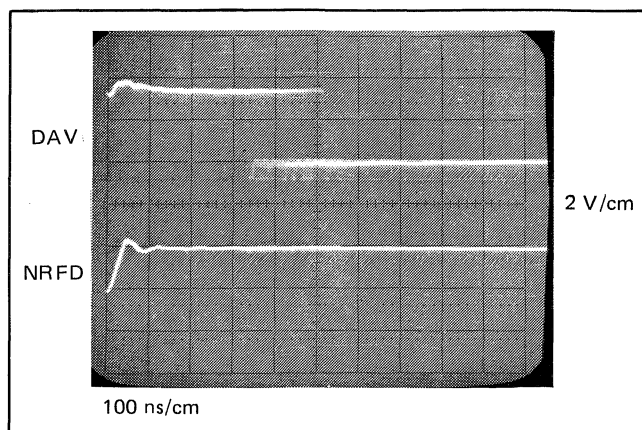


Figure 4-3. Talker Response to NRFD.

**4-13. Talker Response to NRFD.**

a. Remove the Oscilloscope channel "B" input from the 59401A NDAC test point and connect it to the NRFD test point.

b. The Oscilloscope display should be similar to that shown in Figure 4-3. The time between the positive going edge of the NRFD signal and the negative going edge of the DAV signal must be less than 700 nanoseconds. Remove the Function Generator leads from the 59401A.

**4-14. DAV Delay to ATN.**

a. Switch the FAST/SLOW/HALT switch to HALT.

b. Switch the MEMORY, CLEAR/ON/OFF switch to CLEAR and release. The memory should now be ON as indicated by the MEMORY indicator.

c. Switch the DIO 1 switch to the "1" position and momentarily press the EXECUTE button. This loads the octal code "001" in memory location 31.

d. Switch the DIO 1 switch to "0", the ATN switch to "1" and momentarily press the EXECUTE button to load ATN in memory location 00.

e. Switch the DIO 1 switch to the "1" position and momentarily press the EXECUTE button to load octal code "001" and ATN in location 01.

f. Switch the MEMORY, CLEAR/ON/OFF switch to OFF and the ATN switch to "0".

g. Connect the Oscilloscope external trigger input to the 59401A COMPARE OUTPUT connector and set the scope to trigger on a positive going external signal.

h. Remove the Oscilloscope channel "B" input from the NRFD test point and connect it to the ATN test point.

i. Switch the FAST/SLOW/HALT switch to FAST.

j. With the Oscilloscope sweep speed set to 200 nanoseconds per centimeter, the display should be similar to that shown in Figure 4-4. The time between the negative going edge of the ATN signal and the negative going edge of the DAV signal should be greater than 1 microsecond.

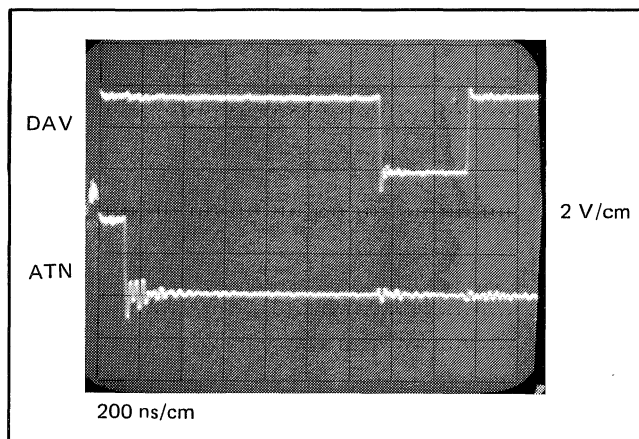


Figure 4-4. DAV Delay to ATN.

**4-15. DAV Delay to Data.**

a. Remove the Oscilloscope channel "B" input from the ATN test point and connect it to the DIO 1 test point.

b. Set the Oscilloscope to trigger on a negative going external signal.

c. Switch the ATN switch to the "1" position.

d. The Oscilloscope display should be similar to that shown in Figure 4-5. The time between the positive going edge of the DIO 1 signal and the negative going edge of the DAV signal must be greater than 500 nanoseconds.

e. Remove all test equipment connections.

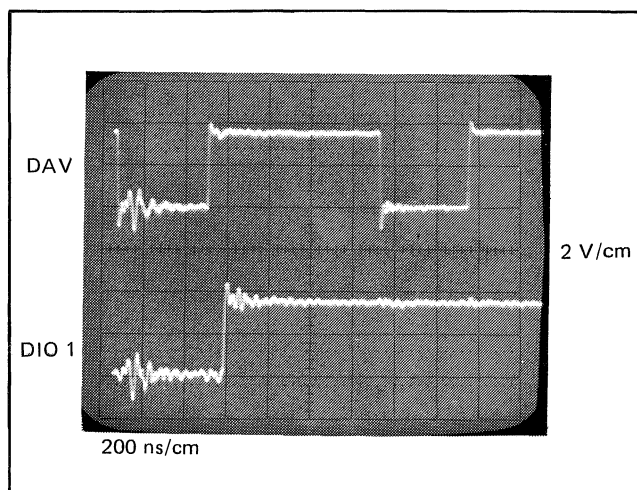


Figure 4-5. DAV Delay to Data.

**4-16. Listen Mode Tests.****DESCRIPTION:**

This procedure tests the response time of the 59401A to "Handshake" signals when it is used in the "listen" mode.

**RECOMMENDED TEST EQUIPMENT:**

Function Generator, -hp- Model 3310A  
 Oscilloscope, -hp- Model 180A  
 DC Power Supply, -hp- Model 6213A  
 Test Load, See Figure 4-1

- a. Set the lower row of switches to the "0" position.  
 Set the upper switches as follows:

LINE .....ON  
 SRQ/IFC .....\*  
 REN .....OFF  
 MEMORY, FORWARD/REVERSE .....\*  
 MEMORY, CLEAR/ON/OFF .....OFF  
 COMP .....OFF  
 TALK/LISTEN .....LISTEN  
 FAST/SLOW/HALT .....FAST

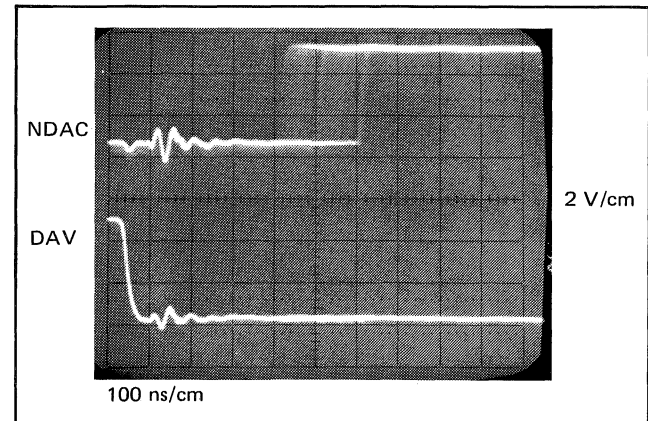
\*Does not apply to test

- b. Set the controls of the Function Generator to obtain a 100 kHz square wave. Adjust the OUTPUT LEVEL control for minimum output.
- c. Set the Oscilloscope controls for a vertical sensitivity of 2 volts per centimeter, a horizontal sweep speed of 100 nanoseconds per centimeter, and a negative going internal trigger from the channel "B" amplifier.
- d. Adjust the Power Supply for an output of +5 V dc.
- e. Connect the Test Load described in Figure 4-1, to the rear panel "HP-IB" connector. Connect the Test Load ground lead to the negative output of the Power Supply and the +5 lead to the positive output.

**4-17. Listen Accept Time Test.**

- a. Connect the Function Generator HIGH output to the DAV test point and adjust the OUTPUT LEVEL and DC OFFSET controls for an amplitude of 0 to +5 V at the HIGH output connector.
- b. Connect the Oscilloscope channel "A" input to the NDAC test point and the channel "B" input to the DAV test point.

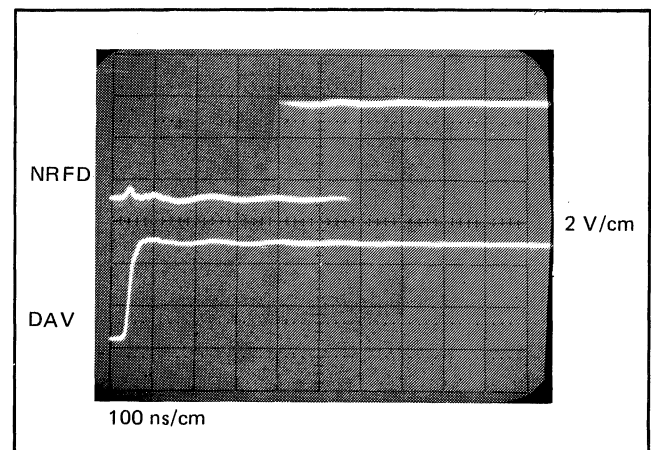
- c. The Oscilloscope display should be similar to that shown in Figure 4-6. The time between the negative going edge of the DAV signal and the positive going edge of the NDAC signal must be less than 750 nanoseconds.



**Figure 4-6. Listen Accept Time Test.**

**4-18. Listen Ready Time Test.**

- a. Remove the Oscilloscope channel "A" input from the NDAC test point and connect it to the NRFD test point.
- b. Set the Oscilloscope to trigger on a positive going internal trigger.
- c. The Oscilloscope display should be similar to that shown in Figure 4-7. The time between the positive going edge of the DAV signal and the positive going edge of the NRFD signal must be less than 750 nanoseconds.
- d. Remove all test equipment connections.



**Figure 4-7. Listen Ready Time Test.**



## PERFORMANCE TEST CARD

Hewlett-Packard Model 59401A  
 Bus System Analyzer  
 Serial No. \_\_\_\_\_

Tests Performed by \_\_\_\_\_  
 Date \_\_\_\_\_

### DISPLAY INDICATOR TEST

Step

b.	ASCII Character			Octal Code			Proper LED's Light	
		Pass	Fail		Pass	Fail	Pass	Fail
	None	_____	_____	000	_____	_____	_____	_____
	\$	_____	_____	244	_____	_____	_____	_____
	None	_____	_____	366	_____	_____	_____	_____
	None	_____	_____	377	_____	_____	_____	_____
	I	_____	_____	111	_____	_____	_____	_____
	H	_____	_____	110	_____	_____	_____	_____
	#	_____	_____	043	_____	_____	_____	_____

c. The BUS indicator must go off. Pass \_\_\_\_\_ Fail \_\_\_\_\_

The MEMORY indicator must go on. Pass \_\_\_\_\_ Fail \_\_\_\_\_

The numeric display must show memory location 31. Pass \_\_\_\_\_ Fail \_\_\_\_\_

d. The numeric display must show an octal code of 000. Pass \_\_\_\_\_ Fail \_\_\_\_\_

There must be no ASCII character displayed. Pass \_\_\_\_\_ Fail \_\_\_\_\_

All indicators, except the MEMORY indicator, must be off. Pass \_\_\_\_\_ Fail \_\_\_\_\_

e. The memory advances to location 00. Pass \_\_\_\_\_ Fail \_\_\_\_\_

The memory returns to location 31. Pass \_\_\_\_\_ Fail \_\_\_\_\_

The memory automatically counts forward. Pass \_\_\_\_\_ Fail \_\_\_\_\_

The memory automatically counts backward. Pass \_\_\_\_\_ Fail \_\_\_\_\_

f. The SRQ, EOI, and ATN indicators must light when the corresponding switches are in the "1" position. SRQ, Pass \_\_\_\_\_ Fail \_\_\_\_\_

EOI, Pass \_\_\_\_\_ Fail \_\_\_\_\_

ATN, Pass \_\_\_\_\_ Fail \_\_\_\_\_

g. The SRQ and IFC indicators must light when the SRQ/IFC switch is in the appropriate position. SRQ, Pass \_\_\_\_\_ Fail \_\_\_\_\_

IFC, Pass \_\_\_\_\_ Fail \_\_\_\_\_

h. The REN indicator must light when the REN switch is set to REN. Pass \_\_\_\_\_ Fail \_\_\_\_\_

i. The DAV indicator must light when the EXECUTE button is pressed. Pass \_\_\_\_\_ Fail \_\_\_\_\_

## PERFORMANCE TEST CARD (Cont'd)

j. The NDAC indicator must light when the TALK/LISTEN switch is in the LISTEN position. Pass \_\_\_\_\_ Fail \_\_\_\_\_

k. The NRFD indicator must light when the DAV test point is connected to the NDAC test point and the EXECUTE button is pressed.  
Pass \_\_\_\_\_ Fail \_\_\_\_\_

### SWITCH REGISTER TEST

#### Step

b. All rear panel test points must measure between + 2.4 and + 5.0 V dc.

Test Point	Pass	Fail	Test Point	Pass	Fail
DIO1	_____	_____	ATN	_____	_____
DIO2	_____	_____	EOI	_____	_____
DIO3	_____	_____	SRQ	_____	_____
DIO4	_____	_____	REN	_____	_____
DIO5	_____	_____	IFC	_____	_____
DIO6	_____	_____	NDAC	_____	_____
DIO7	_____	_____	NRFD	_____	_____
DIO8	_____	_____	DAV	_____	_____

c. All readings must remain within the limits in Step b.

g. The following test points must measure less than + 0.4 V dc when the corresponding switches are set to "1".

Test Point	Pass	Fail	Test Point	Pass	Fail
DIO1	_____	_____	DIO7	_____	_____
DIO2	_____	_____	DIO8	_____	_____
DIO3	_____	_____	ATN	_____	_____
DIO4	_____	_____	EOI	_____	_____
DIO5	_____	_____	SRQ	_____	_____
DIO6	_____	_____			

h. The IFC test point reading must be less than + 0.4 V dc when the SRQ/IFC switch is held in the IFC position. Pass \_\_\_\_\_ Fail \_\_\_\_\_

i. The REN test point must measure less than + 0.4 V dc when the REN switch is set to REN. Pass \_\_\_\_\_ Fail \_\_\_\_\_

j. The DAV test point must measure less than + 0.4 V dc when the EXECUTE button is pressed. Pass \_\_\_\_\_ Fail \_\_\_\_\_

k. The NDAC test point must measure less than + 0.4 V dc when the TALK/LISTEN switch is set to LISTEN. Pass \_\_\_\_\_ Fail \_\_\_\_\_

l. The NRFD test point must measure less than + 0.4 V dc with the DAV test point connected to the NDAC test point and the EXECUTE button pressed. Pass \_\_\_\_\_ Fail \_\_\_\_\_

## PERFORMANCE TEST CARD (Cont'd)

m. The memory location must automatically advance to location 31 and halt. Pass \_\_\_\_\_ Fail \_\_\_\_\_

This step must repeat when the EXECUTE button is pressed. Pass \_\_\_\_\_ Fail \_\_\_\_\_

### TALKER RESPONSE TO NDAC

The time between the positive going portion of the NDAC signal and the positive going portion of the DAV signal must be less than 700 nanoseconds. Pass \_\_\_\_\_ Fail \_\_\_\_\_

### TALKER RESPONSE TO NRFD

The time between the positive going portion of the NRFD signal and the negative going portion of the DAV signal must be less than 700 nanoseconds. Pass \_\_\_\_\_ Fail \_\_\_\_\_

### DAV DELAY TO ATN

The time between the negative going portion of the ATN signal and negative going portion of the DAV signal must be greater than 1 microsecond. Pass \_\_\_\_\_ Fail \_\_\_\_\_

### DAV DELAY TO DATA

The time between the positive going portion of the DI01 signal and the negative going portion of the DAV signal must be greater than 500 nanoseconds. Pass \_\_\_\_\_ Fail \_\_\_\_\_

### LISTEN ACCEPT TIME TEST

The time between the negative going portion of the DAV signal and the positive going portion of the NDAC signal must be less than 750 nanoseconds. Pass \_\_\_\_\_ Fail \_\_\_\_\_

### LISTEN READY TIME TEST

The time between the positive going portion of the DAV signal and the positive going portion of the NRFD signal must be less than 750 nanoseconds. Pass \_\_\_\_\_ Fail \_\_\_\_\_





## **WARNING**

*These servicing instructions are for use by trained service personnel only. To avoid electrical shock, do not perform any servicing other than that contained in the operating instructions unless you are trained to do so.*



## SECTION V MAINTENANCE

### 5-1. INTRODUCTION.

5-2. This section describes how to make all necessary adjustments to the Model 59401A. If the instrument fails to respond satisfactorily to these adjustments, refer to Section VII for troubleshooting information.

### 5-3. TEST EQUIPMENT REQUIRED.

5-4. Table 5-1 shows test equipment required. Hewlett-Packard instruments are recommended but any instruments with rated accuracy are acceptable.

**Table 5-1. Required Test Equipment.**

Item	Accuracy	Recommended
Digital Voltmeter	$\pm .3\%$ of Reading + one digit on 11 V scale	-hp- Model 3476A DMM
Meter Leads	Banana probes on one end, alligator clips on the other	-hp- Model 11002A

### 5-5. ADJUSTMENTS.

#### 5-6. + 5 Volt Power Supply.

5-7. This procedure explains how to adjust the + 5 volt power supply. It is to be performed by qualified service personnel only. The adjustment is unnecessary if + 5 volts is equal to  $+ 5.1 \pm .1$  volts.

- a. Remove power from the Model 59401A.

**WARNING**

*Failure to perform Step a could result in electrical shock to service personnel or damage to the Model 59401A.*

- b. Remove the top cover of the Model 59401A using a large Phillips screwdriver.
- c. Remove the 6 Phillips head retaining screws from the edges of the top printed circuit board A3.
- d. Gently, with fingertips, move the A3 board, now

loose, toward the rear of the instrument so that its front end disengages from the connector.

- e. Gently lift and tilt sideways the A3 board and remove it from the instrument.

- f. Power is still removed.

g. Properly connect meter leads into meter's voltage terminals. The leads should have alligator clips on the dangling ends. Ensure the black lead enters the meter's low terminal.

- h. Set the meter to the 10 volt range.

i. Attach the black lead to the "GND" pin and the red lead to the + 5 V pin on the A1 board as shown in Figure 5-1.

- j. Turn on the meter.

- k. Apply power to the Model 59401A.

l. Using a medium, flat bladed, insulated screwdriver, adjust R12 (see Figure 5-1) until the meter reads  $+ 5.1$  volts  $\pm .1$  volt.

- m. Remove power from the Model 59401A.

- n. Turn off the meter.

- o. Remove the meter leads.

p. Carefully install the A3 board and plug it into its connector.

q. Install the A3 board's 6 retainer screws and tighten them snugly.

r. Replace the Model 59401A top cover and tighten its fastening screw snugly.

- s. Return the Model 59401A to use.

t. Check the + 5 volt supply every six months for the proper voltage.

5-8. There are no other adjustments required.



## SECTION VI

### REPLACEABLE PARTS

#### 6-1. INTRODUCTION.

6-2. This section contains information for ordering replacement parts. Table 6-1 lists in alphanumeric order their reference designators and indicates the description, -hp- Part Number of each part, together with any applicable notes, and provides the following:

- a. Total quantity used in the instrument (Qty column). The total quantity of a part is given the first time the part number appears.
- b. Description of the part. (See list of abbreviations below.)
- c. Typical manufacturer of the part in a five-digit code. (See Appendix C for list of manufacturers.)
- d. Manufacturers part number.

6-3. Miscellaneous parts are listed at the end of Table 6-1.

#### 6-4. ORDERING INFORMATION.

6-5. To obtain replacement parts, address order or inquiry to your local Hewlett-Packard Field Office. (See Appendix

B for list of office locations. Identify parts by their Hewlett-Packard part numbers. Include instrument model and serial numbers.

#### 6-6. NON-LISTED PARTS.

6-7. To obtain a part that is not listed, include:

- a. Instrument model number.
- b. Instrument serial number.
- c. Description of the part.
- d. Function and location of the part.

#### 6-8. PARTS CHANGES.

6-9. Components which have been changed are so marked by one of three symbols; ie.,  $\Delta$ ,  $\Delta$  with a letter subscript, eg.,  $\Delta_a$ , or  $\Delta$  with a number subscript eg.,  $\Delta_{10}$ . A  $\Delta$  with no subscript indicates the component listed is the preferred replacement for an earlier component. A  $\Delta$  with a letter subscript indicates a change which is explained in a note at the bottom of the page. A  $\Delta$  with a number subscript indicates the related change is discussed in backdating (Section VIII). The number of the subscript indicates the number of the change in backdating which should be referred to.

#### Standard Abbreviations.

ABBREVIATIONS	
Ag ..... silver	Hz ..... hertz (cycle(s) per second)
Al ..... aluminum	ID ..... inside diameter
A ..... ampere(s)	imp ..... impregnated
Au ..... gold	incd ..... incandescent
C ..... capacitor	ins ..... insulation(ed)
cer ..... ceramic	k $\Omega$ ..... kilohm(s) = $10^3$ ohms
coef ..... coefficient	kHz ..... kilohertz = $10^3$ hertz
com ..... common	L ..... inductor
comp ..... composition	lin ..... linear taper
conn ..... connection	log ..... logarithmic taper
dep ..... deposited	mA ..... milliampere(s) = $10^{-3}$ amperes
DPDT ..... double-pole double-throw	mHz ..... megahertz = $10^6$ hertz
DPST ..... double-pole single-throw	M $\Omega$ ..... megohm(s) = $10^6$ ohms
elect ..... electrolytic	met flm ..... metal film
encap ..... encapsulate	nitr ..... manufacturer
F ..... farad(s)	ms ..... millisecond
FET ..... field effect transistor	mtg ..... mounting
fxd ..... fixed	mV ..... millivolt(s) = $10^{-3}$ volts
GaAs ..... gallium arsenide	$\mu$ F ..... microfarad(s)
GHz ..... gigahertz = $10^9$ hertz	$\mu$ s ..... microsecond(s)
gd ..... guard(ed)	$\mu$ V ..... microvolt(s) = $10^{-6}$ volts
Ge ..... germanium	my ..... Mylar®
gnd ..... ground(ed)	nA ..... nanoampere(s) = $10^{-9}$ amperes
H ..... henry(ies)	NC ..... normally closed
Hg ..... mercury	Ne ..... neon
	NO ..... normally open
DESIGNATORS	
A ..... assembly	FL ..... filter
B ..... motor	HR ..... heater
BT ..... battery	IC ..... integrated circuit
C ..... capacitor	J ..... jack
CR ..... diode	K ..... relay
DL ..... delay line	L ..... inductor
DS ..... lamp	M ..... meter
E ..... misc electronic part	MP ..... mechanical part
F ..... fuse	P ..... plug
	Q ..... transistor
	QCR ..... transistor-diode
	R ..... resistor
	RT ..... thermistor
	S ..... switch
	T ..... transformer
	TB ..... terminal board
	TC ..... thermocouple
	TP ..... test point
	TS ..... terminal strip
	U ..... microcircuit
	V ..... vacuum tube, neon bulb, photocell, etc.
	W ..... cable
	X ..... socket
	XDS ..... lampholder
	XF ..... fuseholder
	Y ..... crystal
	Z ..... network

Table 6-1. Replaceable Parts

REFERENCE DESIGNATOR	-hp- PART NO.	TQ	DESCRIPTION	MFR.	MFR. PART NO.
			ASSEMBLIES		
A1	59401-66501		PC ASSEMBLY-MOTHER BOARD	28480	59401-66501
A2	59401-66502		PC ASSEMBLY-FRONT PANEL BOARD	28480	59401-66502
A3	59401-66503		PC ASSEMBLY-CONTROLLER BOARD	28480	59401-66503
A4	No Part No.*		TRANSISTOR MOUNT ASSEMBLY		
A5	No Part No.*		REAR END ASSEMBLY		
A6	No Part No.*		FRONT END ASSEMBLY		
MP	No Part No.*		MECHANICAL AND OTHER PARTS		
			*See Parts Breakdown		

Table 6-1. Replaceable Parts (Cont'd)

REFERENCE DESIGNATOR	-hp- PART NO.	TQ	DESCRIPTION	MFR.	MFR. PART NO.
A1	59401-66501	1	A1 PC ASSEMBLY-MOTHER BOARD	28480	59401-66501
A1C1	0180-0549	1	CAPACITOR-FXD 4500 $\mu$ F $\pm$ 25% 30 V	09023	
A1C2	0180-1861	1	CAPACITOR-FXD 27 $\mu$ F $\pm$ 10% 10 V	56289	150D276X9010B2
A1C3	0160-0161	1	CAPACITOR-FXD .01 $\mu$ F $\pm$ 10% 200 V	56289	292P10392
A1C4, C5	0150-0084	2	CAPACITOR-FXD .1 $\mu$ F +80-20% 100WVDC	28480	0150-0084
A1C6	0160-0167	1	CAPACITOR-FXD .082 $\mu$ F $\pm$ 10% 200 V	56289	292P82392
A1C7	0180-0291	1	CAPACITOR-FXD 1 $\mu$ F $\pm$ 10% 35 V	56289	150D105X9035A2
A1C8	0180-0113	3	CAPACITOR-FXD 100 $\mu$ F +20-15% 30 V	56289	109D107C2030T2
A1C10	0180-0159	1	CAPACITOR-FXD 220 $\mu$ F $\pm$ 20% 10 V	56289	150D227X0010S2
A1C11, C12	0180-0113		CAPACITOR-FXD 100 $\mu$ F +20-15% 30 V	56289	109D107C2030T2
A1C102*	0160-2204	1	CAPACITOR-FXD 100 pF $\pm$ 5% 300 V	09023	RDM15F101J3C
A1C103, C104	0180-1704	2	CAPACITOR-FXD 47 $\mu$ F $\pm$ 10% 6 V	56289	150D476X9006B2
A1C105-107	0150-0093	14	CAPACITOR-FXD .01 $\mu$ F +80-20% 100 V	28480	0150-0093
A1C201	0160-2207	1	CAPACITOR-FXD 300 pF $\pm$ 5% 300 V	28480	0160-2207
A1C202	0160-2199	1	CAPACITOR-FXD 30 pF $\pm$ 5% 300 V	28480	0160-2199
A1C203-C207	0150-0093		CAPACITOR-FXD .01 $\mu$ F +80-20% 100 V	28480	0150-0093
A1C301	0150-0093		CAPACITOR-FXD .01 $\mu$ F +80-20% 100 V	28480	0150-0093
A1C401-C405	0150-0093		CAPACITOR-FXD .01 $\mu$ F +80-20% 100 V	28480	0150-0093
A1CR1	1902-3205	1	DIO-BKDN 15 V	04713	SZ 10939-233
A1CR2	1902-3182	1	DIO-BKDN 12.1 V	04713	SZ10939-206
A1CR3	1901-0511	1	DIO-SI 1N3889R	12954	1N3889R
A1CR4-7	1901-0050	4	DIO-SI	28480	1901-0050
A1CR8	1902-3188	1	DIO-BRDN 12.7 V	04713	SZ 10939-213
A1CR101	1902-3085	1	DIO-BKDN 4.75 V	04713	SZ 10939-89
A1J111-J113	1200-0474	3	14 PIN SOCKET IC	28480	1200-0474
A1L2	9100-3232	1	CHOKE 40 $\mu$ H	28480	9100-3232
A1L3	9100-3231	1	CHOKE 180 $\mu$ H	28480	9100-3231
A1MP1, MP2	0380-0160	2	STANDOFF-RVT-ON	28480	0380-0160
A1MP3	59401-01203	1	BRKT-DIODE MTG FOR CR3	28480	59401-01203
A1PC1	59401-26501	1	PC BD-MOTHER	28480	59401-26501
A1Q1	1853-0051	1	XSTR-2N4037	02735	2N4037
A1Q2	1854-0039	1	XSTR SI NPN	04713	2N3053
A1Q3	1854-0071	1	XSTR-SI NPN	28480	1854-0071
A1R1	0683-1025	4	RESISTOR-FXD 1000 $\Omega$ .05	01121	CB1025
A1R2	0757-0411	1	RESISTOR-FXD 332 $\Omega$ .01	24546	C4-1/8-T0-332R-F
A1R3	0683-2015	1	RESISTOR-FXD 200 $\Omega$ .05	01121	CB2015
A1R4	0683-1015	11	RESISTOR-FXD 100 $\Omega$ .05	01121	CB1015
A1R5	0698-3279	1	RESISTOR-FXD 4990 $\Omega$ .01	16299	C4-1/8-T0-4991-F
A1R6	0698-4431	1	RESISTOR-FXD 2050 $\Omega$ .01	16299	C4-1/8-T0-2051-F
A1R7	0683-2215	1	RESISTOR-FXD 220 $\Omega$ .05	01121	CB2215
A1R8	0683-3015	1	RESISTOR-FXD 300 $\Omega$ .05	01121	CB3015
A1R9	0683-0275	1	RESISTOR-FXD 2.7 $\Omega$ .05	01121	CB27G5
A1R10	0683-2205	1	RESISTOR-FXD 22 $\Omega$ .05	01121	CB2205
A1R11	0683-3915	1	RESISTOR-FXD 390 $\Omega$ .05	01121	CB3915
A1R12	2100-1772	1	RESISTOR-VAR 500 $\Omega$ .05	GB027	CT-100-4
A1R13	0683-1035	3	RESISTOR-FXD 10 K .05 1/4W	01121	CB1035
A1R14	0683-5115	25	RESISTOR-FXD 510 $\Omega$ .05	01121	CB5115
A1R15	0683-0395	1	RESISTOR-FXD 3.9 $\Omega$ .05	01121	CB39G5
A1R101-111	0683-5115		RESISTOR-FXD 510 $\Omega$ .05	01121	CB5115
A1R112	0683-1025		RESISTOR-FXD 1000 $\Omega$ .05	01121	CB1025
A1R115	0683-5115		RESISTOR-FXD 510 $\Omega$ .05	01121	CB5115
A1R117	0757-0413	1	RESISTOR-FXD 392 $\Omega$ .01	24546	C4-1/8-T0-392R-F
A1R118	0683-2725	34	RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725



Table 6-1. Replaceable Parts (Cont'd)

REFERENCE DESIGNATOR	-hp- PART NO.	TQ	DESCRIPTION	MFR.	MFR. PART NO.
A1 PC ASSEMBLY (CONT'D)					
A1R119	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A1R122, 123	0683-1005	2	RESISTOR-FXD 10 $\Omega$ .05	01121	CB1005
A1R125, 126	1810-0136	2	R-NETWORK	28480	1810-0136
A1R201, 202	0683-1035		RESISTOR-FXD 10 K .05 1/4 W	01121	CB1035
A1R203	0683-1025		RESISTOR-FXD 1000 $\Omega$ .05	01121	CB1025
A1R204	0683-5115		RESISTOR-FXD 510 $\Omega$ .05	01121	CB5115
A1R205	0683-1025		RESISTOR-FXD 1000 $\Omega$ .05	01121	CB1025
A1R206-214	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A1R215-225	0683-5115		RESISTOR-FXD 510 $\Omega$ .05	01121	CB5115
A1R226	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A1R301-310	0683-1015		RESISTOR-FXD 100 $\Omega$ .05	01121	CB1015
A1R401-422	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A1U1	1820-0196	1	IC-U5R7723393	07263	723HC
A1U101	1820-0621	2	IC-SN7438N	01295	SN7438N
A1U102	1820-1056	1	IC-SN74132	01295	SN74132N
A1U103	1820-0583	14	IC-DM74L00	27014	DM74L00N
A1U104, 105	1820-0618	3	IC-DGTL SN7417N	01295	SN7417N
A1U106	1820-1053	1	IC-SN 7414	01295	SN7414N
A1U107-109	1820-0506	9	IC-DIGITAL	18324	N8266B
A1U110	1820-0621		IC-SN7438N	01295	SN7438N
A1U111-113	1820-1335	3	IC-LINEAR	28480	1820-1335
A1U201	1820-0579	1	IC-DGTL SN74123N	01295	SN74123N
A1U202	1820-1141	1	IC-SN74185	01295	SN74185AN
A1U203	1820-0233	2	IC-SN74193N	01295	SN74193N
A1U204	1820-0054	2	IC-SN7400N	01295	SN7400N
A1U205	1820-0233		IC-SN74193N	01295	SN74193N
A1U206-208	1820-0628	6	IC DGT-SN7489N	01295	SN7489N
A1U209	1820-0577	2	IC-SN7416N	01295	SN7416N
A1U210	1820-0618		IC-DGTL SN7417N	01295	SN7417N
A1U211	1820-0070	1	IC-SN7430N	01295	SN7430N
A1U212	1820-0281	1	IC-DGTL SN74107N	01295	SN74107N
A1U213	1820-0661	1	IC-QUAD SN7432N	01295	SN7432N
A1U214	1820-0301	1	IC-SN7475N	01295	SN7475N
A1U215-217	1820-0628		IC DGT-SN7489N	01295	SN7489N
A1U301-303	1820-0506		IC-DIGITAL	18324	N8266B
A1U304	1820-0577		IC-SN7416N	01295	SN7416N
A1U401-411	1820-0583		IC-DM74L00	27014	DM74L00N
A1U412	1820-0706	1	IC-DGTL-COMPTR	07263	9324DC
A1U413	1820-0054		IC-SN7400N	01295	SN7400N
A1U414	1820-0506		IC-DIGITAL	18324	N8266B
A1U415	1820-0904	2	IC-DGTL-COMPTR	07263	93L24DC
A1U416	1820-0583		IC-DM74L00	27014	DM74L00N
A1U418	1820-0506		IC-DIGITAL	18324	N8266B
A1U419	1820-0904		IC DGT-COMPTR	07263	93L24DC
A1U420	1820-0583		IC-DM74L00	27014	DM74L00N
A1U421	1820-0506		IC-DIGITAL	18324	N8266B
A1W1	59401-61601	1	CABLE ASSEMBLY-HP-IB	28480	59401-61601

Table 6-1. Replaceable Parts (Cont'd)

REFERENCE DESIGNATOR	-hp- PART NO.	TQ	DESCRIPTION	MFR.	MFR. PART NO.
A2	59401-66502	1	A2 PC ASSEMBLY-DISPLAY	28480	59401-66502
A2C1	0180-0197	1	CAPACITOR-FXD 2.2 $\mu$ F 20 V	56289	150D225X9020A2
A2DS1, DS2	1990-0482	1	DISPLAY-PAIR	28480	1990-0482
A2DS3-DS12	1990-0410	10	DIO-LIGHT EM	28480	1990-0410
A2J1, J2 $\Delta$	1200-0696	2	SOCKET-IC 24 CONT DIP W-WRAP	28480	1200-0696
A2MP1-MP4	0380-0458	4	SPACER-RIVET-ON	28480	0380-0458
A2PC1	59401-26502	1	PC BD-DSPL	28480	59401-26502
A2Q1, Q2	1853-0010	2	XSTR-SI PNP	28480	1853-0010
A2R1-4	0683-2725	4	RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A2S1-S11	3101-1834	12	SW-TOGGLE	28480	3101-1834
A2S12	3101-1843	1	SW-PUSHBUTTON	28480	3101-1843
A2S13	3101-1834	1	SW-TOGGLE	28480	3101-1834
A2S14, S15	3101-1621	3	SW-TGL DPDT	28480	3101-1621
A2S16	3101-1835	1	SW-TOGGLE	28480	3101-1835
A2S17	3101-1836	2	SW-TOGGLE	28480	3101-1836
A2S18	3101-1621		SW-TGL DPDT	28480	3101-1621
A2S19	3101-1836		SW-TOGGLE	28480	3101-1836
A2U1-U4	1858-0014	7	PNP QUAD DRIVER	28480	1858-0014
A2U5	1820-0495	2	IC-SN74154N	07263	9311DC
A2U6-U8	1858-0014		PNP QUAD DRIVER	28480	1858-0014
A2U9	1820-0495		IC-SN74154N	07263	9311DC
A2XA1, XA3	1251-3178	2	CONN-PC EDGE	05574	2VH43/1 & 12(079)

Table 6-1. Replaceable Parts (Cont'd)

REFERENCE DESIGNATOR	-hp- PART NO.	TQ	DESCRIPTION	MFR.	MFR. PART NO.
A3	59401-66503	1	A3 PC ASSEMBLY-CONTROLLER	28480	59401-66503
A3C1, C2	0150-0093	22	CAPACITOR-FXD .01 $\mu$ F 100 V	28480	0150-0093
A3C3	0180-1704	1	CAPACITOR-FXD 47 $\mu$ F 6 V	56289	150D476X9006B2
A3C4	0160-2206	1	CAPACITOR-FXD 160 pF 300 V	28480	0160-2206
A3C5	0150-0093	1	CAPACITOR-FXD .01 $\mu$ F 100 V	28480	0150-0093
A3C6	0150-0096	1	CAPACITOR-FXD .05 $\mu$ F 100 V	28480	0150-0096
A3C7-C14	0150-0093		CAPACITOR-FXD .01 $\mu$ F 100 V	28480	0150-0093
A3C15	0180-1701	1	CAPACITOR-FXD 6.8 $\mu$ F 6 V	56289	150D685X0006A2
A3C16-C18	0150-0093		CAPACITOR-FXD .01 $\mu$ F 100 V	28480	0150-0093
A3C20	0160-0205	1	CAPACITOR-FXD 10 pF 500 V	28480	0160-0205
A3C101-102	0150-0093		CAPACITOR-FXD .01 $\mu$ F 100 V	28480	0150-0093
A3C103, 104 $\Delta_{1a}$	0150-0093		CAPACITOR-FXD .01 $\mu$ F +80-20% 100VDC	28480	0150-0093
A3C105	0180-0228	1	CAPACITOR-FXD 22 $\mu$ F 15 V	56289	150D226X9015B2
A3C106	0150-0093		CAPACITOR-FXD .01 $\mu$ F 100 V	28480	0150-0093
A3C107	0150-0121	1	CAPACITOR-FXD .1 $\mu$ F 50 V	28480	0150-0121
A3C108 $\Delta_{1a}$	0150-0093		CAPACITOR-FXD .01 $\mu$ F 100 V	28480	0150-0093
A3C201-206	0150-0084	6	CAPACITOR-FXD .1 $\mu$ F	28480	0150-0084
A3C207, C208	0150-0093		CAPACITOR-FXD .01 $\mu$ F 100 V	28480	0150-0093
A3CR1-CR4	1901-0040	4	DIO-SI .05 A 30 V	28480	1901-0040
A3J1, J3, J4	1200-0473	4	SOCKET-IC 16 PIN	28480	1200-0473
A3J15, J16	1200-0431	3	SOCKET-IC 24 PIN	06776	IC-246-S2
A3J25	1200-0469	2	SOCKET-IC 28 PIN	06776	IC-286-S2
A3J26	1200-0431		SOCKET-IC 24 PIN	06776	IC-246-S2
A3J106 $\Delta_{1a}$	1200-0469		SOCKET-IC 28 PIN	06776	IC-286-S2
A3J108	1200-0473		SOCKET-IC 16 PIN	28480	1200-0473
A3PC1	59401-26503	1	PC BOARD-CONT	28480	59401-26503
A3Q1-Q4	1854-0215	4	XSTR-2N3904	04713	SPS 3611
A3Q101-107	1853-0010	7	XSTR-SI PNP	28480	1853-0010
A3R1	0683-3315	13	RESISTOR-FXD 330 $\Omega$ .05	01121	CB3315
A3R2	0683-2725	15	RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A3R3-R5	0683-3315		RESISTOR-FXD 330 $\Omega$ .05	01121	CB3315
A3R6	0683-5135	1	RESISTOR-FXD 51 K .05 1/4W	01121	CB5135
A3R7	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A3R8	0683-1035	14	RESISTOR-FXD 10 K .05 1/4 W	01121	CB1035
A3R9	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A3R10	0757-0413	2	RESISTOR-FXD 392 $\Omega$ .01	24546	C4-1/8-T0-392R-F
A3R11, R12	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A3R13-R16	0683-1035		RESISTOR-FXD 10 K .05 1/4 W	01121	CB1035
A3R17, R18	0683-1835	2	RESISTOR-FXD 18 K .05 1/4W	01121	CB1835
A3R19, R20	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A3R21	0683-2025	2	RESISTOR-FXD 2000 $\Omega$ .05	01121	CB2025
A3R22	0683-1025	3	RESISTOR-FXD 1000 $\Omega$ .05	01121	CB1025
A3R23	0683-1035		RESISTOR-FXD 10 K .05 1/4W	01121	CB1035
A3R24	0683-2025		RESISTOR-FXD 2000 $\Omega$ .05	01121	CB2025
A3R25	0683-3315		RESISTOR-FXD 330 $\Omega$ .05	01121	CB3315
A3R26	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A3R27	0683-1025		RESISTOR-FXD 1000 $\Omega$ .05	01121	CB1025
A3R28, R29	0683-3335	3	RESISTOR-FXD 33 K .05 1/4W	01121	CB3335
A3R30	0683-6825	1	RESISTOR-FXD 6800 $\Omega$ .05	01121	CB6825
A3R31	0683-3335		RESISTOR-FXD 33 K .05 1/4W	01121	CB3335
A3R32	0683-1025		RESISTOR-FXD 1000 $\Omega$ .05	01121	CB1025
A3R33, R34	1810-0055	2	R-NETWORK	28480	1810-0055
A3R36	0683-3315		RESISTOR-FXD 330 $\Omega$ .05	01121	CB3315
A3R37, R38	0683-1035		RESISTOR-FXD 10 K .05 1/4W	01121	CB1035
A3R101	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A3R102	0683-2215	7	RESISTOR-FXD 220 $\Omega$ .05	01121	CB2215
A3R103	0683-2005	7	RESISTOR-FXD 20 $\Omega$ .05	01121	CB2005
A3R104	0683-2215		RESISTOR-FXD 220 $\Omega$ .05	01121	CB2215
A3R105	0683-2005		RESISTOR-FXD 20 $\Omega$ .05	01121	CB2005
A3R106	0683-2215		RESISTOR-FXD 220 $\Omega$ .05	01121	CB2215
A3R107, 108	0683-2005		RESISTOR-FXD 20 $\Omega$ .05	01121	CB2005

Table 6-1. Replaceable Parts (Cont'd)

REFERENCE DESIGNATOR	-hp- PART NO.	TQ	DESCRIPTION	MFR.	MFR. PART NO.
A3 PC ASSEMBLY (CONT'D)					
A3R109, 110	0683-2215		RESISTOR-FXD 220 $\Omega$ .05	01121	CB2215
A3R111	0683-2005		RESISTOR-FXD 20 $\Omega$ .05	01121	CB2005
A3R112	0683-2215		RESISTOR-FXD 220 $\Omega$ .05	01121	CB2215
A3R113	0683-2005		RESISTOR-FXD 20 $\Omega$ .05	01121	CB2005
A3R114	0683-2215		RESISTOR-FXD 220 $\Omega$ .05	01121	CB2215
A3R115	0683-2005		RESISTOR-FXD 20 $\Omega$ .05	01121	CB2005
A3R116	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A3R117-123	0683-3315		RESISTOR-FXD 330 $\Omega$ .05	01121	CB3315
A3R124	0757-0413		RESISTOR-FXD 392 $\Omega$ .01	24546	C4-1/8-T0-393R-F
A3R125-128 $\Delta_{1a}$	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A3R129-147 $\Delta_{1a}$	0683-2225	19	RESISTOR-FXD 2200 $\Omega$ .05	01121	CB2225
A3R201	0683-1005	6	RESISTOR-FXD 10 $\Omega$ .05	01121	CB1005
A3R202	0683-1035		RESISTOR-FXD 10 K .05 1/4W	01121	CB1035
A3R203	0683-1005		RESISTOR-FXD 10 $\Omega$ .05	01121	CB1005
A3R204	0683-1035		RESISTOR-FXD 10 K .05 1/4W	01121	CB1035
A3R205	0683-1005		RESISTOR-FXD 10 $\Omega$ .05	01121	CB1005
A3R206	0683-1035		RESISTOR-FXD 10 K .05 1/4 W	01121	CB1035
A3R207	0683-1005		RESISTOR-FXD 10 $\Omega$ .05	01121	CB1005
A3R208, 209	0683-1035		RESISTOR-FXD 10 K .05 1/4W	01121	CB1035
A3R210, 211	0683-1005		RESISTOR-FXD 10 $\Omega$ .05	01121	CB1005
A3R212	0683-1035		RESISTOR-FXD 10 K .05 1/4W	01121	CB1035
A3R213	0683-2725		RESISTOR-FXD 2700 $\Omega$ .05	01121	CB2725
A3U1	1820-0507	1	IC DGTL-MUVR	18324	N8263B
A3U2	1820-1191	2	IC DGTL-FF	01295	SN74S175N
A3U3	1816-0425	1	IC-MM6331	28480	1816-0425
A3U4	1816-0438	1	ROM BIPOLAR	28480	1816-0438
A3U5,U6	1820-0301	7	IC-SN7475N	01295	SN7475N
A3U7	1820-0054	4	IC-SN7400N	01295	SN7400N
A3U8	1820-0068	1	IC-SN7410N	01295	SN7410N
A3U9	1820-0511	1	IC-SN7408N	01295	SN7408N
A3U10	1820-0661	2	IC-QUAD SN7432N	01295	SN7432N
A3U11	1820-1191		IC DGTL-FF	01295	SN74S175N
A3U12	1820-0579	1	IC-DGTL SN74123N	01295	SN74123N
A3U13, U14	1820-0640	2	IC-SN74150N	01295	SN74150N
A3U15	1818-2233	1	MOS ROM 4 K	28480	1818-2233
A3U16	1818-2234	1	MOS-ROM 4K	28480	1818-2234
A3U17, U18	1820-0077	3	IC-SN7474N	01295	SN7474N
A3U19, U20	1820-0596	2	IC-DGTL DM74L74N	27014	DM74L74N
A3U21	1820-0301		IC-SN7475N	01295	SN7475N
A3U22	1820-0621	1	IC-SN7438N	01295	SN7438N
A3U23, U24	1820-0989	2	IC-SN8271B	18324	N8271B
A3U25	1818-2232	1	MOS ROM 4K	28480	1818-2232
A3U26	1818-2235	1	MOS-ROM 4K	28480	1818-2235
A3U27-U30	1820-0301		IC-SN7475N	01295	SN7475N
A3U31-U34	1820-0586	6	IC-DGTL DM74L04N	27014	DM74L04N
A3U35	1820-0054		IC-SN7400N	01295	SN7400N
A3U101, 102	1820-0620	2	IC-DGTL SN74153N	01295	SN74153N
A3U103, 104	1820-0506	2	IC-DIGITAL	18324	N8266B
A3U105 $\Delta_{1a}$	1820-0491	1	IC-SN74145N	01295	SN74145N
A3U106 $\Delta_{1a}$	1818-0102		IC-TMS-4103	01295	TMS4103NC
A3U106 $\Delta_{1b}$	1816-1300		IC-ROM	28480	1816-1300
A3U107	1820-0586		IC-DGTL DM74L04N	27014	DM74L04N
A3U108	1816-0424	1	IC-MM6331	28480	1816-0424
A3U109	1820-0099	1	IC-SN7493N	01295	SN7493N
A3U110	1820-0077		IC-SN7474N	01295	SN7474N
A3U111 $\Delta_{1a}$	1820-0577		IC-SN7416N	01295	SN7416N
A3U112	1820-1066	1	IC DGTL-GATE	07263	7411PC
A3U113	1820-1053	2	IC-SN7414	01295	SN7414N

 $\Delta_{1a}$  Used on Serial Numbers 1914A00490 and below only. $\Delta_{1b}$  Used on Serial Numbers 1914A00491 and up only.

Table 6-1. Replaceable Parts (Cont'd)

REFERENCE DESIGNATOR	-hp- PART NO.	TQ	DESCRIPTION	MFR.	MFR. PART NO.
A3U114 A3U115 $\Delta_{1a}$ A3U116 $\Delta_{1a}$ A3U117 $\Delta_{1a}$  A3U201 A3U202, 203	1820-0661	1  1	A3 PC ASSEMBLY (CONT'D)		
	1820-0618		IC-QUAD SN7432N	01295	SN7432N
	1820-0175		IC-DGTL SN7417N	01295	SN7417N
	1820-0586		IC-SN7405N	01295	SN7405N
			IC-DGTL DM74L04N	27014	DM74L04N
	1820-1053		IC-SN 7414	01295	SN7414N
	1820-0054		IC-SN7400N	01295	SN7400N

Table 6-1. Replaceable Parts (Cont'd)

REFERENCE DESIGNATOR	-hp- PART NO.	TQ	DESCRIPTION	MFR.	MFR. PART NO.
A4			TRANSISTOR MOUNT ASSEMBLY (NOT AVAILABLE AS AN ASSEMBLY)		
CR2	1902-1232	1	DIO-BKDN (1N3997R)	04713	1N3997R
I1	0340-0782	1	INSULATOR, XSTR (FOR Q1)	28480	0340-0782
J1	1200-0456	1	SKT-ELEC	28480	1200-0456
MP1	59401-01202	1	BRACKET, XSTR MOUNT W/FASTENERS	28480	59401-01202
MP2	7120-3185	1	LABEL-WARNING	28480	7120-3185
Q1	1853-0311	1	POWER TRANSISTOR (2N3792)	04713	2N3792

Diagram illustrating the internal components and assembly of the Model 59401A chassis, showing the location of various parts relative to the chassis structure.

Diagram labels:

- LABEL WARNING A4MP2
- TRANSISTOR MOUNT A4 ASSY
- TRANSISTOR A4Q1 INSULATOR A4I1 SOCKET A4J1
- DIODE A4CR2
- MOUNT BRACKET A4MP1

Table 6-1. Replaceable Parts (Cont'd)

REFERENCE DESIGNATOR	-hp- PART NO.	TQ	DESCRIPTION	MFR.	MFR. PART NO.
A5			A5 REAR END ASSEMBLY (NOT AVAILABLE AS AN ASSEMBLY)		
CR1	1901-0526	1	DIO ASSEMBLY, SI (SA 3337)	28480	1901-0526
F1	2110-0001	1	FUSE 1 AMP NB (110/120 V OPERATION)	71400	AGC-1
F2	2110-0012		FUSE .5 AMP NB (220/240 V OPERATION)	71400	AGC 1/2
J1	1251-3283	1	CONNECTOR, FEMALE, FOR HP-IB CABLE	28480	1251-3283
J2, J3	1250-0083	2	CONN, RF (BNC)	24931	28JR-130-1
MP1, MP2	0380-0643	2	STDF-STUD MT, METRIC, HP-IB CONN	28480	0380-0643
MP1, MP2	0380-1036		STDF-STUD MT, ENGLISH HP-IB	28480	0380-1036
MP3	0590-0075	1	NUT, CAP 4-40 FOR CR1	73734	8060-NP
MP4	4320-0276			28480	4320-0276
MP5	5020-8816	1	FRAME, REAR	28480	5020-8816
MP6	59401-60301	1	PANEL ASSEMBLY, Rear, Including Slide Switch	28480	59401-60301
MP7	5951-7587	1	LABEL-METRIC FOR HP-IB CONN	28480	5951-7587
MP8	7120-3528	1	LABEL-CAUTION	28480	7120-3528
MP9	7122-0058	1	SERIAL PLATE	28480	7122-0058
MP10-13	5040-7213	4	REAR FEET	28480	5040-7213
PM1	0960-0443	1	MODULE, POWER, LINE	28480	0960-0443
T1	9100-3433	1	XFMR-POWER	28480	9100-3433

Table 6-1. Replaceable Parts (Cont'd)

REFERENCE DESIGNATOR	-hp- PART NO.	TQ	DESCRIPTION	MFR.	MFR. PART NO.
A6			FRONT END ASSEMBLY (NOT AVAILABLE AS AN ASSEMBLY)		
MP1	4040-0599	1	DISPLAY WINDOW	28480	4040-0599
MP2	5020-8815	1	FRAME, FRONT	28480	5020-8815
MP3, 4	5020-0896	2	TRIM, SIDE FOR HANDLES	28480	5020-0896
MP5	5040-7203	1	TRIM, TOP	28480	5040-7203
MP6, 7	5060-9899	2	FT HANDLES	28480	5060-9899
MP8	59401-00201	1	PANEL, SWITCH MOUNTING	28480	59401-00201
MP9	59401-24301	1	TRIM STRIP FOR ID LABEL	28480	59401-24301
MP10	59401-24302	1	PANEL, MASK BEHIND WINDOW	28480	59401-24302
MP11	59401-60302	1	PANEL ASSEMBLY FRONT	28480	59401-60302
MP12	7120-4039	1	LABEL, ID	28480	7120-4039
MP13	9320-2262	1	CARD, PULLOUT	28480	9320-2262
MP14, 15	7101-0326	2	RETAINER, PLASTIC FOR TRIM STRIP	28480	7101-0326
MP16		1	PUSHBUTTON PART OF A2S12- NOT AVAILABLE SEPARATELY		
S1	59401-61901	1	SW ASSEMBLY, POWER (3101-1694)	28480	59401-61901

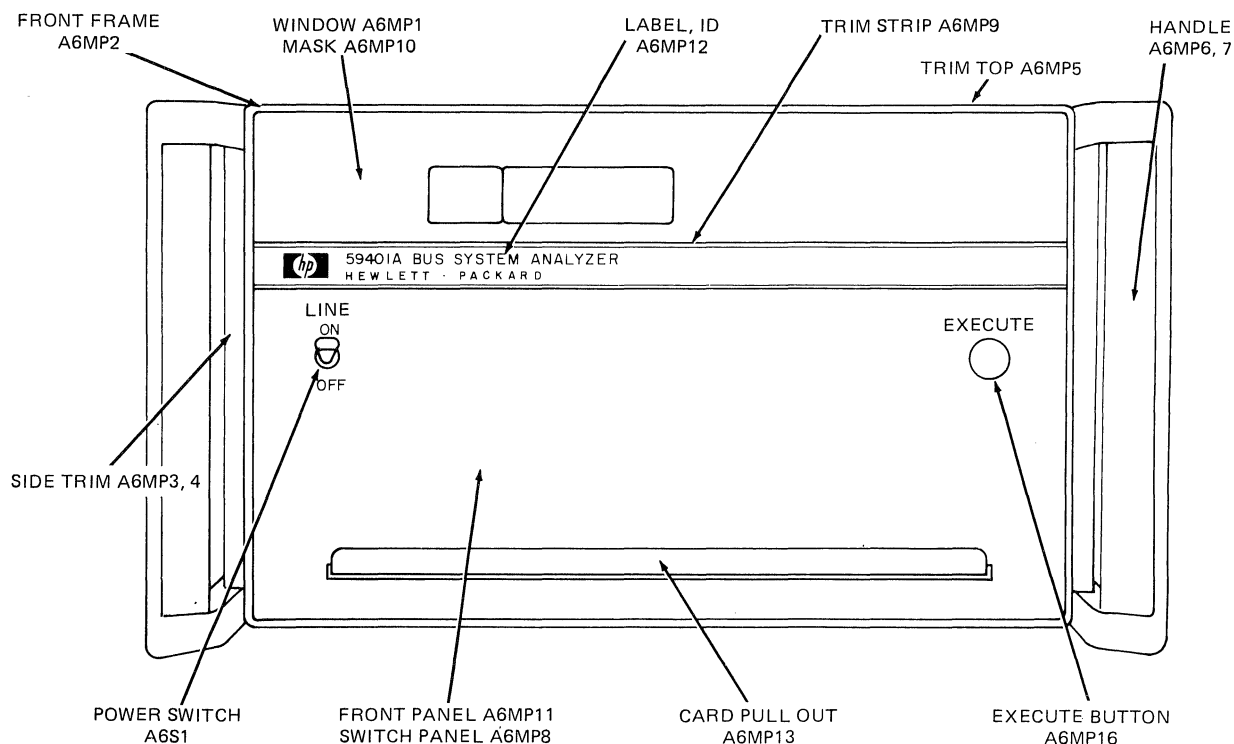
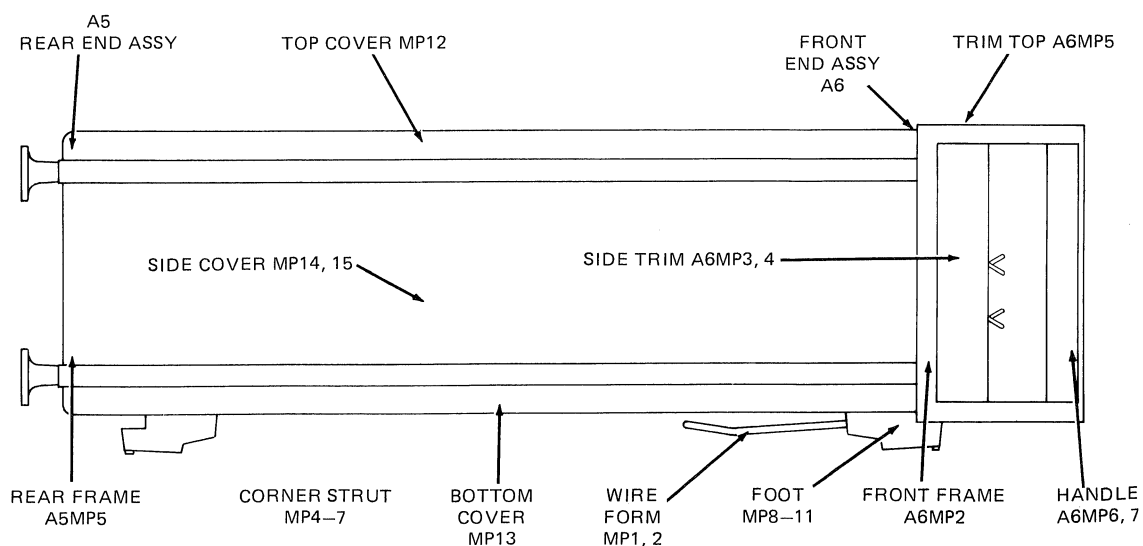




Table 6-1. Replaceable Parts (Cont'd)

REFERENCE DESIGNATOR	-hp- PART NO.	TQ	DESCRIPTION	MFR.	MFR. PART NO.
MECHANICAL AND OTHER PARTS					
MP1, 2	1460-1345	2	WIRE FORM FOR BOTTOM FEET	28480	1460-1345
MP3	4040-0633	1	ENVELOPE -INSTRUCTION CARD	28480	4040-0633
MP4-7	5020-8836	4	STRUT, CORNER	28480	5020-8836
MP8-11	5040-7201	4	FOOT, FOR BOTTOM COVER	28480	5040-7201
MP12	5060-9830	1	TOP COVER	28480	5060-9830
MP13	5060-9842	1	BOTTOM COVER	28480	5060-9842
MP14, 15	5060-9856	2	SIDE COVER	28480	5060-9856
MP16-22	59401-01201	7	BRACKET, PC MOUNTING	28480	59401-01201
MP23A	7124-2309	1	LABEL, INFORMATION-LAB INST	28480	7120-4614
W1	8120-1538	1	CABLE ASSEMBLY, INPUT POWER	28480	8120-1538
ACCESSORIES/OPTIONS					
ACC1	5061-0734		PC ASSEMBLY, EXTRA	28480	5061-0734
ACC2*	59401-90030		HP-IB DESCRIPTION MANUAL	28480	59401-90030
ACC 3	8120-1834		CABLE ASSEMBLY HP-IB 1.8 M (6 ft.) 10631B	28480	8120-1834
ACC 4*	8120-1834		CABLE ASSEMBLY HP-IB .9 M (3 ft.) 10631A	28480	8120-1834
ACC 5*	8120-1834		CABLE ASSEMBLY HP-IB 3.7 M (12 ft) 10631C	28480	8120-1834
ACC6	9211-2134		SHIPPING CARTON, CARDBOARD	28480	9211-2134
MP1,2,3,4*	1390-0360	4	LOCKSCREW, METRIC FOR HP-IB CABLE	28480	1390-0360
MP3,4,5,6*	0510-0015	4	RETAINER FOR LOCKSCREW HP-IB CABLE	0018A	1500-12-CD
OPT910*	59401-90001		OPTION 910, EXTRA MANUAL	28480	59401-90001
*NOT PROVIDED					



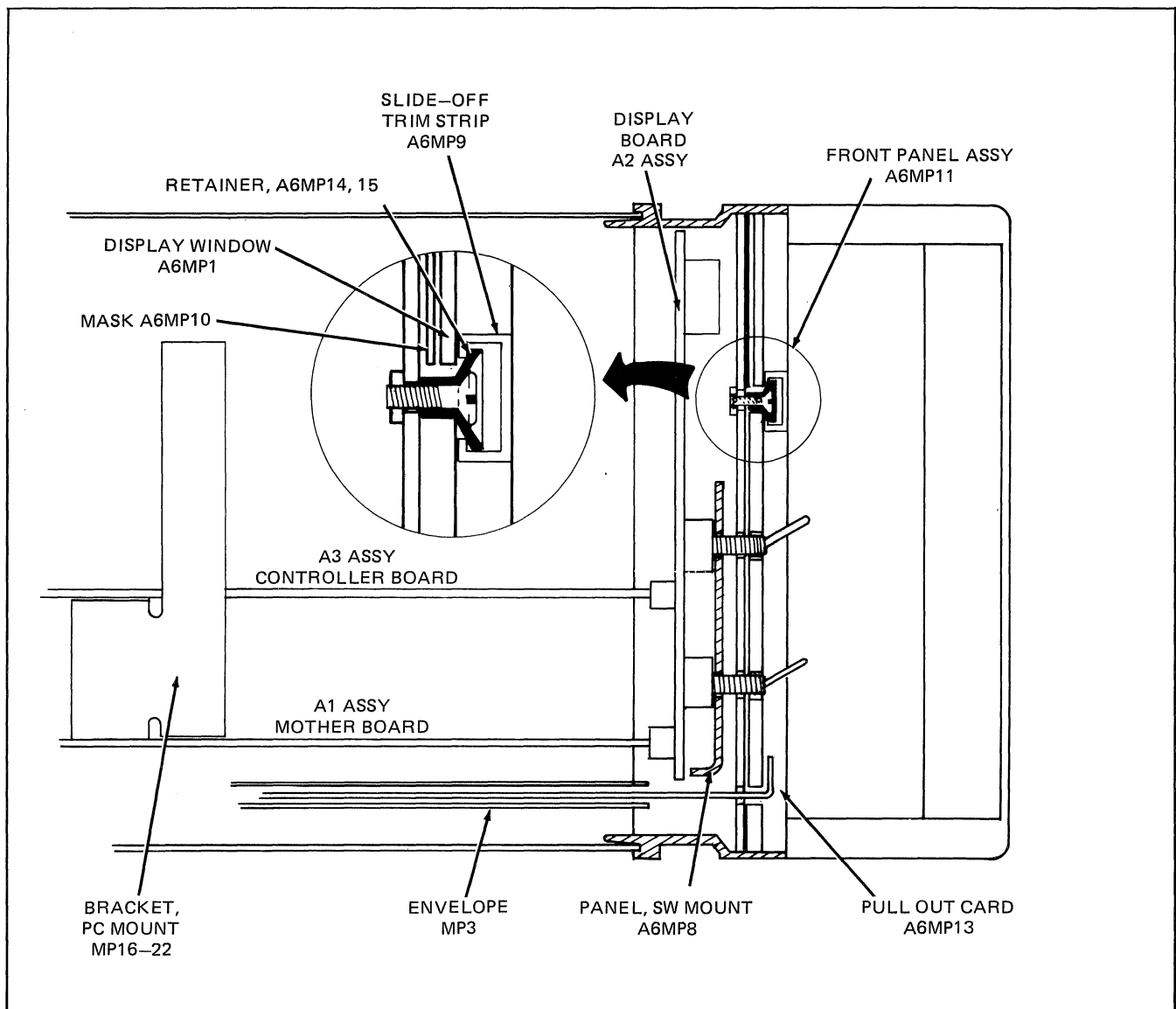


Figure 6-5. Additional Mechanical Parts.



## SECTION VII

### TROUBLESHOOTING AND CIRCUIT DIAGRAMS

**WARNING**

*All troubleshooting is to be done only by qualified service personnel who are aware of the hazard of exposed voltage terminals.*

#### 7-1. INTRODUCTION.

7-2. This section contains the following troubleshooting aids.

- a. Block Diagram, Figure 7-1.
- b. Schematic Diagrams and component locators, Figures 7-2 through 7-11.
- c. Dictionary of Integrated Circuits, including ROM bit patterns, Table 7-1.

7-3. This section contains no theory of operation; however, the theory will be provided as it becomes available. As an interim substitute, use the information in Section III as a guide to studying the block and schematic diagrams and ROM bit patterns. Most circuit functions will thereby become apparent.

#### 7-4. FAILING COMPONENTS.

7-5. The components with the highest history of failure are as follows. They should be checked first in a troubleshooting situation.

- a. A1 assembly: Bus drivers U111, 112, 113. (All are in sockets for easy replacement.)
- b. Front panel LED indicators.
- c. A1 board or A3 board slips out of socket on A2 board when A2 mounting screws are tightened.
- d. Most other problems are on the A3 board.
  1. Fast controller IC's: U2, 5, 6, 10, 11, 12, 17, 18, 20, 21, 27, 28, 29, 30
  2. Open traces between ROM's U15, 16, 25 and 26.

7-6. If any components in the + 5 volt power supply are replaced, perform the + 5 volt power supply adjustment described in Section V.

#### 7-7. ADDITIONAL TROUBLESHOOTING HINTS.

7-8. Additional troubleshooting information will be provided as it becomes available.

Table 7-1. Integrated Circuit Dictionary Including Pin Outs,  
Logic Diagrams, Truth Tables.

IC TO ITEM NUMBER CROSS REFERENCE

Assy/IC No.	-hp- Part No.	Item No.	IC Type
A1U1	1820-0196	15	IC-U5R7723393
A1U101	1820-0621	31	IC-SN7438N
A1U102	1820-1056	39	IC-SN74132
A1U103	1820-0583	26	IC-DM74L00
A1U104, 105	1820-0618	29	IC-DGTL SN7417N
A1U106	1820-1053	38	IC-SN 7414
A1U107-109	1820-0506	21	IC-DIGITAL
A1U110	1820-0621	31	IC-SN7438N
A1U111-113	1820-1335	43	IC - LINEAR
A1U201	1820-0579	25	IC DGTL SN74123N
A1U202	1820-1141	41	IC SN74185
A1U203	1820-0233	16	IC SN74193N
A1U204	1820-0054	9	IC SN7400N
A1U205	1820-0233	16	IC SN74193N
A1U206-208	1820-0628	32	IC DGT- SN7489N
A1U209	1820-0577	24	IC SN7416N
A1U210	1820-0618	29	IC DGTL SN7417N
A1U211	1820-0070	11	IC SN7430N
A1U212	1820-0281	17	IC - DGTL SN74107N
A1U213	1820-0661	34	IC QUAD SN7432N
A1U214	1820-0301	18	IC -SN7475N
A1U215-217	1820-0628	32	IC DGT- SN7489N
A1U301-303	1820-0506	21	IC -DIGITAL
A1U304	1820-0577	24	IC-SN7416N
A1U401-411	1820-0583	26	IC -DM74L00
A1U412	1820-0706	35	IC -DGTL-COMPTR
A1U413	1820-0054	9	IC-SN7400N
A1U414	1820-0506	21	IC-DIGITAL
A1U415	1820-0904	36	IC-DGTL-COMPTR
A1U416	1820-0583	26	IC-DM74L00
A1U418	1820-0506	21	IC-DIGITAL
A1U419	1820-0904	36	IC DGTL-COMPTR
A1U420	1820-0583	26	IC-DM74L00
A1U421	1820-0506	21	IC-DIGITAL
A2U1-U4	1858-0014	44	PNP QUAD DRIVER
A2U5	1820-0495	20	IC-SN74154N
A2U6-U8	1858-0014	44	PNP QUAD DRIVER
A2U9	1820-0495	20	IC-SN74154N

IC TO ITEM NUMBER CROSS REFERENCE (Cont'd)

Assy/IC No.	-hp- Part No.	Item No.	IC Type
A3U1	1820-0507	22	IC DGTL-MUVR
A3U2	1820-1191	42	IC DGTL-FF
A3U3	1816-0425	2	IC-MM6331
A3U4	1816-0438	3	ROM BIPOLAR
A3U5,U6	1820-0301	18	IC-SN7475N
A3U7	1820-0054	9	IC-SN7400N
A3U8	1820-0068	10	IC-SN7410N
A3U9	1820-0511	23	IC-SN7408N
A3U10	1820-0661	34	IC-QUAD SN7432N
A3U11	1820-1191	42	IC DGTL- FF
A3U12	1820-0579	25	IC-DGTL SN74123N
A3U13, U14	1820-0640	33	IC-SN74150N
A3U15	1818-2233	6	MOS ROM 4 K
A3U16	1818-2234	7	MOS-ROM 4K
A3U17, U18	1820-0077	12	IC-SN7474N
A3U19, U20	1820-0596	28	IC-DGTL DM74L74N
A3U21	1820-0301	18	IC-SN7475N
A3U22	1820-0621	31	IC-SN7438N
A3U23, U24	1820-0989	37	IC-SN8271B
A3U25	1818-2232	5	MOS ROM 4K
A3U26	1818-2235	8	MOS-ROM 4K
A3U27-U30	1820-0301	18	IC- SN7475N
A3U31-U34	1820-0586	27	IC -DGTL DM74L04N
A3U35	1820-0054	9	IC-SN7400N
A3U101, 102	1820-0620	30	IC-DGTL SN74153N
A3U103, 104	1820-0506	21	IC- DIGITAL
A3U105 Δ1a	1820-0491	19	IC SN74145N
A3U106 Δ1a	1818-0102	4a	IC- TMS-4103
A3U106 Δ1b	1816-1300	4b	IC-ROM 3624
A3U107	1820-0586	27	IC-DGTL DM74L04N
A3U108	1816-0424	1	IC-MM6331
A3U109	1820-0099	13	IC-SN7493N
A3U110	1820-0077	12	IC-SN7474N
A3U111 Δ1a	1820-0577	24	IC-SN7416N
A3U112	1820-1066	40	IC DGTL-GATE
A3U113	1820-1053	38	IC-SN7414
A3U114	1820-0661	34	IC-QUAD SN7432N
A3U115 Δ1a	1820-0618	29	IC-DGTL SN7417N
A3U116 Δ1a	1820-0175	14	IC-SN7405N
A3U117 Δ1a	1820-0586	27	IC-DGTL DM74L04N
A3U201	1820-1053	38	IC-SN 7414
A3U202, 203	1820-0054	9	IC-SN7400N

Δ1a Used on serial numbers 1714A00490 and below only.

Δ1b Used on serial numbers 1714A00491 and up only.

## ITEM TO PART NUMBER CROSS REFERENCE

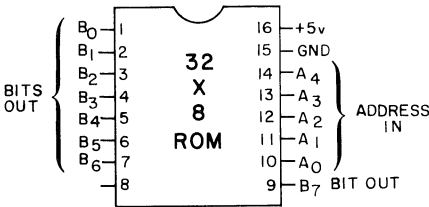
Item No.	Part No.	IC Type	U Number
1	1816-0424	MM6331A	A3U108
2	1816-0425	MM6631B	A3U3
3	1816-0438	ROM Bipolar	A3U4
4a	1818-0102	TMS 4103	A3U106 $\Delta_{1a}$
4b	1818-1300	ROM 3634	A3U106 $\Delta_{1b}$
5	1818-2232	ROM-4K	A3U25
6	1818-2233	ROM-4K	A3U15
7	1818-2234	ROM-4K	A3U16
8	1818-2235	ROM-4K	A3U26
9	1820-0054	SN7400N	A1U204, 413; A3U7, 35, 202, 203
10	1820-0068	SN7410N	A3U8
11	1820-0070	SN7430N	A1U211
12	1820-0077	SN7474	A3U17, 18, 110
13	1820-0099	SN7493	A3U109
14	1820-0175	SN7405N	A3U116
15	1820-0196	723HC	A3U116 $\Delta_{1a}$
16	1820-0233	SN74193N	A1U1
17	1820-0281	SN74107N	A1U203, 205
18	1820-0301	SN7475N	A1U214; A3U5, 6, 21, 27-30
19	1820-0491	SN74145N	A3U105 $\Delta_{1a}$
20	1820-0495	SN74154N	A2U5, 9
21	1820-0506	N8263B	A3U1
22	1820-0507	N8266B	A1U107-109, 301-303, 414, 418, 421; A3U103, 104
23	1820-0511	SN7408N	A3U9
24	1820-0577	SN7416N	A1U209, 304; A3U111 $\Delta_{1a}$ , 201
25	1820-0579	SN74123N	A1U201; A3U12
26	1820-0583	DM74L00	A1U103, 401-411, 416, 420
27	1820-0586	DM74L04N	A3U31-34, 107, 117 $\Delta_{1a}$
28	1820-0596	DM74L74N	A3U19, 20
29	1820-0618	SN7417N	A1U104, 105, 210; A3U115 $\Delta_{1a}$
30	1820-0620	SN74153	A3U101, 102
31	1820-0621	SN7438N	A1U101, 110; A3U22
32	1820-0628	SN7489N	A1U206-208, 215-217
33	1820-0640	SN74150N	A3U13, 14
34	1820-0661	SN7432N	A1U213; A3U10, 114
35	1820-0706	9324DC	A1U412
36	1820-0904	93L24DC	A1U415, 419
37	1820-0989	SN8271	A3U23, 24
38	1820-1053	SN7414	A1U106; A3U113, 201
39	1820-1056	SN74132	A1U102
40	1820-1066	7411PC	A3U112
41	1820-1141	SN74S175N	A3U2, 11
42	1820-1191	SN74185	A1U202
43	1820-1335	Linear	A1U111-113
44	1858-0014	Quad PNP	A2U1-4, 6-8

$\Delta_{1a}$  Used on serial numbers 1714A00490 and below only.

$\Delta_{1b}$  Used on serial numbers 1714A00491 and up only.

1

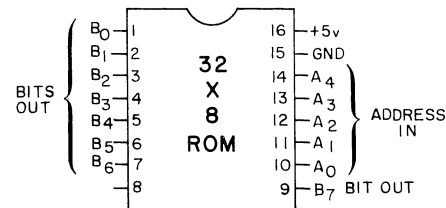
A3U108: MM6331A  
1816-0424



Word No. (Decimal)	Octal Address Input	U108 Bit Pattern Output							
		B7	B6	B5	B4	B3	B2	B1	B0
Word 0:	0	0	0	0	0	1	1	1	1
Word 1:	1	0	0	1	0	1	1	1	1
Word 2:	2	0	1	0	0	1	1	1	1
Word 3:	3	0	1	1	0	1	1	1	1
Word 4:	4	0	0	0	0	1	1	1	1
Word 5:	5	0	0	0	1	1	1	1	1
Word 6:	6	0	0	1	1	1	1	1	1
Word 7:	7	0	1	0	1	1	1	1	1
Word 8:	10	0	1	1	1	1	1	1	1
Word 9:	11	1	0	0	1	1	1	1	1
Word 10:	12	0	0	0	0	1	1	0	0
Word 11:	13	0	0	1	0	1	1	0	0
Word 12:	14	0	1	0	0	1	1	0	0
Word 13:	15	0	1	1	0	1	1	0	0
Word 14:	16	1	0	0	0	1	1	0	0
Word 15:	17	0	0	0	1	1	0	1	0
Word 16:	20	0	0	1	1	1	0	1	0
Word 17:	21	0	1	0	1	1	0	1	0
Word 18:	22	0	1	1	1	1	0	1	0
Word 19:	23	1	0	0	1	1	0	1	0
Word 20:	24	0	0	0	1	0	1	1	0
Word 21:	25	0	0	1	1	0	1	1	0
Word 22:	26	0	1	0	1	0	1	1	0
Word 23:	27	0	1	1	1	0	1	1	0
Word 24:	30	1	0	0	1	0	1	1	0
Word 25:	31	0	0	0	1	0	0	1	0
Word 26:	32	0	0	1	1	0	0	1	0
Word 27:	33	0	1	0	1	0	0	1	0
Word 28:	34	0	1	1	1	0	0	1	0
Word 29:	35	1	0	0	1	0	0	1	0
Word 30:	36	1	1	1	1	1	1	1	1
Word 31:	37	1	1	1	1	1	1	1	1

2

A3U3: MM6331B  
1816-0425



Word No. (Decimal)	Octal Address Input	U3 Bit Pattern Output							
		B7	B6	B5	B4	B3	B2	B1	B0
Word 0:	0	0	0	0	1	0	1	0	1
Word 1:	1	1	0	0	1	0	1	0	0
Word 2:	2	0	0	0	1	1	1	0	0
Word 3:	3	0	1	0	1	1	1	0	0
Word 4:	4	0	0	1	1	0	1	0	0
Word 5:	5	0	0	0	1	0	1	0	0
Word 6:	6	0	0	0	1	0	1	0	0
Word 7:	7	0	0	0	1	0	1	0	0
Word 8:	10	0	0	0	1	0	1	0	1
Word 9:	11	1	0	0	1	0	1	0	1
Word 10:	12	0	1	0	1	0	1	0	1
Word 11:	13	0	0	0	1	0	1	0	1
Word 12:	14	0	0	1	1	0	1	0	1
Word 13:	15	0	0	0	1	0	1	0	1
Word 14:	16	0	0	0	1	0	1	0	1
Word 15:	17	0	0	0	1	0	1	0	1
Word 16:	20	0	0	0	1	0	1	0	1
Word 17:	21	1	0	0	1	0	1	0	0
Word 18:	22	0	0	0	1	1	1	1	0
Word 19:	23	0	1	0	1	1	1	1	0
Word 20:	24	0	0	1	1	1	1	1	0
Word 21:	25	0	0	0	1	0	1	0	0
Word 22:	26	0	0	0	1	0	1	0	0
Word 23:	27	0	0	0	1	1	1	1	0
Word 24:	30	0	0	0	1	0	0	1	1
Word 25:	31	1	0	0	1	0	1	1	1
Word 26:	32	0	1	0	1	0	1	1	1
Word 27:	33	0	0	0	1	0	1	0	1
Word 28:	34	0	0	1	0	0	1	0	1
Word 29:	35	0	0	0	1	0	1	0	1
Word 30:	36	0	0	0	1	0	1	0	1
Word 31:	37	0	0	0	0	0	1	0	1



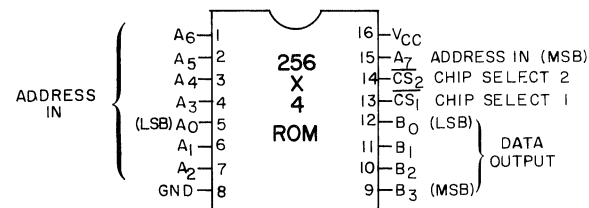
Decimal Word	Input Octal Address	Output Bit Pattern			
		B3	B2	B1	B0
0	000	0	0	1	0
1	001	0	1	0	0
2	002	0	0	1	0
3	003	0	0	0	0
4	004	0	0	1	0
5	005	0	0	0	0
6	006	0	0	1	0
7	007	0	0	0	0
8	010	0	0	1	0
9	011	0	0	0	0
10	012	0	0	1	0
11	013	0	0	0	0
12	014	0	0	1	0
13	015	0	0	0	0
14	016	0	0	1	0
15	017	0	0	0	0
16	020	0	0	1	1
17	021	0	0	0	1
18	022	0	0	1	1
19	023	0	0	0	1
20	024	0	0	1	1
21	025	0	0	0	1
22	026	0	0	1	1
23	027	0	0	0	1
24	030	0	0	1	1
25	031	0	0	0	1
26	032	0	0	1	1
27	033	0	0	0	1
28	034	0	0	1	1
29	035	0	0	0	1
30	036	0	0	1	1
31	037	0	0	0	1
32	040	1	1	1	1
33	041	1	1	1	1
34	042	1	1	1	1
35	043	1	1	1	1
36	044	1	1	1	1
37	045	1	1	1	1
38	046	1	1	1	1
39	047	1	1	1	1
40	050	1	1	1	1
41	051	1	1	1	1
42	052	1	1	1	1
43	053	1	1	1	1
44	054	1	1	1	1
45	055	1	1	1	1
46	056	1	1	1	1
47	057	1	1	1	1
48	060	0	0	0	1
49	061	0	1	1	1
50	062	0	0	0	1

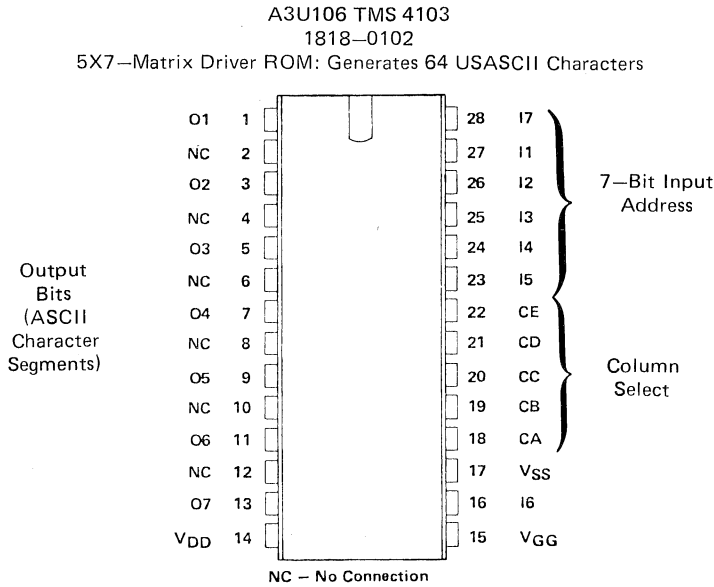
Decimal Word	Input Octal Address	Output Bit Pattern			
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52	064	0	0	0	1
53	065	0	1	1	1
54	066	0	0	0	1
55	067	0	1	1	1
56	070	0	0	0	1
57	071	0	1	1	1
58	072	0	0	0	1
59	073	0	1	1	1
60	074	0	0	0	1
61	075	0	1	1	1
62	076	0	0	0	1
63	077	0	1	1	1
64	100	1	0	0	1
65	101	0	0	0	1
66	102	1	0	0	1
67	103	0	0	0	1
68	104	1	0	0	1
69	105	0	0	0	1
70	106	1	0	0	1
71	107	0	0	0	1
72	110	1	0	0	1
73	111	0	0	0	1
74	112	1	0	0	1
75	113	0	0	0	1
76	114	1	0	0	1
77	115	0	0	0	1
78	116	1	0	0	1
79	117	0	0	0	1
80	120	0	0	0	1
81	121	0	0	0	1
82	122	0	0	0	1
83	123	0	0	0	1
84	124	0	0	0	1
85	125	0	0	0	1
86	126	0	0	0	1
87	127	0	0	0	1
88	130	0	0	0	1
89	131	0	0	0	1
90	132	0	0	0	1
91	133	0	0	0	1
92	134	0	0	0	1
93	135	0	0	0	1
94	136	0	0	0	1
95	137	0	0	0	1
96	140	0	0	0	1
97	141	0	0	0	1
98	142	0	0	0	1
99	143	0	0	0	1
100	144	0	0	1	1

Decimal Word	Input Octal Address	Output Bit Pattern			
		B3	B2	B1	B0
101	145	0	0	0	1
102	146	0	0	0	1
103	147	0	0	0	1
104	150	0	0	0	1
105	151	0	0	0	1
106	152	0	0	0	1
107	153	0	0	0	1
108	154	0	0	0	1
109	155	0	0	0	1
110	156	0	0	0	1
111	157	0	0	0	1
112	160	1	0	0	1
113	161	0	1	1	1
114	162	1	0	0	1
115	163	1	1	1	1
116	164	1	0	0	1
117	165	0	1	1	1
118	166	1	0	0	1
119	167	1	1	1	1
120	170	1	0	0	1
121	171	0	1	1	1
122	172	1	0	0	1
123	173	1	1	1	1
124	174	1	0	0	1
125	175	1	0	1	1
126	176	1	0	0	1
127	177	1	1	1	1
128	200	0	0	1	1
129	201	0	0	0	1
130	202	0	0	1	1
131	203	0	0	0	1
132	204	0	0	1	1
133	205	0	1	0	1
134	206	0	0	1	1
135	207	1	1	1	1
136	210	0	0	1	1
137	211	0	0	0	1
138	212	0	0	1	1
139	213	0	0	0	1
140	214	0	0	1	1
141	215	0	1	0	1
142	216	0	0	1	1
143	217	1	1	1	1
144	220	0	0	1	1
145	221	0	0	0	1
146	222	0	0	1	1
147	223	0	0	0	1
148	224	0	0	1	1
149	225	0	0	0	1
150	226	0	0	1	1

Decimal Word	Input Octal Address	Output Bit Pattern			
		B3	B2	B1	B0
151	227	0	0	0	1
152	230	0	0	1	1
153	231	0	0	0	1
154	232	0	0	1	1
155	233	0	0	0	1
156	234	0	0	1	1
157	235	0	0	0	1
158	236	0	0	1	1
159	237	0	0	0	1
160	240	0	0	0	1
161	241	0	0	0	1
162	242	0	0	0	1
163	243	0	0	0	1
164	244	0	0	0	1
165	245	0	0	0	1
166	246	0	0	0	1
167	247	0	0	0	1
168	250	0	1	0	1
169	251	0	1	0	1
170	252	0	1	0	1
171	253	0	1	0	1
172	254	0	1	0	1
173	255	0	1	0	1
174	256	0	1	0	1
175	257	0	1	0	1
176	260	0	0	0	1
177	261	0	0	0	1
178	262	0	0	0	1
179	263	0	0	0	1
180	264	0	0	0	1
181	265	0	0	0	1
182	266	0	0	0	1
183	267	0	0	0	1
184	270	0	0	0	1
185	271	0	0	0	1
186	272	0	0	0	1
187	273	0	0	0	1
188	274	0	0	0	1
189	275	0	0	0	1
190	276	0	0	0	1
191	277	0	0	0	1
192	300	1	0	0	1
193	301	1	1	1	1
194	302	1	0	0	1
195	303	1	1	1	1
196	304	1	0	0	1
197	305	1	1	1	1
198	306	1	0	0	1
199	307	1	1	1	1
200	310	1	0	0	1

Decimal Word	Input Octal Address	Output Bit Pattern			
		B3	B2	B1	B0
201	311	1	1	1	1
202	312	1	0	0	1
203	313	1	1	1	1
204	314	1	0	0	1
205	315	1	1	1	1
206	316	1	0	0	1
207	317	1	1	1	1
208	320	0	0	0	1
209	321	0	0	0	1
210	322	0	0	0	1
211	323	0	0	0	1
212	324	0	0	0	1
213	325	0	0	0	1
214	326	0	0	0	1
215	327	0	0	0	1
216	330	0	0	0	1
217	331	0	0	0	1
218	332	0	0	0	1
219	333	0	0	0	1
220	334	0	0	0	1
221	335	0	0	0	1
222	336	0	0	0	1
223	337	0	0	0	1
224	340	0	0	0	1
225	341	0	0	0	1
226	342	0	0	0	1
227	343	0	0	0	1
228	344	0	0	0	1
229	345	0	0	0	1
230	346	0	0	0	1
231	347	0	0	0	1
232	350	0	0	0	1
233	351	0	0	0	1
234	352	0	0	0	1
235	353	0	0	0	1
236	354	0	0	0	1
237	355	0	0	0	1
238	356	0	0	0	1
239	357	0	0	0	1
240	360	1	0	0	1
241	361	0	0	0	1
242	362	1	0	0	1
243	363	0	0	0	1
244	364	1	0	0	1
245	365	1	1	1	1
246	366	1	0	0	1
247	367	1	1	1	1
248	370	1	0	0	1
249	371	0	0	0	1
250	372	1	0	0	1
251	373	0	0	0	1
252	374	1	0	0	1
253	375	1	1	1	1
254	376	1	0	0	1
255	377	1	1	1	1

A3U4 Bipolar ROM  
1816-0438



Δ1a: Used on Serial Numbers 1714A00490 and below only.

The TMS 4103 generates 64 USASCII characters for driving a 5 x 7 matrix display. Output buffers are open-drain and are capable of driving Series 74 TTL circuits without external resistors. All inputs can be driven directly from Series 74 TTL circuits.

The five 7-bit column words appear on O1 through O7 as column select inputs CA through CE are strobed in sequence with a high level pulse. The device is enabled with a high level on I7.

functional block diagram

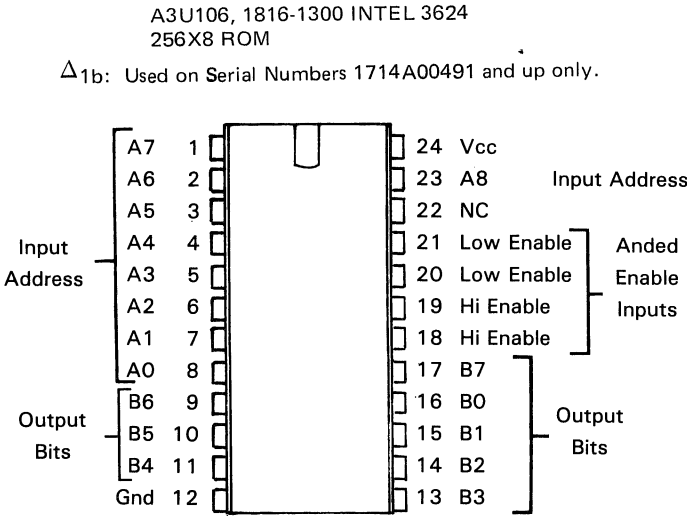
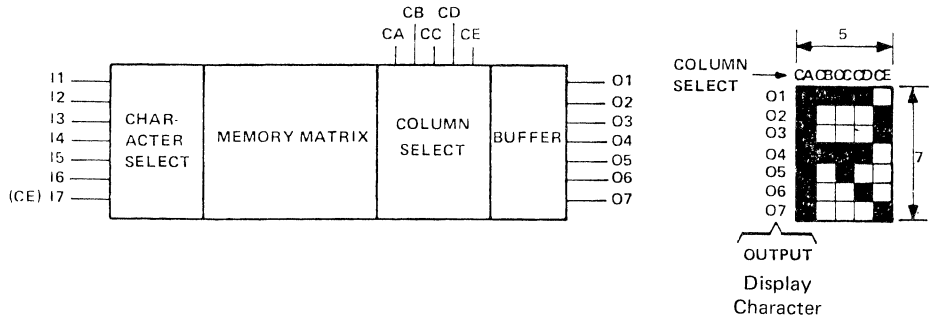


Table of ROM Contents

Address	Contents								Address	Contents							
	X X 0	X X 1	X X 2	X X 3	X X 4	X X 5	X X 6	X X 7		X X 0	X X 1	X X 2	X X 3	X X 4	X X 5	X X 6	X X 7
0 0 X	1 0 1	0 7 6	0 4 2	0 5 2	1 0 3	3 7 7	3 7 7	3 7 7	4 0 X	1 7 7	1 7 7	1 7 7	1 7 7	1 7 7	3 7 7	3 7 7	3 7 7
0 1 X	1 0 0	0 6 7	0 6 7	0 6 7	1 0 0	3 7 7	3 7 7	3 7 7	4 1 X	1 7 7	1 7 7	0 0 6	1 7 7	1 7 7	3 7 7	3 7 7	3 7 7
0 2 X	0 0 0	0 6 6	0 6 6	0 6 6	1 1 1	3 7 7	3 7 7	3 7 7	4 2 X	1 7 7	0 1 7	1 7 7	0 1 7	1 7 7	3 7 7	3 7 7	3 7 7
0 3 X	1 0 1	0 7 6	0 7 6	0 7 6	1 3 5	3 7 7	3 7 7	3 7 7	4 3 X	1 5 3	0 0 0	1 5 3	0 0 0	1 5 3	3 7 7	3 7 7	3 7 7
0 4 X	0 0 0	0 7 6	0 7 6	1 3 5	1 4 3	3 7 7	3 7 7	3 7 7	4 4 X	1 5 5	1 2 5	0 0 0	1 2 5	1 3 3	3 7 7	3 7 7	3 7 7
0 5 X	0 0 0	0 6 6	0 6 6	0 6 6	0 7 6	3 7 7	3 7 7	3 7 7	4 5 X	0 3 4	0 3 3	1 6 7	1 5 4	0 3 4	3 7 7	3 7 7	3 7 7
0 6 X	0 0 0	0 6 7	0 6 7	0 6 7	0 7 7	3 7 7	3 7 7	3 7 7	4 6 X	1 7 1	1 0 6	0 6 2	1 1 5	1 7 2	3 7 7	3 7 7	3 7 7
0 7 X	1 0 1	0 7 6	0 7 6	0 6 6	1 2 0	3 7 7	3 7 7	3 7 7	4 7 X	1 5 7	1 3 7	0 7 7	1 7 7	1 7 7	3 7 7	3 7 7	3 7 7
1 0 X	0 0 0	1 6 7	1 6 7	1 6 7	0 0 0	3 7 7	3 7 7	3 7 7	5 0 X	1 7 7	1 4 3	1 3 5	0 7 6	1 7 7	3 7 7	3 7 7	3 7 7
1 1 X	1 7 7	0 7 6	0 0 0	0 7 6	1 7 7	3 7 7	3 7 7	3 7 7	5 1 X	1 7 7	0 7 6	1 3 5	1 4 3	1 7 7	3 7 7	3 7 7	3 7 7
1 2 X	1 7 5	1 7 6	1 7 6	1 7 6	0 0 1	3 7 7	3 7 7	3 7 7	5 2 X	1 5 3	1 6 7	1 0 1	1 6 7	1 5 3	3 7 7	3 7 7	3 7 7
1 3 X	0 0 0	1 6 7	1 5 3	1 3 5	0 7 6	3 7 7	3 7 7	3 7 7	5 3 X	1 6 7	1 6 7	1 0 1	1 6 7	1 6 7	3 7 7	3 7 7	3 7 7
1 4 X	0 0 0	1 7 6	1 7 6	1 7 6	1 7 6	3 7 7	3 7 7	3 7 7	5 4 X	1 7 7	1 6 2	1 6 1	1 7 7	1 7 7	3 7 7	3 7 7	3 7 7
1 5 X	0 0 0	1 3 7	1 4 7	1 3 7	0 0 0	3 7 7	3 7 7	3 7 7	5 5 X	1 6 7	1 6 7	1 6 7	1 6 7	1 6 7	3 7 7	3 7 7	3 7 7
1 6 X	0 0 0	1 1 7	1 6 7	1 7 1	0 0 0	3 7 7	3 7 7	3 7 7	5 6 X	1 7 7	1 7 4	1 7 4	1 7 7	1 7 7	3 7 7	3 7 7	3 7 7
1 7 X	1 0 1	0 7 6	0 7 6	0 7 6	1 0 1	3 7 7	3 7 7	3 7 7	5 7 X	1 7 4	1 7 3	1 6 7	1 5 7	0 3 7	3 7 7	3 7 7	3 7 7
2 0 X	0 0 0	0 6 7	0 6 7	0 6 7	1 1 7	3 7 7	3 7 7	3 7 7	6 0 X	1 0 1	0 7 2	0 6 6	0 5 6	1 0 1	3 7 7	3 7 7	3 7 7
2 1 X	1 0 1	0 7 6	0 7 2	0 7 5	1 0 2	3 7 7	3 7 7	3 7 7	6 1 X	1 5 6	1 3 6	0 0 0	1 7 6	1 7 6	3 7 7	3 7 7	3 7 7
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2 3 X	1 1 5	0 6 6	0 6 6	0 6 6	1 3 1	3 7 7	2 7 7	3 7 7	6 3 X	1 3 5	0 7 6	0 6 6	0 6 6	1 1 1	3 7 7	3 7 7	3 7 7
2 4 X	0 7 7	0 7 7	0 0 0	0 7 7	0 7 7	3 7 7	3 7 7	3 7 7	6 4 X	1 6 3	1 5 3	1 3 3	0 0 0	1 7 3	3 7 7	3 7 7	3 7 7
2 5 X	0 0 1	1 7 6	1 7 6	1 7 6	0 0 1	3 7 7	3 7 7	3 7 7	6 5 X	0 1 5	0 5 6	0 5 6	0 5 6	0 6 1	3 7 7	3 7 7	3 7 7
2 6 X	0 1 7	1 6 3	1 7 4	1 6 3	0 1 7	3 7 7	3 7 7	3 7 7	6 6 X	1 4 1	1 2 6	0 6 6	0 6 6	0 7 1	3 7 7	3 7 7	3 7 7
2 7 X	0 0 0	1 7 5	1 6 3	1 7 5	0 0 0	3 7 7	3 7 7	3 7 7	6 7 X	0 7 7	0 7 0	0 6 7	0 5 7	0 3 7	3 7 7	3 7 7	3 7 7
3 0 X	0 3 4	1 5 3	1 6 7	1 5 3	0 3 4	3 7 7	3 7 7	3 7 7	7 0 X	1 1 1	0 6 6	0 6 6	0 6 6	1 1 1	3 7 7	3 7 7	3 7 7
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3 4 X	0 3 7	1 5 7	1 6 7	1 7 3	1 7 4	3 7 7	3 7 7	3 7 7	7 4 X	1 5 3	1 5 3	1 3 5	0 7 6	1 7 7	3 7 7	3 7 7	3 7 7
3 5 X	1 7 7	1 7 7	0 7 6	0 7 6	0 0 0	3 7 7	3 7 7	3 7 7	7 5 X	1 5 3	1 5 3	1 3 5	1 5 3	1 5 3	3 7 7	3 7 7	3 7 7
3 6 X	1 3 7	0 7 7	0 7 7	0 7 7	1 3 7	3 7 7	3 7 7	3 7 7	7 6 X	1 7 7	0 7 6	1 3 5	1 5 3	1 6 7	3 7 7	3 7 7	3 7 7
3 7 X	1 7 6	1 7 6	1 7 6	1 7 6	1 7 6	3 7 7	3 7 7	3 7 7	7 7 X	1 3 7	0 7 7	0 7 2	0 6 7	1 1 7	3 7 7	3 7 7	3 7 7

OCTAL ADD	BIT PATTERN MSB ← → LSB
000	1111111101100011
001	1101111101100011
002	1110111101110111
003	1110111101100011
004	1111111111100011
005	1111111111110111
006	1101111101110111
007	1111011110100001
010	1111111101110111
011	11100111110100001
012	1011011110110001
013	10100111110100001
014	1111011110100101
015	1110011110100001
016	1111011110100101
017	1111011110110001
020	1010011110110001
021	1000111111100011
022	1111111111100111
023	1111011111100111
024	1011011110110001
025	1000011111100011
026	1010011110100001
027	0101011110100001
030	1011011110110001
031	1101011110110001
032	1110011110110001
033	1111011110110001
034	0110011110110001
035	1101011110110001
036	1110011110110001
037	1111011110110001
040	0101011110110001
041	1110101011100001
042	1010101011100001
043	1100101011100001
044	1101101011100001
045	1111101011100000
046	1010101011100001
047	1111101101100011
050	1111101111100000
051	1111101111100011
052	1000101111100011
053	1111101111100001
054	0011101111100001
055	1111101111100001
056	1111101111000011
057	1111101111000001
060	1111101111000001
061	1001101111000001
062	1111101111000001
063	1111111111100011
064	1000111111100011
065	1111111111100011
066	1000111111100011
067	1110111101100011
070	1111011111100001

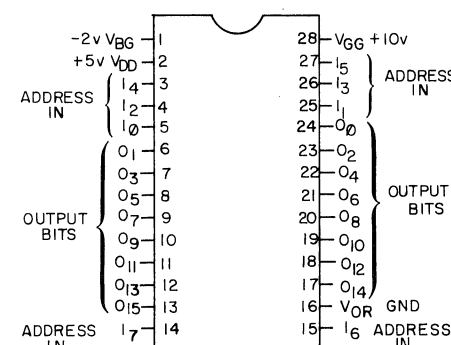
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073	01100111110100001
074	11110111110100001
075	01000111110100001
076	10100111110100001
077	01010111110100001
100	11100111110100001
101	1111111111100011
102	1000111111100011
103	11011111101100011
104	10100111110100001
105	11100111110100001
106	0101011110100001
107	11110111110110101
110	11110111110100001
111	11100111110100001
112	1111111111100011
113	1000111111100011
114	00110111110100001
115	111111111101100011
116	11101111101000011
117	11011111101100011
120	11001111101100011
121	01111111101100011
122	11111111101000011
123	11011111101100011
124	01111111101100011
125	1111111111100000
126	1111111111100011
127	1000111111100011
130	11011111101000011
131	11101111101100011
132	11111111101000011
133	1111110101110111
134	1111111111100000
135	1111111111100011
136	1000111111100011
137	1111111101100001
140	1111101111100001
141	0011101111100001
142	1111101111100001
143	1100111111100011
144	1111111111100011
145	1111111111100001
146	11111011111000001
147	11111011111000001
150	1001101111000001
151	11011111101100011
152	1111110101100000
153	11111111101100011
154	1101110101100011
155	10101111101100011
156	1101100111100001
157	1100101111100001
160	1010101111100001
161	1111111111100011

OCTAL ADD	BIT PATTERN MSB ← → LSB
162	1000111111100011
163	01111111101100011
164	10101111101100011
165	1111111111100011
166	1000111111100011
167	1101111110100001
170	1111111110100001
171	1111111110100001
172	11101111101100011
173	11011111101100011
174	1010110101100011
175	10101111101100011
176	1111110101100000
177	11011111101100011
200	1111110101100000
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214	11111111101100111
215	11101111101100011
216	11011111101100011
217	11111111101100111
220	10101111101101011
221	1111110101111111
222	10111111101110011
223	1111110101100011
224	10111111101110011
225	1111110101100011
226	1110110101100011
227	1101110101100011
230	1100110101100011
231	1100110101100011
232	1111110101100111
233	1010110101100011
234	1110110101100011
235	1101110101100011
236	1011110101110011
237	1100101111100001
240	1111110101100111
241	11111111101000011
242	11111111101000011
243	1111111111100011
244	1000111111100011
245	11111111101100111
246	10101111101101011
247	1010110101110011
250	1111111111100111
251	1011110101100111
252	1010101111100001

OCTAL ADD	BIT PATTERN MSB ← → LSB
253	1110101111100001
254	1101101111100001
255	1000111111100011
256	1111111111100111
257	1000111111100011
260	1111101111101001
261	1111101111100001
262	00111101111100001
263	1111101111100001
264	1100111101000011
265	10001111111100011
266	1111101111000001
267	1001101111000001
270	1111101111000001
271	1111111011100011
272	1111111111100000
273	1111111111100011
274	1000111111100011
275	1011110101100011
276	1111110101100111
277	111111101000011
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301	111111101000011
302	111111101000111
303	111111101000011
304	1011110101110011
305	1000111111100011
306	1011110101110011
307	1000101111100001
310	1111111101100111
311	11101111101000011
312	1111111101100111
313	1111111101000011
314	1111111101000011
315	1111101011100001
316	1000111111100011
317	1111110101101011
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322	1111111101110011
323	1111111101111011
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325	1011011110100001
326	1111111101100011
327	01111111101100011
330	1111110101100011
331	0111110101100011
332	1011011110110101
333	11101111101000011
334	01111111101000011
335	1111111111100011
336	1111111111100011
337	1111111111000011
340	11001111101000011
341	11011111101100011
342	10101111101100011
343	1100101111100001

OCTAL ADD	BIT PATTERN MSB ← → LSB
344	11111011111100001
345	11111011111000001
346	111110111110100001
347	0101011110100001
350	1111111010000111
351	1111111010000111
352	1011111101000011
353	1111111101100000
354	1111110101100011
355	1111110101110011
356	1111111101100011
357	1111110101110011
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367	1111111101100011
370	1111111101100011
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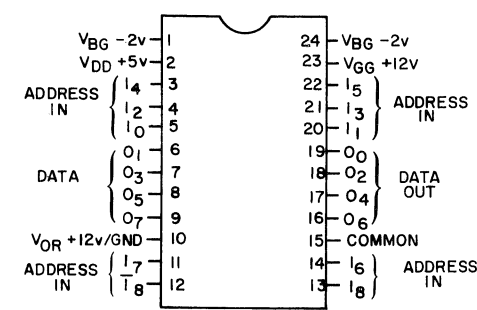
A3U25 ROM 256X16  
1818-2232





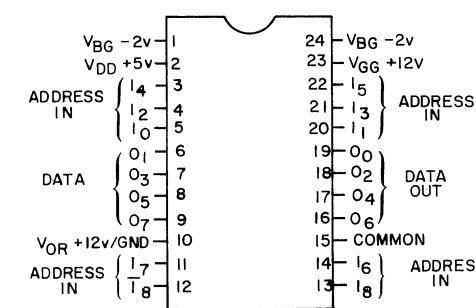


A3U16 ROM 512X8  
1818-2234



OCTAL ADD	BIT PATTERN MSB↔LSB	OCTAL ADD	BIT PATTERN MSB↔LSB	OCTAL ADD	BIT PATTERN MSB↔LSB	OCTAL ADD	BIT PATTERN MSB↔LSB	OCTAL ADD	BIT PATTERN MSB↔LSB
000	00111001	071	00110101	162	00101101	253	00111111	344	10111111
001	00101001	072	00110101	163	00101101	254	00111111	345	00111111
002	00101001	073	00110101	164	00101101	255	00111111	346	11110101
003	00110001	074	01110100	165	10111101	256	10111111	347	00110101
004	10110011	075	01110101	166	00111101	257	00111111	350	00011101
005	00110001	076	01110101	167	00101101	258	00111111	351	10011101
006	00110001	077	01110101	170	10101101	261	00111110	352	00111111
007	00110111	100	01110101	171	00101101	262	00111111	353	00111111
010	00110001	101	10110101	172	00101101	263	10111111	354	00111111
011	00110111	102	00110101	173	00101101	264	00101101	355	00111111
012	00110111	103	00110101	174	00101101	265	00101101	356	00111101
013	00110111	104	01110101	175	00011101	266	00111110	357	00111111
014	11110110	105	01110101	176	00101101	267	00111111	360	00111101
015	00110111	106	01110101	177	00101100	270	10111111	361	00111111
016	00110111	107	00110001	200	00101101	271	00111111	362	00111101
017	00110111	110	00110011	201	00101101	272	00111111	363	00111101
020	00110111	111	00110111	202	00011101	273	10111111	364	00111101
021	00101101	112	10101101	203	10011101	274	00111111	365	00111101
022	10101101	113	00101101	204	00101001	275	00111111	366	00111101
023	10110101	114	11110101	205	00101001	276	00111111	367	00111101
024	00100111	115	00101101	206	00101111	277	10101101	370	00111101
025	00110101	116	00101101	207	00111111	300	00111111	371	00111101
026	11110101	117	00101101	210	00111111	301	10111101	372	00111101
027	11110101	120	00101101	211	00111111	302	00111101	373	00111101
030	00110111	121	00101101	212	00111111	303	00111101	374	00111101
031	00110101	122	00011101	213	00111111	304	00111111	375	00111101
032	00110101	123	00011101	214	00111111	305	00111111	376	00111101
033	00110101	124	00011101	215	00111111	306	00111111	377	00111101
034	00110101	125	00101101	216	00111111	307	00110101	400	11111111
035	01110101	126	10101101	217	00111111	310	00101101	•	
036	01110101	127	00101101	220	00011111	311	10111111	•	
037	01110101	130	00101101	221	00101001	312	00111111	•	
040	01110101	131	00101101	222	00111111	313	00101101	776	11111111
041	00110101	132	10101101	223	00101011	314	00111111	777	11111111
042	00110101	133	00111111	224	00111111	315	10110101		
043	00110101	134	00011101	225	00111111	316	00011101		
044	00110101	135	10011101	226	00111111	317	00011111		
045	00110101	136	00011101	227	00111111	320	00111101		
046	00110101	137	00101101	230	00111111	321	00011111		
047	00110101	140	00101100	231	00111111	322	00111111		
050	00110101	141	00101101	232	00001111	323	00011111		
051	10110101	142	10101101	233	00111111	324	00011111		
052	00110101	143	00101101	234	00111111	325	00110111		
053	00110100	144	00101101	235	00111111	326	00011111		
054	00110101	145	10101101	236	00111111	327	00011111		
055	10110101	146	00101100	237	00111111	330	00011111		
056	00110101	147	10101101	240	00111111	331	00011111		
057	10110101	150	00101101	241	00111111	332	11110101		
060	00110100	151	00101101	242	10111111	333	00101101		
061	00110101	152	00101101	243	10111111	334	00101101		
062	10110101	153	10101101	244	00111111	335	00101101		
063	10110101	154	00101101	245	00111111	336	10101101		
064	00110101	155	00101101	246	00011101	337	00101101		
065	10110101	156	00101101	247	00111111	340	00101101		
066	00110101	157	00101101	250	10111111	341	00101101		
067	00110101	160	00101101	251	00011101	342	00101101		
070	10110101	161	10101101	252	00111111	343	00111111		

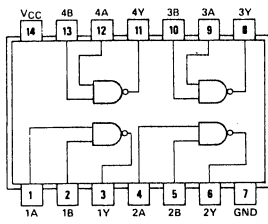
A3U26 ROM 512X8  
1818—2235



NOTE  
If Both I8 and I8 are high the output bits are all high.

9

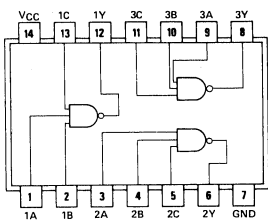
A1U204, 413  
A3U7, 35, 202, 203  
SN7400N



Quad 2 Input Nand Gates

10

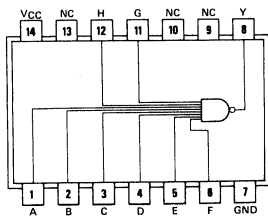
A3U8  
SN7410N  
1820-0068



Triple 3-Input  
Positive Nand Gates

11

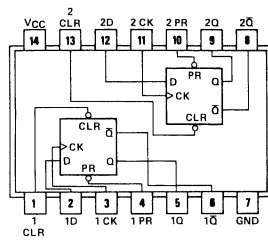
A1U211  
SN7430N



8 Input Nand Gates

12

A3U17, 18, 110  
SN7474

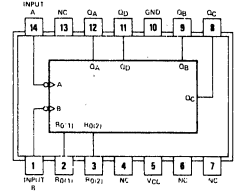


Dual D Flip Flops

FUNCTION TABLE			
INPUTS			
PRESET	CLEAR	CLOCK	D
L	H	X	X
H	L	X	X
L	L	X	X
H	H	↑	H
H	H	↑	L
H	H	L	X
OUTPUTS			
Q	Q-bar		
H	L		
L	H		
H*	H*		
H	L		
L	H		
Q <sub>0</sub>	Q <sub>0</sub>		

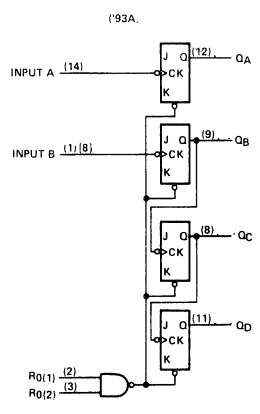
13

A3U109  
SN7493



4-Bit Binary Up Counter

'93A, COUNT SEQUENCE				
COUNT	OUTPUT			
	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	L	H	L	H
6	L	H	H	L
7	L	H	H	H
8	H	L	L	L
9	H	L	L	H
10	H	L	H	L
11	H	L	H	H
12	H	H	L	L
13	H	H	L	H
14	H	H	H	L
15	H	H	H	H



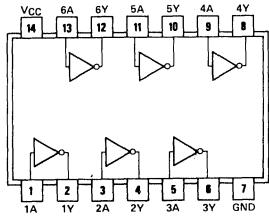
93A RESET/COUNT FUNCTION TABLE				
RESET INPUTS		OUTPUT		
R <sub>0</sub> (1)	R <sub>0</sub> (2)	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub> Q <sub>A</sub>
H	H	L	L	L L
L	X	COUNT		
X	L	COUNT		

A3U116

SN7405N  
1820-0175

14

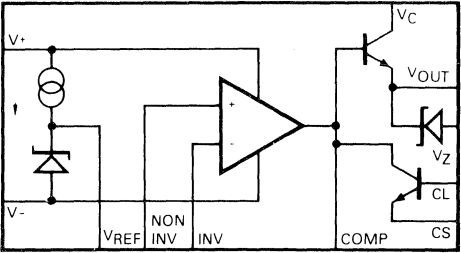
$\Delta_{1a}$  Used on serial numbers 1714A00490 and below only.



Hex Inverters  
With Open Collector Outputs

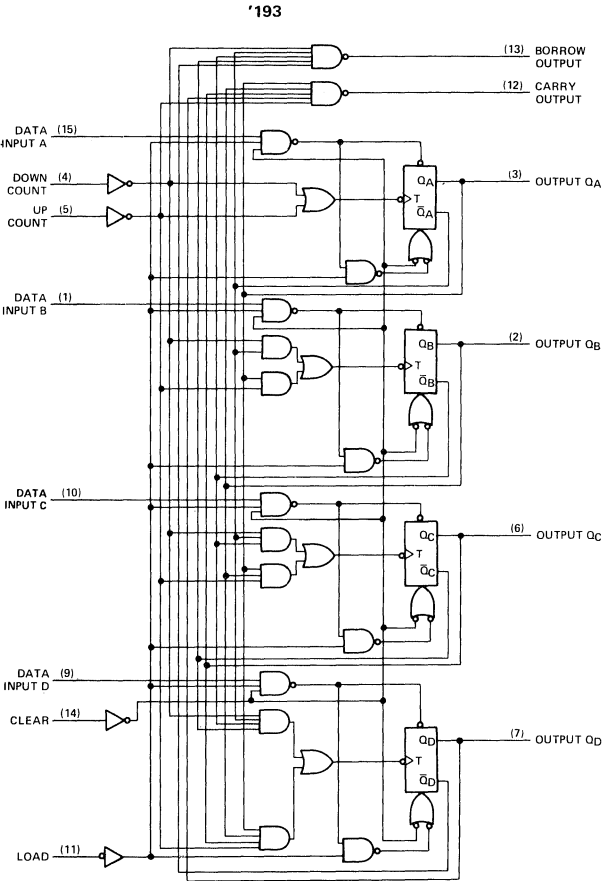
A1U1  
723 HC  
1820-0196

15

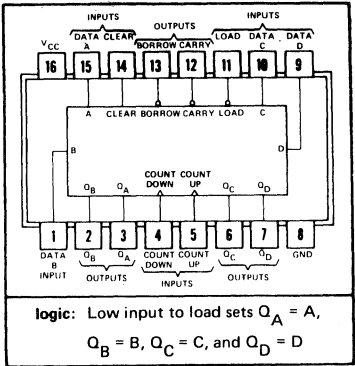


Voltage Regulator

16



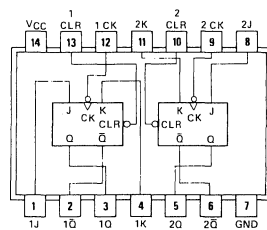
A1U203, 205  
SN74193N  
1820-0233









17

A1U212  
SN74107N  
1820-0281

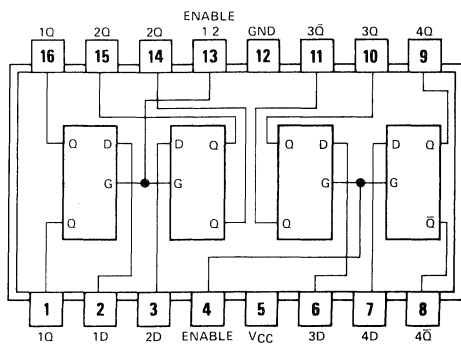


DUAL J-K MASTER-SLAVE FLIP-FLOPS WITH CLEAR

FUNCTION TABLE					
INPUTS				OUTPUTS	
CLEAR	CLOCK	J	K	Q	$\bar{Q}$
L	X	X	X	L	H
H		L	L	Q <sub>0</sub>	$\bar{Q}_0$
H		H	L	H	L
H		L	H	L	H
H		H	H	TOGGLE	

18

A1U214  
A3U5, 6, 21, 27-30  
SN7475N



Quad D Flip Flop

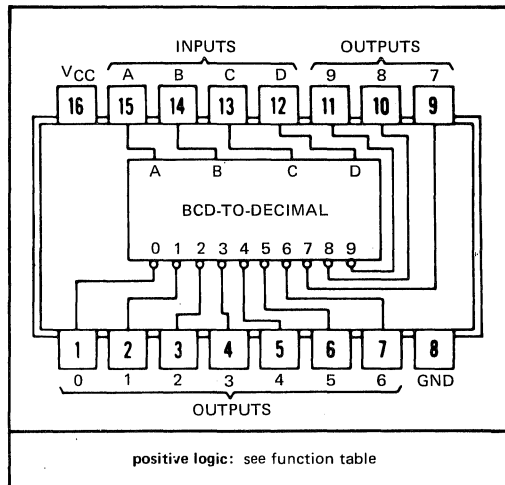
FUNCTION TABLE			
(Each Latch)			
INPUTS		OUTPUTS	
D	G	Q	$\bar{Q}$
L	H	L	H
H	H	H	L
X	L	Q <sub>0</sub>	$\bar{Q}_0$

H = high level, L = low level, X = irrelevant  
Q<sub>0</sub> = the level of Q before the high-to-low transition of G

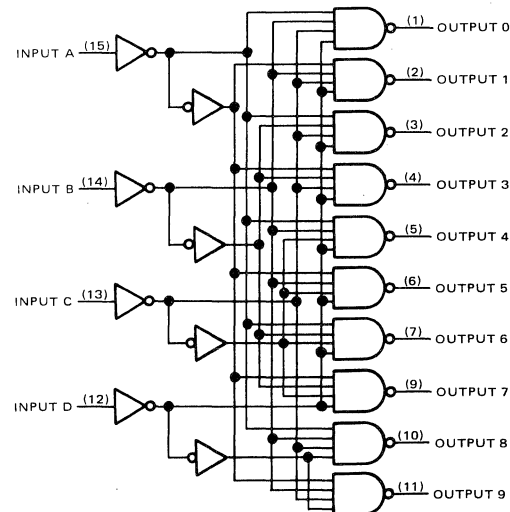
19

A3U105  
SN74145  
1820-0491

Δ1a Used on serial numbers 1714A00490 and below only.



functional block diagram

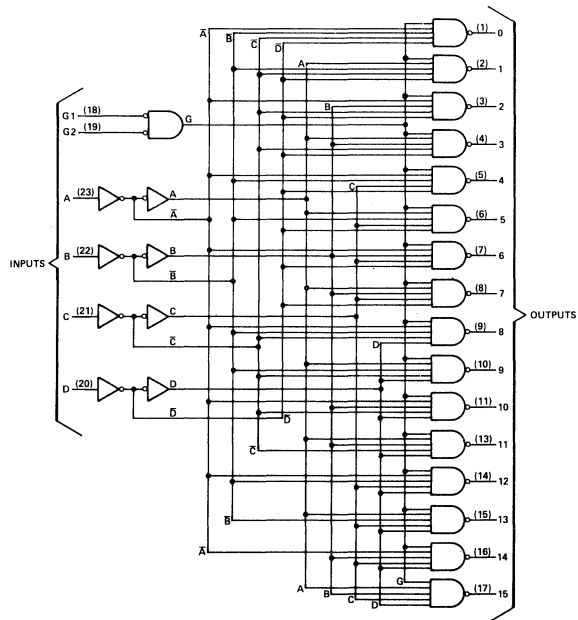


NO.	INPUTS				OUTPUTS									
	D	C	B	A	0	1	2	3	4	5	6	7	8	9
0	L	L	L	L	L	H	H	H	H	H	H	H	H	H
1	L	L	L	H	H	L	H	H	H	H	H	H	H	H
2	L	L	H	L	H	H	L	H	H	H	H	H	H	H
3	L	L	H	H	H	H	H	L	H	H	H	H	H	H
4	L	H	L	L	H	H	H	H	L	H	H	H	H	H
5	L	H	L	H	H	H	H	H	H	L	H	H	H	H
6	L	H	H	L	H	H	H	H	H	H	L	H	H	H
7	L	H	H	H	H	H	H	H	H	H	H	L	H	H
8	H	L	L	L	H	H	H	H	H	H	H	H	L	H
9	H	L	L	H	H	H	H	H	H	H	H	H	H	L
INVALID	H	L	H	L	H	H	H	H	H	H	H	H	H	H
	H	L	H	H	H	H	H	H	H	H	H	H	H	H
	H	H	L	L	H	H	H	H	H	H	H	H	H	H
	H	H	L	H	H	H	H	H	H	H	H	H	H	H
	H	H	H	L	H	H	H	H	H	H	H	H	H	H

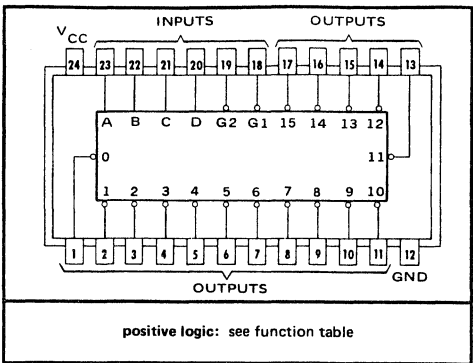
H = high level (off), L = low level (on)

functional block diagram and schematics of inputs and outputs

20



A2U5, 9  
SN74154N  
1820-0495



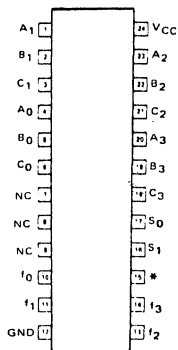
FUNCTION TABLE

INPUTS						OUTPUTS															
G1	G2	D	C	B	A	0	1	2	3	4	5	6	7	8	9	10	11	12	13	14	15
L	L	L	L	L	L	L	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H
L	L	L	L	L	H	H	L	H	H	H	H	H	H	H	H	H	H	H	H	H	H
L	L	L	L	H	L	H	H	L	H	H	H	H	H	H	H	H	H	H	H	H	H
L	L	L	L	H	H	H	H	L	H	H	H	H	H	H	H	H	H	H	H	H	H
L	L	L	H	L	L	H	H	H	H	L	H	H	H	H	H	H	H	H	H	H	H
L	L	L	H	L	H	H	H	H	H	H	L	H	H	H	H	H	H	H	H	H	H
L	L	L	H	H	L	H	H	H	H	H	H	L	H	H	H	H	H	H	H	H	H
L	L	L	H	H	H	H	H	H	H	H	H	H	L	H	H	H	H	H	H	H	H
L	L	H	L	L	L	H	H	H	H	H	H	H	H	L	H	H	H	H	H	H	H
L	L	H	L	L	H	H	H	H	H	H	H	H	H	H	L	H	H	H	H	H	H
L	L	H	L	H	L	H	H	H	H	H	H	H	H	H	H	L	H	H	H	H	H
L	L	H	L	H	H	H	H	H	H	H	H	H	H	H	H	H	L	H	H	H	H
L	L	H	H	L	L	H	H	H	H	H	H	H	H	H	H	H	H	L	H	H	H
L	L	H	H	L	H	H	H	H	H	H	H	H	H	H	H	H	H	H	L	H	H
L	L	H	H	H	L	H	H	H	H	H	H	H	H	H	H	H	H	H	H	L	H
L	L	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	L
L	H	X	X	X	X	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H
H	L	X	X	X	X	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H
H	H	X	X	X	X	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H	H

H = high level, L = low level, X = irrelevant

21

A3U1  
N8263B  
1820-0506  
  
8263  
N,F,Q PACKAGE



DESCRIPTION

The 8263/8264 3-Input, 4-Bit Multiplexer is a gating array whose function is analogous to that of a 4-pole, 3-position switch. Four bits of digital data are selected from one of three inputs. A 2-bit channel-selection code determines which input is to be active.

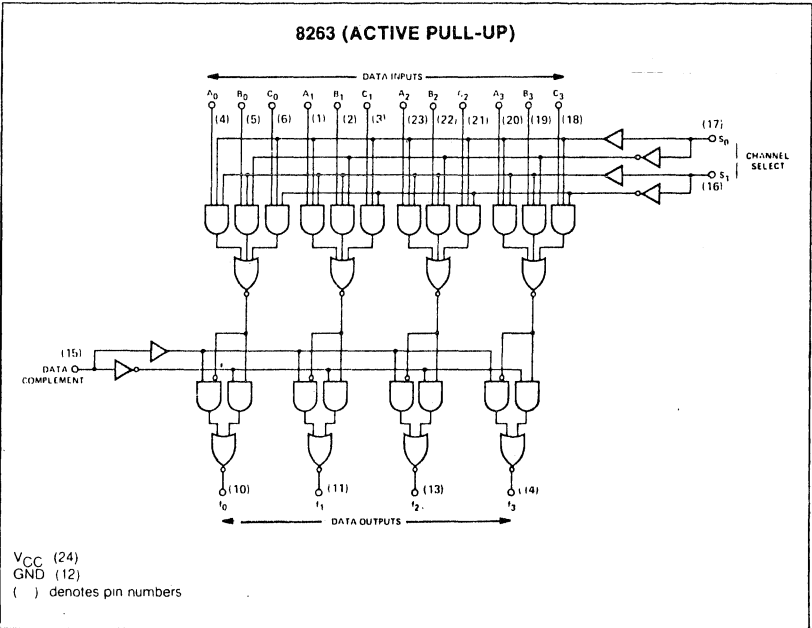
The Data Complement input controls the conditional complement circuit at the Multiplexer output to effect either inverting or non-inverting data flow.

TRUTH TABLE

DATA INPUT			CHANNEL SELECT		DATA COMPLEMENT	OUTPUT ENABLE (8264)	DATA OUTPUTS
A <sub>n</sub>	B <sub>n</sub>	C <sub>n</sub>	S <sub>0</sub>	S <sub>1</sub>			
A <sub>n</sub>	x	x	1	1	0	1	A <sub>n</sub>
x	B <sub>n</sub>	x	0	1	0	1	B <sub>n</sub>
x	x	C <sub>n</sub>	1	0	0	1	C <sub>n</sub>
x	x	x	0	0	0	1	0
A <sub>n</sub>	x	x	1	1	1	1	$\overline{A_n}$
x	B <sub>n</sub>	x	0	1	1	1	$\overline{B_n}$
x	x	C <sub>n</sub>	1	0	1	1	$\overline{C_n}$
x	x	x	0	0	1	1	1
x	x	x	x	x	x	0	1

X either state

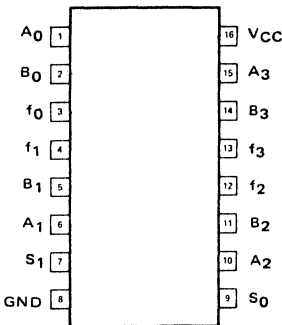
LOGIC DIAGRAM



22

A1U107-109, 301-303, 414, 418, 421  
A3U103, 104  
N8266B  
1820-0507

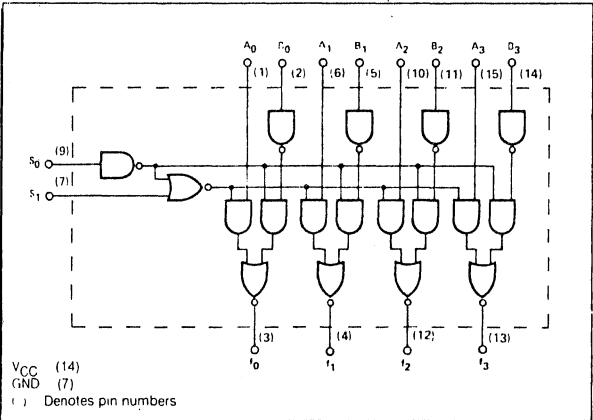
B,F,W PACKAGE



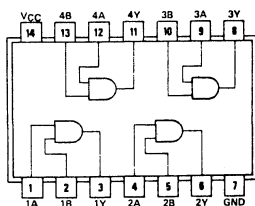
TRUTH TABLE

SELECT LINES		OUTPUTS
S <sub>0</sub>	S <sub>1</sub>	f <sub>n</sub> (0, 1, 2, 3)
0	0	B <sub>n</sub>
0	1	B <sub>n</sub>
1	0	$\overline{A_n}$
1	1	1

LOGIC DIAGRAM



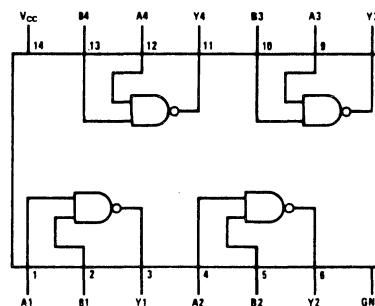
A3U9  
SN7408N  
1820-0511



Quadruple 2-Input  
Positive and Gates

23

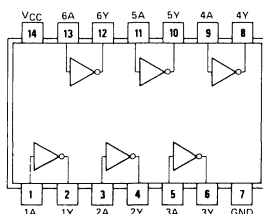
A1U103, 401-411, 416, 420  
DM74L00  
1820-0583



Quad 2-Input NAND Gates

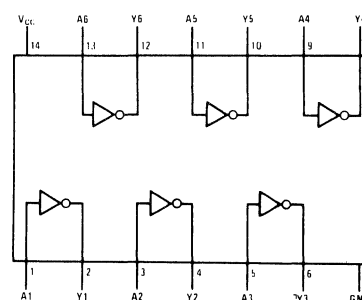
26

A1U209, 304  
A3U111  $\Delta$ 1a, 201  
SN7416N  
1820-0577



24

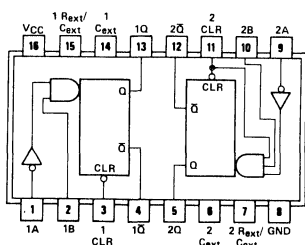
A3U31-34, 107  $\Delta$ 1a, 117  $\Delta$ 1a  
DM74L04N  
1820-0586



Hex Inverter

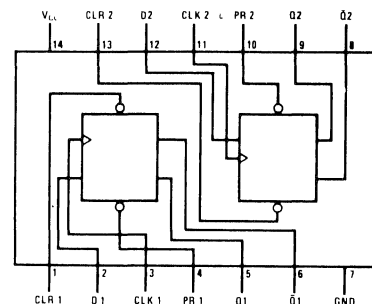
27

A1U201  
A3U12  
SN74123N  
1820-0579



25

A3U19, 20  
DM74L74N  
1820-0596



28

DUAL RETRIGGERABLE MONOSTABLE MULTIVIBRATORS WITH CLEAR

FUNCTION TABLE

INPUTS			OUTPUTS	
CLEAR	A	B	Q	$\bar{Q}$
L	X	X	L	H
X	H	X	L	H
X	X	L	L	H
H	L	$\uparrow$	$\downarrow$	$\uparrow$
H	$\downarrow$	H	$\downarrow$	$\uparrow$
$\uparrow$	L	H	$\downarrow$	$\uparrow$

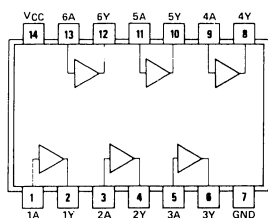
TRUTH TABLE

INPUTS				OUTPUTS	
PR	CLR	CLK	D	Q	$\bar{Q}$
L	H	X	X	H	L
H	L	X	X	L	H
L	L	X	X	H*	H*
H	H	$\uparrow$	H	H	L
H	H	$\uparrow$	L	L	H
H	H	L	X	Q0	$\bar{Q}0$

$\Delta$ 1a Used on serial numbers 7414A00490 and below only.

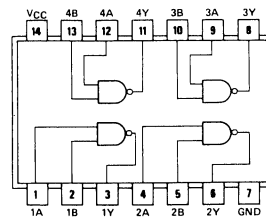
29

A1U104, 105  $\Delta$ 1a, 210  
A3U115  
SN7417N  
1820-0618



31

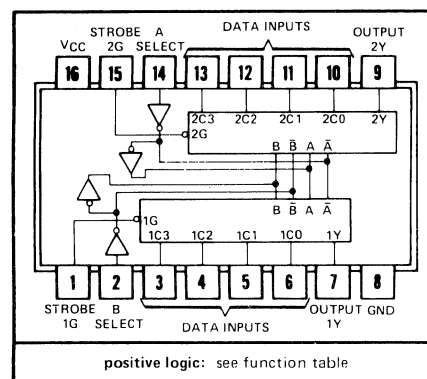
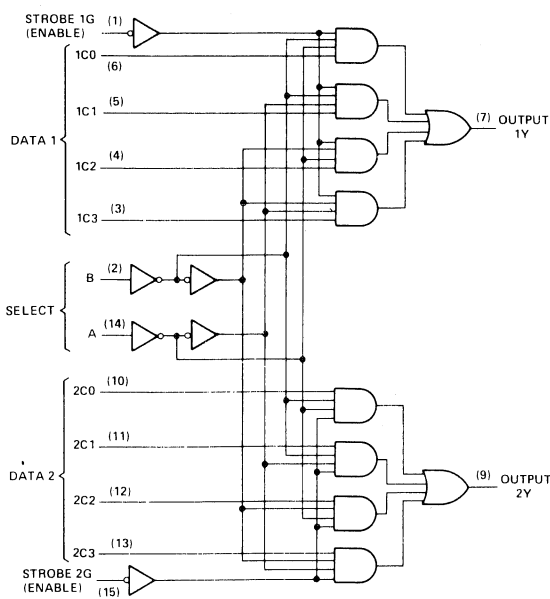
A1U101, 110  
A3U22  
SN7438N  
1820-0621



$\Delta$ 1a Used on serial numbers 1714A00490 and below only.

30

A3U101, 102  
SN74153  
1820-0620

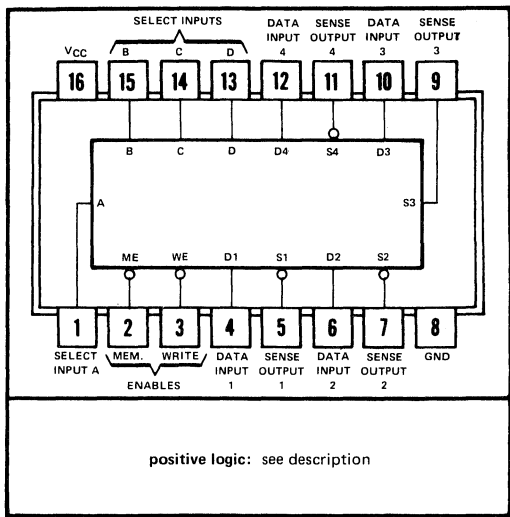


positive logic: see function table

FUNCTION TABLE

SELECT INPUTS		DATA INPUTS				STROBE	OUTPUT
B	A	C0	C1	C2	C3	G	Y
X	X	X	X	X	X	H	L
L	L	L	X	X	X	L	L
L	L	H	X	X	X	L	H
L	H	X	L	X	X	L	L
L	H	X	H	X	X	L	H
H	L	X	X	L	X	L	L
H	L	X	X	H	X	L	H
H	H	X	X	X	L	L	L
H	H	X	X	X	H	L	H

Select inputs A and B are common to both sections.  
H = high level, L = low level, X = irrelevant



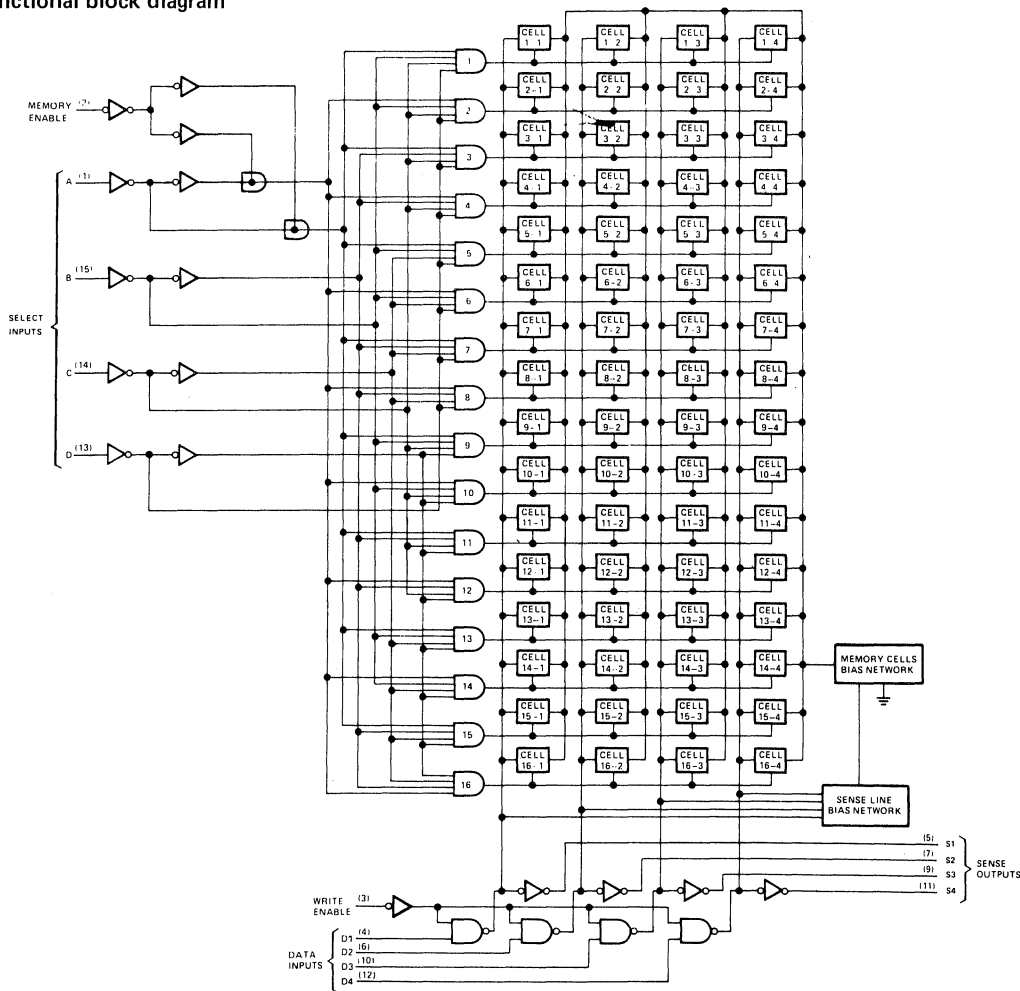
A1U206-208, 215-217  
SN7489N  
1820-0628

FUNCTION TABLE

ME	WE	OPERATION	CONDITION OF OUTPUTS
L	L	Write	Complement of Data Inputs
L	H	Read	Complement of Selected Word
H	L	Inhibit Storage	Complement of Data Inputs
H	H	Do Nothing	High

† Pin assignments for these circuits are the same for all packages.

functional block diagram

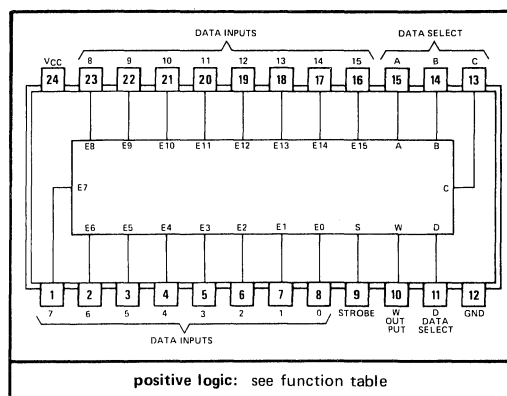
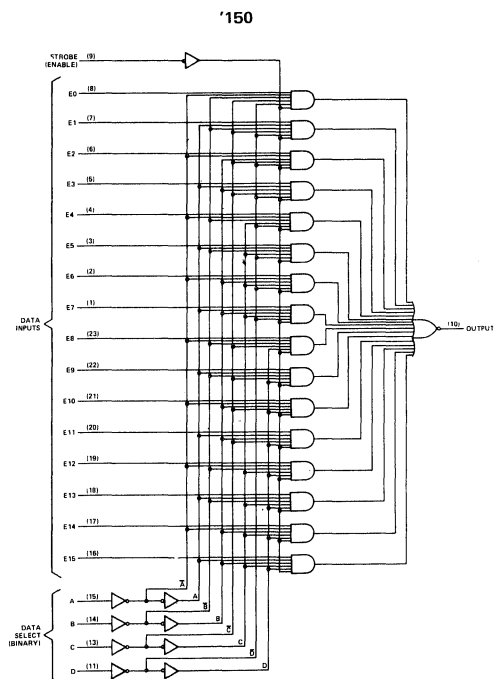


**33**

A3U13, 14  
SN74150N  
1820-0640

One-Of-16-Data-Selector

functional block diagrams



logic

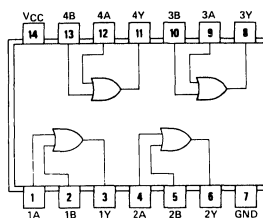
'150

FUNCTION TABLE

INPUTS					OUTPUT W
SELECT D	C	B	A	STROBE S	
X	X	X	X	H	H
L	L	L	L	L	$\overline{E0}$
L	L	L	H	L	$\overline{E1}$
L	L	H	L	L	$\overline{E2}$
L	L	H	H	L	$\overline{E3}$
L	H	L	L	L	$\overline{E4}$
L	H	L	H	L	$\overline{E5}$
L	H	H	L	L	$\overline{E6}$
L	H	H	H	L	$\overline{E7}$
H	L	L	L	L	$\overline{E8}$
H	L	L	H	L	$\overline{E9}$
H	L	H	L	L	$\overline{E10}$
H	L	H	H	L	$\overline{E11}$
H	H	L	L	L	$\overline{E12}$
H	H	L	H	L	$\overline{E13}$
H	H	H	L	L	$\overline{E14}$
H	H	H	H	L	$\overline{E15}$

**34**

A1U213  
A3U10, 114  
SN7432N  
1820-0661



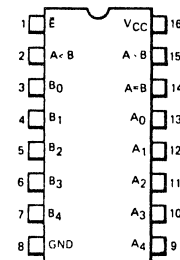
TRUTH TABLE

$\bar{E}$	A <sub>y</sub>	B <sub>y</sub>	A < B	A > B	A = B
H	X	X	L	L	L
L	Word A = Word B		L	L	H
L	Word A > Word B		L	H	L
L	Word B > Word A		H	L	L

H = HIGH Voltage Level

L = LOW Voltage Level

X = Either HIGH or LOW Voltage Level

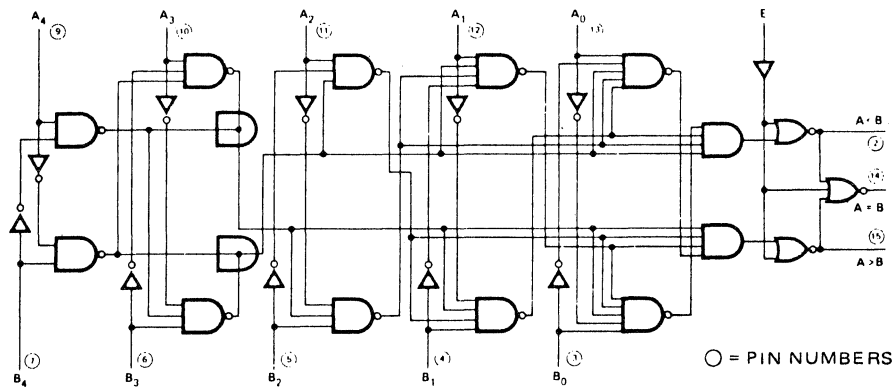
CONNECTION DIAGRAMS  
DIP (TOP VIEW)A1U412  
9324DC  
1820-0706

35

36

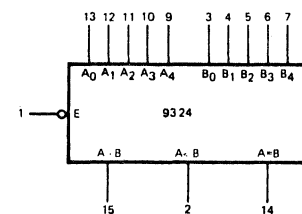
A1U415, 419  
93L24DC  
1820-0904

LOGIC DIAGRAM



○ = PIN NUMBERS

LOGIC SYMBOL

V<sub>CC</sub> = Pin 16  
GND = Pin 8

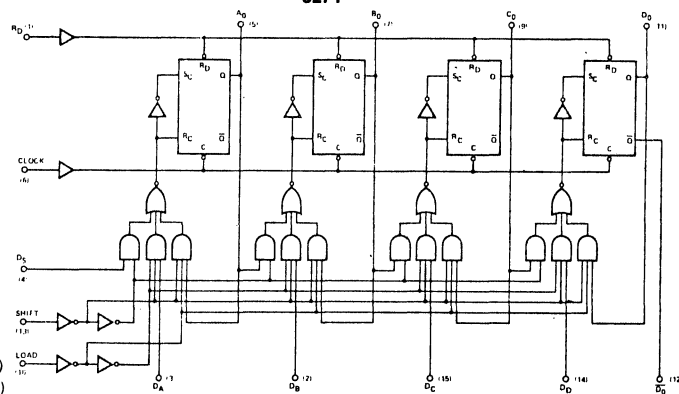
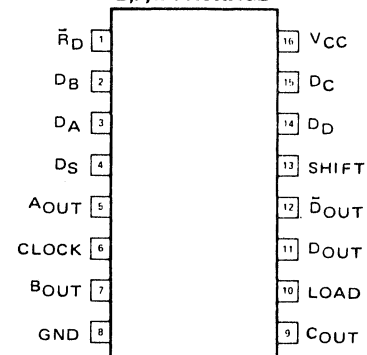
TRUTH TABLE

CONTROL STATE	LOAD	SHIFT
Hold	0	0
Parallel Entry	1	0
Shift Right	0	1
Shift Left	1	1

A3U23, 24  
SN8271  
1820-0989

37

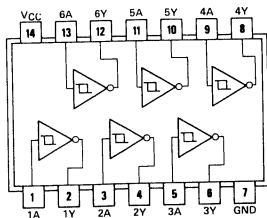
8271

V<sub>CC</sub> = (16)  
GND = (8)  
( ) = denotes pin numbers8271  
B,F,W PACKAGE



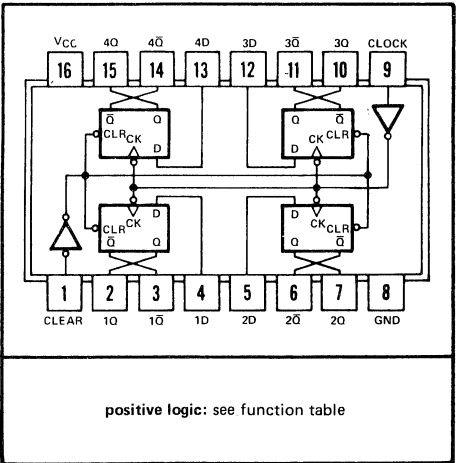
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A1U106  
A3U113, 201  
SN7414  
1820-1053



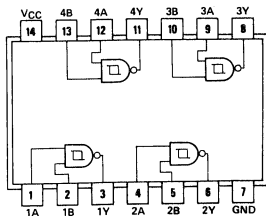
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A3U2, 11  
SN74S175N  
1820-1141



39

A1U102  
SN74132  
1820-1056

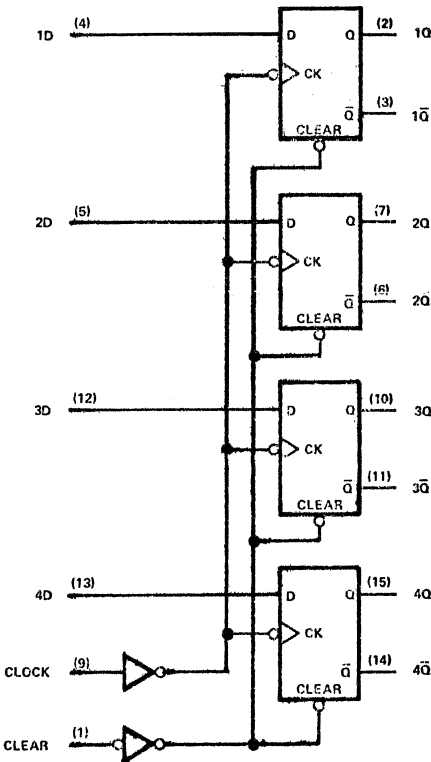
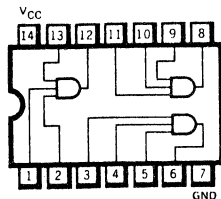


FUNCTION TABLE  
(EACH FLIP-FLOP)

INPUTS			OUTPUTS	
CLEAR	CLOCK	D	Q	Q̄
L	X	X	L	H
H	↑	H	H	L
H	↑	L	L	H
H	L	X	Q <sub>0</sub>	Q̄ <sub>0</sub>

40

A3U112  
7411PC  
1820-1066



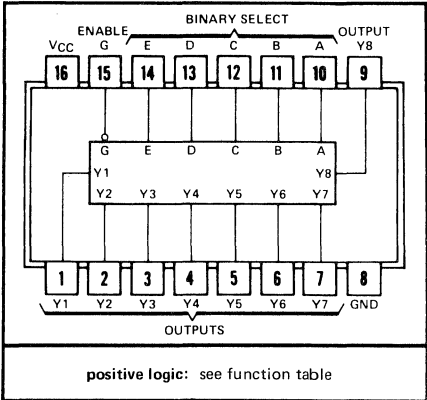
42

FUNCTION TABLE

BINARY WORDS	INPUTS					OUTPUTS							
	BINARY SELECT				ENABLE								
	E	D	C	B		Y8	Y7	Y6	Y5	Y4	Y3	Y2	Y1
0 1	L	L	L	L	L	H	H	L	L	L	L	L	L
2 3	L	L	L	L	H	H	H	L	L	L	L	L	H
4 5	L	L	L	H	L	H	H	L	L	L	L	H	L
6 7	L	L	L	H	H	H	H	L	L	L	L	H	H
8 9	L	L	H	L	L	H	H	L	L	L	H	L	L
10 11	L	L	H	L	H	H	H	L	L	H	L	L	L
12 13	L	L	H	H	L	H	H	L	L	H	L	L	H
14 15	L	L	H	H	H	H	H	L	L	H	L	H	L
16 17	L	H	L	L	L	H	H	L	L	H	L	H	H
18 19	L	H	L	L	H	H	H	L	L	H	L	L	L
20 21	L	H	L	H	L	H	H	L	L	H	L	L	L
22 23	L	H	L	H	H	H	H	L	L	H	L	L	H
24 25	L	H	H	L	L	H	H	L	H	L	L	H	L
26 27	L	H	H	L	H	H	H	L	H	L	L	H	H
28 29	L	H	H	H	L	H	H	L	H	L	L	L	L
30 31	L	H	H	H	H	H	H	L	H	L	L	L	L
32 33	H	L	L	L	L	H	H	L	H	H	L	L	H
34 35	H	L	L	L	H	H	H	L	H	H	L	L	H
36 37	H	L	L	H	L	H	H	L	H	H	L	H	H
38 39	H	L	L	H	H	H	H	L	H	H	L	L	L
40 41	H	L	H	L	L	H	H	L	L	L	L	L	L
42 43	H	L	H	L	H	H	H	L	L	L	L	L	H
44 45	H	L	H	H	L	H	H	L	L	L	L	L	L
46 47	H	L	H	H	H	H	H	L	L	L	L	H	H
48 49	H	H	L	L	L	H	H	L	L	L	H	L	L
50 51	H	H	L	L	H	H	H	L	L	H	L	L	L
52 53	H	H	L	H	L	H	H	L	L	H	L	L	H
54 55	H	H	L	H	H	H	H	L	L	H	L	H	L
56 57	H	H	H	L	L	H	H	L	L	H	L	H	H
58 59	H	H	H	L	H	H	H	L	L	H	L	L	L
60 61	H	H	H	H	L	H	H	L	L	L	L	L	L
62 63	H	H	H	H	H	H	H	L	L	L	L	L	H
ALL	X	X	X	X	X	H	H	H	H	H	H	H	H

H - high level, L - low level, X - irrelevant

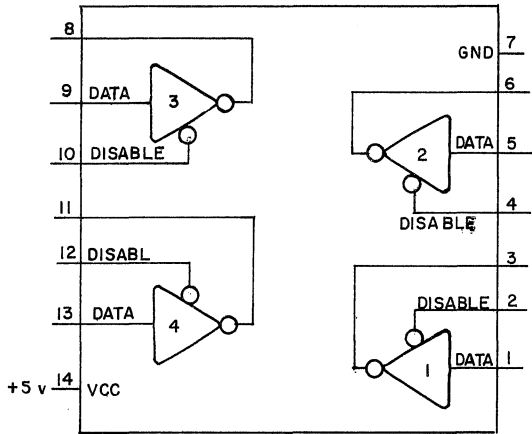
A1U202  
1820-1191  
SN74185



positive logic: see function table

43

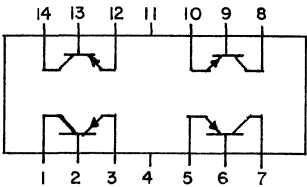
A1U111-113  
Quad Tri-State Driver  
1820-1335



DATA	DISABLE	OUTPUT
0	0	1
1	0	0
0	1	HI-Z
1	1	HI-Z

44

A2U1-4, 6-8  
Quad PNP  
1858-0014





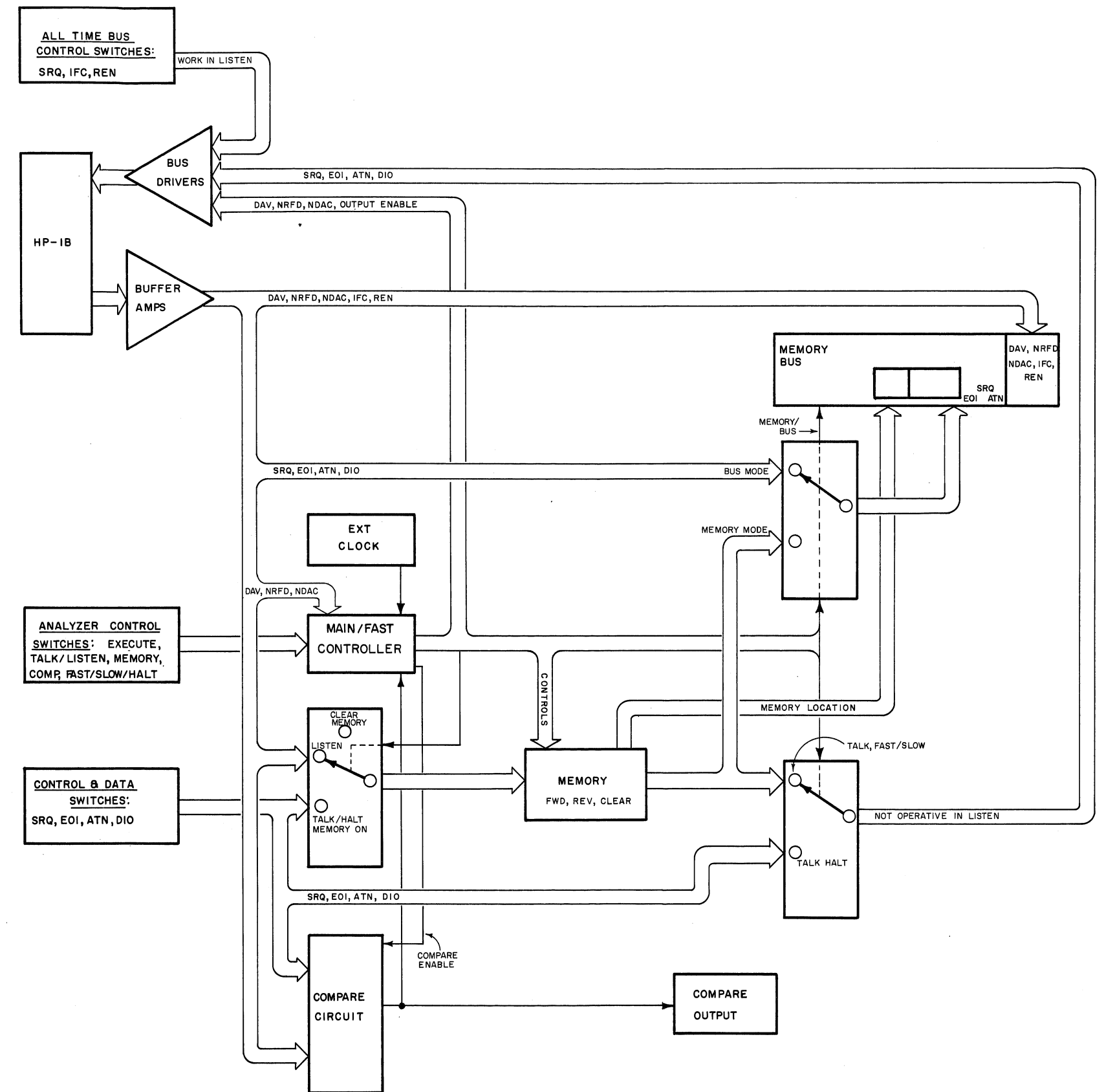
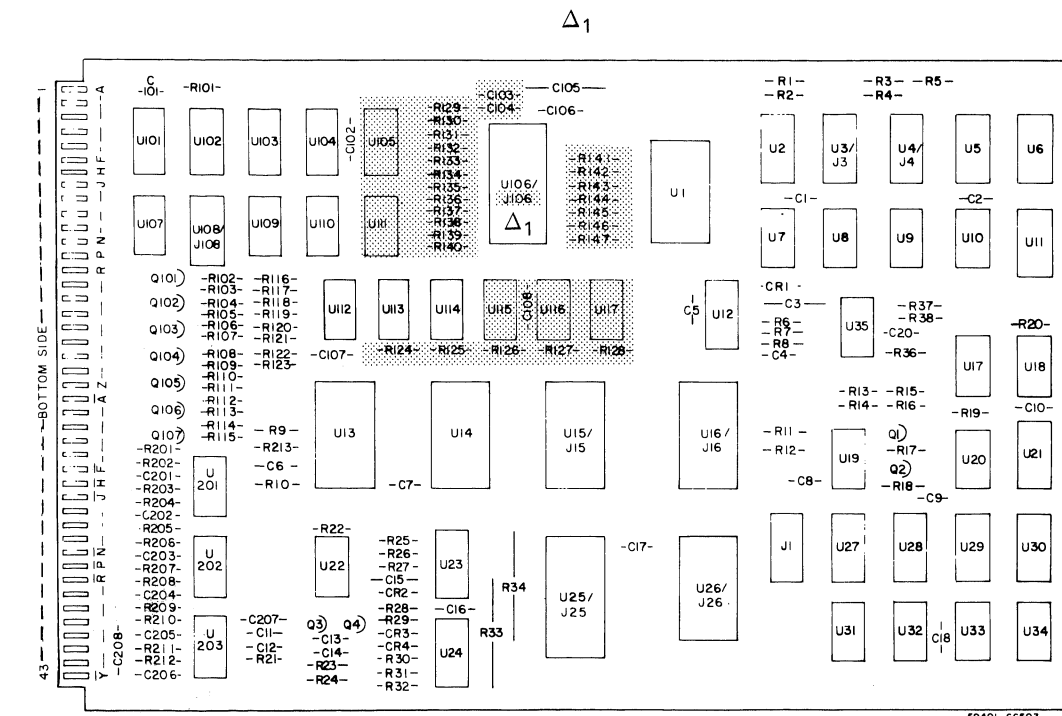


Figure 7-1. Block Diagram, 59401A.  
7-25

## SIGNAL MNEMONICS

MAIN CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
LEXE	EXECUTE pressed	LBOE	Bus Output Enable
HSTF	STEP MEMORY FORWARD pressed	LMDP	Connects Memory Output to Display
HSTR	STEP MEMORY REVERSE pressed	LWTE <sub>2</sub>	Enables Data to be Written into Memory
HCLR	CLEAR MEMORY pressed	LCPS <sub>2</sub>	Selects a Location in Memory (Chip Select)
HTLK	TALK FUNCTION selected	LMIS	Connects Bus to Memory Input (Select)
HRSL	HALT selected	LMIE	Connects Panel Switches to Memory Input (Enable)
HRFS	RUN FAST selected		
LRSL, LRFS	RUN SLOW selected	HMIS, HMIE	Applies All 1's to Memory Input (Disable)
HCMP	COMPARE switch on	HDSD	Unblanks Memory Location Digits
LTCM	COMPARE switch on and comparison is true	LCLK <sub>2</sub>	Clocks Memory Location Counters
HCNT	STEP MEMORY counter reads 30	HDVO <sub>2</sub>	Drives LDAH True
HDVI	LDAH is true	HRFO <sub>2</sub>	Drives HRFD False
HRFI	LNRFD is false (RFD is Low)	LDAO <sub>2</sub>	Drives HDAC False
HDAI	LNDAC is false (DAC is Low)	LMTB	Select Memory to Drive Bus
HMEO	MEMORY off	LCND	Counts Memory in Reverse (Down)
LMEO, LCLR	MEMORY on	HCO1	Clock F1
HOOA	SIGNAL A from fast controller	HCO2	Clock F2
HOOB	SIGNAL B from fast controller	HCO3	Clock F3
HOOC	SIGNAL C from fast controller	LRST	Reset Fast Machine
HDEL	.5 sec DELAY	LSTA	Select Talk Operation for Fast Controller
LEMY	STEP MEMORY counter reads 31	HENF	Enable Fast Controller Output
		LTRG	Triggers .5 Second Delay

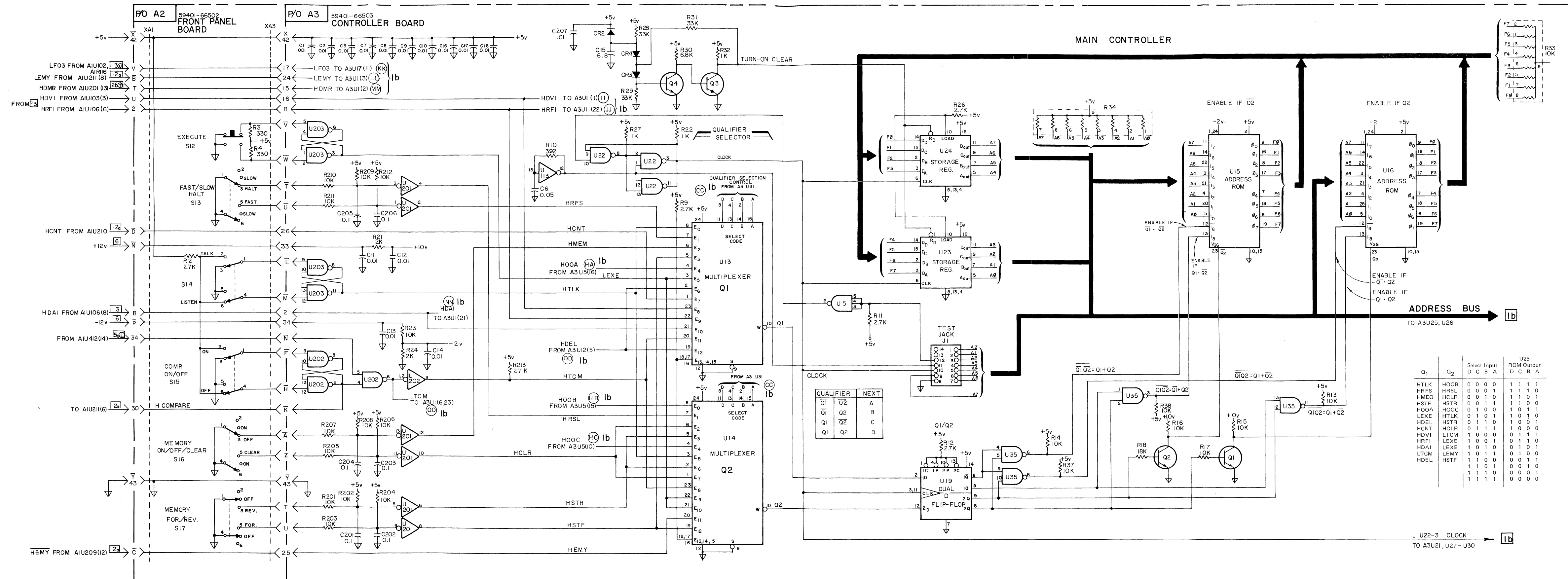
FAST CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
HQO1	Wait 500 ns After Changing Data	HDVO <sub>1</sub>	LDAH is True
HDMR	Wait 1 $\mu$ s After MRE Driven Low	LRFO <sub>1</sub>	HDAC is True
HRFI	RFD is False	HRFO <sub>1</sub>	HRFD is False
HFO1	Signal F1 From Main Controller	LWTE <sub>1</sub>	Drives LWTE and LCPS True if LFO3 is True
HFO2	Signal F2 From Main Controller	HCLK <sub>1</sub>	Drives HCLK True if HFO3 is True
HDAI	HDAC is False	HOOA	Signal A to Main Controller
LTCM	Compare Switch on and Comparison is True	HOOB	Signal B to Main Controller
LEMY	Compare Switch on and Last Memory Location is Sent	HOOC	Signal C to Main Controller
HDVI	LDAH is True		
HENF	Enable Fast Controller Output		
LSTA	Fast Controller Should Select Talk Operation		



A3  
-hp- Part No. 59401-66503

Revisions A & B Boards.

Δ1: Shaded area components do not exist on Rev. B Boards;  
U106 is different between Rev. A & B Boards.



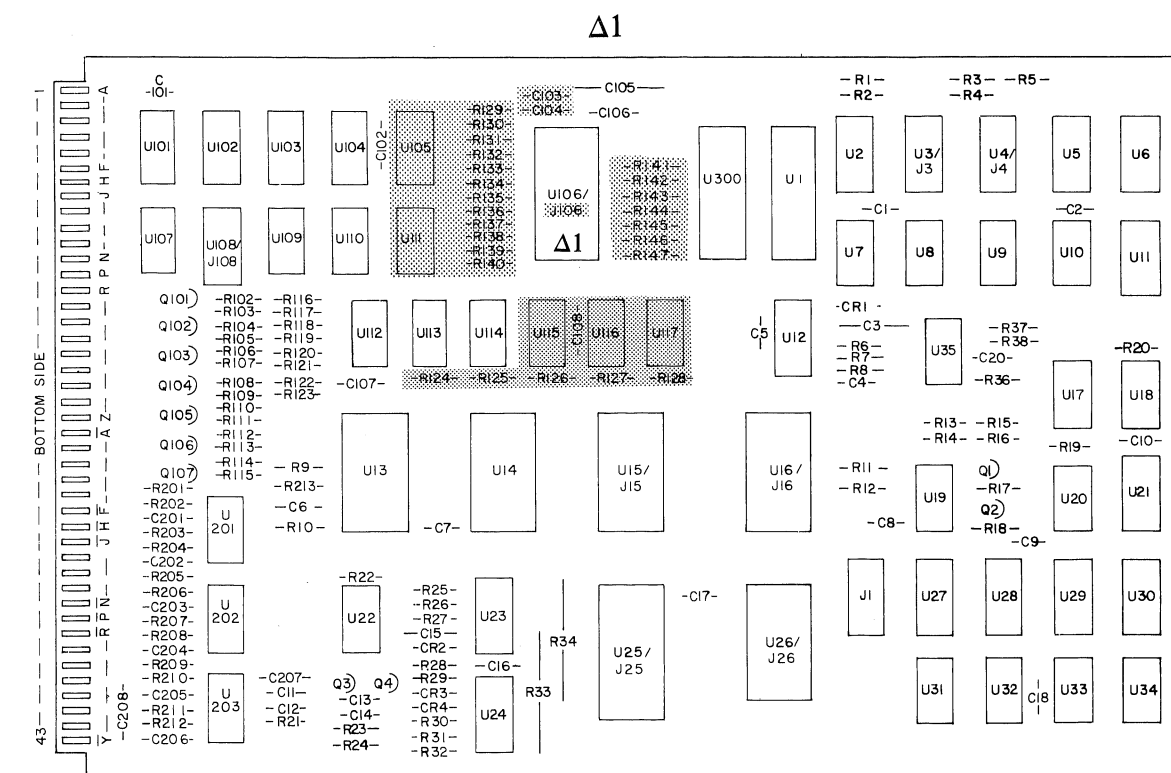
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Figure 7-2. Controller, A3: Main Controller, Function Select, Address Bus.

## SIGNAL MNEMONICS

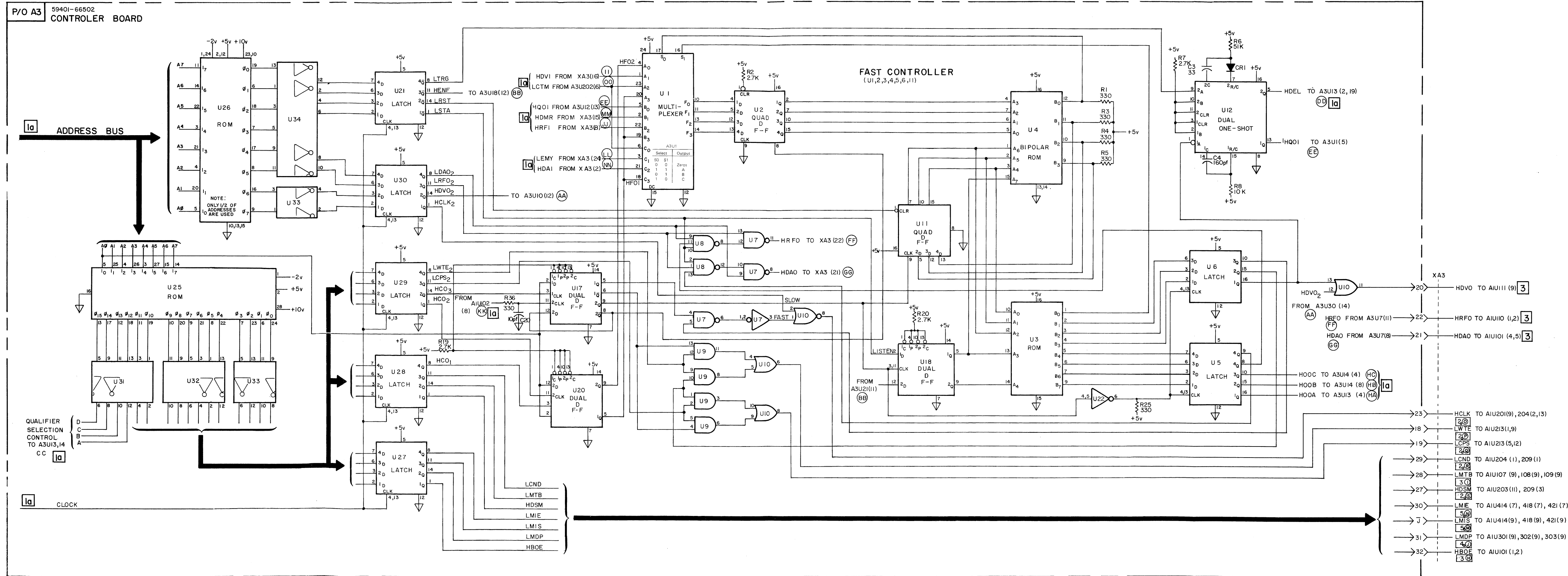
MAIN CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
LEXE	EXECUTE pressed	LBOE	Bus Output Enable
HSTF	STEP MEMORY FORWARD pressed	LMDP	Connects Memory Output to Display
HSTR	STEP MEMORY REVERSE pressed	LWTE <sub>2</sub>	Enables Data to be Written into Memory
HCLR	CLEAR MEMORY pressed	LCPS <sub>2</sub>	Selects a Location in Memory (Chip Select)
HTLK	TALK FUNCTION selected	LMIS	Connects Bus to Memory Input (Select)
HRSL	HALT selected	LMIE	Connects Panel Switches to Memory Input (Enable)
HRFS	RUN FAST selected	HMIS, HMIE	Applies All I's to Memory Input (Disable)
LRSL, LRFS	RUN SLOW selected	HDSM	Unblanks Memory Location Digits
HCMP	COMPARE switch on	LCLK <sub>2</sub>	Clocks Memory Location Counters
LTCM	COMPARE switch on and comparison is true	HDVO <sub>2</sub>	Drives LDAH True
HCNT	STEP MEMORY counter reads 30	HRFO <sub>2</sub>	Drives HRFD False
HDVI	LDAH is true	LDAO <sub>2</sub>	Drives HDAC False
HRFI	LNRFD is false (RFD is Low)	LMTB	Select Memory to Drive Bus
HDAI	LNDAC is false (DAC is Low)	LCND	Counts Memory in Reverse (Down)
HMEO	MEMORY off	HCO1	Clock F1
LMEO, LCLR	MEMORY on	HCO2	Clock F2
HOOA	SIGNAL A from fast controller	HCO3	Clock F3
HOOB	SIGNAL B from fast controller	LRST	Reset Fast Machine
HOOC	SIGNAL C from fast controller	LSTA	Select Talk Operating for Fast Controller
HDEL	.5 sec DELAY	HENF	Enable Fast Controller Output
LEMY	STEP MEMORY counter reads 31	LTRG	Triggers .5 Second Delay

FAST CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
HQO1	Wait 500 ns After Changing Data	HDVO <sub>1</sub>	LDAH is True
HDMR	Wait 1 $\mu$ s After MRE Driven Low	LRFO <sub>1</sub>	HDAC is True
HRFI	RFD is False	HRFO <sub>1</sub>	HRFD is False
HFO1	Signal F1 From Main Controller	} if LSTA False (From MAIN CONTROLLER)	
HFO2	Signal F2 From Main Controller		
HDAI	HDAC is False	LWTE <sub>1</sub>	Drives LWTE and LCPS True if LFO3 is True
LTCM	Compare Switch on and Comparison is True	HCLK <sub>1</sub>	Drives HCLK True if HFO3 is True
LEMY	Compare Switch on and Last Memory Location is Sent	HOOA	Signal A to Main Controller
HDVI	LDAH is True	HOOB	Signal B to Main Controller
HENF	Enable Fast Controller Output	HOOC	Signal C to Main Controller
LSTA	Fast Controller Should Select Talk Operation		



A3  
hp Part No. 59401-66503  
Revisions A & B Boards

Δ1: Shaded area components do not exist on Rev. B boards;  
U106 is different between Rev. A & B Boards.

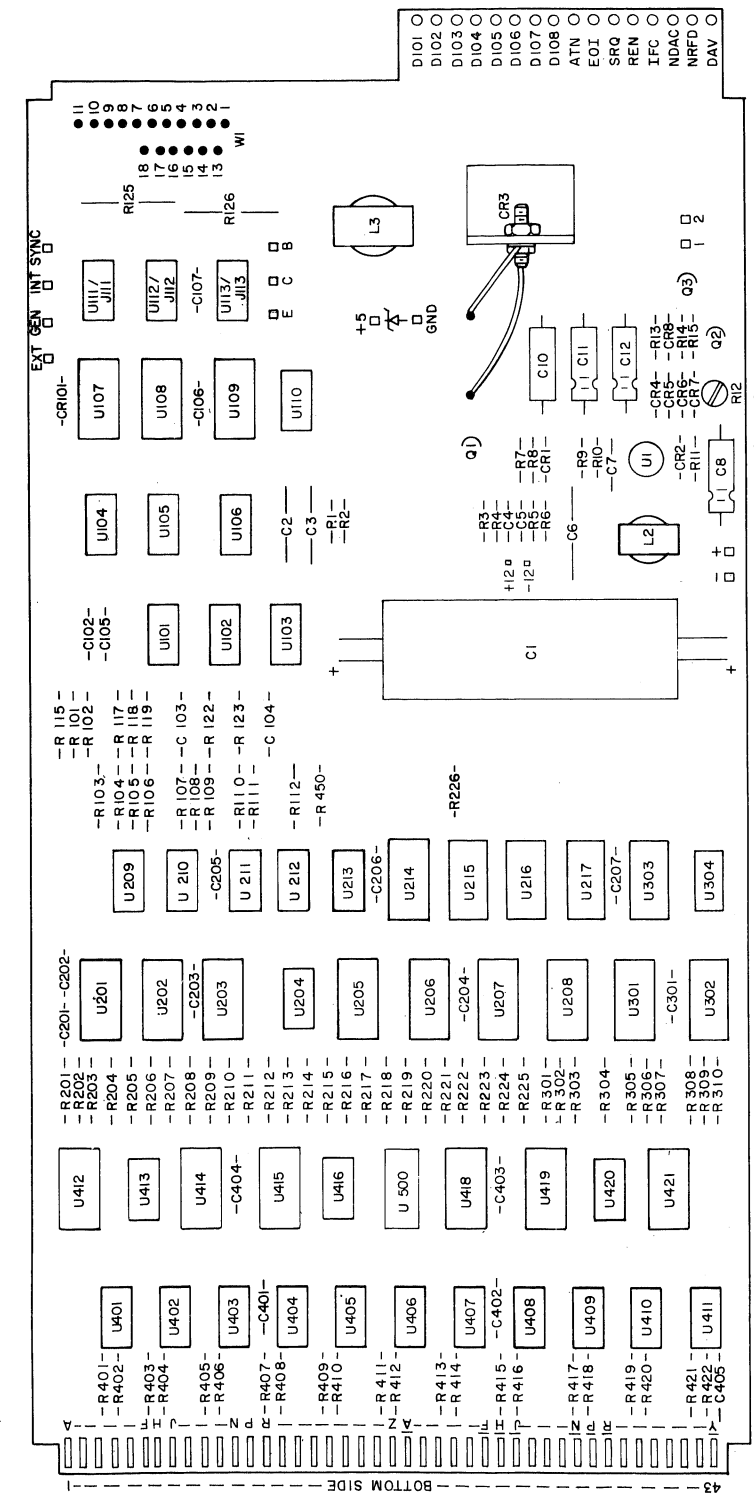




## SIGNAL MNEMONICS

MAIN CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
LEXE	EXECUTE pressed	LBOE	Bus Output Enable
HSTF	STEP MEMORY FORWARD pressed	LMDP	Connects Memory Output to Display
HSTR	STEP MEMORY REVERSE pressed	LWTE <sub>2</sub>	Enables Data to be Written into Memory
HCLR	CLEAR MEMORY pressed	LCPS <sub>2</sub>	Selects a Location in Memory (Chip Select)
HTLK	TALK FUNCTION selected	LMIS	Connects Bus to Memory Input (Select)
HRSL	HALT selected	LMIE	Connects Panel Switches to Memory Input (Enable)
HRFS	RUN FAST selected	HMIS, HMIE	Applies All 1's to Memory Input (Disable)
LRSL, LRFS	RUN SLOW selected	HDSM	Unblanks Memory Location Digits
HCMP	COMPARE switch on	LCLK <sub>2</sub>	Clocks Memory Location Counters
LTCM	COMPARE switch on and comparison is true	HDVO <sub>2</sub>	Drives LDAH True
HCNT	STEP MEMORY counter reads 30	HRFO <sub>2</sub>	Drives HRFD False
HDVI	LDAH is true	LDAO <sub>2</sub>	Drives HDAC False
HRFI	LNRFD is false (RFD is Low)	LMTB	Select Memory to Drive Bus
HDAI	LNDAC is false (DAC is Low)	LCND	Counts Memory in Reverse (Down)
HMEO	MEMORY off	HCO1	Clock F1
LMEO, LCLR	MEMORY on	HCO2	Clock F2
HOOA	SIGNAL A from fast controller	HCO3	Clock F3
HOOB	SIGNAL B from fast controller	LRST	Reset Fast Machine
HOOC	SIGNAL C from fast controller	LSTA	Select Talk Operations for Fast Controller
HDEL	.5 sec DELAY	HENF	Enable Fast Controller Output
LEMY	STEP MEMORY counter reads 31	LTRG	Triggers .5 Second Delay

FAST CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
HQO1	Wait 500 ns After Changing Data	HDVO <sub>1</sub>	LDAH is True
HDMR	Wait 1 $\mu$ s After MRE Driven Low	LRFO <sub>1</sub>	HDAC is True
HRFI	RFD is False	HRFO <sub>1</sub>	HRFD is False } if LSTA False (From MAIN CONTROLLER)
HFO1	Signal F1 From Main Controller	LWTE <sub>1</sub>	Drives LWTE and LCPS True if LFO3 is True
HFO2	Signal F2 From Main Controller	HCLK <sub>1</sub>	Drives HCLK True if HFO3 is True
HDAI	HDAC is False	HOOA	Signal A to Main Controller
LTCM	Compare Switch on and Comparison is True	HOOB	Signal B to Main Controller
LEMY	Compare Switch on and Last Memory Location is Sent	HOOC	Signal C to Main Controller
HDVI	LDAH is True		
HENF	Enable Fast Controller Output		
LSTA	Fast Controller Should Select Talk Operation		



A1  
hp Part No. 59401-66501

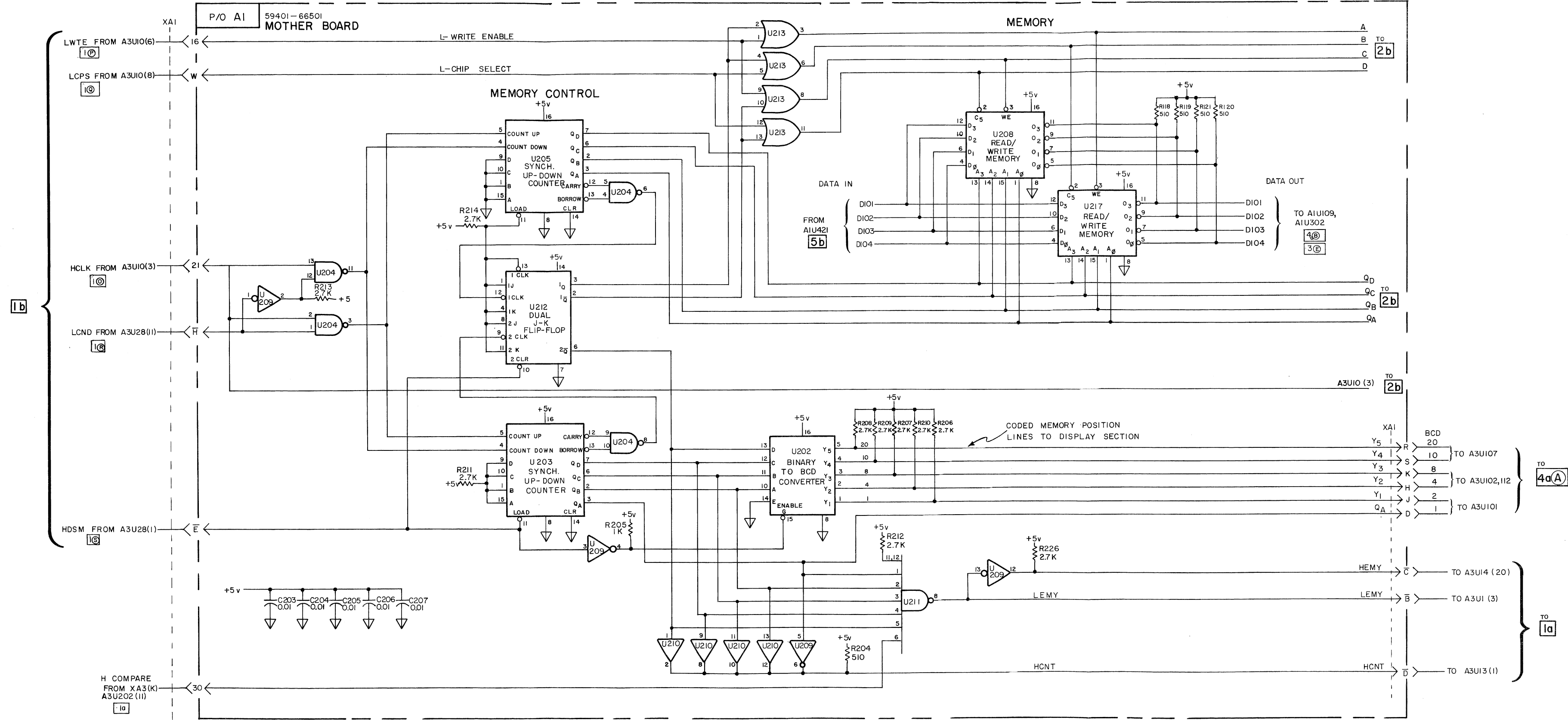
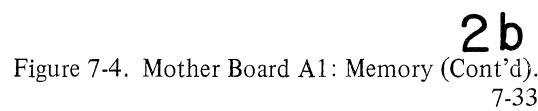
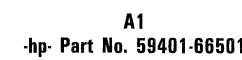


Figure 7-4. Mother Board A1: Memory.  
7-31

## SIGNAL MNEMONICS

MAIN CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
LEXE	EXECUTE pressed	LBOE	Bus Output Enable
HSTF	STEP MEMORY FORWARD pressed	LMDP	Connects Memory Output to Display
HSTR	STEP MEMORY REVERSE pressed	LWTE <sub>2</sub>	Enables Data to be Written into Memory
HCLR	CLEAR MEMORY pressed	LCPS <sub>2</sub>	Selects a Location in Memory (Chip Select)
HTLK	TALK FUNCTION selected	LMIS	Connects Bus to Memory Input (Select)
HRSL	HALT selected	LMIE	Connects Panel Switches to Memory Input (Enable)
HRFS	RUN FAST selected	HMIS, HMIE	Applies All I's to Memory Input (Disable)
LRSL, LRFS	RUN SLOW selected	HDSD	Unblanks Memory Location Digits
HCMP	COMPARE switch on	LCLK <sub>2</sub>	Clocks Memory Location Counters
LTCM	COMPARE switch on and comparison is true	HDVO <sub>2</sub>	Drives LDAH True
HCNT	STEP MEMORY counter reads 30	HRFO <sub>2</sub>	Drives HRFD False
HDVI	LDAH is true	LDAO <sub>2</sub>	Drives HDAC False
HRFI	LNRFD is false (RFD is Low)	LMTB	Select Memory to Drive Bus
HDAI	LNDAC is false (DAC is Low)	LCND	Counts Memory in Reverse (Down)
HMEO	MEMORY off	HCO1	Clock F1
LMEO, LCLR	MEMORY on	HCO2	Clock F2
HOOA	SIGNAL A from fast controller	HCO3	Clock F3
HOOB	SIGNAL B from fast controller	LRST	Reset Fast Machine
HOOC	SIGNAL C from fast controller	LSTA	Select Talk Operation for Fast Controller
HDEL	.5 sec DELAY	HENF	Enable Fast Controller Output
LEMY	STEP MEMORY counter reads 31	LTRG	Triggers .5 Second Delay

FAST CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
HQO1	Wait 500 ns After Changing Data	HDVO <sub>1</sub>	LDAH is True
HDMR	Wait 1 $\mu$ s After MRE Driven Low	LRFO <sub>1</sub>	HDAC is True } if LSTA False (From MAIN CONTROLLER)
HRFI	RFD is False	HRFO <sub>1</sub>	HRFD is False }
HFO1	Signal F1 From Main Controller	LWTE <sub>1</sub>	Drives LWTE and LCPS True if LFO3 is True
HFO2	Signal F2 From Main Controller	HCLK <sub>1</sub>	Drives HCLK True if HFO3 is True
HDAI	HDAC is False	HOOA	Signal A to Main Controller
LTCM	Compare Switch on and Comparison is True	HOOB	Signal B to Main Controller
LEMY	Compare Switch on and Last Memory Location is Sent	HOOC	Signal C to Main Controller
HDVI	LDAH is True		
HENF	Enable Fast Controller Output		
LSTA	Fast Controller Should Select Talk Operation		



## SIGNAL MNEMONICS

MAIN CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
LEXE	EXECUTE pressed	LBOE	Bus Output Enable
HSTF	STEP MEMORY FORWARD pressed	LMDP	Connects Memory Output to Display
HSTR	STEP MEMORY REVERSE pressed	LWTE <sub>2</sub>	Enables Data to be Written into Memory
HCLR	CLEAR MEMORY pressed	LCPS <sub>2</sub>	Selects a Location in Memory (Chip Select)
HTLK	TALK FUNCTION selected	LMIS	Connects Bus to Memory Input (Select)
HRSL	HALT selected	LMIE	Connects Panel Switches to Memory Input (Enable)
HRFS	RUN FAST selected	HMIS, HMIE	Applies All I's to Memory Input (Disable)
LRSL, LRFS	RUN SLOW selected	HDSM	Unblanks Memory Location Digits
HCMP	COMPARE switch on	LCLK <sub>2</sub>	Clocks Memory Location Counters
LTCM	COMPARE switch on and comparison is true	HDVO <sub>2</sub>	Drives LDAH True
HCNT	STEP MEMORY counter reads 30	HRFO <sub>2</sub>	Drives HRFD False
HDVI	LDAH is true	LDAO <sub>2</sub>	Drives HDAC False
HRFI	LNRFD is false (RFD is Low)	LMTB	Select Memory to Drive Bus
HDAI	LNDAC is false (DAC is Low)	LCND	Counts Memory in Reverse (Down)
HME0	MEMORY off	HCO1	Clock F1
LME0, LCLR	MEMORY on	HCO2	Clock F2
HOOA	SIGNAL A from fast controller	HCO3	Clock F3
HOOB	SIGNAL B from fast controller	LRST	Reset Fast Machine
HOOC	SIGNAL C from fast controller	LSTA	Select Talk Operation for Fast Controller
HDEL	.5 sec DELAY	HENF	Enable Fast Controller Output
LEMY	STEP MEMORY counter reads 31	LTRG	Triggers .5 Second Delay

FAST CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
HQ01	Wait 500 ns After Changing Data	HDVO <sub>1</sub>	LDAH is True
HDMR	Wait 1 $\mu$ s After MRE Driven Low	LRFO <sub>1</sub>	HDAC is True
HRFI	RFD is False	HRFO <sub>1</sub>	HRFD is False } if LSTA False (From MAIN CONTROLLER)
HFO1	Signal F1 From Main Controller	LWTE <sub>1</sub>	Drives LWTE and LCPS True if LFO3 is True
HFO2	Signal F2 From Main Controller	HCLK <sub>1</sub>	Drives HCLK True if HFO3 is True
HDAI	HDAC is False	HOOA	Signal A to Main Controller
LTCM	Compare Switch on and Comparison is True	HOOB	Signal B to Main Controller
LEMY	Compare Switch on and Last Memory Location is Sent	HOOC	Signal C to Main Controller
HDVI	LDAH is True		
HENF	Enable Fast Controller Output		
LSTA	Fast Controller Should Select Talk Operation		



## SIGNAL MNEMONICS

MAIN CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
LEXE	EXECUTE pressed	LBOE	Bus Output Enable
HSTF	STEP MEMORY FORWARD pressed	LMDP	Connects Memory Output to Display
HSTR	STEP MEMORY REVERSE pressed	LWTE <sub>2</sub>	Enables Data to be Written into Memory
HCLR	CLEAR MEMORY pressed	LCPS <sub>2</sub>	Selects a Location in Memory (Chip Select)
HTLK	TALK FUNCTION selected	LMIS	Connects Bus to Memory Input (Select)
HRSL	HALT selected	LMIE	Connects Panel Switches to Memory Input (Enable)
HRFS	RUN FAST selected	HMIS, HMIE	Applies All I's to Memory Input (Disable)
LRSL, LRFS	RUN SLOW selected	HDSM	Unblanks Memory Location Digits
HCMP	COMPARE switch on	LCLK <sub>2</sub>	Clocks Memory Location Counters
LTCM	COMPARE switch on and comparison is true	HDVO <sub>2</sub>	Drives LDAH True
HCNT	STEP MEMORY counter reads 30	HRFO <sub>2</sub>	Drives HRFD False
HDVI	LDAH is true	LDAO <sub>2</sub>	Drives HDAC False
HRFI	LNRFD is false (RFD is Low)	MTB	Select Memory to Drive Bus
HDAI	LNDAC is false (DAC is Low)	LCND	Counts Memory in Reverse (Down)
HMEO	MEMORY off	HCO1	Clock F1
LMEO, LCLR	MEMORY on	HCO2	Clock F2
HOOA	SIGNAL A from fast controller	HCO3	Clock F3
HOOB	SIGNAL B from fast controller	LRST	Reset Fast Machine
HOOC	SIGNAL C from fast controller	LSTA	Select Talk Operation for Fast Controller
HDEL	.5 sec DELAY	HENF	Enable Fast Controller Output
LEMY	STEP MEMORY counter reads 31	LTRG	Triggers .5 Second Delay

FAST CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
HQO1	Wait 500 ns After Changing Data	HDVO <sub>1</sub>	LDAH is True
HDMR	Wait 1 $\mu$ s After MRE Driven Low	LRFO <sub>1</sub>	HDAC is True
HRFI	RFD is False	HRFO <sub>1</sub>	HRFD is False
HFO1	Signal F1 From Main Controller	LWTE <sub>1</sub>	Drives LWTE and LCPS True if LFO3 is True
HFO2	Signal F2 From Main Controller	HCLK <sub>1</sub>	Drives HCLK True if HFO3 is True
HDAI	HDAC is False	HOOA	Signal A to Main Controller
LTCM	Compare Switch on and Comparison is True	HOOB	Signal B to Main Controller
LEMY	Compare Switch on and Last Memory Location is Sent	HOOC	Signal C to Main Controller
HDVI	LDAH is True		
HENF	Enable Fast Controller Output		
LSTA	Fast Controller Should Select Talk Operation		





## SIGNAL MNEMONICS

MAIN CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
LEXE	EXECUTE pressed	LBOE	Bus Output Enable
HSTF	STEP MEMORY FORWARD pressed	LMDP	Connects Memory Output to Display
HSTR	STEP MEMORY REVERSE pressed	LWTE <sub>2</sub>	Enables Data to be Written into Memory
HCLR	CLEAR MEMORY pressed	LCPS <sub>2</sub>	Selects a Location in Memory (Chip Select)
HTLK	TALK FUNCTION selected	LMIS	Connects Bus to Memory Input (Select)
HRSL	HALT selected	LMIE	Connects Panel Switches to Memory Input (Enable)
HRFS	RUN FAST selected		
LRSL, LRFS	RUN SLOW selected	HMIS, HMIE	Applies All I's to Memory Input (Disable)
HCMP	COMPARE switch on	HDSM	Unblanks Memory Location Digits
LTCM	COMPARE switch on and comparison is true	LCLK <sub>2</sub>	Clocks Memory Location Counters
HCNT	STEP MEMORY counter reads 30	HDVO <sub>2</sub>	Drives LDAH True
HDVI	LDAH is true	HRFO <sub>2</sub>	Drives HRFD False
HRFI	LNRFD is false (RFD is Low)	LDAO <sub>2</sub>	Drives HDAC False
HDAI	LNDAC is false (DAC is Low)	LMTB	Select Memory to Drive Bus
HME0	MEMORY off	LCND	Counts Memory in Reverse (Down)
LME0, LCLR	MEMORY on	HCO1	Clock F1
HO0A	SIGNAL A from fast controller	HCO2	Clock F2
HO0B	SIGNAL B from fast controller	HCO3	Clock F3
HO0C	SIGNAL C from fast controller	LRST	Reset Fast Machine
HDEL	.5 sec DELAY	LSTA	Select Talk Operations for Fast Controller
LEMY	STEP MEMORY counter reads 31	HENF	Enable Fast Controller Output
		LTRG	Triggers .5 Second Delay

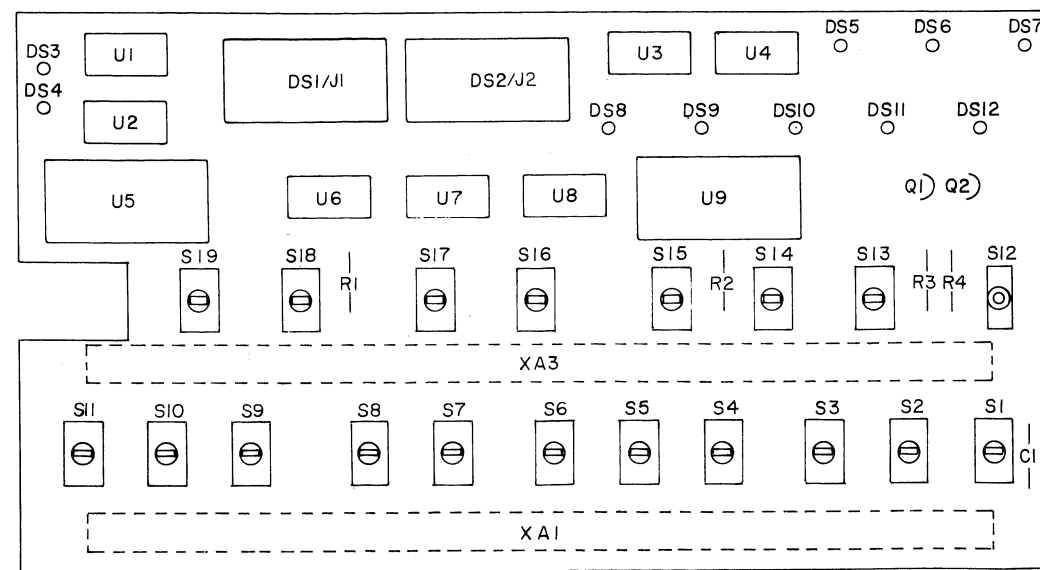
FAST CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
HQ01	Wait 500 ns After Changing Data	HDVO <sub>1</sub>	LDAH is True
HDMR	Wait 1 $\mu$ s After MRE Driven Low	LRFO <sub>1</sub>	HDAC is True
HRFI	RFD is False	HRFO <sub>1</sub>	HRFD is False } if LSTA False (From MAIN CONTROLLER)
HFO1	Signal F1 From Main Controller	LWTE <sub>1</sub>	Drives LWTE and LCPS True if LFO3 is True
HFO2	Signal F2 From Main Controller	HCLK <sub>1</sub>	Drives HCLK True if HFO3 is True
HDAI	HDAC is False	HO0A	Signal A to Main Controller
LTCM	Compare Switch on and Comparison is True	HO0B	Signal B to Main Controller
LEMY	Compare Switch on and Last Memory Location is Sent	HO0C	Signal C to Main Controller
HDVI	LDAH is True		
HENF	Enable Fast Controller Output		
LSTA	Fast Controller Should Select Talk Operation		



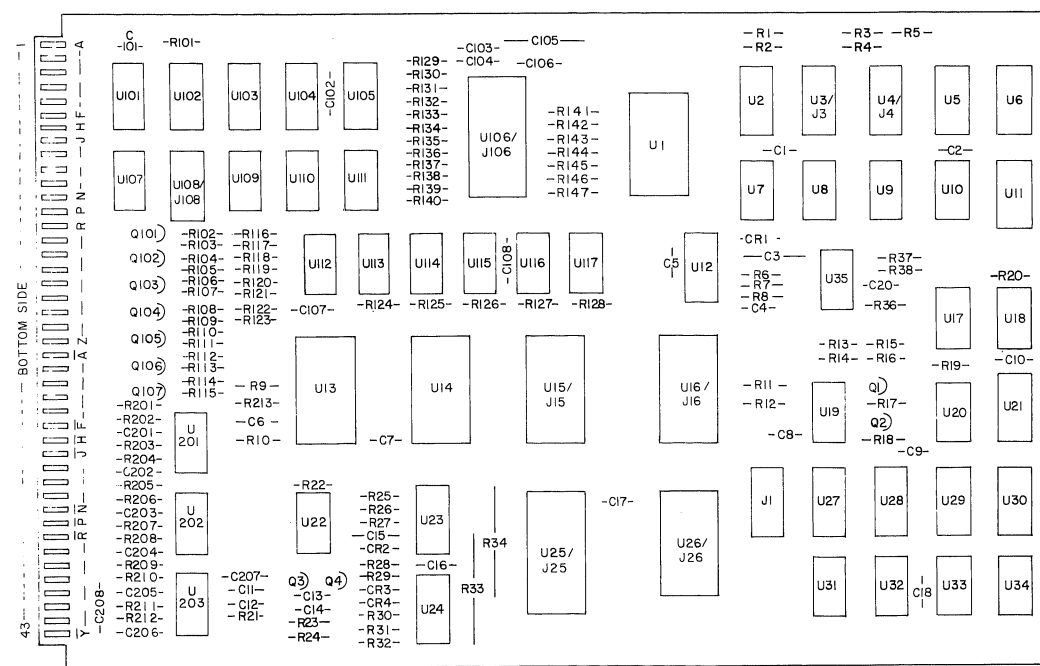
## SIGNAL MNEMONICS

MAIN CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
LEXE	EXECUTE pressed	LBOE	Bus Output Enable
HSTF	STEP MEMORY FORWARD pressed	LMDP	Connects Memory Output to Display
HSTR	STEP MEMORY REVERSE pressed	LWTE <sub>2</sub>	Enables Data to be Written into Memory
HCLR	CLEAR MEMORY pressed	LCPS <sub>2</sub>	Selects a Location in Memory (Chip Select)
HTLK	TALK FUNCTION selected	LMIS	Connects Bus to Memory Input (Select)
HRSL	HALT selected	LMIE	Connects Panel Switches to Memory Input (Enable)
HRFS	RUN FAST selected	HMIS, HMIE	Applies All I's to Memory Input (Disable)
LRSL, LRFS	RUN SLOW selected	HDSM	Unblanks Memory Location Digits
HCMP	COMPARE switch on	LCLK <sub>2</sub>	Clocks Memory Location Counters
LTCM	COMPARE switch on and comparison is true	HDVO <sub>2</sub>	Drives LDAV True
HCNT	STEP MEMORY counter reads 30	HRFO <sub>2</sub>	Drives HRFD False
HDVI	LDAV is true	LDAO <sub>2</sub>	Drives HDAC False
HRFI	LNRFD is false (RFD is Low)	LMTB	Select Memory to Drive Bus
HDAI	LNDAC is false (DAC is Low)	LCND	Counts Memory in Reverse (Down)
HMEO	MEMORY off	HCO1	Clock F1
LMEO, LCLR	MEMORY on	HCO2	Clock F2
HOOA	SIGNAL A from fast controller	HCO3	Clock F3
HOOB	SIGNAL B from fast controller	LRST	Reset Fast Machine
HOOC	SIGNAL C from fast controller	LSTA	Select Talk Operations for Fast Controller
HDEL	.5 sec DELAY	HENF	Enable Fast Controller Output
LEMY	STEP MEMORY counter reads 31	LTRG	Triggers .5 Second Delay

FAST CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
HQO1	Wait 500 ns After Changing Data	HDVO <sub>1</sub>	LDAV is True
HDMR	Wait 1 $\mu$ s After MRE Driven Low	LRFO <sub>1</sub>	HDAC is True
HRFI	RFD is False	HRFO <sub>1</sub>	HRFD is False } if LSTA False (From MAIN CONTROLLER)
HFO1	Signal F1 From Main Controller	LWTE <sub>1</sub>	Drives LWTE and LCPS True if LFO3 is True
HFO2	Signal F2 From Main Controller	HCLK <sub>1</sub>	Drives HCLK True if HFO3 is True
HDAI	HDAC is False	HOOA	Signal A to Main Controller
LTCM	Compare Switch on and Comparison is True	HOOB	Signal B to Main Controller
LEMY	Compare Switch on and Last Memory Location is Sent	HOOC	Signal C to Main Controller
HDVI	LDAV is True		
HENF	Enable Fast Controller Output		
LSTA	Fast Controller Should Select Talk Operation		

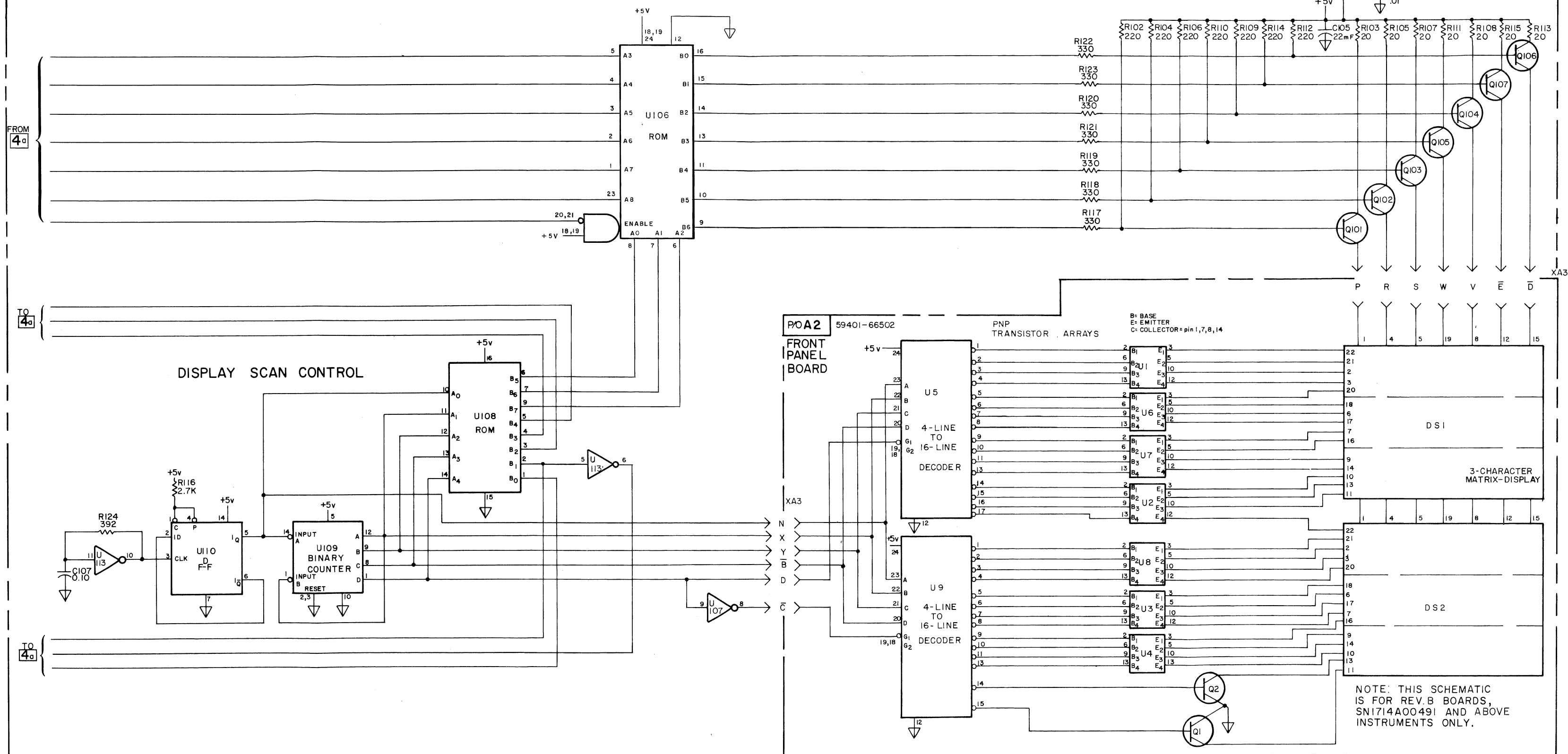


A2  
-hp Part No. 59401-66502



A3  
-hp Part No. 59401-66503

P/O A3 59401-66503  
CONTROLLER BOARD



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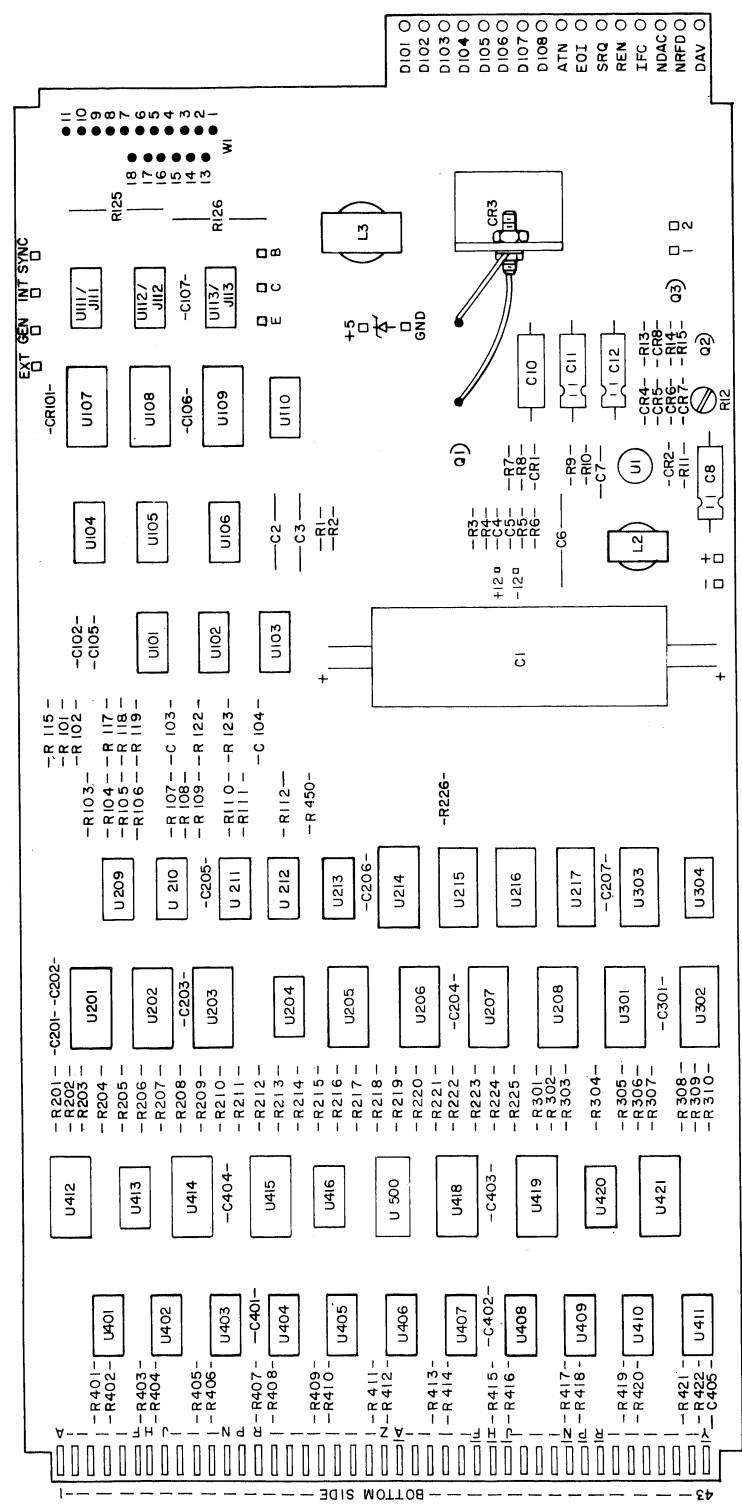
NOTE: THIS SCHEMATIC IS FOR  
REV. B BOARDS, SERIAL  
NUMBERS 1714A00495 AND  
UP INSTRUMENTS ONLY.

Figure 7-6b. Controller A3 Rev. B Boards only, Display A2: Display Control (Cont'd).  
Rev. B 7-39b

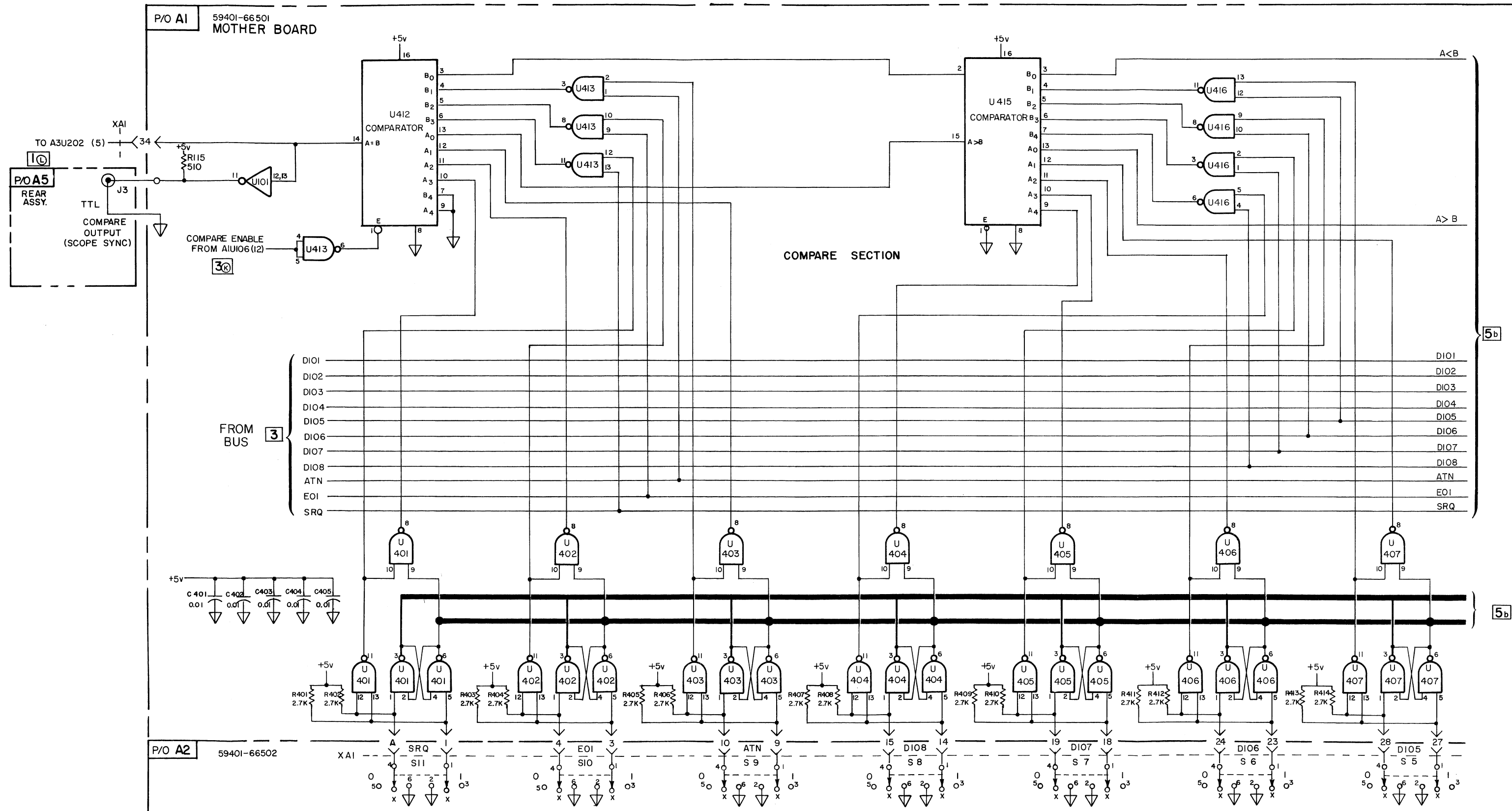
## SIGNAL MNEMONICS

MAIN CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
LEXE	EXECUTE pressed	LBOE	Bus Output Enable
HSTF	STEP MEMORY FORWARD pressed	LMDP	Connects Memory Output to Display
HSTR	STEP MEMORY REVERSE pressed	LWTE <sub>2</sub>	Enables Data to be Written into Memory
HCLR	CLEAR MEMORY pressed	LCPS <sub>2</sub>	Selects a Location in Memory (Chip Select)
HTLK	TALK FUNCTION selected	LMIS	Connects Bus to Memory Input (Select)
HRSL	HALT selected	LMIE	Connects Panel Switches to Memory Input (Enable)
HRFS	RUN FAST selected	HMIS, HMIE	Applies All I's to Memory Input (Disable)
LRSL, LRFS	RUN SLOW selected	HDSM	Unblanks Memory Location Digits
HCMP	COMPARE switch on	LCLK <sub>2</sub>	Clocks Memory Location Counters
LTCM	COMPARE switch on and comparison is true	HDVO <sub>2</sub>	Drives LDAH True
HCNT	STEP MEMORY counter reads 30	HRFO <sub>2</sub>	Drives HRFD False
HDVI	LDAH is true	LDAO <sub>2</sub>	Drives HDAC False
HRFI	LNRFD is false (RFD is Low)	LMTB	Select Memory to Drive Bus
HDAI	LNDAC is false (DAC is Low)	LCND	Counts Memory in Reverse (Down)
HME0	MEMORY off	HCO1	Clock F1
LME0, LCLR	MEMORY on	HCO2	Clock F2
HO0A	SIGNAL A from fast controller	HCO3	Clock F3
HO0B	SIGNAL B from fast controller	LRST	Reset Fast Machine
HO0C	SIGNAL C from fast controller	LSTA	Select Talk Operation for Fast Controller
HDEL	.5 sec DELAY	HENF	Enable Fast Controller Output
LEMY	STEP MEMORY counter reads 31	LTRG	Triggers .5 Second Delay

FAST CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
HQ01	Wait 500 ns After Changing Data	HDVO <sub>1</sub>	LDAH is True
HDMR	Wait 1 $\mu$ s After MRE Driven Low	LRFO <sub>1</sub>	HDAC is True
HRFI	RFD is False	HRFO <sub>1</sub>	HRFD is False } if LSTA False (From MAIN CONTROLLER)
HFO1	Signal F1 From Main Controller	LWTE <sub>1</sub>	Drives LWTE and LCPS True if LFO3 is True
HFO2	Signal F2 From Main Controller	HCLK <sub>1</sub>	Drives HCLK True if HFO3 is True
HDAI	HDAC is False	HO0A	Signal A to Main Controller
LTCM	Compare Switch on and Comparison is True	HO0B	Signal B to Main Controller
LEMY	Compare Switch on and Last Memory Location is Sent	HO0C	Signal C to Main Controller
HDVI	LDAH is True		
HENF	Enable Fast Controller Output		
LSTA	Fast Controller Should Select Talk Operation		



A1  
-hp- Part No. 59401-66501

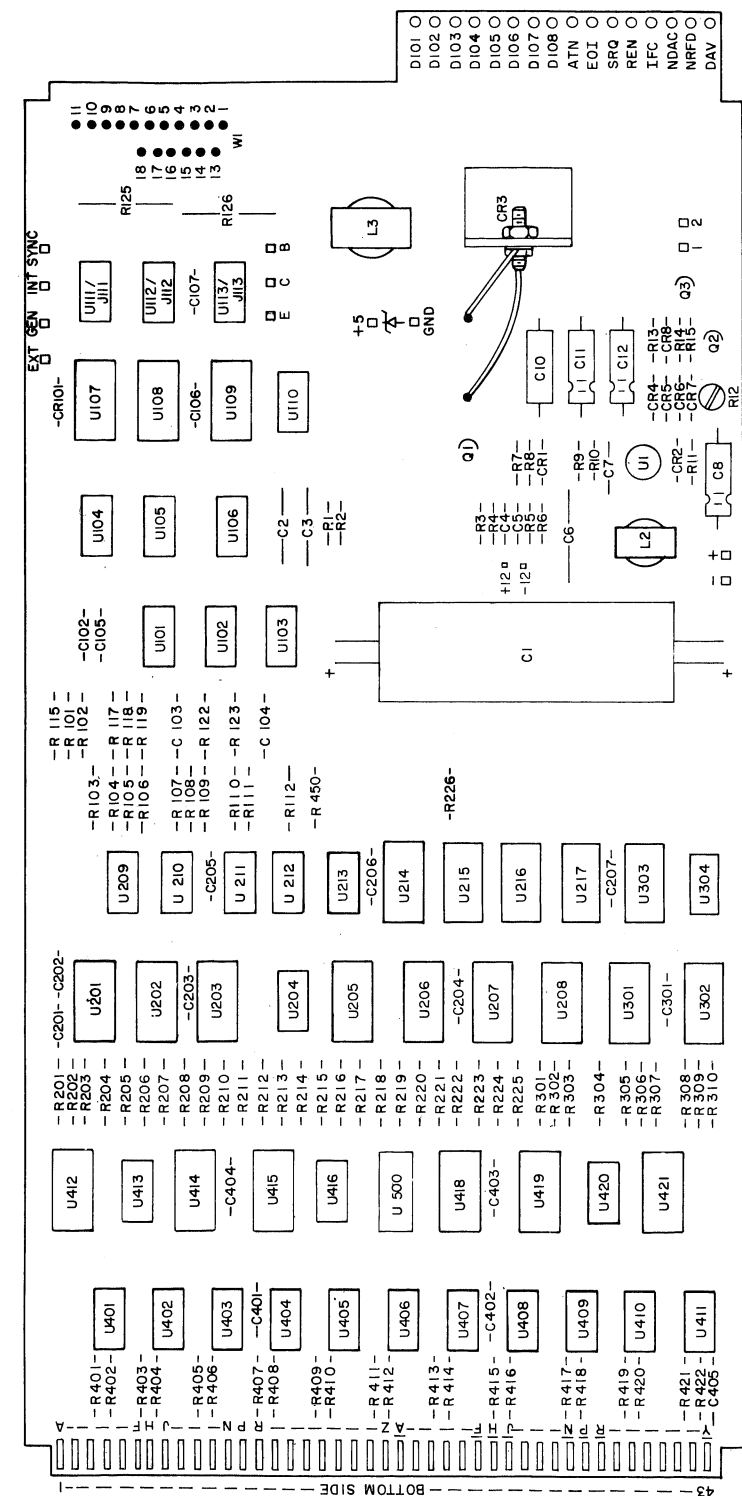


5a  
Figure 7-7. Mother Board A1: Compare.  
7-41

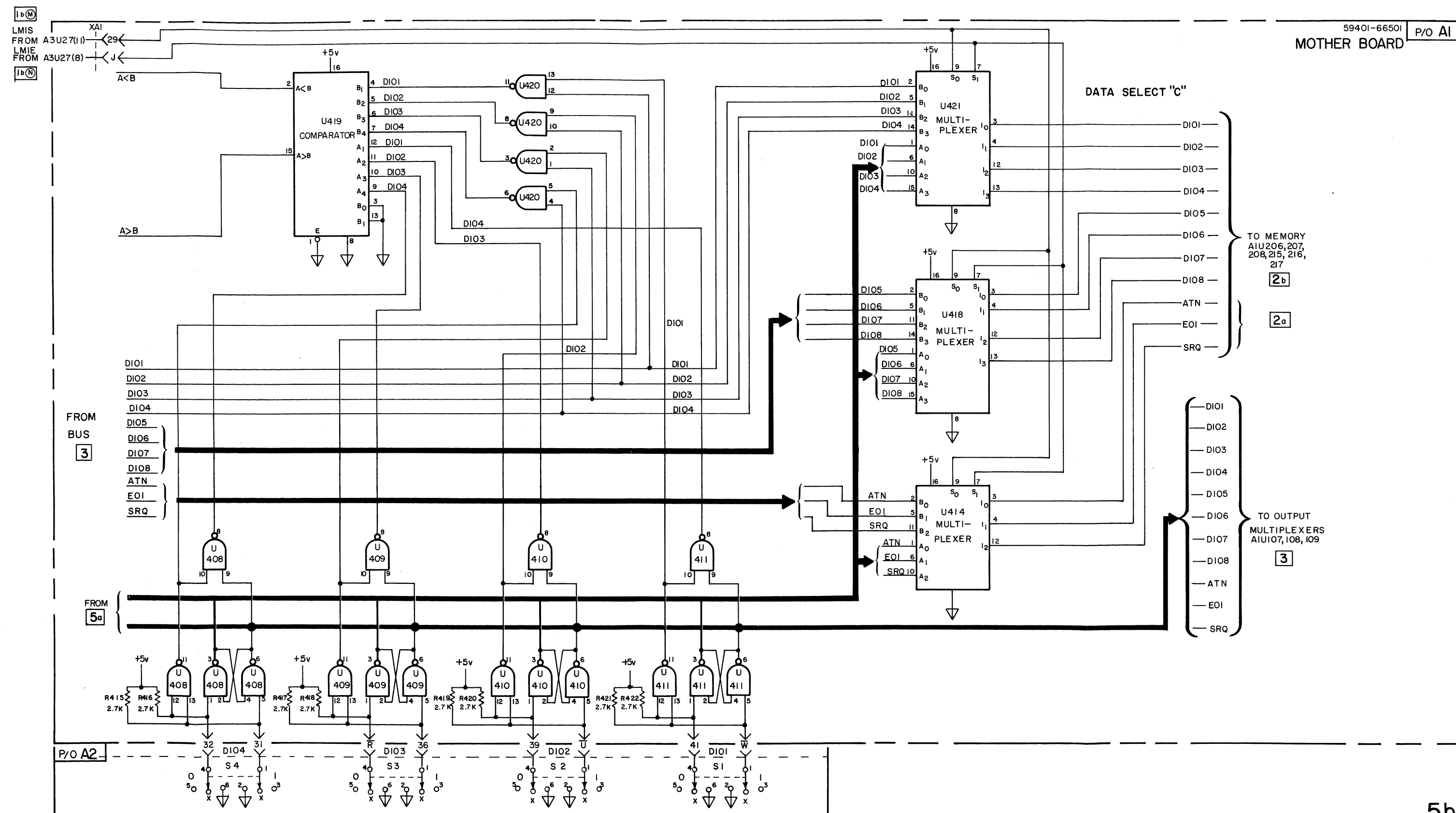
## SIGNAL MNEMONICS

MAIN CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
LEXE	EXECUTE pressed	LBOE	Bus Output Enable
HSTF	STEP MEMORY FORWARD pressed	LMDP	Connects Memory Output to Display
HSTR	STEP MEMORY REVERSE pressed	LWTE <sub>2</sub>	Enables Data to be Written into Memory
HCLR	CLEAR MEMORY pressed	LCPS <sub>2</sub>	Selects a Location in Memory (Chip Select)
HTLK	TALK FUNCTION selected	LMIS	Connects Bus to Memory Input (Select)
HRSL	HALT selected	LMIE	Connects Panel Switches to Memory Input (Enable)
HRFS	RUN FAST selected	HMIS, HMIE	Applies All I's to Memory Input (Disable)
LRSL, LRFS	RUN SLOW selected	HDSM	Unblanks Memory Location Digits
HCMP	COMPARE switch on	LCLK <sub>2</sub>	Clocks Memory Location Counters
LTCM	COMPARE switch on and comparison is true	HDVO <sub>2</sub>	Drives LDAH True
HCNT	STEP MEMORY counter reads 30	HRFO <sub>2</sub>	Drives HRFD False
HDVI	LDAH is true	LDAO <sub>2</sub>	Drives HDAC False
HRFI	LNRFD is false (RFD is Low)	LMTB	Select Memory to Drive Bus
HDAI	LNDAC is false (DAC is Low)	LCND	Counts Memory in Reverse (Down)
HMEO	MEMORY off	HCO1	Clock F1
LMEO, LCLR	MEMORY on	HCO2	Clock F2
HOOA	SIGNAL A from fast controller	HCO3	Clock F3
HOOB	SIGNAL B from fast controller	LRST	Reset Fast Machine
HOOC	SIGNAL C from fast controller	LSTA	Select Talk Operations for Fast Controller
HDEL	.5 sec DELAY	HENF	Enable Fast Controller Output
LEMY	STEP MEMORY counter reads 31	LTRG	Triggers .5 Second Delay

FAST CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
HQO1	Wait 500 ns After Changing Data	HDVO <sub>1</sub>	LDAH is True
HDMR	Wait 1 $\mu$ s After MRE Driven Low	LRFO <sub>1</sub>	HDAC is True
HRFI	RFD is False	HRFO <sub>1</sub>	HRFD is False } if LSTA False (From MAIN CONTROLLER)
HFO1	Signal F1 From Main Controller	LWTE <sub>1</sub>	Drives LWTE and LCPS True if LFO3 is True
HFO2	Signal F2 From Main Controller	HCLK <sub>1</sub>	Drives HCLK True if HFO3 is True
HDAI	HDAC is False	HOOA	Signal A to Main Controller
LTCM	Compare Switch on and Comparison is True	HOOB	Signal B to Main Controller
LEMY	Compare Switch on and Last Memory Location is Sent	HOOC	Signal C to Main Controller
HDVI	LDAH is True		
HENF	Enable Fast Controller Output		
LSTA	Fast Controller Should Select Talk Operation		



A1  
-hp- Part No. 59401-66501





## SIGNAL MNEMONICS

MAIN CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
LEXE	EXECUTE pressed	LBOE	Bus Output Enable
HSTF	STEP MEMORY FORWARD pressed	LMDP	Connects Memory Output to Display
HSTR	STEP MEMORY REVERSE pressed	LWTE <sub>2</sub>	Enables Data to be Written into Memory
HCLR	CLEAR MEMORY pressed	LCPS <sub>2</sub>	Selects a Location in Memory (Chip Select)
HTLK	TALK FUNCTION selected	LMIS	Connects Bus to Memory Input (Select)
HRSL	HALT selected	LMIE	Connects Panel Switches to Memory Input (Enable)
HRFS	RUN FAST selected	HMIS, HMIE	Applies All I's to Memory Input (Disable)
LRSL, LRFS	RUN SLOW selected	HDSM	Unblanks Memory Location Digits
HCMP	COMPARE switch on	LCLK <sub>2</sub>	Clocks Memory Location Counters
LTCM	COMPARE switch on and comparison is true	HDVO <sub>2</sub>	Drives LDAH True
HCNT	STEP MEMORY counter reads 30	HRFO <sub>2</sub>	Drives HRFD False
HDVI	LDAH is true	LDAO <sub>2</sub>	Drives HDAC False
HRFI	LNRFD is false (RFD is Low)	LMTB	Select Memory to Drive Bus
HDAI	LNDAC is false (DAC is Low)	LCND	Counts Memory in Reverse (Down)
HME0	MEMORY off	HCO1	Clock F1
LMEO, LCLR	MEMORY on	HCO2	Clock F2
HOOA	SIGNAL A from fast controller	HCO3	Clock F3
HOOB	SIGNAL B from fast controller	LRST	Reset Fast Machine
HOOC	SIGNAL C from fast controller	LSTA	Select Talk Operations for Fast Controller
HDEL	.5 sec DELAY	HENF	Enable Fast Controller Output
LEMY	STEP MEMORY counter reads 31	LTRG	Triggers .5 Second Delay

FAST CONTROLLER			
QUALIFIERS		INSTRUCTIONS	
HQO1	Wait 500 ns After Changing Data	HDVO <sub>1</sub>	LDAH is True
HDMR	Wait 1 $\mu$ s After MRE Driven Low	LRFO <sub>1</sub>	HDAC is True } if LSTA False (From MAIN CONTROLLER)
HRFI	RFD is False	HRFO <sub>1</sub>	HRFD is False }
HFO1	Signal F1 From Main Controller	LWTE <sub>1</sub>	Drives LWTE and LCPS True if LFO3 is True
HFO2	Signal F2 From Main Controller	HCLK <sub>1</sub>	Drives HCLK True if HFO3 is True
HDAI	HDAC is False	HOOA	Signal A to Main Controller
LTCM	Compare Switch on and Comparison is True	HOOB	Signal B to Main Controller
LEMY	Compare Switch on and Last Memory Location is Sent	HOOC	Signal C to Main Controller
HDVI	LDAH is True		
HENF	Enable Fast Controller Output		
LSTA	Fast Controller Should Select Talk Operation		



## **APPENDIX A**

### **VERIFYING BUS INSTRUMENT INTERFACE FUNCTIONS**

#### **INTRODUCTION.**

The Model 59401A Bus System Analyzer is the ideal instrument for verifying that another bus instrument performs its designed interface functions in accordance with IEEE Standard 448-1975. This appendix provides a detailed procedure for performing such a verification.

Any questions the user may have regarding interface functions are answered in the standard, copies of which may be ordered from

The Institute of Electrical and Electronic Engineers, Inc.  
345 East 47th Street  
New York, New York 10017



## SECTION I

### ACCEPTER HANDSHAKE INTERFACE FUNCTION

#### 1-1. DESCRIPTION.

1-2. The Acceptor Handshake Interface Function, in conjunction with the Source Handshake Interface Function, is used to guarantee the proper reception of remote multiline messages by a “listen” device. The Acceptor and Source Handshake Interface Functions interlock to permit asynchronous transfer of each data byte. The Acceptor Handshake Interface Function may delay the initiation or termination of a message transfer until the “listen” device is prepared to continue with the transfer process. The Acceptor Handshake Interface Function controls the message transfer process by means of the DAV, NRFD, and NDAC control lines.

#### 1-3. Acceptor Handshake Interface Codes.

1-4. The code “AH” is used to identify the Acceptor Interface Function. Two codes are used to denote the capability of a particular device to the Hewlett-Packard Interface Bus. These are AH0 which indicates the device has no Acceptor Handshake capability and AH1 which denotes the device has complete Acceptor Handshake capability.

#### 1-5. Acceptor Handshake Interface Function Requirements and Tests.

a. The device under test must not drive the NRFD and NDAC outputs low (true) when power is initially applied and before any messages are sent on the Bus.

#### NOTE

*Devices with “listen only” capability, such as those classified L1, L3, LE1, or LE3, must not be in the “listen only” mode for this test.*

#### TEST:

1. Set the Bus System Analyzer to the TALK/HALT/MEMORY—OFF mode and connect it to the HP—IB connector of the device to be tested.
  2. Set all switches in the lower switch register of the Analyzer to the “0” position.
  3. Apply power to the device under test and observe that the NRFD and NDAC indicators on the Bus Analyzer do not light.
- b. When the device under test is not addressed to “listen” or active, it must be set NDAC low (true) within 200 nanoseconds after receiving an ATN low (true) signal. NDAC and NRFD must be high (false) when ATN is high (false).

#### NOTE

*Devices with “listen only” capability, such as those classified L1, L3, LE1, or LE3, must not be in the “listen only” mode for this test.*

#### TEST:

1. Set the Bus System Analyzer to the TALK/HALT/MEMORY—ON mode and momentarily switch the SRQ/IFC switch to IFC.

2. Connect the 59405-66503 Test Card to the Bus cable at the instrument under test.
  3. Adjust the Pulse Generator controls to obtain a 100 kHz square wave and minimum output. Connect the Generator OUTPUT between the GND and ATN test point on the test card. Adjust the AMPLITUDE and DC OFFSET controls of the Generator to obtain a signal amplitude of 0 to + 5 volts.
  4. Connect the Oscilloscope vertical inputs to the test card ATN and NDAC test points. Adjust the Scope to trigger on the negative-going portion of the ATN signal. The time between the negative-going portion of the ATN signal and the negative-going portion of the NDAC signal must be less than 200 nano-seconds.
  5. Remove the Function Generator from the ATN test point and set the Bus Analyzer to TALK/HALT/MEMORY-OFF. The NDAC and NRFD indicators must be unlit.
- c. When the device under test is not addressed to "listen" or active and ATN is low (true), it must "handshake" as a data acceptor to valid data transmitted on the Bus. NRFD must be set low (true) only after DAV has gone low (true) but before or at the same time NDAC is set high (false). NDAC must be set low (true) only after DAV has gone high (false) but before or at the same time NRFD is set high (false).

## TEST:

1. Set the Bus System Analyzer to the TALK/HALT/MEMORY-ON mode. Load octal code "ATN 001" into memory location "00". Load octal code "ATN 000" into all other memory locations. Switch the memory OFF.
  2. Set the lower switch register of the Bus Analyzer to octal code "ATN 001" and switch to TALK/FAST/COMP-OFF.
  3. Use the Bus Analyzer COMPARE OUTPUT signal to externally trigger the Oscilloscope. Connect the Oscilloscope vertical inputs to the DAV and NRFD test points on the 59405-66503 Test Card. The NRFD signal must go low (true) only after the DAV signal has gone low (true).
  4. Remove the Oscilloscope input from the NRFD test point and connect it to the NDAC test point. The NDAC signal must go low (true) only after the DAV signal has gone high (false).
  5. Remove the Oscilloscope input from the DAV test point and connect it to the NRFD test point. NRFD must go low (true) before or at the same time NDAC goes high (false). NDAC must go low (true) before or at the same time NRFD is set high (false).
- d. The device under test must "handshake as a data acceptor when ATN is high (false) and the device is addressed to "listen".

## TEST:

1. Set the Bus System Analyzer to the TALK/HALT/MEMORY-ON mode. Load octal code "001" into memory location "00". Load octal code "000" into all other memory locations and switch the memory OFF.
2. Momentarily switch the analyzer SRQ/IFC switch to IFC. Set the lower switch register to the listen address of the device being tested, set the ATN switch to "1", and momentarily press the EXECUTE button.

**NOTE**

*If the device under test has extended listener capability, such as those classified LE1 through LE4, both a primary and secondary listen address are required to address the device to listen. Devices with listen only capability, such as those classified L1, L3, LE1, or LE3, do not need to be addressed to listen if the “lon” (listen only) message is true.*

3. Set the Analyzer to the TALK/FAST/COMP—OFF mode. Set the lower switch register to octal code “001”.
4. Use the Bus Analyzer COMPARE OUTPUT to externally trigger the Oscilloscope. Connect the Oscilloscope vertical inputs to the DAV and NRFD test points on the test card. The NRFD signal must go low (true) only after the DAV signal has gone low (true).
5. Remove the Oscilloscope input from the NRFD test point and connect it to the NDAC test point. The NDAC signal must go low (true) only after the DAV signal has gone high (false).
6. Remove the Oscilloscope input from the DAV test point and connect it to the NRFD test point. NRFD must go low (true) before or at the same time NDAC goes high (false). NDAC must go low (true) before or at the same time NRFD goes high (false).

**LISTENER AND EXTENDED LISTENER INTERFACE FUNCTION****2-1. DESCRIPTION.**

2-2. The Listener Interface Function provides a device with the capability to receive device dependent data (including status data) over the Interface from other devices. This capability exists only when the function is addressed to “listen”. There are two alternative versions of the Function, one with and one without address extension. The normal Listener Interface Function uses a one-byte address. The Listener Interface Function with address extension (Extended Listener Function) uses a two-byte address.

**2-3. Listener Interface Function Codes.**

2-4. The basic code used to identify the Listener Interface Function is “L”, while the basic code for the Extended Listener Interface Function is “LE”. The codes used to identify the Listener or Extended Listener Interface Function capability of a particular device are L0 or LE0 which indicates the device has no Listener or Extended Listener Interface capability; and L1 through L4 or LE1 through LE4 which indicate various specified capabilities.

**2-3. Listener Interface Function Requirements and Tests.**

- a. When power is first applied, the device under test must *not* “come on” addressed to “listen”. *This test applies to devices classified L1 through L4 or LE1 through LE4.*

**NOTE**

*The device under test must not be in the “listen only” mode for this test.*

**TEST:**

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—ON and connect it to the HP—IB connector of the device under test.

2. Connect the 59405-66503 test card to the Bus cable at the instrument under test.
3. Apply power to the device under test. The device must *not* drive the NRFD or NDAC lines low (true). The Analyzer NRFD and NDAC indicators must be unlit.
  - b. The device under test must become addressed to “listen” if the IFC message is false and the Listen Only message (lon) is true. *This test applies to devices classified L1, L3, LE1, or LE3.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set all switches in the lower switch register to the “0” position and momentarily switch the SRQ/IFC switch to IFC.
2. Switch the “listen only” mode of the device under test to ON. The device must drive the NDAC line low (true). The Analyzer NDAC indicator must light.
3. Press and hold the Analyzer EXECUTE button. The device must stop driving the NDAC line low (true) and drive the NRFD line low (true). The Analyzer NDAC indicator must be unlit and the NRFD indicator must light.
  - c. When in the “listen only” mode, the device under test must become unaddressed to listen in less than 100 microseconds after receiving IFC low (true). *This test applies to devices classified L1, L3, LE1, or LE3 only.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—ON.
2. Adjust the Pulse Generator controls to obtain a square wave with a negative pulse width of 100 microseconds (5 kHz) and an amplitude of 0 to + 5 volts. Connect the Generator OUTPUT between the GND and IFC test point on the Test Card.
3. Connect the Oscilloscope vertical inputs to the Test Card IFC and NDAC test points. Trigger the Oscilloscope on the negative—going edge of the IFC signal. The NDAC signal must go high (false) in less than 100 microseconds after the IFC signal goes low (true).
4. Disconnect the Function Generator from the Analyzer and set the “listen only” switch of the device under test to OFF.
  - d. The device under test must become addressed to “listen” if the IFC message is false, the listen message (ltn) is true, and the device is an active controller. *This test applies to devices classified L3, L4, LE3, or LE4.*

## TEST:

1. Set the Bus System Analyzer to LISTEN/HALT. Activate the device under test as a controller. The device under test must drive the ATN line low (true) if it is an active controller. The Analyzer ATN indicator will be lit.
2. Press and hold the Analyzer EXECUTE button to accept a character from the Bus. The device under test must drive the NDAC line low (the NRFD line will be driven low by the Analyzer). The Analyzer NDAC and NRFD indicators must be lit.



3. Release the Analyzer EXECUTE button. The device under test must drive the NRFD line low. (The NDAC line will be driven low by the Analyzer.) The Analyzer NDAC and NRFD indicators must be lit.
- e. If the device under test is an active controller addressed to listen, and the “listen only” (lon) and “local listen” (ltn) messages are false, it must become unaddressed to listen if the “local unlisten” message (lun) is true. *This test applies to devices classified L3, L4, LE3, or LE4 only.*

## TEST:

1. Put the device under test in an active control mode such that it will address itself to listen and then send other Bus commands.
2. Set the Analyzer to LISTEN/HALT and accept characters from the Bus by pressing the EXECUTE button. The device under test should drive ATN and DAV low (true) if the “local unlisten” message is true.
3. After several Bus Commands have been accepted, switch the Analyzer to TALK/HALT/MEMORY—OFF and set all switches in the lower switch register to “0”. The device under test must not drive the NRFD and NDAC lines low. (The Analyzer NRFD and NDAC indicators must be unlit.)
- f. The device under test must become addressed to “listen” if the ATN and DAV signals are true, the IFC message is false, and the DIO lines contain the device’s listen address code. The device must *not* become addressed to listen when listen address codes other than its own are received. *This test applies to devices classified L1 through L4 or LE1 through LE4.*

## NOTE

*The “listen” address code is an eight digit binary code in the form X, 0, 1, A5, A4, A3, A2, A1 where “X” can take on the value of “0” or “1” and A5 through A1 contain the code for a particular device. The Extended Listener also requires a secondary listen address code in the form X, 1, 1, S5, S4, S3, S2, S1.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—ON. Clear the memory and load consecutive listen address codes into alternate memory locations. (See Table 2-1.) Exclude the listen address of the device under test. If the device is an Extended Listener, load consecutive primary listen addresses, excluding the primary listen address of the device under test and the secondary listen address of the device into alternate memory locations. (See Table 2-1.)
2. Switch the memory OFF and the COMP switch to ON. Momentarily switch the SRQ/IFC switch to IFC. Set all switches in the lower switch register to the “X” position and the FAST/SLOW/HALT switch to FAST.
3. Output each character from memory by pressing the EXECUTE button. The device under test must drive NRFD low (true) when ATN and DAV are low (EXECUTE button released) and NDAC low (true) when only ATN is low (EXECUTE button held in). Neither NDAC nor NRFD should be driven low when ATN is high (false).
4. Repeat Steps 1, 2, and 3 until all listen address codes, except the listen address of the device under test and the “unlisten” command have been checked. This test verifies the device will not become addressed to listen by listen addresses other than its own.

**Table 2-1. No—Listen Test Pattern.**

STANDARD LISTENER		EXTENDED LISTENER	
Memory Location Number	Memory Contents (octal code)	Memory Location Number	Memory Contents (octal code)
00	ATN 040	00	ATN 040
01	000	01	ATN 171 --- secondary listen
02	ATN 041	02	000 address of device
03	000	03	ATN 041 under test
04	ATN 042	04	ATN 171
		05	000
28	ATN 056	26	000
29	000	27	ATN 051
30	ATN 057	28	ATN 171
31	000	29	000
		30	ATN 052
		31	ATN 171

5. If the device is an Extended Listener, repeat Steps 1 through 4 to load consecutive secondary listen address of the device under test. (See Table 2-2.)

**Table 2-2. Extended No—Listen Test Pattern.**

EXTENDED LISTENER	
Memory Location Number	Memory Contents (octal code)
00	ATN 052 - - - primary listen address
01	ATN 140 of device under test
02	000
03	ATN 052
04	ATN 141
05	000
26	000
27	ATN 052
28	ATN 151
29	000
30	ATN 052
31	ATN 152

6. Switch the Analyzer to TALK/HALT/MEMORY—ON and load the listen address of the device under test in memory location “00”. (If the device is an Extended Listener, load the primary listen address in memory location “00” and the secondary listen address in location “01”. The memory should now contain the listen address of the device under test and other listen addresses in alternate memory locations. (See Table 2-3.)
7. Turn the memory OFF, set all lower switches to the “X” position, and set the Analyzer to TALK/FAST.

Table 2-3. Listen Test Pattern.

STANDARD LISTENER		EXTENDED LISTENER	
Memory Location Number	Memory Contents (octal code)	Memory Location Number	Memory Contents (octal code)
00	ATN 052 --- listen address	00	ATN 052 --- primary and
01	000 of device	01	ATN 152 secondary
02	ATN 061 under test	02	000 listen address
03	000	03	ATN 052 of device
04	ATN 062	04	ATN 165 under test
		05	000
		06	ATN 052
		07	ATN 166
28	ATN 075	27	ATN 052
29	000	28	ATN 175
30	ATN 076	29	000
31	000	30	ATN 052
		31	ATN 176

8. Output each character from memory by pressing the EXECUTE button. The device under test, if addressed to listen, must drive NRFD low (true) when DAV is low (EXECUTE button released) and drive NDAC low (true) when DAV is high (EXECUTE button held in) whether ATN is high or low.

g. The device under test must become unaddressed to "listen" upon receiving the Unlisten Command (UNL). *This test applies to devices classified L1 through L4 or LE1 through LE4.*

## NOTE

*The device under test must not be in the "listen only" mode for this test.*

## TEST:

- Set the Bus System Analyzer to TALK/HALT/MEMORY-ON and load the following program into memory:

Table 2-4. Listen/Unlisten Test Pattern.

STANDARD LISTENER		EXTENDED LISTENER	
Memory Location Number	Memory Contents (octal code)	Memory Location Number	Memory Contents (octal code)
00	ATN 052 --- listen address	00	ATN 052 --- primary and
01	000 of device	01	ATN 152 secondary
02	ATN 077 under test	02	000 listen address
03	000	03	ATN 077 of device
04	ATN 052	04	000 under test
		05	ATN 052
		06	ATN 152
27	000		
28	ATN 052	28	ATN 077 --- unlisten
29	000	29	000 address
30	ATN 077 --- unlisten	30	ATN 052
31	000 address	31	ATN 152

2. Switch the Analyzer memory OFF and set the COMP switch to ON. Set all switches in the lower switch register to the "X" position and momentarily switch the SRQ/IFC switch to IFC.
3. Set the Analyzer to TALK/FAST and output each character from memory by pressing the EXECUTE button. The device under test must drive NDAC low (true) when ATN is low and DAV is high (when a command is present on the Bus but data has not been made valid). The device must drive NRFD low (true) when ATN and DAV are low. After the device has become addressed to listen (as at memory location "01" for the Standard Listener, or memory location "02" for the Extended Listener), it must drive NDAC low (true) when DAV is high (false) and drive NRFD low (true) when DAV is low (true). After the device has become unaddressed to listen (as at memory location "03" for the Standard Listener, or memory location "04" for the Extended listener), it must *not* drive NDAC or NRFD low whether DAV is high or low.
- h. The device under test must become unaddressed to listen within 100 microseconds after receiving IFC low (true). *This test applies to devices classified L1 through L4 and LE1 through LE4.*

#### NOTE

*The device under test must not be in the listen only mode for this test.*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—ON and load the following program into memory:

**Table 2-5. Listen Response Time Test Pattern.**

STANDARD LISTENER			EXTENDED LISTENER		
Memory Location Number	Memory Contents (octal code)		Memory Location Number	Memory Contents (octal code)	
00	ATN 052	listen address	00	ATN 052	primary and
01	000	of device	01	152	secondary
02	ATN 052	under test	02	000	listen address
03	000		03	ATN 052	of device
04	ATN 052		04	ATN 152	under test
28	ATN 052		05	000	
29	000				
30	ATN 052		27	ATN 052	
31	000		28	ATN 152	
			29	000	
			30	ATN 052	
			31	ATN 152	

2. Set the Analyzer MEMORY and COMP switches OFF. Set all lower switches to the "0" position and switch the Analyzer to TALK/FAST.
3. Adjust the Pulse Generator controls to obtain a square wave with an amplitude of 0 to + 5 volts.
4. Set the Analyzer rear panel clock switch to EXTERNAL CLOCK and connect the Generator to the EXTERNAL CLOCK INPUT. Connect the Analyzer COM—PARE OUTPUT to the IFC test point on the 59405—66503 Test Card.

5. Connect the Oscilloscope vertical inputs to the Test Card IFC and NDAC test points. Adjust the Generator frequency to obtain an IFC signal with a negative pulse width of 100 microseconds. Trigger the Oscilloscope on the negative-going edge of the IFC signal. The NDAC signal must go high (false) within 100 microseconds after IFC goes low (true).
6. Remove the Oscilloscope and Pulse Generator connections from the Test Card. Remove the connection between the COMPARE OUTPUT and IFC test point and return the clock switch to INTERNAL CLOCK.
  - i. The device under test must become unaddressed to listen and become addressed to talk upon receiving its talk address code. *This test applies to devices classified L3, L4, LE3, or LE4 only.*

#### NOTE

*The device under test must not be in the "listen only" mode for this test.*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF and momentarily switch the SRQ/IFC switch to IFC. Set the lower switch register to the listen address of the device under test, set the ATN switch to "1", and momentarily press the EXECUTE button. (If the device is an Extended Listener, both a primary and secondary listen address must be sent.)
2. Set the Analyzer ATN switch to the "0" position. The device under test must drive NDAC low (true) and NRFD high (false) indicating it is addressed to listen.
3. Set the Analyzer lower switch register to the talk address of the device under test, set the ATN switch to "1", and momentarily press the EXECUTE button. (If the device is an Extended Talker, both a primary and secondary talk address must be sent.) Set the ATN switch to "0". The device under test must *not* drive NDAC or NRFD low (true). The Analyzer NDAC and NRFD indicators must be unlit.

#### NOTE

*When the device under test becomes an active talker and the ATN signal is high, it may drive the DIO lines at Bus speeds. The Analyzer digital display may be a blur.*

## SOURCE HANDSHAKE INTERFACE FUNCTION

### 3-1. DESCRIPTION.

3-2. The source Handshake Interface Function, in conjunction with the Acceptor Handshake Interface Function, is used to guarantee the proper transfer of multiline messages. An interlocked handshake sequence between the Source Handshake Interface Function and one or more Acceptor Handshake Interface Functions (each contained within separate devices) guarantees asynchronous transfer of each multiline message. The Source Handshake Interface Function controls the initiation of, and termination of, the transfer of a multiline message byte. This function utilizes the DAV, NRFD, and NDAC messages to effect each message byte transfer.

### 3-3. Source Handshake Interface Function Codes.

3-4. The basic code "SH" is used to identify the Source Handshake Interface Function. Two codes are used to denote the capability of the Source Handshake Interface Function of a particular device to the Hewlett-Packard Interface Bus. These are SH0, which indicates the device has no Source Handshake capability; and SH1, which indicates the device has complete Source Handshake capability.

### 3-5. Source Handshake Interface Function Requirements and Tests.

- a. The device under test must *not* drive the DAV, EOI, or DIO lines low (true) when power is initially applied and before any messages are sent on the Bus.

#### NOTE

*Devices with "talk only" capability, such as those classified T1, T3, T5, T7, TE1, TE3, TE5, or TE7, must not be in the "talk only" mode for this test.*

#### TEST:

1. Set the Bus System Analyzer to LISTEN/HALT/MEMORY—OFF and connect it to the HP—IB connector of the device under test.
  2. Connect the 59405—66503 Test Card to the Bus cable at the instrument under test.
  3. Apply power to the Device being tested and observe that the DAV, ATN, and EOI indicators do not light. The numeric display should read "000".
- b. The device under test may set DAV low (true) only if NRFD is high (false) and the data on the DIO lines is valid. This applies to devices which are active "talkers" or "controllers" or are in an active serial poll mode.

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the talk address of the device under test, set the ATN switch to "1", and momentarily press the EXECUTE button.

#### NOTE

*If the device under test is an extended talker, both a primary and secondary talk address is required. If the device is a controller, it must be programmed to send a repetitive sequence when in active control. (Refer to the operating manual of the device under test for programming information.)*

2. Switch the Analyzer to LISTEN and single step the output of the device to find a unique character such as the ASCII character "CR" (octal code 015).
3. Set the Analyzer lower switch register to the code of the character selected and switch to LISTEN/FAST/COMP—OFF.
4. Connect the Oscilloscope vertical inputs to the DAV and NRFD test points on the Test Card. Use the Analyzer COMPARE OUTPUT to trigger the Oscilloscope. NRFD must go high (false) before DAV goes low (true).
5. Remove the Oscilloscope input from the NRFD test point and connect it to a DIO test point which will go low (true) for the character selected. For example,

the DIO lines DIO1, DIO3, and DIO4 will be low for the character “CR” (octal code 015). DAV must *not* go low (true) for more than 2 microseconds after the DIO line selected goes low (true).

#### NOTE

*If tri-state drivers are used to drive the DAV, DIO, and EOI lines, this time may be reduced. Refer to the Hewlett-Packard Interface Bus Manual, Page 93, for particular timing values.*

#### NOTE

*This test only applies to devices which can continuously output data when addressed to talk.*

- c. The device under test may set DAV high only after NDAC has gone high (false).

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the talk address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.

#### NOTE

*If the device is an extended talker, a secondary talk address is required. If the device is an active controller, it must be programmed to repetitively output commands.*

2. Connect the Oscilloscope vertical inputs to the NDAC and DAV test points on the Test Card. Set the Analyzer to LISTEN/FAST/COMP—OFF.
  3. Trigger the Oscilloscope on the positive—going edge of the NDAC signal. Observe that the NDAC signal goes high (false) before the DAV signal goes high (false).
- d. Data may be changed at the same time or after DAV goes high, but it must be changed before DAV is again set low.

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the talk address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.

#### NOTE

*If the device is an extended talker, a secondary talk address is required. If the device is an active controller, it must be programmed to repetitively output commands.*

2. Connect the oscilloscope vertical inputs to the DAV test point and an active DIO test point on the Analyzer rear panel. Set the Analyzer to LISTEN/FAST/COMP—OFF.
3. Trigger the Oscilloscope on the positive—going edge of the DAV signal. Observe that the DIO signal does not change before the DAV signal goes high.
4. Trigger the Oscilloscope on the negative—going edge of the DAV signal. Observe that the DIO signal does not change after the DAV signal has gone low.

5. Trigger the Oscilloscope on the negative-going edge of the DIO signal. Observe that the DIO signal goes low more than 2 microseconds before the DAV signal goes low.

#### NOTE

*If tri-state drivers are used to drive the DAV, DIO, and EOI lines, this time may be reduced to 1100 nanoseconds or greater. If the device being tested is a controller and uses tri-state drivers to control the DAV, DIO, EOI, and ATN lines, the time may be reduced to 700 nanoseconds or greater for the first byte of information output and 500 nanoseconds or greater for subsequent bytes of information.*

- e. If the device under test is an active talker, it must stop driving the DIO, DAV, and EOI lines in less than 200 nanoseconds after ATN goes low (true).

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY-OFF. Set the lower switch register to the talk address of the device under test, set the ATN switch to "1", and momentarily press the EXECUTE button.
2. Adjust the Pulse Generator controls to obtain a square wave with a frequency less than the talk rate of the device under test and a minimum output. Connect the Generator OUTPUT between the ground lug and ATN test point on the Test Card. Set the Analyzer to LISTEN/FAST/COMP-OFF.
3. Connect the Oscilloscope vertical inputs to the ATN and DAV test points on the Test Card and adjust the Generator for a signal amplitude of 0 to + 5 volts at the ATN test point.
4. Trigger the Oscilloscope on the negative-going edge of the ATN signal and observe that the DAV signal goes high in less than 200 nanoseconds after ATN goes low.
5. Remove the Oscilloscope vertical input from the DAV test point and connect it to an active DIO test point. Observe that the DIO signal goes high in less than 200 nanoseconds after the ATN signal goes low.
6. Remove the Oscilloscope input from the DIO test point and connect it to the EOI test point. If the device is driving the EOI line low, the EOI signal must go high in less than 200 nanoseconds after ATN goes low.
7. Press and hold the Analyzer EXECUTE button and repeat the procedures in Steps 5 and 6.

#### NOTE

*It may be necessary to use a counter to measure the time between signals if the talk rate of the device under test is too slow for the Oscilloscope to display.*



## TALKER AND EXTENDED TALKER INTERFACE FUNCTION

### 4-1. DESCRIPTION.

4-2. The Talker Interface Function provides a device with the capability to send device dependent data (including status data) over the interface to other devices. This capability exists only when the Talker Interface Function is addressed to talk. There are two alternative versions of the Function, one with and one without address extension. The normal Talker Interface Function uses a one-byte address. The Talker Interface Function with address extension (Extended Talker Function) uses a two-byte address.

### 4-3. Talker Interface Function Codes.

4-4. The basic code used to identify the Talker Interface Function is "T" while the basic code for the Extended Talker Interface Function is "TE". The codes used to identify the Talker or Extended Talker Interface Function capability of a particular device are T0 or TE0 which indicates the device has no Talker or Extended Talker Interface capability, and T1 through T8 or TE1 through TE8 which indicate various specified capabilities.

### 4-5. Talker Interface Function Requirements and Tests.

a. When power is first applied, the device under test must *not* "come on" addressed to "talk" or in the serial poll mode. *This test applies to devices classified T1 through T8 and TE1 through TE8.*

#### NOTE

*Devices with "talk only" capability must not be in the talk only mode for this test.*

#### TEST:

1. Set the Bus System Analyzer to LISTEN/HALT and connect it to the HP-IB connector of the device under test. Connect the 59405-66503 Test Card to the Bus cable at the device under test.
2. Apply power to the device under test. The device must *not* drive the DAV, EOI, or any of the DIO lines low (true). The Analyzer DAV and EOI indicators must be unlit and the digital display must read "000".
- b. The device under test must become addressed to "talk" when the IFC signal is high (false) and the "talk" only" message (ton) is true. *This test applies to devices classified T1, T3, T5, T7, TE1, TE3, TE5, or TE7 only.*

#### TEST:

1. Set the Bus System Analyzer to LISTEN/HALT.
2. Set the device under test to the "talk only" mode. The device must apply data to the DIO lines and set the DAV line low (true).
3. Switch the "talk only" mode OFF and momentarily switch the Analyzer SRQ/IFC switch to IFC. The device under test must stop driving the DAV, EOI, and all DIO lines. The Analyzer DAV and EOI indicators must be unlit and the digital display must read "000".
- c. The device under test must become addressed to "talk" only upon receiving its individual talk address code and must become unaddressed to talk upon receiving a talk address code other than its own or the Untalk Command (UNT). *This test applies to devices classified T1 through T8 or TE1 through TE8.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the talk address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button. If the device is an Extended Talker, set the lower switch register to the secondary talk address and again momentarily press the EXECUTE button.
  2. Set the Analyzer to LISTEN/HALT. The device under test must drive DAV low (true) and output the first byte of data on the DIO lines.
  3. Set the Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to a talk address other than that of the device being tested, set ATN to “1”, and momentarily press the EXECUTE button.
  4. Set the Analyzer to LISTEN/HALT. The device must have stopped driving all Bus lines (the Analyzer will drive the NDAC line) indicating it is no longer addressed to talk.
  5. Repeat Steps 3 and 4 to check all talk addresses other than the talk address of the device being tested.
  6. Readdress the device to talk as outlined in Steps 1 and 2. Set the Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the “untalk” command (octal code ATN 137) and momentarily press the EXECUTE button. Set the Analyzer to LISTEN/HALT. The device must have stopped driving all Bus lines (the Analyzer will drive NDAC) indicating it is no longer addressed to talk.
- d. The device under test must become unaddressed to talk in less than 100 microseconds after receiving IFC low (true). *This test applies to devices classified T1 through T8 and TE1 through TE8.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the talk address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button. If the device is an Extended Talker, set the lower switch register to the secondary talk address and again momentarily press the EXECUTE button. Set the Analyzer to LISTEN/HALT and verify that the device is addressed to talk. (The device must drive DAV low and output the first byte of data on the DIO lines.)
  2. Adjust the Pulse Generator controls to obtain a square wave with a negative pulse width of 100 microseconds (5 kHz) and an amplitude of 0 to + 5 volts.
  3. Connect the Generator OUTPUT between the GND and IFC test point on the Test Card. The device under test must stop driving all Bus lines. (The IFC line will be driven by the Pulse Generator.)
- e. The device under test must enter the serial poll mode if IFC is high (false), the device is addressed to talk, and the Serial Poll Enable Command (SPE) is received. *This test applies to devices classified T1, T2, T5, T6, TE2, TE5, or TE6.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the talk address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button. If the device is an Extended

Talker, set the lower switch register to the secondary talk address and again momentarily press the EXECUTE button.

2. Set the Analyzer to LISTEN/HALT. The device under test must drive DAV low (true) and output the first byte of data on the DIO lines.
  3. Set the Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the SPE command (octal code ATN 030) and momentarily press the EXECUTE button.
  4. Set the Analyzer to LISTEN/HALT. The device must output a status byte. The status byte, in octal code, will be of the form “1XX” to indicate the device requested service, or “0XX” to indicate the device did not request service. (Digits indicated by “X” are device dependent.)
  5. Set the Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the Serial Poll Disable (SPD) command (octal code ATN 031) and momentarily press the EXECUTE button. The device under test must stop responding to the serial poll.
  6. Set the Analyzer lower switch register to the SPE command (octal code ATN 030) and momentarily press the EXECUTE button.
  7. Set the lower switch register to the talk address of the device under test (with ATN set to “1”) and momentarily press the EXECUTE button.
  8. Set the Analyzer to LISTEN/HALT. The device under test must respond to the serial poll by outputting its status byte.
- f. The device under test must exit the serial poll mode within 100 microseconds after receiving IFC low (true). *This test applies to devices classified T1, T2, T5, T6, TE1, TE2, TE5, or TE6.*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the talk address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button. If the device is an Extended Talker, set the lower switch register to the secondary talk address and again momentarily press the EXECUTE button.
  2. Set the lower switch register to the SPE command (octal code ATN 030) and momentarily press the EXECUTE button. Set the Analyzer to LISTEN/HALT. The device should now be in the serial poll mode.
  3. Adjust the Pulse Generator controls to obtain a square wave with a negative pulse width of 100 microseconds (5 kHz) and an amplitude of 0 to + 5 volts.
  4. Connect the Generator OUTPUT between the GND and IFC test points on the Test Card. The device being tested must stop driving all Bus lines. (The IFC line will be driven by the Pulse Generator.)
  5. Readdress the device to talk as in Step 1. Set the Analyzer to LISTEN/HALT. The device should again respond to the serial poll and output a status byte on the DIO lines.
- g. The device under test must exit the serial poll mode upon receiving the Serial Poll Disable command (SPD). *This test applies to devices classified T1, T2, T5, T6, TE1, TE2, TE5, or TE6.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the talk address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button. If the device is an Extended Talker, set the lower switch register to the secondary talk address and again momentarily press the EXECUTE button.
  2. Set the lower switch register to the SPE command (octal code ATN 030) and momentarily press the EXECUTE button. Set the Analyzer to LISTEN/HALT and confirm that the device is in the serial poll mode.
  3. Set the Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the SPD command (octal code ATN 031) and momentarily press the EXECUTE button.
  4. Set the Analyzer to LISTEN/HALT. The device should drive the DAV line low (true) and output the first byte of device dependent data on the DIO lines.
  5. Momentarily switch the Analyzer SRQ/IFC switch to IFC.
  6. Set the Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the SPE command (octal code ATN 030) and momentarily press the EXECUTE button.
  7. Set the Analyzer lower switch register to the SPD command (octal code ATN 031) and momentarily press the EXECUTE button.
  8. Set the lower switch register to the talk address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.
  9. Set the Analyzer to LISTEN/HALT. The device should drive the DAV line low (true) and output the first byte of device dependent data.
- h. The device under test must become unaddressed to talk and addressed to listen upon receiving its listen address. *This test applies to devices classified T5, T6, T7, T8, TE5, TE6, TE7, or TE8.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the talk address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button. If the device is an Extended Talker, set the lower switch register to the secondary talk address and again momentarily press the EXECUTE button.
2. Set the Analyzer to LISTEN/HALT. The device under test must drive DAV low (true) and output the first byte of data on the DIO lines.
3. Switch the Analyzer back to TALK/HALT/MEMORY—OFF. Set the lower switch register to the “listen” address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button. If the device is an Extended Listener, set the lower switch register to the secondary listen address and again momentarily press the EXECUTE button.
4. Set all switches in the lower switch register to “0”. The device under test must drive the NDAC line low (true).

- i. If the device under test is capable of driving EOI, it must do so when sending the last byte of device dependent data. This test applies to devices classified T1 through T8 and TE1 through TE8.

**TEST:**

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the listen address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.
2. Set the Analyzer to LISTEN/HALT. Accept characters from the device under test one at a time by momentarily pressing the Analyzer EXECUTE button. The device under test must drive EOI low (true) at the same time it outputs the last byte of data.

## **REMOTE LOCAL INTERFACE FUNCTION**

### **5-1. DESCRIPTION.**

5-2. The Remote Local Interface Function provides a device with the capability to select between two sources of input information. The Remote Local Interface Function indicates to the device that either input from the front panel controls (local) or corresponding input information from the Bus is to be used.

### **5-3. Remote Local Interface Function Codes.**

5-4. The basic code used to identify the Remote Local Interface Function is “RL”. The codes used to denote the Remote Local Interface Function capability of a particular device are RL0, which indicates the device has no Remote Local Interface capability, and RL1 and RL2, which denote particular specified capabilities.

### **5-5. Remote Local Interface Function Requirements and Tests.**

- a. When power is first applied, the device under test must “come on” in the local mode. *This test applies to devices classified RL1 or RL2.*

**TEST:**

1. Set the Bus System Analyzer to LISTEN/HALT and connect it to the HP—IB connector of the device to be tested. Connect the 59405-66503 Test Card to the Bus cable at the device under test.
  2. Apply power to the device under test. The device must respond to its front panel controls and not respond to data transmitted on the Bus.
  3. Switch the Analyzer REN switch to REN. The device under test must remain in local and not respond to Bus data.
- b. The device under test must enter the remote mode if REN is low (true) and the device receives its listen address. *This test applies to devices classified RL1 or RL2.*

**TEST:**

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF and switch the REN switch to REN. Set the lower switch register to the listen address of the

device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.

#### NOTE

*If the device is an Extended Listener, it will be necessary to send both a primary and secondary listen address.*

2. The device should now be in the remote mode and must not respond to its front panel controls.
- c. The device under test must exit the remote mode in less than 100 microseconds after the REN signal goes high. *This test applies to devices classified RL1 or RL2.*

#### TEST:

1. Adjust the Pulse Generator controls to obtain a 100 microsecond pulse with an amplitude of 0 to + 5 volts.
2. Set the Generator repetition rate to MANUAL and connect the OUTPUT between the GND and REN test points on the Test Card.
3. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF/REN—OFF. Set the lower switch register to the listen address of the device under test and momentarily press the EXECUTE button.
4. Make certain the device is in the remote mode by testing its front panel controls. The device should not respond to the front panel controls.
5. Momentarily press the Pulse Generator’s MANUAL trigger button. (The Generator should output a single 100 microsecond pulse.) The device under test must return to the local mode and respond to its front panel controls.
6. Remove the Pulse Generator OUTPUT from the Test Card.
- d. If the device under test is addressed to listen, it must go to the local mode upon receiving the Go To Local Command (GTL). *This test applies to devices classified RL1 or RL2.*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF and switch the REN switch to REN. Set the lower switch register to the listen address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.
2. Make certain the device is in the remote mode.
3. Set the Analyzer lower switch register to the Go To Local command (octal code ATN 001) and momentarily press the EXECUTE button. The device must respond to its front panel controls, indicating it is in the local mode.
- e. The device under test must switch from remote to local control when the front panel “return to local” switch is pressed if the device has not received the Local Lockout Command (LLO). If the return to local message is true the device must still remain addressed to listen. *This test applies to devices classified RL1 only.*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF and switch the REN switch to REN. Set the lower switch register to the listen address of the

device under test, set ATN to “1”, and momentarily press the EXECUTE button.

2. The device under test should not respond to its front panel controls, indicating it is in the remote mode.
  3. Press the “return to local” switch of the device being tested. The device must now respond to its front panel controls.
  4. Switch the Analyzer ATN switch to the “0” position. The NDAC indicator must remain lit, indicating the device is still addressed to listen. Return the ATN switch to the “1” position.
  5. Momentarily press the Analyzer EXECUTE button. The device must return to the remote mode.
- f. The device under test must ignore the “return to local” command (rtl) after receiving the “local lockout” command (LLO) while the remote enable message (REN) is true. *This test applies to devices classified RLI only.*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF and switch the REN switch to REN. Set the lower switch register to the listen address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.
2. Set the Analyzer lower switch register to the Local Lockout Command (octal code ATN 021) and momentarily press the EXECUTE button.
3. Press the “return to local” switch of the device under test. The device must remain in the remote mode and not respond to the front panel controls.
4. Switch the Analyzer REN switch OFF and then back to REN. The device must remain addressed to listen and return to local control. Set the ATN switch to “0”. The NDAC indicator must remain lit, indicating the device is still addressed to listen.
5. Readdress the device to listen, as in Step 1. The device must go to the remote mode. Press the return to local switch of the device being tested. The device must return to the local mode.

## DEVICE CLEAR INTERFACE FUNCTION

### 6-1. DESCRIPTION.

6-2. The Device Clear Interface Function provides the device with the capability to be cleared (initialized) either individually or collectively as part of a group. The group may be a subset or all addressed devices in one system.

### 6-3. Device Clear Interface Function Codes.

6-4. The basic code used to identify the Device Clear Interface Function is “DC”. The codes used identify the Device Clear Interface Function capability of a particular device are DC0, which indicates the device has no Device Clear Interface Function capability, and DC1 and DC2, which specify particular capabilities.

### 6-5. Device Clear Interface Function Requirements and Tests.

a. The device under test must go to a predefined state upon receiving the “device clear” command (DCL) if ATN is true and the device has been addressed to listen. *This test applies to devices classified DC1 or DC2.*

#### NOTE

*If the device is classified DC2 and does not have “listen” capability, replace Steps 1 and 2 with the following procedure:*

*Set the front panel controls of the device under test to a non-cleared mode of operation.*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF and switch the REN to REN. Set the lower switch register to the listen address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.
2. Program the device under test to a “non-cleared” mode by setting the Analyzer lower switch register to the required character and pressing the EXECUTE button. (It may be necessary to output more than one character.)
3. Set the Analyzer lower switch register to the DCL command (octal code ATN 024) and momentarily press the EXECUTE button. The device must go to the “cleared” mode.

b. The device under test must go to a predefined state upon receiving the Selected Device Clear Command (SDC) if the device has been addressed to listen and the ATN signal is true. *This test applies to devices classified DC1 only.*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF and switch the REN switch to REN. Set the lower switch register to the listen address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.
2. Program the device under test to a “non-cleared” mode by setting the Analyzer lower switch register to the required character and pressing the EXECUTE button. (It may be necessary to output more than one character.)
3. Set the Analyzer lower switch register to the SDC command (octal code ATN 004) and momentarily press the EXECUTE button. The device must go to the “cleared” mode.

c. The device under test must respond to the Device Clear Command (DCL) but *not* respond to the Selected Device Clear Command (SDC) when unaddressed to listen. *This test applies to devices classified DC1 only.*

#### TEST:

1. Program the device under test as described in Steps 1 and 2 of Part B.
2. Set the Analyzer lower switch register to the unlisten command (octal code ATN 077) and momentarily press the EXECUTE button.



3. Set the lower switch register to the DCL command (octal code ATN 024) and momentarily press the EXECUTE button. The device must go to the “cleared” mode.
4. Program the device under test as described in Steps 1 and 2 of Part B.
5. Set the Analyzer lower switch register to the unlisten command (octal code ATN 077) and momentarily press the EXECUTE button.
6. Set the lower switch register to the SDC command (octal code ATN 004) and momentarily press the EXECUTE button. The device under test must *not* go to the “cleared” mode.

## DEVICE TRIGGER INTERFACE FUNCTION

### 7-1. DESCRIPTION.

7-2. The Device Trigger Interface Function provides the device with the capability to have its basic (measurement) operation initiated either individually or collectively as part of a group of devices. The group may be either a subset or all addressed devices in one system.

### 7-3. Device Trigger Interface Function Codes.

7-4. The basic code used to identify the Device Trigger Interface Function is “DT”. The codes used to denote the Device Clear Interface Function capability of a particular device are DT0, which indicates the device has no Device Trigger Interface capability, and DT1, which indicates the device has complete Device Trigger Interface capability.

### 7-5. Device Trigger Interface Function Requirements and Tests.

- a. The measurement sequence, of the device under test, must be initiated upon receiving the Group Execute Trigger command (GET) if the device is addressed to listen.

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the listen address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.
2. Set the lower switch register to the GET command (octal code ATN 010) and momentarily press the EXECUTE button. The device under test must initiate the measurement sequence when the EXECUTE button is pressed.
3. Set the lower switch register to the Unlisten command (octal code ATN 077) and momentarily press the EXECUTE button.
4. Reset the Analyzer lower switch register to the GET command (octal code ATN 010) and momentarily press the EXECUTE button. The device under test must *not* respond to the GET command.

## SERVICE REQUEST INTERFACE FUNCTION

### 8-1. DESCRIPTION.

8-2. The Service Request Interface Function provides a device with the capability to asynchronously request service from the controller in charge of the Interface. This function also synchronizes the value of the service request bit of the status byte present during a serial poll so that the Service Request message (SRQ) can be removed from the Interface once this bit has been received true by the controller in charge.

### 8-3. Service Request Interface Function Codes.

8-4. The basic code used to identify the Service Request Interface Function is "SR". The codes used to denote the Service Request Interface Function capability of a particular device are SRO, which indicates the device has no Service Request Interface capability; and SR1 which indicates the device has complete Service Request Interface capability.

### 8-5. Service Request Interface Function Requirements and Tests.

a. The device under test must *not* drive the SRQ line low (true) when power is initially applied.

#### TEST:

1. Set the Bus System Analyzer to the TALK/HALT/MEMORY-OFF mode and connect it to the HP-IB connector of the device being tested.
  2. Set all lower switches of the Analyzer to the "0" position and apply power to the device under test. The device must not drive the SRQ line low as indicated by the Analyzer SRQ indicator being unlit.
- b. If the device under test is not actively responding to a serial poll and does not require service, it must not drive the SRQ line low (true).

#### TEST:

1. Observe that the Analyzer SRQ indicator is not lit.
- c. If the device under test does not require service it must indicate this by driving the DIO7 line high (false) when it is actively responding to a serial poll.

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY-OFF. Set the lower switch register to the Serial Poll Enable command (octal code ATN 030) and momentarily press the EXECUTE button.
  2. Set the lower switch register to the talk address of the device under test, set the ATN switch to "1", and momentarily press the EXECUTE button.
  3. Switch the Analyzer to LISTEN/HALT. The device should now be actively responding to the serial poll. The Analyzer digital readout should display octal code "0XX" or "2XX". (The "X" indicates the digit displayed is dependent upon the device being tested.)
- d. If the device under test is not actively responding to a serial poll and requires service, it must drive the SRQ line low (true).

**TEST:**

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the Serial Poll Disable command (octal code ATN 031) and momentarily press the EXECUTE button.
2. Cause the device under test to request service (drive the SRQ line low). The Analyzer SRQ indicator must light.

**NOTE**

*There is no particular method of causing a device to request service. Refer to the Operating and Service Manual of the device being tested to determine a means of causing the device to request service.*

3. Set the lower switch register to the Serial Poll Enable command (octal code ATN 030) and momentarily press the EXECUTE button. Reset the lower switch register to the talk address of the device under test and again momentarily press the EXECUTE button. The device should now be addressed to talk in the serial poll mode. The Analyzer SRQ indicator must remain lit.
  4. Switch the Analyzer to LISTEN/HALT. The device under test must stop driving the SRQ line low (SRQ indicator unlit), and drive the DIO7 line low (true) indicating it did request service. The Analyzer digital readout should display octal code “1XX” or “3XX”. (The “X” indicates the digit displayed is dependent upon the device being tested.) Press the EXECUTE button to accept one byte of information.
- e. The device under test must continue driving the SRQ line low (true) after receiving the IFC message if it requires service.

**TEST:**

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the Serial Poll Disable command (octal code ATN 031) and momentarily press the EXECUTE button.
2. Cause the device to request service (drive the SRQ line low). The Analyzer SRQ indicator must light.
3. Momentarily switch the Analyzer SRQ/IFC switch to IFC. The device under test must continue driving the SRQ line low (true). The Analyzer SRQ indicator must remain lit.

**PARALLEL POLL INTERFACE FUNCTION****9-1. DESCRIPTION.**

9-2. The Parallel Poll Interface Function provides a device with the capability to output one bit of status information to the controller in charge without being previously addressed to talk.

9-3. The signal lines, DIO1 through DIO8, are used to convey the device status bits during the Parallel Poll. This allows the status of up to eight devices to be checked simultaneously. Any number of devices can be checked by sharing of the DIO lines.

9-4. The use of the Parallel Poll facility within a system requires that the controller must periodically conduct a Parallel Poll.

9-5. The Parallel Poll differs from the Serial Poll in that a device can request service only when polled, in a Parallel Poll configuration. Each device is assigned an individual DIO line on which to respond to the Parallel Poll, allowing the controller to identify the device or devices requiring service immediately.

#### 9-6. Parallel Poll Interface Function Codes.

9-7. The basic code used to identify the Parallel Poll Interface Function is “PP”. The codes used to denote the Parallel Poll Interface Function capability of a particular device are PPO, which indicates the device has no Parallel Poll Interface capability, and PP1 or PP2 which specify particular Parallel Poll Interface capabilities.

#### 9-8. Parallel Poll Interface Function Requirements and Tests.

a. The device under test must *not* “come on” in the Parallel Poll mode when power is first applied. *This test applies to devices classified PP1 or PP2.*

#### NOTE

*Devices classified PP2 must not be in the “local poll enable” (lpe) mode for this test.*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF and connect it to the HP—IB connector of the device under test. Set all switches in the lower switch register to “0”.
2. Apply power to the device under test. The device must not drive any of the DIO lines low (true). The Analyzer readout must display octal code “000”.
3. Set the Analyzer EOI and ATN switches to the “1” position. The device under test must not drive any of the DIO lines low (true). The digital readout must display “000”.

b. The device under test, after being addressed to listen and having received both the Parallel Poll Configure command (PPC) and the Parallel Poll Enable command (PPE), must respond to a Parallel Poll on the DIO line assigned and in the “sense” indicated by the Parallel Poll Enable code when it receives both ATN and EOI low (true). The device must “stand by” for Parallel Poll after receiving the Parallel Poll Enable command and before EOI is set low. *This test applies to devices classified PP1 only.*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the listen address code of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.
2. Set the Analyzer lower switch register to the PPC command (octal code ATN 005) and momentarily press the EXECUTE button. The device under test should now be configured for Parallel Poll.
3. Reset the lower switch register to the Parallel Poll Enable command (octal code ATN 150) and momentarily press the EXECUTE button. The device should now be in standby for parallel poll.

## NOTE

*The Parallel Poll Enable code is an eight digit binary code in the form X, 1, 1, 0, S, P3, P2, P1 where "X" can take on the value of either "0" or "1", "S" determines the "sense" of the poll, and P3, P2, and P1 program which DIO line the device will respond on when active. Octal code 150 converted to binary would be X, 1, 1, 0, 1, 0, 0, 0. The "sense of the poll is "1" and the device would be programmed to respond to the poll on the DIO1 line.*

4. Set all switches in the lower switch register to "0". Switch the ATN and EOI switches to the "1" position. If the device requires service the Analyzer digital display should read "001". If the device does not require service the display should read "000", before and after the EOI switch is switched from the "0" position to the "1" position.
5. Return the EOI switch to the "0" position. The Analyzer digital display should read "000".
6. Set the Analyzer lower switch register to the Parallel Poll Enable command (octal code ATN 140) and momentarily press the EXECUTE button.
7. Set all DIO switches to the "0" position. Set the ATN and EOI switches to "1". If the device requires service, the digital display should read "000". If the device does not require service the display should read "001". Set the EOI switch to "0". The display must read "000".
8. Repeat Steps 3 through 7 for the Parallel Enable Codes and responses listed in Table 9-1.

Table 9-1. Bus Conditions for Parallel Poll.

PARALLEL POLL ENABLE CODES		PARALLEL POLL ACTIVE RESPONSE (octal code)		DEVICE RESPONDS ON LINE
"1" Sense	"0" Sense	Service Requested	Service Not Requested	
150	140	001	000	DIO1
		000	001	DIO1
151	141	002	000	DIO2
		000	002	DIO2
152	142	004	000	DIO3
		000	004	DIO3
153	143	010	000	DIO4
		000	010	DIO4
154	144	020	000	DIO5
		000	020	DIO5
155	145	040	000	DIO6
		000	040	DIO6
156	146	100	000	DIO7
		000	100	DIO7
157	147	200	000	DIO8
		000	200	DIO8

c. The device under test must respond to a Parallel Poll in less than 200 nanoseconds after receiving ATN and EOI low (true). The device must stop responding within 200 nanoseconds after ATN or EOI go high (false). *This test applies to devices classified PPI only.*

## TEST:

1. Connect the 59405-66503 Test Card to the Bus cable at the device under test.
2. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the listen address of the device under test and momentarily press the EXECUTE button.
3. Set the lower switch register to the Parallel Poll Configure command (octal code ATN 005) and momentarily press the EXECUTE button.
4. Set the lower switch register to the Parallel Poll Configure command (octal code ATN 005) and momentarily press the EXECUTE button.
5. Set the lower switch register to the Unlisten command (octal code ATN 077) and momentarily press the EXECUTE button.
6. Clear the Analyzer memory and load the following program into memory:

**Table 9-2. Parallel Poll Test Pattern.**

Memory Location Number	Memory Contents (octal code)
00	EOI ATN 000
01	000
02	EOI ATN 000
03	000
28	EOI ATN 000
29	000
30	EOI ATN 000
31	000

7. Switch the Analyzer memory OFF and set the Analyzer to TALK/FAST.
  8. Connect the Oscilloscope vertical inputs to the EOI and DIO1 test points on the Test Card. Trigger the Oscilloscope on the negative-going edge of the EOI signal. The DIO1 signal must go low (true) in less than 200 nanoseconds after the EOI signal goes low (true).
  9. Trigger the Oscilloscope on the positive-going edge of the EOI signal. The DIO1 signal must go high (false) in less than 200 nanoseconds after the EOI signal goes high (false).
- d. The device under test must *not* “stand by” for Parallel Poll after receiving the Parallel Poll Unconfigure command (PPU) or the Parallel Poll Disable command (PPD) if it has previously configured for parallel poll. *This test applies to devices classified PPI only.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set the lower switch register to the listen address of the device under test, set the ATN switch to “1”, and momentarily press the EXECUTE button.
2. Set the lower switch register to the Parallel Poll Configure command (octal code ATN 005) and momentarily press the EXECUTE button.
3. Set the lower switch register to the Parallel Poll Enable command (octal code ATN 140 if the device does not require service, octal code ATN 150 if the device requires service) and momentarily press the EXECUTE button.

4. Insure that the device will respond to the Parallel Poll by setting all DIO switches to "0" and setting the ATN and EOI switches to "1". The Analyzer digital display should read "001". Return the EOI switch to the "0" position.
  5. Set the Analyzer lower switch register to the Parallel Poll Unconfigure command (octal code ATN 025) and momentarily press the EXECUTE button.
  6. Set all Analyzer DIO switches to the "0" position and set the ATN and EOI switches to the "0" position and set the ATN and EOI switches to "1". The device must not respond to the Parallel Poll. The Analyzer digital display must read "000".
  7. Repeat Steps 1 through 4 to put the device in the Parallel Poll mode.
  8. Set the Analyzer lower switch register to the Parallel Poll Disable command (octal code ATN 160) and momentarily press the EXECUTE button.
  9. Set all Analyzer DIO switches to the "0" position and set the ATN and EOI switches to "1". The device should not respond to the Parallel Poll. The Analyzer digital display must read "000".
- e. The device under test must remain in "standby" for Parallel Poll when it receives the Parallel Poll Disable command (PPD) if it is not addressed to listen. *This test applies to devices classified PPI only.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY-OFF. Set the lower switch register to the listen address of the device under test, set the ATN switch to "1", and momentarily press the EXECUTE button.
  2. Set the lower switch register to the Parallel Poll Configure command (octal code ATN 005) and momentarily press the EXECUTE button.
  3. Set the lower switch register to the Parallel Poll Enable command (octal code ATN 140 if the device does not require service, octal code ATN 150 if the device requires service) and momentarily press the EXECUTE button.
  4. Insure that the device will respond to the Parallel Poll by setting all DIO switches to "0" and setting the ATN and EOI switches to "1". The Analyzer digital display should read "001". Return the EOI switch to "0".
  5. Set the Analyzer lower switch register to the Unlisten command (octal code ATN 077) and momentarily press the EXECUTE button.
  6. Set the lower switch register to the PPD command (octal code ATN 160) and momentarily press the EXECUTE button.
  7. Set all DIO switches to "0" and switch the ATN and EOI switches to "1". The device must again respond to the Parallel Poll. The Analyzer digital display must read "001".
  8. Set the lower switch register to the Parallel Poll Unconfigure command (octal code ATN 025) and momentarily press the EXECUTE button. The device must not respond to the Parallel Poll when ATN and EOI are true.
- f. The device under test must *not* "stand by" for Parallel Poll when the Local Poll Enable message (lpe) is false. *This test applies to devices classified PP2 only.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF and connect it to the HP—IB connector of the device under test. Set all switches in the lower switch register to the “0” position.
2. Set the Local Poll Enable of the device under test to OFF and the “sense” to “1”.
3. Set the Analyzer ATN and EOI switches to the “1” position. The device must *not* drive any of the DIO lines low (true). The Analyzer digital display must read “000”.
4. Change the “sense” bit of the device under test to “0”. The device must *not* drive any of the DIO lines low (true). The Analyzer digital display must read “000”.

g. The device under test must “stand by” for Parallel Poll when the Local Poll Enable message (lpe) is true. *This test applies to devices classified PP2 only.*

## TEST:

1. Set the Analyzer to TALK/HALT/MEMORY—OFF. Set all switches in the lower switch register to the “0” position.
2. Set the Local Poll Enable of the device under test to ON and the “sense” switch to “1”. The device should now be in “standby” for Parallel Poll. Set the device to respond on the DIO1 line.
3. Set the Analyzer ATN and EOI switches to “1”. If the device requires service it must drive the DIO1 line low. The Analyzer digital readout should read “001”. If the device does not require service, set the “sense” switch of the device to “0”. The Analyzer digital display should read “001”.
4. Repeat Steps 2 and 3 to test DIO lines 2 through 8.

h. The device under test must respond to a Parallel Poll in less than 200 nanoseconds after both the ATN and EOI signals go low (true) if the Local Poll Enable message (lpe) is true. The device must stop responding in less than 200 nanoseconds after either the ATN or EOI signal goes high (false). *This test applies to devices classified PP2 only.*

## TEST:

1. Set the Local Poll Enable switch of the device under test to ON. Set the device to respond on the DIO1 line and set the “sense” switch to “0” or “1” so the device will drive the DIO1 line low (true) when it responds.



2. Set the Bus System Analyzer to TALK/HALT/MEMORY-ON and load the following program into memory:

**Table 9-3. Parallel Poll Test Pattern.**

Memory Location Number	Memory Contents (octal code)
00	EOI ATN 000
01	000
02	EOI ATN 000
03	000
28	EOI ATN 000
29	000
30	EOI ATN 000
31	000

3. Switch the memory OFF and set the Analyzer to TALK/FAST.
4. Connect the Oscilloscope vertical inputs to the EOI and DIO1 test points on the Analyzer rear panel. Trigger the Oscilloscope on the negative-going edge of the EOI signal. The DIO1 signal must go low (true) in less than 200 nanoseconds after EOI goes low (true).

#### NOTE

*If the DIO1 line is not being driven low, change the “sense” switch of the device under test.*

5. Trigger the Oscilloscope on the positive-going edge of the EOI signal. The DIO1 signal must go high (false) in less than 200 nanoseconds after EOI goes high (false).

## CONTROLLER INTERFACE FUNCTION

### 10-1. DESCRIPTION.

10-2. The Controller Interface Function provides a device with the capability to send device addresses, universal commands, and addressed commands to other devices over the Interface. It also provides the capability to conduct parallel polls to determine which devices require service. A Controller Interface Function can exercise its capabilities only when it is sending the ATN message over the Interface. Only one device can be an active controller at any given time even though more than one device on the Interface has the Controller Interface Function capability. Only one controller on the Interface is allowed to send the IFC and REN messages and take control of the Interface at any time. This device is called the System Controller.

### 10-3. Controller Interface Function Codes.

10-4. The basic code used to identify the Controller Interface Function is "C". The codes used to identify the Controller Interface Function capability of a particular device are "C0" which indicates the device has no Controller Interface capability; and "C1" through "C28" which specify various Controller Interface capabilities.

### 10-5. Controller Interface Function Requirements and Tests.

a. The device under test must become a System Controller and send the IFC message if the local Request System Control message (rsv) and the local Send Interface Clear message (sic) are true. The device must set IFC low (true) for more than 100 microseconds, and until the "sic" message is false. *This test applies to devices classified as both C1 and C2 only. (C1 capability is required for devices having C2 capability.)*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY-OFF. Connect the Oscilloscope vertical input to the Test Card IFC test point.
2. Activate the device as a System Controller and send the Interface Clear message. The device must drive IFC low for more than 100 microseconds.
3. Remove the Oscilloscope input and connect the Counter to the IFC test point. Send several IFC messages. The device must not send an IFC signal with a pulse width less than 100 microseconds.
4. The device must not send the IFC message if either the "rsv" or "sic" message is false.

b. The device under test must become a System Controller and send the Remote Enable message (REN) if the "rsv" message and the Send Remote Enable message (sre) are true. The device must not send REN true unless the "sre" message has been true for more than 100 microseconds. The device must hold REN true until the "sre" message becomes false. *This test applies to devices classified as both C1 and C3 only. (C1 capability is required for devices having C3 capability.)*

#### TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY-OFF/REN-OFF. Connect the Oscilloscope vertical input to the Test Card REN test point. The REN signal must be high (false).
2. Activate the device as a system controller (rsv true) and send the Remote Enable message (REN). The REN line must be driven low (true).
3. Program the device to send REN true and then false at its maximum rate. The positive portion of the REN signal must be greater than 100 microseconds in duration.

#### NOTE

*Devices classified as having C1, C2, and C3 Interface capability must be capable of performing the IFC and REN functions independently.*

c. The device under test must respond to the Service Request message (SRQ). *This test applies to devices classified C4 only.*

## TEST:

1. Set the Bus System Analyzer to LISTEN/HALT and momentarily switch the SRQ/IFC switch to IFC.
2. Activate the device under test as a controller.
3. Switch the Analyzer SRQ/IFC switch to SRQ. The device under test must respond to the Service Request message.

## NOTE

*The response to the Service Request message is dependent upon the particular device being tested. Refer to the Operating and Service Manual of the device being tested for its particular response to SRQ.*

*The device under test may have any or all of the preceding capabilities (C1 through C4) but may have only one of the following capabilities (C5 through C28).*

- d. The device under test must stop driving the ATN, EOI, and DIO lines low (true) within 100 microseconds after receiving the Interface Clear message (IFC) low if the device is *not* an active System Controller. *This test applies to devices classified C5 through C28.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF and set all switches in the lower switch register to the “0” position.
2. Adjust the Pulse Generator controls to obtain a square wave with a negative pulse width of 100 microseconds (5 kHz) and an amplitude of 0 to + 5 volts. Set the repetition rate to MANUAL and connect the Generator OUTPUT between the GND and IFC test points on the Analyzer rear panel.
3. Program the device under test to continuously send commands on the Bus. (Drive the ATN and DIO lines.)
4. Momentarily press the Generator MANUAL trigger button. The device under test must stop driving the ATN and EOI line low. The Analyzer ATN and EOI indicator must be unlit. The device under test must stop driving the ATN and DIO lines. The Analyzer ATN indicator must be unlit and the digital display must read “000”.
5. Program the device to drive the ATN and EOI lines. Momentarily press the Generator MANUAL trigger button. The device under test must stop driving the ATN and EOI lines low. The Analyzer ATN and EOI indicators must be unlit.

- e. The device under test must become the “Controller in Charge” when the ATN signal goes high (false) if the IFC message is false, if the device has been addressed to talk, and if it has received the “take control” command (TCT). The device under test must become the Controller in Charge when the IFC signal goes high (false) if the device is the “active” System Controller and is driving the IFC line low (true). *This test applies to devices classified C5, C7, C9, C11, C13, C15, C17, C19, C21, C23, C25, or C27 only.*

## TEST:

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF and momentarily switch the SRQ/IFC switch to IFC to stop all Bus traffic. (If the device is an active system controller, it must be set to stop transmitting on the Bus [“rsc” set false]).

2. Set the Analyzer lower switch register to the talk address of the device under test, set the ATN switch to "1", and momentarily press the EXECUTE button.
3. Reset the lower switch register to the TCT command (octal code ATN 011) and momentarily press the EXECUTE button.
4. Set the Analyzer to LISTEN/HALT. The device under test must now have control of the Bus and be capable of driving the ATN and DIO lines.

#### NOTE

*The following test applies to "System Controllers" only.*

5. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF. Set all switches in the lower switch register to the "0" position.
6. Activate the device under test as a system controller (set "rsc" true) and cause it to drive the IFC line low (true). The device must not drive the ATN, EOI, or DIO lines low while IFC is true.
7. Cause the device to stop driving the IFC line low. The device must take control of the Bus and be capable of driving the ATN, EOI, and DIO lines.

#### NOTE

*Only devices with Parallel Poll capability are required to drive the EOI line.*

f. The device under test must *not* drive the DAV, ATN, EOI, or DIO lines after it has "passed control" to another device on the Bus. *This test applies to devices classified C5 through C12 and C17 through C24 only.*

#### TEST:

1. Set the Bus System Analyzer to LISTEN/HALT/MEMORY—OFF and set all switches in the lower switch register to the "0" position.
2. Program the device under test to transmit a talk address, other than its own, on the Bus. Press the Analyzer EXECUTE button to accept the Bus information.
3. Program the device to send the TCT command (octal code ATN 011).
4. Press and hold the Analyzer EXECUTE button to accept the TCT command. The device must stop driving the ATN, DAV, EOI, and DIO lines. The Analyzer ATN, DAV, and EOI indicators must be unlit and digital display must read "000". Release the EXECUTE button.

g. The device under test must not lose control of the Bus when passing control to itself. *This test applies to devices classified C5 through C8 and C17 through C20 only.*

#### TEST:

1. Set the Bus System Analyzer to LISTEN/HALT/MEMORY—OFF.
2. Program the device under test to send its own talk address on the Bus.
3. Momentarily press the Analyzer EXECUTE button to accept the character.
4. Program the device to send the TCT command (octal code ATN 011) on the Bus. The Analyzer ATN indicator must be lit.

5. Press and hold the EXECUTE button to accept the TCT command. The ATN indicator must remain lit, indicating the device still has control of the Bus. Release the EXECUTE button.
- h. The device under test must be capable of sending device addresses, addressed commands, secondary commands, and universal commands. *This test applies to devices classified C5 through C28.*

## TEST:

1. Set the Bus System Analyzer to LISTEN/HALT/MEMORY—OFF.
2. Program the device under test to transmit the address codes listed in Table 10-1 on the Bus.
3. Accept each byte from the Bus by pressing the Analyzer EXECUTE button. The device must put the next byte of information on the Bus and set DAV low when the EXECUTE button is released. The Analyzer digital readout must display the octal code and ASCII character listed in Table 10-1 and the ATN indicator must be lit.

Table 10-1. Listen Address Codes.

Octal Code	ASCII Character	Octal Code	ASCII Character	Octal Code	ASCII Character
ATN 040	SP	ATN 053	+	ATN 066	6
ATN 041	!	ATN 054	'	ATN 067	7
ATN 042	"	ATN 055	—	ATN 070	8
ATN 043	≠	ATN 056	.	ATN 071	9
ATN 044	S	ATN 057	/	ATN 072	:
ATN 045	%	ATN 060	0	ATN 073	;
ATN 046	&	ATN 061	1	ATN 074	<
ATN 047	'	ATN 062	2	ATN 075	=
ATN 050	(	ATN 063	3	ATN 076	>
ATN 051	)	ATN 064	4		
ATN 052	*	ATN 065	5		

4. Program the device under test to transmit the talk address codes listed in Table 10-2. (Exclude the talk address of the device under test.)

Table 10-2. Talk Address Codes.

Octal Code	ASCII Character	Octal Code	ASCII Character	Octal Code	ASCII Character
ATN 100	@	ATN 113	K	ATN 126	V
ATN 101	A	ATN 114	L	ATN 127	W
ATN 102	B	ATN 115	M	ATN 130	X
ATN 103	C	ATN 116	N	ATN 131	Y
ATN 104	D	ATN 117	O	ATN 132	Z
ATN 105	E	ATN 120	P	ATN 133	[
ATN 106	F	ATN 121	Q	ATN 134	\
ATN 107	G	ATN 122	R	ATN 135	]
ATN 110	H	ATN 123	S	ATN 136	(
ATN 111	I	ATN 124	T		
ATN 112	J	ATN 125	U		

5. Accept each byte from the Bus by pressing the Analyzer EXECUTE button. The device must put the next byte of information on the Bus and set DAV low when the EXECUTE button is released. The Analyzer must display the octal codes and ASCII characters as listed in Table 10-2.
6. Program the device under test to transmit the “command codes listed in Table 10-3.

**Table 10-3. Command Codes.**

ADDRESSED COMMANDS			UNIVERSAL COMMANDS		
Command	Octal Code	ASCII Character	Command	Octal Code	ASCII Character
GTL go to local	ATN 001	SOH	LLO local lockout	ATN 021	DC1
SDC select device	ATN 004	EOT	DCL device clear	ATN 024	DC4
clear					
PPC parallel poll	ATN 005	ENQ	PPU parallel poll	ATN 025	NAK
configure			unconfigure		
GET group	ATN 010	BS	SPE serial poll enable	ATN 030	CAN
execute trigger					
TCT take control	ATN 011	HT	SPD serial poll disable	ATN 031	EM

UNADDRESS COMMANDS		
Command	Octal Code	ASCII Character
UNL unlisten	ATN 077	?
UNT untalk	ATN 137	—

7. Accept each byte of information from the Bus by pressing the Analyzer EXECUTE button. The device must put the next byte of information on the Bus and set DAV low when the EXECUTE button is released. The Analyzer must display the octal codes as listed in Table 10-3.
- i. If the device goes to “standby” (local “gts” message true) after transmitting address or command messages, it must set ATN high (false) after the last message has been sent. (Exclude the TCT command.) *This test applies to devices classified C5 through C24 only.*

**TEST:**

1. Set the Bus System Analyzer to LISTEN/FAST/MEMORY—OFF.
2. Program the device under test to transmit commands or addresses on the Bus. (Exclude the listen and talk addresses of the device and the TCT command.) The device under test must set ATN high and stop transmitting on the Bus after the last address or command is sent.
- j. The device under test must set ATN low (true) when the “take control asynchronously” message (tca) is true. *This test applies to devices classified C5 through C28.*

**TEST:**

1. Set the Bus System Analyzer to TALK/HALT/MEMORY—OFF.
2. Program the device under test to take control of the Bus. The device must drive ATN low (true) when it has control. The Analyzer ATN indicator must light.

k. The device under test must take control and set ATN low (true) only when the DAV, NDAC, and NRFD signals are low (true) and the “take control synchronously” message (tcs) is true. *This test applies to devices classified C5, C7, C9, C11, C13, C15, C17, C19, C21, C23, C25, and C27 only.*

TEST:

1. Set the Bus System Analyzer to LISTEN/HALT/MEMORY—OFF. Connect a clip lead between the NDAC and DAV test points on the Test Card.
  2. Program the device under test to take control synchronously. The device must *not* drive ATN low.
  3. Press the Analyzer EXECUTE button. The device must now drive the ATN line low. The Analyzer ATN indicator must light.
  4. Remove the clip lead from the NDAC and DAV test points.
1. The device under test must wait 2 microseconds (1.1 microseconds if a tri-state driver is used on the EOI line) after regaining control, before it can drive the DIO lines (if the device is not requesting parallel poll). *This test applies to devices classified C5 through C28.*

TEST:

1. Set the Bus System Analyzer to LISTEN/FAST/MEMORY—OFF/COMP—OFF.
2. Program the device under test to repeatedly send commands or addresses on the Bus, go to “standby”, and regain control.
3. Connect the Oscilloscope vertical inputs to the Analyzer ATN test point and an active DIO test point (one which goes low when the device regains control and outputs commands or addresses). The device must *not* drive the DIO line low for at least 2 microseconds (1.1 microseconds if a tri-state driver is used on the EOI line) after setting ATN low.

NOTE

*Because of the repetition rate of the device under test, it may be necessary to use a counter to measure the time between the negative-going ATN and DIO signals.*

m. If the device under test regains control of the Bus for the purpose of conducting a parallel poll, it must not drive EOI low (true) for more than 500 nanoseconds after setting ATN low (true). The device must hold EOI low for at least 2 microseconds. The device must *not* drive the DIO lines for more than 1.5 microseconds (600 nanoseconds if the EOI line is driven by a tri-state driver) after setting EOI high (false). *This test applies to devices classified C5, C6, C9, C10, C13, C14, C17, C18, C21, C22, C25, and C26 only.*

TEST:

1. Set the Bus System Analyzer to LISTEN/FAST/MEMORY—OFF/COMP—OFF.
2. Program the device under test to repeatedly send commands or addresses on the Bus, go to “standby”, regain control of the Bus, and conduct a parallel poll.
3. Connect the Oscilloscope vertical inputs to the Analyzer ATN and EOI test points. EOI must not go low for more than 500 nanoseconds after ATN goes low and must remain low for at least 2 microseconds.

4. Remove the Oscilloscope input from the ATN test point and connect it to an active DIO test point. The DIO line must not go low for more than 1.5 microseconds (600 nanoseconds if the EOI line is driven by a tri-state driver) after EOI goes high.

**NOTE**

*Because of the repetition rate of the device under test, it may be necessary to use a counter to measure the time between the negative-going ATN and DIO signals.*





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de Aguiar 138

P-Lisbon

Tel: (19) 53 21 31/7

Telex: 16691 munter p

Cable: INTERCAMBIO Lisbon

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Nasser Trading & Contracting

P.O. Box 1563

**Doha**

Tel: 22170

Telex: 4439 NASSER

### ROMANIA

Hewlett-Packard Reprezentanta

Bd.n. Balcescu 16

**Bucuresti**

Tel: 15 80 23/13 88 85

Telex: 10440

### SAUDI ARABIA

Modern Electronic

Establishment (Head Office)

P.O. Box 1228, Baghdadiah Street

**Jeddah**

Tel: 27 798

Telex: 40035

Cable: ELECTA JEDDAH

Modern Electronic Establishment

(Branch)

P.O. Box 2728

**Riyadh**

Tel: 62596/66232

Telex: 202049

Modern Electronic Establishment  
(Branch)

P.O. Box 193

**Al-Khobar**

Tel: 44678-44813

Telex: 670136

Cable: ELECTA AL-KHOBAR

### SPAIN

Hewlett-Packard Española, S.A.

Calle Jerez 3

**E-Madrid** 16

Tel: (1) 458 26 00 (10 lines)

Telex: 23515 hpe

Hewlett-Packard Española S.A.

Colonia Mirasierra

Edificio Juban

c/o Costa Brava, 13

**Madrid** 34

Hewlett-Packard Española, S.A.

Milanesado 21-23

**E-Barcelona** 17

Tel: (3) 203 6200 (5 lines)

Telex: 52603 hpbe e

Hewlett-Packard Española, S.A.

Av Ramón y Cajal, 1

Edificio Sevilla, planta 9°

**E-Sevilla** 5

Tel: 64 44 54/58

Hewlett-Packard Española S.A.

Edificio Albia II 7° B

**E-Bilbao** 1

Tel: 23 83 06/23 82 06

Hewlett-Packard Española S.A.

C/Ramon Gordillo 1

(Entlo.)

**E-Valencia** 10

Tel: 96-361.13.54/361.13.58

### SWEDEN

Hewlett-Packard Sverige AB

Enighetsvägen 3, Fack

S-161 **Bromma** 20

Tel: (08) 730 05 50

Telex: 10721

Cable: MEASUREMENTS

Stockholm

Hewlett-Packard Sverige AB

Frötällsgatan 30

S-421 32 **Västra Frölunda**

Tel: (031) 49 09 50

Telex: 10721 via Bromma office

### SWITZERLAND

Hewlett-Packard (Schweiz) AG

Zürcherstrasse 20

P.O. Box 307

CH-8952 **Schlieren-Zürich**

Tel: (01) 7305240

Telex: 53933 hpag ch

Cable: HPAG CH

Hewlett-Packard (Schweiz) AG

Château Bloc 19

CH-1219 **Le Lignon-Geneva**

Tel: (022) 96 03 22

Telex: 27333 hpag ch

Cable: HEWPACAG Geneva

### SYRIA

General Electronic Inc.

Nuri Basha-Ahnaf Ebn Kays Street

P.O. Box 5781

**Damascus**

Tel: 33 24 87

Telex: 11215 ITIKAL

Cable: ELECTROBOR DAMASCUS

Medical only  
Sawah & Co.  
Place Azmé  
B.P. 2308  
**Damascus**  
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Telex: 11304 SATACO SY  
Cable: SAWAH, DAMASCUS

Suleiman Hilal El Mlawi  
P.O. Box 2528  
Mamoun Bitar Street, 56-58  
**Damascus**  
Tel: 11 46 63  
Telex: 11270  
Cable: HILAL DAMASCUS

**TUNISIA**  
Tunisie Electronique  
31 Avenue de la Liberte  
**Tunis**  
Tel: 280 144

Corema  
1 ter. Av. de Carthage  
**Tunis**  
Tel: 253 821  
Telex: 12319 CABAM TN

**TURKEY**  
TEKNIM Company Ltd.  
Riza Sah Pehlevi  
Caddesi No. 7  
Kavaklıdere, **Ankara**  
Tel: 275800  
Telex: 42155

Teknim Com., Ltd.  
Barbaros Bulvari 55/12  
Besikyas, **Istanbul**  
Tel: 613 546  
Telex: 23540

E.M.A.  
Muhendislik Kollektif Sirketi  
Mediha Eldem Sokak 41/6  
Yüksel Caddesi  
**Ankara**  
Tel: 17 56 22  
Cable: EMATRADE/Ankara

Yilmaz Ozyurek  
Milli Mudafaa Cad 16/6  
Kizilay  
**Ankara**  
Tel: 25 03 09 - 17 80 26  
Telex: 42576 OZEK TR  
Cable: OZYUREK ANKARA

**UNITED ARAB EMIRATES**  
Emilac Ltd. (Head Office)  
P.O. Box 1641

**Sharjah**  
Tel: 354121/3  
Telex: 8136

Emilac Ltd. (Branch Office)  
P.O. Box 2711

**Abu Dhabi**  
Tel: 331370/1

**UNITED KINGDOM**  
Hewlett-Packard Ltd.  
King Street Lane

**Winnersh**, Wokingham  
Berkshire RG11 5AR  
GB-England

Tel: (0734) 784774  
Telex: 84 71 78/9

Hewlett-Packard Ltd.  
Fourier House,  
257-263 High Street  
London Colney

**St. Albans**, Herts  
GB-England  
Tel: (0727) 24400  
Telex: 1-8952716

Hewlett-Packard Ltd.  
Trafalgar House  
Navigation Road  
**Altrincham**  
Cheshire WA14 1NU  
GB-England  
Tel: (061) 928 6422  
Telex: 668068

Hewlett-Packard Ltd.  
Lygon Court  
Hereward Rise  
Dudley Road

**Halesowen**,  
West Midlands, B62 8SD  
GB-England  
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Telex: 339105

Hewlett-Packard Ltd.  
Wedge House  
799, London Road  
**Thornton Heath**  
Surrey, CR4 6XL  
GB-England

Tel: (01) 684-0103/8  
Telex: 946825

Hewlett-Packard Ltd.  
14 Wesley St  
**Castleford**  
Yorks WF10 1AE

Tel: (0977) 550016  
TWX: 5557335

Hewlett-Packard Ltd.  
Tradax House  
St. Mary's Walk

**Maidenhead**  
Berkshire, SL6 1ST  
GB-England

Hewlett-Packard Ltd.  
Morley Road  
**Staplehill**  
Bristol, BS16 4QT  
GB-England

Hewlett-Packard Ltd.  
Kestrel House  
Clanwilliam Place

Lower Mount Street  
**Dublin** 2, Eire  
Hewlett-Packard Ltd.  
2C Avonberg Ind. Est.

Long Mile Road  
**Dublin** 12  
Tel: 514322/514224  
Telex: 30439

**USSR**  
Hewlett-Packard  
Representative Office

USSR  
Pokrovsky Boulevard 4/17-kw 12  
**Moscow** 101000

Tel: 294.20.24  
Telex: 7825 hewpak su

**YUGOSLAVIA**  
Iskra Commerce, n.sol.o.  
Zastopstvo Hewlett-Packard

Obilicev Venac 26  
YU 11000 **Beograd**  
Tel: 636-955  
Telex



## SALES OFFICES (cont.)

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Hewlett-Packard Ges.m.b.H.  
Handelskai 52  
P.O. Box 7  
A-1205 **Vienna**, Austria  
Tel: (0222) 35 16 21 to 27  
Cable: HEWPAK Vienna  
Telex: 75923 hewpak a

#### MEDITERRANEAN AND MIDDLE EAST COUNTRIES NOT SHOWN, PLEASE CONTACT:

Hewlett-Packard S.A.  
Mediterranean and Middle East  
Operations  
35, Kolokotroni Street  
Platia Kefallariou  
GR-Kifissia-**Athens**, Greece  
Tel: 8080359/429  
Telex: 21-6588  
Cable: HEWPAKSA Athens

#### FOR OTHER AREAS NOT LISTED, CONTACT:

Hewlett-Packard S.A.  
7, rue du Bois-du-Lan  
P.O. Box  
CH-1217 Meyrin 2 - **Geneva**  
Switzerland  
Tel: (022) 82 70 00  
Cable: HEWPAKSA Geneva  
Telex: 2 24 86

### UNITED STATES

#### ALABAMA

P.O. Box 4207  
8290 Whitesburg Dr.  
**Huntsville** 35802  
Tel: (205) 881-4592

8933 E. Roebuck Blvd.  
**Birmingham** 35206  
Tel: (205) 836-2203/2

#### ARIZONA

2336 E. Magnolia St.  
**Phoenix** 85034  
Tel: (602) 244-1361

2424 East Aragon Rd.  
**Tucson** 85706  
Tel: (602) 889-4661

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Medical Service Only  
P.O. Box 5646  
Brady Station  
**Little Rock** 72215  
Tel: (501) 376-1844

#### CALIFORNIA

1579 W. Shaw Ave.  
**Fresno** 93771  
Tel: (209) 224-0582  
1430 East Orangethorpe Ave.  
**Fullerton** 92631  
Tel: (714) 870-1000

3939 Lankershim Boulevard  
**North Hollywood** 91604  
Tel: (213) 877-1282  
TWX: 910-499-2671

5400 West Rosecrans Blvd.  
P.O. Box 92105  
World Way Postal Center  
**Los Angeles** 90009  
Tel: (213) 776-7500  
TWX: 910-325-6608

\***Los Angeles**  
Tel: (213) 776-7500  
3200 Hillview Av  
**Palo Alto**, CA 94304  
Tel: (408) 988-7000

3003 Scott Boulevard  
**Santa Clara** 95050  
Tel: (408) 988-7000  
TWX: 910-338-0518

\***Ridgecrest**  
Tel: (714) 446-6165

646 W. North Market Blvd.  
**Sacramento** 95834  
Tel: (916) 929-7222

9606 Aero Drive  
P.O. Box 23333  
**San Diego** 92123  
Tel: (714) 279-3200

\***Tarzana**

TEL: (213) 705-3344  
**COLORADO**  
5600 DTC Parkway  
**Englewood** 80110  
Tel: (303) 771-3455

#### CONNECTICUT

47 Barnes Industrial Road  
Barnes Park South  
**Wallingford** 06492  
Tel: (203) 265-7801

#### FLORIDA

P.O. Box 24210  
2727 N.W. 62nd Street  
**Ft. Lauderdale** 33309  
Tel: (305) 973-2600

4080 Woodcock Drive #132  
Brownell Building  
**Jacksonville** 32207  
Tel: (904) 398-0863

P.O. Box 13910  
6177 Lake Ellenor Dr.  
**Orlando** 32809  
Tel: (305) 859-2900

P.O. Box 12826  
Suite 5, Bldg. 1  
Office Park North  
**Pensacola** 32575  
Tel: (904) 476-8422

Computer Systems Only  
110 South Hoover Blvd.  
Suite 120

**Tampa** 33609  
Tel: (813) 872-0900

#### GEORGIA

P.O. Box 105005  
450 Interstate North Parkway  
**Atlanta** 30348  
Tel: (404) 955-1500  
TWX: 810-766-4890

Medical Service Only  
\***Augusta** 30903  
Tel: (404) 736-0592

P.O. Box 2103  
1172 N. Davis Drive  
**Warner Robins** 31098  
Tel: (912) 922-0449

#### HAWAII

2875 So. King Street  
**Honolulu** 96826  
Tel: (808) 955-4455

#### ILLINOIS

5201 Tollview Dr.  
**Rolling Meadows**  
60008  
Tel: (312) 255-9800  
TWX: 910-687-2260

#### INDIANA

7301 North Shadeland Ave.  
**Indianapolis** 46250  
Tel: (317) 842-1000  
TWX: 810-260-1797

#### IOWA

2415 Heinz Road  
**Iowa City** 52240  
Tel: (319) 351-1020

#### KENTUCKY

10170 Linn Station Road  
Suite 525  
**Louisville** 40223  
Tel: (502) 426-0100

#### LOUISIANA

P.O. Box 1449  
3229-39 Williams Boulevard  
**Kenner** 70063  
Tel: (504) 443-6201

#### MARYLAND

7121 Standard Drive  
Parkway Industrial Center  
**Hanover** 21076  
Tel: (301) 948-6370  
TWX: 710-862-1943

2 Choke Cherry Road  
**Rockville** 20850  
Tel: (301) 948-6370

TWX: 710-828-9684  
**MASSACHUSETTS**  
32 Hartwell Ave.

**Lexington** 02173  
Tel: (617) 861-8960  
TWX: 710-326-6904

#### MICHIGAN

23855 Research Drive  
**Farmington Hills** 48024  
Tel: (313) 476-6400  
724 West Centre Ave.

**Kalamazoo** 49002  
Tel: (616) 323-8362

#### MINNESOTA

2400 N. Prior Ave.  
**St. Paul** 55113  
Tel: (612) 636-0700

#### MISSISSIPPI

322 N. Mart Plaza  
**Jackson** 39206  
Tel: (601) 982-9363

#### MISSOURI

11131 Colorado Ave.  
**Kansas City** 64137  
Tel: (816) 763-8000  
TWX: 910-771-2087

1024 Executive Parkway  
**St. Louis** 63141  
Tel: (314) 878-0200

#### NEBRASKA

Medical Only  
7101 Mercy Road  
Suite 101  
**Omaha** 68106  
Tel: (402) 392-0948

#### NEVADA

\***Las Vegas**  
Tel: (702) 736-6610

#### NEW JERSEY

W. 120 Century Rd.  
**Paramus** 07652  
Tel: (201) 265-5000  
TWX: 710-990-4951

Crystal Brook Professional Building  
Route 35  
**Eatontown** 07724  
Tel: (201) 542-1384

#### NEW MEXICO

P.O. Box 11634  
Station E  
11300 Lomas Blvd., N.E.  
**Albuquerque** 87123  
Tel: (505) 292-1330  
TWX: 910-989-1185

156 Wyatt Drive  
**Las Cruces** 88001  
Tel: (505) 526-2484  
TWX: 910-9983-0550

#### NEW YORK

6 Automation Lane  
Computer Park  
**Albany** 12205  
Tel: (518) 458-1550  
TWX: 710-444-4961  
650 Perinton Hill Office Park  
**Fairport** 14450  
Tel: (716) 223-9950  
TWX: 510-253-0092

No. 1 Pennsylvania Plaza  
55th Floor  
34th Street & 8th Avenue  
**New York** 10001  
Tel: (212) 971-0800

5858 East Molloy Road  
**Syracuse** 13211  
Tel: (315) 455-2486

1 Crossways Park West  
**Woodbury** 11797  
Tel: (516) 921-0300  
TWX: 510-221-2183  
Tel: (513) 671-7400

#### NORTH CAROLINA

5605 Roanne Way  
**Greensboro** 27405  
Tel: (919) 852-1800

#### OHIO

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1313 E. Kemper Rd.  
**Cincinnati** 45426  
16500 Sprague Road  
**Cleveland** 44130

Tel: (216) 243-7300  
TWX: 810-423-9430  
330 Progress Rd.  
**Dayton** 45449  
Tel: (513) 859-8202

1041 Kingsmill Parkway  
**Columbus** 43229  
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6301 N. Meridan Avenue  
**Oklahoma City** 73112  
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9920 E. 42nd Street  
Suite 121  
**Tulsa** 74145  
Tel: (918) 665-3300

#### OREGON

17890 S.W. Lower Boones Ferry  
Road  
**Tualatin** 97062  
Tel: (503) 620-3350

#### PENNSYLVANIA

111 Zeta Drive  
**Pittsburgh** 15238  
Tel: (412) 782-0400

1021 8th Avenue  
King of Prussia Industrial Park  
**King of Prussia** 19406  
Tel: (215) 265-7000  
TWX: 510-660-2670

#### PUERTO RICO

Hewlett-Packard Inter-Americas  
Puerto Rico Branch Office  
Calle 272,  
Edif. 203 Urg. Country Club  
**Carolina** 00924  
Tel: (809) 762-7255  
Telex: 345 0514

#### SOUTH CAROLINA

P.O. Box 6442  
6941-O N. Trenholm Road  
**Columbia** 29260  
Tel: (803) 782-6493

#### TENNESSEE

8914 Kingston Pike  
**Knoxville** 37922  
Tel: (615) 523-0522  
3027 Vanguard Dr.  
Director's Plaza  
**Memphis** 38131  
Tel: (901) 346-8370

#### \*Nashville

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Tel: (615) 244-5448

#### TEXAS

4171 North Mesa  
Suite C110  
**El Paso** 79902  
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201 E. Arapaho Rd.  
**Richardson** 75080  
Tel: (214) 231-6101

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10535 Harwin Dr.  
**Houston** 77036  
Tel: (713) 776-6400

#### \*Lubbock

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**San Antonio** 78226  
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#### UTAH

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**Salt Lake City** 84119  
Tel: (801) 972-4711

#### VIRGINIA

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2914 Hungry Springs Road  
**Richmond** 23228  
Tel: (804) 285-3431

Computer Systems/Medical Only  
Airport Executive Center  
Suite 111  
5700 Thurston Avenue  
**Virginia Beach** 23455  
Tel: (804) 460-2471

#### WASHINGTON

Bellefield Office Pk.  
1203 - 114th Ave. S.E.  
**Bellevue** 98004  
Tel: (206) 454-3971  
TWX: 910-443-2446

P.O. Box 4010

**Spokane** 99202

Tel: (509) 535-0864

#### \*WEST VIRGINIA

Medical/Analytical Only  
4604 Mac Corkle Ave., S.E.  
**Charleston** 25304  
Tel: (304) 925-0492

## APPENDIX C

## CODE LIST OF MANUFACTURERS

The following code numbers are from the Federal Supply Code for Manufacturers Cataloging Handbooks H4-1 (Name to Code) and H4-2 (Code to Name) and their latest supplements. The date of revision and the date of the supplements used appear at the bottom of each page. Alphabetical codes have been arbitrarily assigned to suppliers not appearing in the H4 Handbooks.

Code No.	Manufacturer	Address	Code No.	Manufacturer	Address	Code No.	Manufacturer	Address
00000	U.S.A Common	Any supplier of U.S.	05347	Ultronix, Inc.	San Mateo, Cal.	11236	CTS of Berne, Inc.	Berne, Ind.
00136	McCoy Electronics	Mount Holly Springs, Pa.	05397	Union Carbide Corp., Elect.		11237	Chicago Telephone of	
00213	Sage Electronics Corp.	Rochester, N. Y.		Div.	New York, N. Y.		California, Inc.	So. Pasadena, Cal.
00287	Cemco, Inc.	Danielson, Conn.	05574	Viking Ind. Inc.	Canoga Park, Cal.	11242	Bay State Electronics Corp.	Waltham, Mass.
00334	Humidial	Colton, Calif.	05593	Icore Electro-Plastics Inc.	Sunnyvale, Cal.	11312	Teledyne Inc., Microwave	
00348	Mictrom, Co., Inc.	Valley Stream, N. Y.	05616	Cosmo Plastic (c/o Electrical			Div.	Palo Alto, Cal.
00373	Carlock Inc.	Cherry Hill, N. J.		Spec. Co.)	Cleveland, Ohio	11314	National Seal	Downey, Cal.
00656	Aerovox Corp.	New Bedford, Mass.	05624	Barber Colman Co.	Rockford, Ill.	11453	Precision Connector Corp.	Jamaica, N. Y.
00779	Amp. Inc.	Harrisburg, Pa.	05728	Tiffen Optical Co.		11534	Duncan Electronics Inc.	Costa Mesa, Cal.
00781	Aircraft Radio Corp.	Boonton, N. J.			Roslyn Heights, Long Island, N. Y.	11711	General Instrument Corp.,	
00809	Croven, Ltd.	Whitby, Ontario, Canada	05729	Metro-Tel Corp.	Westbury, N. Y.		Semiconductor Division Products	
00815	Northern Engineering		05783	Stewart Engineering Co.	Santa Cruz, Cal.		Group	Newark, N. J.
	Laboratories, Inc.	Burlington, Wis.	05820	Wakefield Engineering Inc.	Wakefield, Mass.	11717	Imperial Electronic, Inc.	Buena Park, Cal.
00853	Sangamo Electric Co.,		06004	Bassick Co., Div. of Stewart		11870	Melabs, Inc.	Palo Alto, Cal.
	Pickens Div.	Pickens, S. C.		Warner Corp.	Bridgeport, Conn.	12136	Philadelphia Handle Co.	Camden, N. J.
00866	Goe Engineering Co.	City of Industry, Cal.	06090	Raychem Corp.	Redwood City, Cal.	12361	Grove Mfg. Co., Inc.	Shady Grove, Pa.
00891	Carl E. Holmes Corp.	Los Angeles, Cal.	06175	Bausch and Lomb Optical		12574	Gulton Ind. Inc., Data System	
00929	Microlab Inc.	Livingston, N. J.		Co.	Rochester, N. Y.		Div.	Albuquerque, N. M.
01002	General Electric Co.,		06402	E. T. A. Products Co. of		12697	Clarostat Mfg. Co.	Dover, N. H.
	Capacitor Dept.	Hudson Falls, N. Y.		America	Chicago, Ill.	12728	Elmar Filter Corp.	W. Haven, Conn.
01009	Alden Products Co.	Brockton, Mass.	06540	Anatom Electronic Hardware		12859	Nippon Electric Co., Ltd.	Tokyo, Japan
01121	Allen Bradley Co.	Milwaukee, Wis.		Co., Inc.	New Rochelle, N. Y.	12881	Metex Electronics Corp.	Clark, N. J.
01255	Litton Industries, Inc.	Beverly Hills, Cal.	06555	Beede Electrical Instrument		12930	Delta Semiconductor Inc.	Newport Beach, Cal.
01281	TRW Semiconductors, Inc.	Lawndale, Cal.		Co., Inc.	Penacook, N. H.	12954	Dickson Electronics Corp.	Scottsdale, Arizona
01295	Texas Instruments, Inc.,		06666	General Devices Co., Inc.	Indianapolis, Ind.	13019	Airco Supply Co., Inc.	Wichita, Kansas
	Transistor Products Div.	Dallas, Texas	06751	Components Inc., Ariz. Div.	Phoenix, Arizona	13061	Wilco Products	Detroit, Mich.
01349	The Alliance Mfg. Co.	Alliance, Ohio	06812	Torrington Mfg. Co., West Div.	Van Nuys, Cal.	13103	Thermolloy	Dallas, Texas
01538	Small Parts Inc.	Los Angeles, Cal.	06980	Varian Assoc. Etmac Div.	San Carlos, Cal.	13327	Soliton Devices Inc.	Tappan, N. Y.
01589	Pacific Relays, Inc.	Van Nuys, Cal.	07088	Kelvin Electric Co.	Van Nuys, Cal.	13396	Telefunken (GmbH)	Hanover, Germany
01670	Gudebrod Bros. Silk Co.	New York, N. Y.	07126	Digitran Co.	Pasadena, Cal.	13835	Midland-Wright Div. of	
01930	Amerock Corp.	Rockford, Ill.	07137	Transistor Electronics			Pacific Industries, Inc.	Kansas City, Kansas
01960	Pulse Engineering Co.	Santa Clara, Cal.		Corp.	Minneapolis, Minn.	14099	Sem-Tech	Newbury Park, Cal.
02114	Ferroxcube Corp. of		07138	Westinghouse Electric		14193	Calif. Resistor Corp.	Santa Monica, Cal.
	America	Saugerties, N. Y.		Corp., Electronic Tube Div.	Elmira, N. Y.	14298	American Components, Inc.	Conshohocken, Pa.
02116	Wheelock Signals, Inc.	Long Branch, N. J.	07149	Filmohm Corp.	New York, N. Y.	14433	ITT Semiconductor, a Div. of	
02286	Cole Rubber and Plastics Inc.	Sunnyvale, Cal.	07233	Cinch-Graphik Co.	City of Industry, Cal.		Int. Telephone and Telegraph	
02660	Amphenol-Borg Electronics		07256	Silicon Transistor Corp.	Carle Place, N. Y.		Corporation	West Palm Beach, Fla.
	Corp.	Broadview, Ill.	07261	Avnet Corp.	Culver City, Cal.	14493	Hewlett-Packard Company	Loveland, Colo.
02735	Radio Corp. of America, Semi-		07263	Fairchild Camera & Inst. Corp.,		14655	Cornell Dublier Electric Corp.	Newark, N. J.
	conductor and Materials			Semiconductor Div.	Mountain View, Cal.	14674	Corning Glass Works	Corning, N. Y.
	Division	Somerville, N. J.	07322	Minnesota Rubber Co.	Minneapolis, Minn.	14752	Electro Cube Inc.	San Gabriel, Cal.
02771	Vocaline Co. of America,		07387	Birther Corp. The	Monterey Park, Cal.	14960	Williams Mfg. Co.	San Jose, Cal.
	Inc.	Old Saybrook, Conn.	07397	Sylvania Elect. Prod. Inc.,		15106	The Sphere Co., Inc.	Little Falls, N. J.
02777	Hopkins Engineering Co.	San Fernando, Cal.		Mt. View Operations	Mountain View, Cal.	15203	Webster Electronics Co.	New York, N. Y.
02875	Hudson Tool & Die	Newark, N. J.	07700	Technical Wire Products		15287	Scionics Corp.	Northridge, Cal.
03296	Nylon Molding Corp.	Springfield, N. J.		Inc.	Cranford, N. J.	15291	Adjustable Bushing Co.	N. Hollywood, Cal.
03508	G. E. Semiconductor Prod.		07829	Bodine Elect. Co.	Chicago, Ill.	15558	Micron Electronics	Garden City, Long Island, N. Y.
	Dept.	Syracuse, N. Y.	07910	Continental Device Corp.	Hawthorne, Cal.	15566	Amprobe Inst. Corp.	Lynbrook, N. Y.
03705	Apex Machine & Tool Co.	Dayton, Ohio	07933	Raytheon Mfg. Co., Semi-		15631	Cabletronics	Costa Mesa, Cal.
03797	Eldeema Corp.	Compton, Calif.		conductor Div.	Mountain View, Cal.	15772	Twentieth Century Coil	
03818	Parker Seal Co.	Los Angeles, Cal.	07980	Hewlett-Packard Co.			Spring Co.	Santa Clara, Cal.
03877	Transitron Electric Corp.	Wakefield, Mass.		New Jersey Division	Rockaway, N. J.	15801	Fenwal Elect. Inc.	Framingham, Mass.
03888	Pyrofilm Resistor Co.,		08145	U. S. Engineering Co.	Los Angeles, Cal.	15818	Amelco Inc.	Mountain View, Cal.
	Inc.	Cedar Knolls, N. J.	08289	Blinn, Delbert Co.	Pomona, Cal.	16037	Spruce Pine Mica Co.	Spruce Pine, N. C.
03954	Singer Co., Diehl Div.,		08358	Burgess Battery Co.		16179	Omni-Spectra Inc.	Detroit, Ill.
	Finderne Plant	Sumerville, N. J.			Niagara Falls, Ontario, Canada	16352	Computer Diode Corp.	Lodi, N. J.
04009	Arrow, Hart and Hegeman		08524	Deutsch Fastener Corp.	Los Angeles, Cal.	16554	Electroid Co.	Union, N. J.
	Elect. Co.	Hartford, Conn.	08664	Bristol Co., The	Waterbury, Conn.	16585	Boots Aircraft Nut Corp.	Pasadena, Cal.
04013	Tarus Corp.	Lambertville, N. J.	08717	Sloan Company	Sun Valley, Cal.	16688	Ideal Prec. Meter Co., Inc.	
04062	Arco Electronic Inc.	Great Neck, N. Y.	08718	ITT Cannon Electric Inc.,			De Jur Meter Div.	Brooklyn, N. Y.
04217	Essex Wire	Los Angeles, Cal.		Phoenix Div.	Phoenix, Arizona	16758	Delco Radio Div. of G. M. Corp.	Kokomo, Ind.
04222	Hi-Q Division of Aerovox	Myrtle Beach, S. C.	08727	National Radio Lab. Inc.	Paramus, N. J.	17109	Thermonetics Inc.	Canoga Park, Cal.
04354	Precision Paper Tube Co.	Wheeling, Ill.	08792	CBS Electronics Semiconductor		17474	Tranex Company	Mountain View, Cal.
04404	Palo Alto Division of Hewlett-			Operations, Div. of CBS Inc.	Lowell, Mass.	17675	Hamlin Metal Products Corp.	Akron, Ohio
	Packard Co.	Palo Alto, Cal.	08806	General Electric Co.,		17745	Angstrom Prec. Inc.	No. Hollywood, Cal.
04651	Sylvania Electric Products,			Miniature Lamp Dept.	Cleveland, Ohio	17856	Siliconix Inc.	Sunnyvale, Cal.
	Microwave Device Div.	Mountain View, Cal.	08984	Mel-Rain	Indianapolis, Ind.	17870	McGraw-Edison Co.	Manchester, N. H.
04673	Dakota Engr. Inc.	Culver City, Cal.	09026	Babcock Relays Div.	Costa Mesa, Cal.	18042	Power Design Pacific Inc.	Palo Alto, Cal.
04713	Motorola Inc. Semiconductor		09097	Electronic Enclosures Inc.	Los Angeles, Calif.	18083	Clevite Corp. Semiconductor Div.	Palo Alto, Cal.
	Prod. Div.	Phoenix, Arizona	09134	Texas Capacitor Co.	Houston, Texas	18324	Signetics Corp.	Sunnyvale, Cal.
04732	Filtron Co., Inc. Western		09145	Tech. Ind. Inc. Atohm		18476	Ty-Car Mfg. Co., Inc.	Holliston, Mass.
	Div.	Culver City, Cal.		Elect.	Burbank, Cal.	18486	TRW Elect. Comp. Div.	Des Plaines, Ill.
04773	Automatic Electric Co.	Northlake, Ill.	09250	Electro Assemblies, Inc.	Chicago, Ill.	18565	Chomerics	Plainville, Mass.
04796	Sequoia Wire Co.	Redwood City, Cal.	09353	C & K Components Inc.	Newton, Mass.	18583	Curtis Instrument, Inc.	Mt. Kisco, N. Y.
04811	Precision Coil Spring Co.	El Monte, Cal.	09569	Mallory Battery Co. of		18612	Vishay Instruments Inc.	Malvern, Pa.
04870	P. M. Motor Company	Westchester, Ill.		Canada, Ltd.	Toronto, Ontario, Canada	18873	E. I. DuPont and Co., Inc.	Wilmington, Del.
04919	Component Mfg. Service		09795	Pennsylvania Florocarbon	Clifton Heights, Penn.	18911	Durant Mfg. Co.	Milwaukee, Wis.
	Co.	W. Bridgewater, Mass.	09922	Burndy Corp.	Norwalk, Conn.	19315	The Bendix Corp., Navigation &	
05006	Twentieth Century Plastics,		10214	General Transistor Western			Control Div.	Teterboro, N. J.
	Inc.	Los Angeles, Cal.		Corp.	Los Angeles, Cal.	19500	Thomas A. Edison Industries	
05277	Westinghouse Electric Corp.		10411	Ti-Tal, Inc.	Berkeley, Cal.		Div. of McGraw-Edison	West Orange, N. J.
	Semiconductor Dept.	Youngwood, Pa.	10646	Carborundum Co.	Niagara Falls, N. Y.	19589	Concoa	Baldwin Park, Cal.

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## CODE LIST OF MANUFACTURERS (Continued)

Code No.	Manufacturer	Address	Code No.	Manufacturer	Address	Code No.	Manufacturer	Address
19644	LRC Electronics	Horseheads, N. Y.	71482	C. P. Clare & Co.	Chicago, Ill.	78452	Thompson-Bremer & Co.	Chicago, Ill.
19701	Electra Mfg. Co.	Independence, Kansas	71590	Centralab Div. of		78471	Tilley Mfg. Co.	San Francisco, Cal.
20183	General Atomics Corp.	Philadelphia, Pa.		Globe Union Inc.	Milwaukee, Wis.	78488	Stackpole Carbon Co.	St. Marys, Pa.
21226	Executone, Inc.	Long Island City, N. Y.	71616	Commercial Plastics Co.	Chicago, Ill.	78493	Standard Thomson Corp.	Waltham, Mass.
21355	Fafnir Bearing Co., The	New Britain, Conn.	71700	Cornish Wire Co., The	New York, N. Y.	78553	Tinnerman Products, Inc.	Cleveland, Ohio
21520	Fansteel Metallurgical Corp.	N. Chicago, Ill.	71707	Coto Coil Co., Inc.	Providence, R. I.	78790	Transformer Engineers	San Gabriel, Cal.
23020	General Reed Co.	Metuchen, N. J.	71744	Chicago Miniature Lamp Works	Chicago, Ill.	78947	Ucinite Co.	Newtonville, Mass.
23042	Texscan Corp.	Indianapolis, Ind.	71785	Cinch Mfg. Co.		79136	Waldes Kohinoor Inc.	Long Island City, N. Y.
23783	British Radio Electronics Ltd.	Washington, D.C.		Howard B. Jones Div.	Chicago, Ill.	79142	Veeder Root, Inc.	Hartford, Conn.
24455	G. E. Lamp Division, Nela Park	Cleveland, Ohio	71984	Dow Corning Corp.	Midland, Mich.	79251	Wenco Mfg. Co.	Chicago, Ill.
24655	General Radio Co.	West Concord, Mass.	72136	Electro Motive Mfg. Co., Inc.		79727	Continental-Wirt Electronics Corp.	
24681	Memcor Inc., Comp. Div.	Huntington, Ind.			Willimantic, Conn.			Philadelphia, Pa.
26365	Gries Reproducer Corp.	New Rochelle, N. Y.	72619	Dialight Corp.	Brooklyn, N. Y.	79963	Zierick Mfg. Corp.	New Rochelle, N. Y.
26462	Grobert File Co. of America, Inc.	Carlstadt, N. J.	72656	Indiana General Corp.		80031	Mepco Division of Sessions Clock Co.	
26851	Compac Hollister Co.	Hollister, Cal.		Electronics Div.	Keasby, N. J.			Morristown, N. J.
26992	Hamilton Watch Co.	Lancaster, Pa.	72699	General Instrument Corp.		80033	Prestole Corp.	Toledo, Ohio
28480	Hewlett-Packard Co.	Palo Alto, Cal.		Cap Division	Newark, N. J.	80120	Schnitzer Alloy Products Co.	Elizabeth, N. J.
28520	Heyman Mfg. Co.	Kenilworth, N. J.	72765	Drake Mfg. Co.	Harwood Heights, Ill.	80131	Electronic Industries Association.	
30817	Instrument Specialties Co., Inc.	Little Falls, N. J.	72825	Hugh H. Eby Inc.	Philadelphia, Pa.		Standard tube or semi-conductor device, any manufacturer.	
33173	G. E. Receiving Tube Dept.	Owensboro, Ky.	72928	Gudeman Co.	Chicago, Ill.	80207	Unimax Switch, Div. Maxon Electronics Corp.	Wallingford, Conn.
35434	Lectrohm Inc.	Chicago, Ill.	72962	Elastic Stop Nut Corp.	Union, N. J.	80223	United Transformer Corp.	New York, N. Y.
36196	Stanwyck Coil Products, Ltd.	Hawkesbury, Ontario, Canada	72964	Robert M. Hadley Co.	Los Angeles, Cal.	80248	Oxford Electric Corp.	Chicago, Ill.
			72982	Erie Technological Products, Inc.	Erie, Pa.	80294	Bourns Inc.	Riverside, Cal.
36287	Cunningham, W. H. & Hill, Ltd.	Toronto, Ontario, Canada	73061	Hansen Mfg. Co., Inc.	Princeton, Ind.	80411	Arco Div. of Robertshaw Controls Co.	
			73138	H. M. Harper Co.	Chicago, Ill.			Columbus, Ohio
37942	P. R. Mallory & Co., Inc.	Indianapolis, Ind.		Helipot Div. of Beckman Inst., Inc.		80486	All Star Products Inc.	Defiance, Ohio
39543	Mechanical Industries Prod. Co.	Akron, Ohio	73293	Hughes Products Division of		80509	Avery Label Co.	Monrovia, Cal.
40920	Miniature Precision Bearings, Inc.	Keene, N. H.		Hughes Aircraft Co.	Newport Beach, Cal.	80583	Hammalund Co., Inc.	Mars Hill, N. C.
40931	Honeywell Inc.	Minneapolis, Minn.	73445	Amperex Elect. Co.	Hicksville, L. I., N. Y.	80640	Stevens, Arnold, Co., Inc.	Boston, Mass.
42190	Muter Co.	Chicago, Ill.	73506	Bradley Semiconductor Corp.		80813	Dimco Gray Co.	Dayton, Ohio
43990	C. A. Norgren Co.	Englewood, Colo.			New Haven, Conn.	81030	International Inst. Inc.	Orange, Conn.
44655	Ohmite Mfg. Co.	Skokie, Ill.	73559	Carling Electric, Inc.	Hartford, Conn.	81073	Grayhill Co.	LaGrange, Ill.
46384	Penn Eng. & Mfg. Corp.	Doylestown, Pa.	73586	Circle F Mfg. Co.	Trenton, N. J.	81095	Triad Transformer Corp.	Venice, Cal.
47904	Polaroid Corp.	Cambridge, Mass.	73682	George K. Garrett Co.		81312	Winchester Elec. Div. Litton Ind., Inc.	
48620	Precision Thermometer & Inst. Co.	Southampton, Pa.		Div. MSL Industries, Inc.	Philadelphia, Pa.			Oakville, Conn.
49956	Microwave & Power Tube Div.	Waltham, Mass.	73734	Federal Screw Products, Inc.	Chicago, Ill.	81349	Military Specification	
52090	Rowan Controller Co.	Westminster, Md.	73743	Fischer Special Mfg. Co.	Cincinnati, Ohio	81483	International Rectifier Corp.	El Segundo, Cal.
52983	HP Co., Med. Elec. Div.	Waltham, Mass.	73793	General Industries Co., The	Elyria, Ohio	81541	Airpax Electronics, Inc.	Cambridge, Maryland
54294	Shallcross Mfg. Co.	Selma, N. C.	73846	Goshen Stamping & Tool Co.	Goshen, Ind.	81860	Barry Controls, Div. Barry Wright Corp.	
55026	Simpson Electric Co.	Chicago, Ill.	73899	JFD Electronics Corp.	Brooklyn, N. Y.			Watertown, Mass.
55933	Sonotone Corp.	Elmsford, N. Y.	73905	Jennings Radio Mfg. Corp.	San Jose, Cal.	82042	Carter Precision Electric Co.	Skokie, Ill.
55938	Raytheon Co. Commercial Apparatus & System Div.	So. Norwalk, Conn.	73957	Groove-Pin Corp.	Ridgefield, N. J.	82047	Sperli Faraday Inc., Copper Hewitt Electric Div.	Hoboken, N. J.
56137	Spaulding Fibre Co., Inc.	Tonawanda, N. Y.	74276	Signalite Inc.	Neptune, N. J.	82116	Electric Regulator Corp.	Norwalk, Conn.
56289	Sprague Electric Co.	North Adams, Mass.	74455	J. H. Winns, and Sons	Winchester, Mass.	82142	Jefferis Electronics Division of	
58474	Superior Elect. Co.	Bristol, Conn.	74861	Industrial Condenser Corp.	Chicago, Ill.		Speer Carbon Co.	Du Bois, Pa.
59446	Telex Corp.	Tulsa, Okla.	74868	R. F. Products Division of		82170	Fairchild Camera & Inst. Corp.	
59730	Thomas & Betts Co.	Elizabeth, N. J.		Amphenol-Borg Electronic Corp.			Space & Defense Systems Div.	Paramus, N. J.
60741	Triplett Electrical Inst. Co.	Bluffton, Ohio	74970	E. F. Johnson Co.	Waseca, Minn.	82209	Magurie Industries, Inc.	Greenwich, Conn.
61775	Union Switch and Signal Div. of		75042	International Resistance Co.	Philadelphia, Pa.	82219	Sylvania Electric Prod., Inc.	
	Westinghouse Air Brake Co.	Pittsburgh, Pa.	75263	Keystone Carbon Co., Inc.	St. Marys, Pa.		Electronic Tube Division	Emporium, Pa.
62119	Universal Electric Co.	Owosso, Mich.	75378	CTS Knights, Inc.	Sandwich, Ill.	82376	Astron Corp.	East Newark, Harrison, N. J.
63743	Ward-Leonard Electric Co.	Mt. Vernon, N. Y.	75382	Kulka Electric Corp.	Mt. Vernon, N. Y.	82389	Switchcraft, Inc.	Chicago, Ill.
64959	Western Electric Co., Inc.	New York, N. Y.	75818	Lenz Electric Mfg. Co.	Chicago, Ill.	82647	Metals & Controls Inc.	
65092	Weston Inst. Inc. Weston-Newark	Newark, N. J.	75915	Littlefuse, Inc.	Des Plaines, Ill.		Spencer Products	Attleboro, Mass.
66295	Wittek Mfg. Co.	Chicago, Ill.	76005	Lord Mfg. Co.	Erie, Pa.	82768	Phillips-Advance Control Co.	Joliet, Ill.
66346	Minnesota Mining & Mfg. Co.		76210	C. W. Marwedel	San Francisco, Cal.	82866	Research Products Corp.	Madison, Wis.
	Revere Mincom Div.	St. Paul, Minn.	76433	General Instrument Corp.		82877	Rolton Mfg. Co., Inc.	Woodstock, N. Y.
70276	Allen Mfg. Co.	Hartford, Conn.		Micamold Division	Newark, N. J.	82893	Vector Electronic Co.	Glendale, Cal.
70309	Allied Control	New York, N. Y.	76487	James Millen Mfg. Co., Inc.	Malden, Mass.	83058	Carr Fastener Co.	Cambridge, Mass.
70318	Allmetal Screw Product Co., Inc.		76493	J. W. Miller Co.	Los Angeles, Cal.	83086	New Hampshire Ball Bearing, Inc.	Peterborough, N. H.
		Garden City, N. Y.	76530	Cinch-Monadnock, Div. of United Carr Fastener Corp.	San Leandro, Cal.	83125	General Instrument Corp.	
70417	Amplex, Div. of Chrysler Corp.	Detroit, Mich.	76545	Mueller Electric Co.	Cleveland, Ohio		Capacitor Div.	Darlington, S. C.
70485	Atlantic India Rubber Works, Inc.	Chicago, Ill.	76703	National Union	Newark, N. J.	83148	ITT Wire and Cable Div.	Los Angeles, Cal.
70563	Amperite Co., Inc.	Union City, N. J.	76854	Oak Manufacturing Co.	Crystal Lake, Ill.	83186	Victory Eng. Corp.	Springfield, N. J.
70674	ADC Products Inc.	Minneapolis, Minn.	77068	The Bendix Corp.		83298	Bendix Corp., Red Bank Div.	Red Bank, N. J.
70903	Belden Mfg. Co.	Chicago, Ill.		Electrodynamics Div.	N. Hollywood, Cal.	83315	Hubbell Corp.	Mundelein, Ill.
70998	Bird Electric Corp.	Cleveland, Ohio	77075	Pacific Metals Co.	San Francisco, Cal.	83324	Rosan Inc.	Newport Beach, Cal.
71002	Birnback Radio Co.	New York, N. Y.	77221	Phaostran Instrument and		83330	Smith, Herman H., Inc.	Brooklyn, N. Y.
71034	Bliley Electric Co., Inc.	Erie, Pa.		Electronic Co.	So. Pasadena, Cal.	83332	Tech Labs	Palisades Park, N. J.
71041	Boston Gear Works Div. of		77252	Philadelphia Steel and		83385	Central Screw Co.	Chicago, Ill.
	Murray Co. of Texas	Quincey, Mass.		Wire Corp.	Philadelphia, Pa.	83501	Gavitt Wire and Cable Co., Div. of	
71218	Bud Radio, Inc.	Willoughby, Ohio	77342	American Machine & Foundry Co.			Amerace Corp.	Brookfield, Mass.
71279	Cambridge Thermionics Corp.	Cambridge, Mass.		Potter & Brumfield Div.	Princeton, Ind.	83594	Burroughs Corp., Electronic	
71286	Camloc Fastener Corp.	Paramus, N. J.	77630	TRW Electronic Components Div.	Camden, N. J.		Tube Div.	Plainfield, N. J.
71313	Cardwell Condenser Corp.		77638	General Instrument Corp.		83740	Union Carbide Corp., Consumer	
		Lindenhurst, L. I., N. Y.		Rectifier Division	Brooklyn, N. Y.		Prod. Div.	New York, N. Y.
71400	Bussmann Mfg. Div. of		77764	Resistance Products Co.	Harrisburg, Pa.	83777	Model Eng. and Mfg., Inc.	Huntington, Ind.
	McGraw-Edison Co.	St. Louis, Mo.	77969	Rubbercraft Corp. of Calif.	Torrance, Cal.	83821	Loyd Scruggs Co.	Festus, Mo.
71436	Chicago Condenser Corp.	Chicago, Ill.	78189	Shakeproof Division of		83942	Aeronautical Inst. & Radio Co.	Lodi, N. J.
71447	Calif. Spring Co., Inc.	Pico-Rivera, Cal.		Illinois Tool Works	Elgin, Ill.	84171	Arco Electronics Inc.	Great Neck, N. Y.
71450	CTS Corp.	Elkhart, Ind.	78277	Sigma	So. Braintree, Mass.	84396	A. J. Glesener Co., Inc.	San Francisco, Cal.
71468	ITT Cannon Electric Inc.	Los Angeles, Cal.	78283	Signal Indicator Corp.	New York, N. Y.	84411	TRW Capacitor Div.	Ogallala, Neb.
71471	Cinema, Div. Aerovox Corp.	Burbank, Cal.	78290	Struthers-Dunn Inc.	Pitman, N. J.			

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## APPENDIX C

## CODE LIST OF MANUFACTURERS

The following code numbers are from the Federal Supply Code for Manufacturers Cataloging Handbooks H4-1 (Name to Code) and H4-2 (Code to Name) and their latest supplements. The date of revision and the date of the supplements used appear at the bottom of each page. Alphabetical codes have been arbitrarily assigned to suppliers not appearing in the H4 Handbooks.

Code No.	Manufacturer	Address	Code No.	Manufacturer	Address	Code No.	Manufacturer	Address
00000	U.S.A Common	Any supplier of U.S.	05347	Ultronix, Inc.	San Mateo, Cal.	11236	CTS of Berne, Inc.	Berne, Ind.
00136	McCoy Electronics	Mount Holly Springs, Pa.	05397	Union Carbide Corp., Elect.		11237	Chicago Telephone of	
00213	Sage Electronics Corp.	Rochester, N. Y.		Div.	New York, N. Y.		California, Inc.	So. Pasadena, Cal.
00287	Cemco, Inc.	Danielson, Conn.	05574	Viking Ind. Inc.	Canoga Park, Cal.	11242	Bay State Electronics Corp.	Waltham, Mass.
00334	Humidial	Colton, Calif.	05593	Icore Electro-Plastics Inc.	Sunnyvale, Cal.	11312	Teledyne Inc., Microwave	
00348	Mictron, Co., Inc.	Valley Stream, N. Y.	05616	Cosmo Plastic (c/o Electrical			Div.	Palo Alto, Cal.
00373	Garlock Inc.	Cherry Hill, N. J.		Spec. Co.)	Cleveland, Ohio	11314	National Seal	Downey, Cal.
00656	Aerovox Corp.	New Bedford, Mass.	05624	Barber Colman Co.	Rockford, Ill.	11453	Precision Connector Corp.	Jamaica, N. Y.
00779	Amp. Inc.	Harrisburg, Pa.	05728	Tiffen Optical Co.		11534	Duncan Electronics Inc.	Costa Mesa, Cal.
00781	Aircraft Radio Corp.	Boonton, N. J.			Roslyn Heights, Long Island, N. Y.	11711	General Instrument Corp.,	
00809	Croven, Ltd.	Whitby, Ontario, Canada	05729	Metro-Tel Corp.	Westbury, N. Y.		Semiconductor Division Products	
00815	Northern Engineering		05783	Stewart Engineering Inc.	Santa Cruz, Cal.		Group	Newark, N. J.
	Laboratories, Inc.	Burlington, Wis.	05820	Wakefield Engineering Inc.	Wakefield, Mass.	11717	Imperial Electronic, Inc.	Buena Park, Cal.
00853	Sangamo Electric Co.,		06004	Bassick Co., Div. of Stewart		11870	Melabs, Inc.	Palo Alto, Cal.
	Pickens Div.	Pickens, S. C.		Warner Corp.	Bridgeport, Conn.	12136	Philadelphia Handle Co.	Camden, N. J.
00866	Goe Engineering Co.	City of Industry, Cal.	06090	Raychem Corp.	Redwood City, Cal.	12361	Grove Mfg. Co., Inc.	Shady Grove, Pa.
00891	Carl E. Holmes Corp.	Los Angeles, Cal.	06175	Bausch and Lomb Optical		12574	Gulton Ind. Inc., Data System	
00929	Microlab Inc.	Livingston, N. J.		Co.	Rochester, N. Y.		Div.	Albuquerque, N. M.
01002	General Electric Co.,		06402	E. T. A. Products Co. of		12697	Clarostat Mfg. Co.	Dover, N. H.
	Capacitor Dept.	Hudson Falls, N. Y.		America	Chicago, Ill.	12728	Elmar Filter Corp.	W. Haven, Conn.
01009	Alden Products Co.	Brockton, Mass.	06540	Amatom Electronic Hardware		12859	Nippon Electric Co., Ltd.	Tokyo, Japan
01121	Allen Bradley Co.	Milwaukee, Wis.		Co., Inc.	New Rochelle, N. Y.	12881	Metex Electronics Corp.	Santa Monica, Cal.
01255	Litton Industries, Inc.	Beverly Hills, Cal.	06555	Beede Electrical Instrument		12930	Delta Semiconductor Inc.	Newport Beach, Cal.
01281	TRW Semiconductors, Inc.	Lawndale, Cal.		Co., Inc.	Penacook, N. H.	12954	Dickson Electronics Corp.	Scottsdale, Arizona
01295	Texas Instruments, Inc.		06666	General Devices Co., Inc.	Indianapolis, Ind.	13019	Airco Supply Co., Inc.	Wichita, Kansas
	Transistor Products Div.	Dallas, Texas	06751	Components Inc., Ariz. Div.	Phoenix, Arizona	13061	Wilco Products	Detroit, Mich.
01349	The Alliance Mfg. Co.	Alliance, Ohio	06812	Torrington Mfg. Co., West Div.	Van Nuys, Cal.	13103	Thermolloy	Dallas, Texas
01538	Small Parts Inc.	Los Angeles, Cal.	06980	Varian Assoc. Etmac Div.	San Carlos, Cal.	13327	Soliton Devices Inc.	Tappan, N. Y.
01589	Pacific Relays, Inc.	Van Nuys, Cal.	07088	Kelvin Electric Co.	Van Nuys, Cal.	13396	Telefunken (GmbH)	Hanover, Germany
01670	Gudebrod Bros. Silk Co.	New York, N. Y.	07126	Digitran Co.	Pasadena, Cal.	13835	Midland-Wright Div. of	
01930	Amerock Corp.	Rockford, Ill.	07137	Transistor Electronics			Pacific Industries, Inc.	Kansas City, Kansas
01960	Pulse Engineering Co.	Santa Clara, Cal.		Corp.	Minneapolis, Minn.	14099	Sem-Tech	Newbury Park, Cal.
02114	Ferroxcube Corp. of		07138	Westinghouse Electric		14193	Calif. Resistor Corp.	Santa Monica, Cal.
	America	Saugerties, N. Y.		Corp., Electronic Tube Div.	Elmira, N. Y.	14298	American Components, Inc.	Conshohocken, Pa.
02116	Wheelock Signals, Inc.	Long Branch, N. J.	07149	Filmohm Corp.	New York, N. Y.	14433	ITT Semiconductor, a Div. of	
02286	Cole Rubber and Plastics Inc.	Sunnyvale, Cal.	07233	Cinch-Graphik Co.	City of Industry, Cal.		Int. Telephone and Telegraph	
02660	Amphenol-Borg Electronics		07256	Silicon Transistor Corp.	Carle Place, N. Y.		Corporation	West Palm Beach, Fla.
	Corp.	Broadview, Ill.	07261	Avnet Corp.	Culver City, Cal.	14493	Hewlett-Packard Company	Loveland, Colo.
02735	Radio Corp. of America, Semi-		07263	Fairchild Camera & Inst. Corp.,		14655	Cornell Dublier Electric Corp.	Newark, N. J.
	conductor and Materials			Semiconductor Div.	Mountain View, Cal.	14674	Corning Glass Works	Corning, N. Y.
	Division	Somerville, N. J.	07322	Minnesota Rubber Co.	Minneapolis, Minn.	14752	Electro Cube Inc.	San Gabriel, Cal.
02771	Vocaline Co. of America,		07387	Birtcher Corp., The	Monterey Park, Cal.	14960	Williams Mfg. Co.	San Jose, Cal.
	Inc.	Old Saybrook, Conn.	07397	Sylvania Elect. Prod. Inc.,		15106	The Sphere Co., Inc.	Little Falls, N. J.
02777	Hopkins Engineering Co.	San Fernando, Cal.		Mt. View Operations	Mountain View, Cal.	15203	Webster Electronics Co.	New York, N. Y.
02875	Hudson Tool & Die	Newark, N. J.	07700	Technical Wire Products		15287	Seionics Corp.	Northridge, Cal.
03296	Nylon Molding Corp.	Springfield, N. J.		Inc.	Cranford, N. J.	15291	Adjustable Bushing Co.	N. Hollywood, Cal.
03508	G. E. Semiconductor Prod.		07829	Bodine Elect. Co.	Chicago, Ill.	15558	Micron Electronics	Garden City, Long Island, N. Y.
	Dept.	Syracuse, N. Y.	07910	Continental Device Corp.	Hawthorne, Cal.	15566	Amprobe Inst. Corp.	Lynbrook, N. Y.
03705	Apex Machine & Tool Co.	Dayton, Ohio	07933	Raytheon Mfg. Co., Semi-		15631	Cabletronics	Costa Mesa, Cal.
03797	Eldema Corp.	Compton, Calif.		conductor Div.	Mountain View, Cal.	15772	Twentieth Century Coil	
03818	Parker Seal Co.	Los Angeles, Cal.	07980	Hewlett-Packard Co.			Spring Co.	Santa Clara, Cal.
03877	Transitron Electric Corp.	Wakefield, Mass.		New Jersey Division	Rockaway, N. J.	15801	Fenwal Elect. Inc.	Framingham, Mass.
03888	Pyrofilm Resistor Co.,		08145	U.S. Engineering Co.	Los Angeles, Cal.	15818	Amelco Inc.	Mountain View, Cal.
	Inc.	Cedar Knolls, N. J.	08289	Blinn, Delbert Co.	Pomona, Cal.	16037	Spruce Pine Mica Co.	Spruce Pine, N. C.
03954	Singer Co., Diehl Div.,		08358	Burgess Battery Co.		16179	Omni-Spectra Inc.	Detroit, Ill.
	Finderne Plant	Sumerville, N. J.			Niagara Falls, Ontario, Canada	16352	Computer Diode Corp.	Lodi, N. J.
04009	Arrow, Hart and Hegeman		08524	Deutsch Fastener Corp.	Los Angeles, Cal.	16554	Electroid Co.	Union, N. J.
	Elect. Co.	Hartford, Conn.	08664	Bristol Co., The	Waterbury, Conn.	16585	Boots Aircraft Nut Corp.	Pasadena, Cal.
04013	Taruus Corp.	Lambertville, N. J.	08717	Sloan Company	Sun Valley, Cal.	16688	Ideal Prec. Meter Co., Inc.	
04062	Arco Electronic Inc.	Great Neck, N. Y.	08718	ITT Cannon Electric Inc.,			De Jur Meter Div.	Brooklyn, N. Y.
04217	Essex Wire	Los Angeles, Cal.		Phoenix Div.	Phoenix, Arizona	16758	Delco Radio Div. of G. M. Corp.	Kokomo, Ind.
04222	Hi-Q Division of Aerovox	Myrtle Beach, S. C.	08727	National Radio Lab. Inc.	Paramus, N. J.	17109	Thermonetics Inc.	Canoga Park, Cal.
04354	Precision Paper Tube Co.	Wheeling, Ill.	08792	CBS Electronics Semiconductor		17474	Tranex Company	Mountain View, Cal.
04404	Palo Alto Division of Hewlett-			Operations, Div. of CBS Inc.	Lowell, Mass.	17675	Hamlin Metal Products Corp.	Akron, Ohio
	Packard Co.	Palo Alto, Cal.	08806	General Electric Co.,		17745	Angstrom Prec. Inc.	No. Hollywood, Cal.
04651	Sylvania Electric Products,			Miniature Lamp Dept.	Cleveland, Ohio	17856	Siliconix Inc.	Sunnyvale, Cal.
	Microwave Device Div.	Mountain View, Cal.	08984	Mel-Rain	Indianapolis, Ind.	17870	McGraw-Edison Co.	Manchester, N. H.
04673	Dakota Engr. Inc.	Culver City, Cal.	09026	Babcock Relays Div.	Costa Mesa, Cal.	18042	Power Design Pacific Inc.	Palo Alto, Cal.
04713	Motorola Inc. Semiconductor		09097	Electronic Enclosures Inc.	Los Angeles, Calif.	18083	Clevite Corp. Semiconductor Div.	Palo Alto, Cal.
	Prod. Div.	Phoenix, Arizona	09134	Texas Capacitor Co.	Houston, Texas	18324	Signetics Corp.	Sunnyvale, Cal.
04732	Filtron Co., Inc. Western		09145	Tech. Ind. Inc. Atohm		18476	Ty-Car Mfg. Co., Inc.	Holliston, Mass.
	Div.	Culver City, Cal.		Elect.	Burbank, Cal.	18486	TRW Elect. Comp. Div.	Des Plaines, Ill.
04773	Automatic Electric Co.	Northlake, Ill.	09250	Electro Assemblies, Inc.	Chicago, Ill.	18565	Chomerics	Plainville, Mass.
04796	Sequoia Wire Co.	Redwood City, Cal.	09353	C & K Components Inc.	Newton, Mass.	18583	Curtis Instrument, Inc.	Mt. Kisco, N. Y.
04811	Precision Coil Spring Co.	El Monte, Cal.	09569	Mallory Battery Co. of		18612	Vishay Instruments Inc.	Malvern, Pa.
04870	P. M. Motor Company	Westchester, Ill.		Canada, Ltd.	Toronto, Ontario, Canada	18873	E. I. DuPont and Co., Inc.	Wilmington, Del.
04919	Component Mfg. Service		09795	Pennsylvania Florocarbon	Clifton Heights, Penn.	18911	Durant Mfg. Co.	Milwaukee, Wis.
	Co.	W. Bridgewater, Mass.	09922	Burndy Corp.	Norwalk, Conn.	19315	The Bendix Corp., Navigation &	
05006	Twentieth Century Plastics,		10214	General Transistor Western			Control Div.	Teterboro, N. J.
	Inc.	Los Angeles, Cal.		Corp.	Los Angeles, Cal.	19500	Thomas A. Edison Industries	
05277	Westinghouse Electric Corp.		10411	Ti-Tal, Inc.	Berkeley, Cal.		Div. of McGraw-Edison	West Orange, N. J.
	Semiconductor Dept.	Youngwood, Pa.	10646	Carborundum Co.	Niagara Falls, N. Y.	19589	Concoa	Baldwin Park, Cal.

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## CODE LIST OF MANUFACTURERS (Continued)

Code No.	Manufacturer	Address	Code No.	Manufacturer	Address	Code No.	Manufacturer	Address
19644	LRC Electronics	Horseheads, N. Y.	71482	C. P. Clare & Co.	Chicago, Ill.	78452	Thompson-Bremer & Co.	Chicago, Ill.
19701	Electra Mfg. Co.	Independence, Kansas	71590	Centralab Div. of	Chicago, Ill.	78471	Tilley Mfg. Co.	San Francisco, Cal.
20183	General Atronic Corp.	Philadelphia, Pa.		Globe Union Inc.	Milwaukee, Wis.	78488	Stackpole Carbon Co.	St. Marys, Pa.
21226	Executone, Inc.	Long Island City, N. Y.	71616	Commercial Plastics Co.	Chicago, Ill.	78493	Standard Thomson Corp.	Waltham, Mass.
21355	Fafnir Bearing Co., The	New Britain, Conn.	71700	Cornish Wire Co., The	New York, N. Y.	78553	Tinnerman Products, Inc.	Cleveland, Ohio
21520	Fansteel Metallurgical Corp.	N. Chicago, Ill.	71707	Coto Coil Co., Inc.	Providence, R. I.	78790	Transformer Engineers	San Gabriel, Cal.
23020	General Reed Co.	Metuchen, N. J.	71744	Chicago Miniature Lamp Works	Chicago, Ill.	78947	Ucinite Co.	Newtonville, Mass.
23042	Texscan Corp.	Indianapolis, Ind.	71785	Cinch Mfg. Co.	Chicago, Ill.	79136	Waldes Kohinoor Inc.	Long Island City, N. Y.
23783	British Radio Electronics Ltd.	Washington, D.C.		Howard B. Jones Div.	Chicago, Ill.	79142	Veeder Root, Inc.	Hartford, Conn.
24455	G. E. Lamp Division, Nela Park	Cleveland, Ohio	71984	Dow Corning Corp.	Midland, Mich.	79251	Wenco Mfg. Co.	Chicago, Ill.
24655	General Radio Co.	West Concord, Mass.	72136	Electro Motive Mfg. Co., Inc.	Willimantic, Conn.	79727	Continental-Wirt Electronics Corp.	Philadelphia, Pa.
24681	Memcor Inc., Comp. Div.	Huntington, Ind.						
26365	Gries Reproducer Corp.	New Rochelle, N. Y.	72619	Dialight Corp.	Brooklyn, N. Y.	79963	Zierick Mfg. Corp.	New Rochelle, N. Y.
26462	Grobert File Co. of America, Inc.	Carlstadt, N. J.	72656	Indiana General Corp.	Keasby, N. J.	80031	Mepco Division of Sessions Clock Co.	Morristown, N. J.
26851	Compac Hollister Co.	Hollister, Cal.		Electronics Div.	Keasby, N. J.			
26992	Hamilton Watch Co.	Lancaster, Pa.	72699	General Instrument Corp.	Newark, N. J.	80033	Prestole Corp.	Toledo, Ohio
28480	Hewlett-Packard Co.	Palo Alto, Cal.		Cap Division	Newark, N. J.	80120	Schnitzer Alloy Products Co.	Elizabeth, N. J.
28520	Heyman Mfg. Co.	Kenilworth, N. J.	72765	Drake Mfg. Co.	Harwood Heights, Ill.	80131	Electronic Industries Association	Standard tube or semi-conductor device, any manufacturer.
30817	Instrument Specialties Co.	Little Falls, N. J.	72825	Hugh H. Eby Inc.	Philadelphia, Pa.	80207	Unimax Switch, Div. Maxon Electronics Corp.	Wallingford, Conn.
			72928	Gudeman Co.	Chicago, Ill.	80223	United Transformer Corp.	New York, N. Y.
33173	G. E. Receiving Tube Dept.	Owensboro, Ky.	72962	Elastic Stop Nut Corp.	Union, N. J.	80248	Oxford Electric Corp.	Chicago, Ill.
35434	Lectrohm Inc.	Chicago, Ill.	72964	Robert M. Hadley Co.	Los Angeles, Cal.	80294	Bourns Inc.	Riverside, Cal.
36196	Stanwyck Coil Products Ltd.	Hawkesbury, Ontario, Canada	72982	Erie Technological Products, Inc.	Erie, Pa.	80411	Arco Div. of Robertshaw Controls Co.	Columbus, Ohio
			73061	Hansen Mfg. Co., Inc.	Princeton, Ind.	80486	All Star Products Inc.	Monrovia, Cal.
36287	Cunningham, W. H. & Hill, Ltd.	Toronto, Ontario, Canada	73076	H. M. Harper Co.	Chicago, Ill.	80509	Avery Label Co.	Monrovia, Cal.
			73138	Heliprot Div. of Beckman Inst., Inc.	Fullerton, Cal.	80583	Hammarlund Co., Inc.	Mars Hill, N. C.
37942	P. R. Mallory & Co., Inc.	Indianapolis, Ind.	73293	Hughes Products Division of Hughes Aircraft Co.	Newport Beach, Cal.	80640	Stevens, Arnold, Co., Inc.	Boston, Mass.
39543	Mechanical Industries Prod. Co.	Akron, Ohio	73445	Amperex Elect. Co.	Hicksville, L. I., N. Y.	80813	Dimco Gray Co.	Dayton, Ohio
40920	Miniature Precision Bearings, Inc.	Keene, N. H.	73506	Bradley Semiconductor Corp.	New Haven, Conn.	81030	International Inst. Inc.	Orange, Conn.
40931	Honeywell Inc.	Minneapolis, Minn.				81073	Grayhill Co.	LaGrange, Ill.
42190	Muter Co.	Chicago, Ill.	73559	Carling Electric, Inc.	Hartford, Conn.	81095	Triad Transformer Corp.	Venice, Cal.
43990	C. A. Norgren Co.	Englewood, Colo.	73586	Circle F Mfg. Co.	Trenton, N. J.	81312	Winchester Elec. Div. Litton Ind., Inc.	Oakville, Conn.
44655	Ohmite Mfg. Co.	Skokie, Ill.	73734	George K. Garrett Co.	Philadelphia, Pa.			
46384	Penn Eng. & Mfg. Corp.	Doylestown, Pa.		Div. MSL Industries, Inc.	Philadelphia, Pa.	81349	Military Specification	El Segundo, Cal.
47904	Polaroid Corp.	Cambridge, Mass.	73743	Federal Screw Products, Inc.	Chicago, Ill.	81541	Airpax Electronics, Inc.	Cambridge, Maryland
48620	Precision Thermometer & Inst. Co.	Southampton, Pa.	73793	Fischer Special Mfg. Co.	Cincinnati, Ohio	81860	Barry Controls, Div. Barry Wright Corp.	Watertown, Mass.
49956	Microwave & Power Tube Div.	Waltham, Mass.	73846	General Industries Co., The	Elyria, Ohio	82042	Carter Precision Electric Co.	Skokie, Ill.
52090	Rowan Controller Co.	Westminster, Md.	73899	Goshen Stamping & Tool Co.	Goshen, Ind.	82047	Sperti Faraday Inc., Copper Hewitt Electric Div.	Hoboken, N. J.
52983	HP Co., Med. Elec. Div.	Waltham, Mass.	73905	JFD Electronics Corp.	Brooklyn, N. Y.	82116	Electric Regulator Corp.	Norwalk, Conn.
54294	Shallcross Mfg. Co.	Selma, N. C.	73957	Jennings Radio Mfg. Corp.	San Jose, Cal.	82142	Jeffers Electronics Division of Speer Carbon Co.	Du Bois, Pa.
55026	Simpson Electric Co.	Chicago, Ill.	74276	Groove-Pin Corp.	Ridgefield, N. J.	82170	Fairchild Camera & Inst. Corp.	Paramus, N. J.
55933	Sonotone Corp.	Elmsford, N. Y.	74455	Signalite Inc.	Neptune, N. J.	82209	Magurie Industries, Inc.	Greenwich, Conn.
55938	Raytheon Co. Commercial Apparatus & System Div.	So. Norwalk, Conn.	74861	J. H. Winns, and Sons	Winchester, Mass.	82219	Sylvania Electric Prod., Inc.	Emporium, Pa.
56137	Spaulding Fibre Co., Inc.	Tonawanda, N. Y.	74868	Industrial Condenser Corp.	Chicago, Ill.	82376	Astron Corp.	East Newark, Harrison, N. J.
56289	Sprague Electric Co.	North Adams, Mass.		R. F. Products Division of Amphenol-Borg Electronic Corp.	Danbury, Conn.	82389	Switchcraft, Inc.	Chicago, Ill.
58474	Superior Elect. Co.	Bristol, Conn.	74970	E. F. Johnson Co.	Waseca, Minn.	82647	Metals & Controls Inc.	Attleboro, Mass.
59446	Telex Corp.	Tulsa, Okla.	75042	International Resistance Co.	Philadelphia, Pa.	82768	Phillips-Advance Control Co.	Joliet, Ill.
59730	Thomas & Betts Co.	Elizabeth, N. J.	75263	Keystone Carbon Co., Inc.	St. Marys, Pa.	82866	Research Products Corp.	Madison, Wis.
60741	Triplett Electrical Inst. Co.	Bluffton, Ohio	75378	CTS Knights, Inc.	Sandwich, Ill.	82877	Rolton Mfg. Co., Inc.	Woodstock, N. Y.
61775	Union Switch and Signal Div. of Westinghouse Air Brake Co.	Pittsburgh, Pa.	75382	Kulka Electric Corp.	Mt. Vernon, N. Y.	82893	Vector Electronic Co.	Glendale, Cal.
62119	Universal Electric Co.	Owosso, Mich.	75818	Lenz Electric Mfg. Co.	Chicago, Ill.	83058	Carr Fastener Co.	Cambridge, Mass.
63743	Ward-Leonard Electric Co.	Mt. Vernon, N. Y.	75915	Littelfuse, Inc.	Des Plaines, Ill.	83086	New Hampshire Ball Bearing, Inc.	Peterborough, N. H.
64959	Western Electric Co., Inc.	New York, N. Y.	76005	Lord Mfg. Co.	Erie, Pa.	83125	General Instrument Corp.	Darlington, S. C.
65092	Weston Inst. Inc. Weston-Newark	Newark, N. J.	76210	C. W. Marwedel	San Francisco, Cal.	83148	ITT Wire and Cable Div.	Los Angeles, Cal.
66295	Witte Mfg. Co.	Chicago, Ill.	76433	General Instrument Corp.	Newark, N. J.	83186	Victory Eng. Corp.	Springfield, N. J.
66346	Minnesota Mining & Mfg. Co.	St. Paul, Minn.	76487	Micamold Division	Newark, N. J.	83298	Bendix Corp., Red Bank Div.	Red Bank, N. J.
70276	Allen Mfg. Co.	Hartford, Conn.	76493	James Millen Mfg. Co., Inc.	Malden, Mass.	83315	Hubbell Corp.	Mundelein, Ill.
70309	Allied Control	New York, N. Y.	76530	J. W. Miller Co.	Los Angeles, Cal.	83324	Rosan Inc.	Newport Beach, Cal.
70318	Allmetal Screw Product Co., Inc.	Garden City, N. Y.		Cinch-Monadnock, Div. of United Carr Fastener Corp.	San Leandro, Cal.	83330	Smith, Herman H., Inc.	Brooklyn, N. Y.
70417	Amplex, Div. of Chrysler Corp.	Detroit, Mich.	76545	Mueller Electric Co.	Cleveland, Ohio	83332	Tech Labs	Palisades Park, N. J.
70485	Atlantic India Rubber Works, Inc.	Chicago, Ill.	76703	National Union	Newark, N. J.	83385	Central Screw Co.	Chicago, Ill.
70563	Amperite Co., Inc.	Union City, N. J.	76854	Oak Manufacturing Co.	Crystal Lake, Ill.	83501	Gavitt Wire and Cable Co., Div. of Amerace Corp.	Brookfield, Mass.
70674	ADC Products Inc.	Minneapolis, Minn.	77068	The Bendix Corp.	N. Hollywood, Cal.	83594	Burroughs Corp., Electronic Tube Div.	Plainfield, N. J.
70903	Belden Mfg. Co.	Chicago, Ill.	77075	Electrodynamics Div.	N. Hollywood, Cal.	83740	Union Carbide Corp., Consumer Prod. Div.	New York, N. Y.
70998	Bird Electric Corp.	Cleveland, Ohio	77221	Pacific Metals Co.	San Francisco, Cal.	83777	Model Eng. and Mfg., Inc.	Huntington, Ind.
71002	Birnbach Radio Co.	New York, N. Y.		Phaostan Instrument and Electronic Co.	So. Pasadena, Cal.	83821	Loyd Scruggs Co.	Festus, Mo.
71034	Bliley Electric Co., Inc.	Erie, Pa.	77252	Philadelphia Steel and Wire Corp.	Philadelphia, Pa.	83942	Aeronautical Inst. & Radio Co.	Lodi, N. J.
71041	Boston Gear Works Div. of Murray Co. of Texas	Quincey, Mass.	77342	American Machine & Foundry Co.	Princeton, Ind.	84171	Arco Electronics Inc.	Great Neck, N. Y.
71218	Bud Radio, Inc.	Willoughby, Ohio	77630	Potter & Brumfield Div.	Princeton, Ind.	84396	A. J. Glesener Co., Inc.	San Francisco, Cal.
71279	Cambridge Thermionics Corp.	Cambridge, Mass.	77638	TRW Electronic Components Div.	Camden, N. J.	84411	TRW Capacitor Div.	Ogallala, Neb.
71286	Camloc Fastener Corp.	Paramus, N. J.		Rectifier Division	Brooklyn, N. Y.			
71313	Cardwell Condenser Corp.	Lindenhurst, L. I., N. Y.	77764	Resistance Products Co.	Harrisburg, Pa.			
71400	Bussmann Mfg. Div. of McGraw-Edison Co.	St. Louis, Mo.	77969	Rubbercraft Corp. of Calif.	Torrance, Cal.			
71436	Chicago Condenser Corp.	Chicago, Ill.	78189	Shakeproof Division of Illinois Tool Works	Elgin, Ill.			
71447	Calif. Spring Co., Inc.	Pico-Rivera, Cal.	78277	Sigma	So. Braintree, Mass.			
71450	CTS Corp.	Elkhart, Ind.	78283	Signal Indicator Corp.	New York, N. Y.			
71468	ITT Cannon Electric Inc.	Los Angeles, Cal.	78290	Struthers-Dunn Inc.	Pitman, N. J.			
71471	Cinema, Div. Aerovox Corp.	Burbank, Cal.						

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## CODE LIST OF MANUFACTURERS (Continued)

Code No.	Manufacturer	Address	Code No.	Manufacturer	Address	Code No.	Manufacturer	Address
94870	Sarkes Tarzian, Inc.	Bloomington, Ind.	91929	Honeywell Inc., Micro Switch Division	Freeport, Ill.	96095	Hi-Q Div. of Aerovox Corp.	Olean, N.Y.
85454	Boonton Molding Company	Boonton, N.J.	91961	Nahm-Bros. Spring Co.	Oakland, Cal.	96256	Thordarson-Meissner Inc.	Mt. Carmel, Ill.
85471	A. B. Boyd Co.	San Francisco, Cal.	92180	Tru-Connector Corp.	Peabody, Mass.	96296	Solar Mfg. Co.	Los Angeles, Cal.
85474	R. M. Bracamonte & Co.	San Francisco, Cal.	92367	Elgeet Optical Co., Inc.	Rochester, N.Y.	96396	Microswitch, Div. of	
85660	Koiled Kords, Inc.	Hamden, Conn.	92607	Tensolite Insulated Wire Co., Inc.	Tarrytown, N.Y.		Minn.-Honeywell	Freeport, Ill.
85911	Seamless Rubber Co.	Chicago, Ill.	92702	IMC Magnetics Corp.	Westbury, L.I., N.Y.	96330	Carlton Screw Co.	Chicago, Ill.
86174	Fafnir Bearing Co.	Los Angeles, Calif.	92966	Hudson Lamp Co.	Kearney, N.J.	96341	Microwave Associates, Inc.	Burlington, Mass.
86197	Clifton Precision Products Co., Inc.	Clifton Heights, Pa.	93332	Sylvania Electric Prod. Inc., Semiconductor Div.	Woburn, Mass.	96501	Excel Transformer Co.	Oakland, Cal.
86579	Precision Rubber Products Corp.	Dayton, Ohio	93369	Robbins & Myers Inc.	Pallisades Park, N.J.	96508	Xcelite, Inc.	Orchard Park, N.Y.
86684	Radio Corp. of America, Electronic Comp. & Devices Division	Harrison, N.J.	93410	Stemco Controls, Div. of Essex Wire Corp.	Mansfield, Ohio	96733	San Fernando Elec. Mfg. Co.	San Fernando, Cal.
86928	Seastrom Mfg. Co.	Glendale, Cal.	93632	Waters Mfg. Co.	Culver City, Cal.	96881	Thomson Ind. Inc.	Long Island, N.Y.
87034	Marco Industries	Anaheim, Cal.	93929	G.V. Controls	Livingston, N.J.	97464	Industrial Retaining Ring Co.	Irvine, N.J.
87216	Philco Corporation (Lansdale Division)	Lansdale, Pa.	94137	General Cable Corp.	Bayonne, N.J.	97539	Automatic & Precision Mfg.	Englewood, N.J.
87473	Western Fibrous Glass Products Co.	San Francisco, Cal.	94144	Raytheon Co., Comp. Div., Ind. Comp. Operations	Quincy, Mass.	97979	Reon Resistor Corp.	Yonkers, N.Y.
87664	Van Waters & Rogers Inc.	San Francisco, Cal.	94148	Scientific Electronics Products, Inc.	Loveland, Colo.	97983	Litton System Inc., Adler-Westrex Commun. Div.	New Rochelle, N.Y.
87930	Tower Mfg. Corp.	Providence, R.I.	94154	Wagner Elect. Corp., Tung-Sol Div.	Newark, N.J.	98141	R-Tronics, Inc.	Jamaica, N.Y.
88140	Cutler-Hammer, Inc.	Lincoln, Ill.	94197	Curtiss-Wright Corp., Electronics Div.	East Patterson, N.J.	98159	Rubber Teck, Inc.	Gardena, Cal.
88220	Gould-National Batteries, Inc.	St. Paul, Minn.	94222	South Chester Corp.	Chester, Pa.	98220	Hewlett-Packard Co., Medical Elec. Div.	Pasadena, Cal.
88698	General Mills, Inc.	Buffalo, N.Y.	94330	Wire Cloth Products, Inc.	Bellwood, Ill.	98278	Microdot, Inc.	So. Pasadena, Cal.
89231	Graybar Electric Co.	Oakland, Cal.	94375	Automatic Metal Products Co.	Brooklyn, N.Y.	98291	Sealectro Corp.	Mamaronech, N.Y.
89473	G.E. Distributing Corp.	Schenectady, N.Y.	94682	Worcester Pressed Aluminum Corp.	Worcester, Mass.	98376	Zero Mfg. Co.	Burbank, Cal.
89479	Security Co.	Detroit, Mich.	94696	Magnecraft Electric Co.	Chicago, Ill.	98410	Etc. Inc.	Cleveland, Ohio
89665	United Transformer Co.	Chicago, Ill.	95023	George A. Philbrick Researchers, Inc.	Boston, Mass.	98731	General Mills Inc., Electronics Div.	
90030	United Shoe Machinery Corp.	Beverly, Mass.	95146	Alco Elect. Mfg. Co.	Lawrence, Mass.			Minneapolis, Minn.
90179	U.S. Rubber Co., Consumer Ind. & Plastics Prod. Div.	Passaic, N.J.	95236	Allies Products Corp.	Dania, Fla.	98734	Paeco Division of Hewlett-Packard Co.	Palo Alto, Cal.
90365	Belleville Speciality Tool Mfg., Inc.	Belleville, Ill.	95238	Continental Connector Corp.	Woodside, N.Y.	98821	North Hills Electronics, Inc.	Glen Cove, N.Y.
90763	United Carr Fastener Corp.	Chicago, Ill.	95263	Leecraft Mfg. Co., Inc.	Long Island, N.Y.	98978	International Electronic Research Corp.	Burbank, Cal.
90970	Bearing Engineering Co.	San Francisco, Cal.	95265	National Coil Co.	Sheridan, Wyo.	99109	Columbia Technical Corp.	New York, N.Y.
91146	ITT Cannon Elect. Inc., Salem Div.	Salem, Mass.	95275	Vitramon, Inc.	Bridgeport, Conn.	99313	Varian Associates	Palo Alto, Cal.
91260	Connor Spring Mfg. Co.	San Francisco, Cal.	95348	Gordos Corp.	Bloomfield, N.J.	99378	Atlee Corp.	Winchester, Mass.
91345	Miller Dial & Nameplate Co.	El Monte, Cal.	95354	Methode Mfg. Co.	Rolling Meadows, Ill.	99515	Marshall Ind., Capacitor Div.	Monrovia, Cal.
91418	Radio Materials Co.	Chicago, Ill.	95566	Arnold Engineering Co.	Marengo, Ill.	99707	Control Switch Division, Controls Co. of America	El Segundo, Cal.
91506	Augat Inc.	Attleboro, Mass.	95712	Dage Electric Co., Inc.	Franklin, Ind.	99800	Delevan Electronics Corp.	East Aurora, N.Y.
91637	Dale Electronics, Inc.	Columbus, Nebr.	95984	Siemon Mfg. Co.	Wayne, Ill.	99848	Wilco Corporation	Indianapolis, Ind.
91662	Elco Corp.	Willow Grove, Pa.	95987	Weckesser Co.	Chicago, Ill.	99928	Branson Corp.	Whippany, N.J.
91673	Epiphone Inc.	New York, N.Y.	96067	Microwave Assoc. West, Inc.	Sunnyvale, Cal.	99934	Rembrandt, Inc.	Boston, Mass.
91737	Gremar Mfg. Co., Inc.	Wakefield, Mass.				99942	Hoffman Electronics Corp., Semiconductor Division	El Monte, Cal.
91827	K F Development Co.	Redwood City, Cal.				99957	Technology-Instrument Corp. of California	Newbury Park, Cal.
91886	Malco Mfg., Inc.	Chicago, Ill.						

The following HP Vendors have no number assigned in the latest supplement to the Federal Supply Code for Manufacturers Handbook.

0000F	Malco Tool and Die	Los Angeles, Calif.	000CS	Hewlett-Packard Co., Colorado Springs Div.	Colorado Springs, Colorado	000QQ	Cooltron	Oakland, Cal.
0000Z	Willow Leather Products Corp.	Newark, N.J.	000MM	Rubber Eng. & Development	Hayward, Cal.	000WW	California Eastern Lab	Burlington, Cal.
000AB	ETA	England	000NN	A "N" D Mfg. Co.	San Jose, Cal.	000YY	S.K. Smith Co.	Los Angeles, Cal.
000BB	Precision Instrument Comp. Co.	Van Nuys, Cal.						

